

# **JEDEC STANDARD**

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## **Embedded Multi-Media Card (e•MMC) Electrical Standard (5.0)**

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## Foreword

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This standard has been prepared by JEDEC and the MMC Association, hereafter referred to as MMCA. JEDEC took the basic MMCA specification and adopted it for embedded applications, calling it “*e*•MMC.”

The purpose of this standard is the definition of the *e*•MMC Electrical Interface, its environment and handling. It provides guidelines for systems designers. The standard also defines a tool box (a set of macro functions and algorithms) that contributes to reducing design-in effort.

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## Introduction

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The *e*•MMC is a managed memory capable of storing code and data. It is specifically designed for mobile devices. The *e*•MMC is intended to offer the performance and features required by mobile devices while maintaining low power consumption. The *e*•MMC device contains features that support high throughput for large data transfers and performance for small random data more commonly found in code usage. It also contains many security features.

*e*•MMC communication is based on an advanced 11-signal bus. The communication protocol is defined as a part of this standard and referred to as the *e*•MMC mode.

The *e*•MMC standard only covers embedded devices, however, the protocol and commands were originally developed for a removable Device. The spec has been updated to remove references to the removable Device but some functions remain to support backward compatibility.

As used in this document, “shall” or “will” denotes a mandatory provision of the standard. “Should” denotes a provision that is recommended but not mandatory. “May” denotes a feature whose presence does not preclude compliance, which may or may not be present at the option of the implementer.



## EMBEDDED MULTIMEDIA DEVICE PRODUCT STANDARD (*e*•MMC 5.0)

(From JEDEC Board Ballot JCB-13-49, formulated under the cognizance of the JC-64.1 Subcommittee on Electrical Specifications and Command Protocols.)

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### 1 Scope

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This document provides a comprehensive definition of the *e*•MMC Electrical Interface, its environment, and handling. It also provides design guidelines and defines a tool box of macro functions and algorithms intended to reduce design-in overhead.

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### 2 Normative reference

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The following normative documents contain provisions that through reference in this text, constitutes provisions of this standard. For dated references, subsequent amendments to, or revisions of, any of these publications do not apply. However, parties to agreements based on this standard are encouraged to investigate the possibility of applying the most recent editions of the normative documents indicated below. For undated references, the latest edition of the normative document referred to applies.

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### 3 Terms and definitions

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For the purposes of this publication, the following abbreviations for common terms apply:

**Address Space Definitions:**

**Mapped Host Address Space:** the area of the *e*•MMC device that can be accessed by a read command from the host software.

**Private Vendor Specific Address Space:** the area of the *e*•MMC device that cannot be accessed by a read command from the host software. It contains vendor specific internal management data. This data can be either loaded at manufacturing or generated during device operation e.g., Memory Vendor Firmware and mapping tables. It does not contain any data (or portion of data) that was sent from the host to the device.

**Unmapped Host Address Space:** the area of the *e*•MMC device that cannot be accessed by a read command from the host software. It excludes private vendor specific address space. It may contain old host data or copies of host data.

**Block:** A number of bytes, basic data transfer unit

**CID:** Device IDentification register

**CLK:** Clock signal

**CMD:** Command line or *e*•MMC bus command (if extended CMDXX)

**Data Strobe:** Return Clock signal used in HS400 mode

**CRC:** Cyclic Redundancy Check

### 3 Terms and definitions (cont'd)

**CSD:** Device Specific Data register

**DAT:** Data line

**DISCARD:** This command allows the host to identify regions that aren't needed. It does not require action from the device. This is a performance command. For data removal see TRIM.

**DSR:** Driver Stage Register

**D-V<sub>DD</sub>:** + Supply voltage for a cache memory

**D-V<sub>SS</sub>:** + Supply voltage ground for a cache memory

**D-V<sub>DDQ</sub>:** + Supply voltage for a cache memory

**D-V<sub>SSQ</sub>:** + Supply voltage ground for a cache memory

**e•MMC:** embedded MultiMediaCard (The Cache feature is optional and only supports a single VDDi pin)

**e<sup>2</sup>•MMC:** An e•MMC device that supports the e•MMC Cache feature and 3 VDDi pins.

**ERASE:** Block erase operation which does not require actual physical NAND erase operation

**Flash:** A type of multiple time programmable nonvolatile memory

**Group:** A number of write blocks, composite erase and write protect unit

**HS200:** High Speed interface timing mode of up to 200MB/s @200MHz Single Date Rate Bus, 1.8V or 1.2V IOs

**HS400:** High Speed DDR interface timing mode of up to 400MB/s @200MHz Dual Date Rate Bus, 1.8V or 1.2V IOs

**ISI:** InterSymbol Interference (referred to certain Noise type)

**LOW, HIGH:** Binary interface states with defined assignment to a voltage level

**NSAC:** Defines the worst case for the clock rate dependent factor of the data access time

**Non-Persistent:** A part of the storage device that may lose contents after a power cycle

**MSB, LSB:** Most Significant Bit or Least Significant Bit

**OCR:** Operation Conditions Register

**open-drain:** A logical interface operation mode. An external resistor or current source is used to pull the interface level to HIGH, the internal transistor pushes it to LOW

**payload:** Net data

**push-pull:** A logical interface operation mode, a complementary pair of transistors is used to push the interface level to HIGH or LOW

**RCA:** Relative Device Address register

**Reset:** CMD0 with argument of 0x00000000 or 0xF0F0F0F0, H/W reset (or CMD15)

**ROM:** Read Only Memory

**RPMB:** Replay Protected Memory Block

**SSO:** Simultaneous Switching Out (referred as certain type of Noise)

### 3 Terms and definitions (cont'd)

**Secure Purge:** The process operates on the addressable locations.. When the operation is executed it results in removing all the data from the unmapped host address space. This is done in accordance with the Secure Removal Type parameter value of the EXT\_CSD. One or multiple write blocks or write protect groups depending on context.

NOTE The definition of secure purge is technology dependent (the definition above assumes NAND flash). Please refer to the <http://www.killdisk.com/dod.htm> or the following documents for more details. DoD 5220.22M (<http://www.dtic.mil/whs/directives/corres/html/522022m.htm>) and NIST SP 800-88 ([http://csrc.nist.gov/publications/nistpubs/800-88/NISTSP800-88\\_rev1.pdf](http://csrc.nist.gov/publications/nistpubs/800-88/NISTSP800-88_rev1.pdf))

**stuff bit:** Filling 0 bits to ensure fixed length frames for commands and responses

**TAAC:** Defines the time dependent factor of the data access time

**three-state driver:** A driver stage which has three output driver states: HIGH, LOW and high impedance (which means that the interface does not have any influence on the interface level)

**token:** Code word representing a command

**TRIM:** A command which removes data from a write group. When TRIM is executed the region shall read as '0'. This serves primarily as a data removal command. (See Discard for performance command)

**Tuning Process:** A process commonly done by the host to find the optimal sampling point of a data input signals. The device may provide a tuning data block as specified for HS200 mode

**UI:** Unit Interval; It is one bit nominal time. For example, UI=5ns at 200MHz SDR, UI = 2.5ns for 200MHz DDR.

**UTC:** Universal time coordinated

**V<sub>DD</sub>:** represents the common supply in case of a single supply device (VCC=VCCQ) or when related to consumed currents it represents the total consumed current for VCC and VCCQ. Device

**V<sub>SS</sub>:** + Supply voltage ground for Core Device

**V<sub>CC</sub>:** + Supply voltage for Core

**V<sub>CCQ</sub>:** + Supply voltage for I/O

**V<sub>SSQ</sub>:** + Supply voltage ground for I/O

**Write Protection, Permanent:** Write and erase prevention scheme, which once enabled, cannot be reversed.

**Write Protection, Power-on:** Write and erase prevention scheme, which once enabled, can only be reversed when a power failure event, that causes the device to reboot occurs, or the device is reset using the reset pin.

**Write protection, Temporary:** Write and erase prevention scheme that can be enabled and disabled.

---

## 4 System Features

---

The *e*•MMC device is a managed memory, which defines a mechanism for indirect memory accesses to the memory array. This indirect access is often enabled by a separate controller. The advantage of indirect memory access is that the memory device can perform several background memory management tasks without the involvement of the host software. This results in a simpler flash management layer on the host system.

The *e*•MMC device supports the following features:

- System Voltage ( $V_{CC}$  and  $V_{CCQ}$ ) Ranges (Table 1).

**Table 1 — *e*•MMC Voltage Modes**

	<b>High Voltage <i>e</i>•MMC</b>	<b>Dual Voltage <i>e</i>•MMC<sup>1</sup></b>
Communication ( $V_{CCQ}$ )	2.7 – 3.6	1.70 – 1.95, 2.7 – 3.6
Memory Access ( $V_{CC}$ )	2.7 – 3.6	1.70 – 1.95, 2.7 – 3.6

NOTE 1 Refer to Table 178 — *e*•MMC voltage combinations for all the valid combinations of dual voltage devices.

- Eleven-wire bus (clock, Data Strobe, 1 bit command, 8 bit data bus) and a hardware reset.
  - Clock frequencies of 0-200MHz
  - Three different data bus width modes: 1-bit (default), 4-bit, and 8-bit
- Data protection Mechanisms :
  - Password
  - Permanent
  - Power-On
  - Temporary
- Different types of error protected read and write modes:
  - Single Block
  - Multiple Block
- Data Removal Commands:
  - Erase
  - Trim
  - Sanitize
- Protection methods for data during sudden power failures
- Capability for customized solutions using application specific commands
- Power Saving Sleep mode

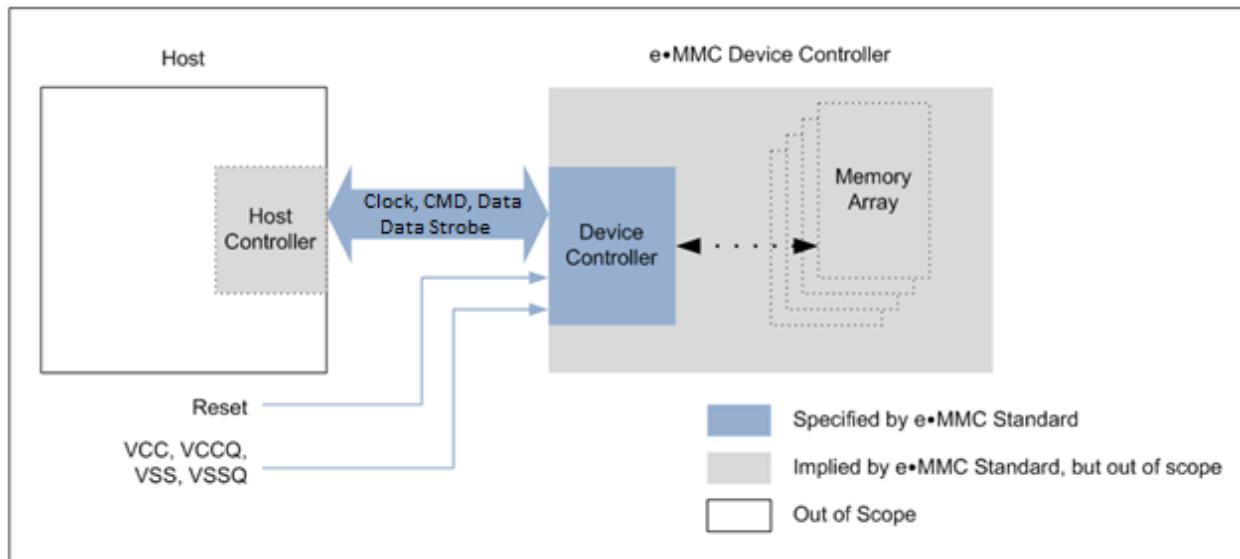
#### 4 System Features (cont'd)

- Enhance host and device communication techniques to improve performance
  - Power Off Notification
  - High Priority Interrupt (HPI)
  - Background Operations
  - Partitioning
  - Enhanced Regions
  - Real Time Clock
  - Partition Attributes
  - Context management
  - System data tagging
  - Packed commands
  - Dynamic Device Capacity
  - Optional Volatile Cache
  - Package Case Temperature
- Boot Areas that will automatically stream data when using defined boot modes.
- Signed access to a Replay Protected Memory Block.
- Two types of high capacity devices: small 512B sector devices and large 4KB sector devices.

## 5 e•MMC Device and System

### 5.1 e•MMC System Overview

The *e*•MMC specification covers the behavior of the interface and the device controller. As part of this specification the existence of a host controller and a memory storage array are implied but the operation of these pieces is not fully specified.



**Figure 1 — *e*•MMC System Overview**

### 5.2 Memory Addressing

Previous implementations of the *e*•MMC specification (versions up to v4.1) implemented byte addressing using a 32 bit field. This addressing mechanism permitted for *e*•MMC densities up to and including 2 GB.

To support larger densities the addressing mechanism was updated to support sector addresses (512 B sectors). The sector addresses shall be used for all devices with capacity larger than 2 GB.

To determine the addressing mode use the host should read bit [30:29] in the OCR register.

### 5.3 e•MMC Device Overview

The *e*•MMC device transfers data via a configurable number of data bus signals. The communication signals are:

- **CLK:** Each cycle of this signal directs a one bit transfer on the command and either a one bit (1x) or a two bits transfer (2x) on all the data lines. The frequency may vary between zero and the maximum clock frequency.
- **Data Strobe:** This signal is generated by the device and used for data output and CRC status response output in HS400 mode. The frequency of this signal follows the frequency of CLK. For data output each cycle of this signal directs two bits transfer(2x) on the data - one bit for positive edge and the other bit for negative edge. For CRC status response output, the CRC status is latched on the positive edge only, and don't care on the negative edge.
- **CMD:** This signal is a bidirectional command channel used for device initialization and transfer of commands. The CMD signal has two operation modes: open-drain for initialization mode, and push-pull for fast command transfer. Commands are sent from the *e*•MMC host controller to the *e*•MMC device and responses are sent from the device to the host.
- **DAT0-DAT7:** These are bidirectional data channels. The DAT signals operate in push-pull mode. Only the device or the host is driving these signals at a time. By default, after power up or reset, only DAT0 is used for data transfer. A wider data bus can be configured for data transfer, using either DAT0-DAT3 or DAT0-DAT7, by the *e*•MMC host controller. The *e*•MMC device includes internal pull-ups for data lines DAT1-DAT7. Immediately after entering the 4-bit mode, the device disconnects the internal pull ups of lines DAT1, DAT2, and DAT3. Correspondingly, immediately after entering to the 8-bit mode the device disconnects the internal pull-ups of lines DAT1–DAT7.

The signals on the *e*•MMC interface are described in Table 2.

**Table 2 — *e*•MMC interface**

Name	Type <sup>1</sup>	Description
CLK	I	Clock
DS	O	Data Strobe
DAT0 <sup>2</sup>	I/O/PP	Data
DAT1	I/O/PP	Data
DAT2	I/O/PP	Data
DAT3	I/O/PP	Data
DAT4	I/O/PP	Data
DAT5	I/O/PP	Data
DAT6	I/O/PP	Data
DAT7	I/O/PP	Data
CMD	I/O/PP/OD	Command/Response
RST_n	I	Hardware reset
VCC	S	Supply voltage for Core
VCCQ	S	Supply voltage for I/O
VSS	S	Supply voltage ground for Core
VSSQ	S	Supply voltage ground for I/O

NOTE 1 I: input; O: output; PP: push-pull; OD: open-drain; NC: Not connected (or logical high); S: power supply.

### 5.3 e•MMC Device Overview (cont'd)

Each device has a set of information registers (see also Section 7 Device Registers):

**Table 3 — e•MMC registers**

Name	Width (bytes)	Description	Implementation
CID	16	Device Identification number, an individual number for identification.	Mandatory
RCA	2	Relative Device Address, is the Device system address, dynamically assigned by the host during initialization.	Mandatory
DSR	2	Driver Stage Register, to configure the Device's output drivers.	Optional
CSD	16	Device Specific Data, information about the Device operation conditions.	Mandatory
OCR	4	Operation Conditions Register. Used by a special broadcast command to identify the voltage type of the Device.	Mandatory
EXT_CSD	512	Extended Device Specific Data. Contains information about the Device capabilities and selected modes. Introduced in standard v4.0	Mandatory

The host may reset the device by:

- Switching the power supply off and back on. The device shall have its own power-on detection circuitry which puts the device into a defined state after the power-on. Device
- A reset signal
- By sending a special command

#### 5.3.1 Bus Protocol

After a power-on reset, the host must initialize the device by a special message-based e•MMC bus protocol. Each message is represented by one of the following tokens:

- command: a command is a token which starts an operation. A command is sent from the host to a device . A command is transferred serially on the CMD line.
- response: a response is a token which is sent from the device to the host as an answer to a previously received command. A response is transferred serially on the CMD line.
- data: data can be transferred from the device to the host or vice versa. Data is transferred via the data lines. The number of data lines used for the data transfer can be 1(DAT0), 4(DAT0-DAT3) or 8(DAT0-DAT7).

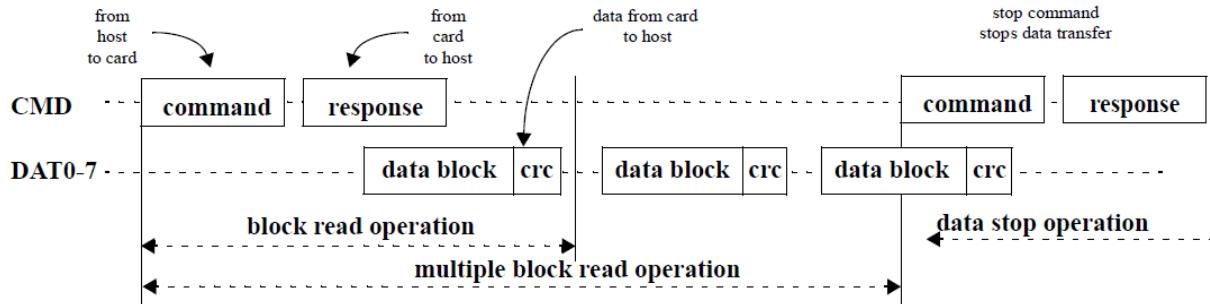
For each data lines, data can be transferred at the rate of one bit (single data rate) or two bits (dual data rate) per clock cycle.

Device addressing is implemented using a session address, assigned during the initialization phase, by the bus controller to the connected device. A device is identified by its CID number. This method requires the device to have a unique CID number. To ensure uniqueness of CIDs the CID register contains 24 bits (MID and OID fields, see 7.2) which are defined by the MMCA/JEDEC. Every device manufacturer is required to apply for an unique MID (and optionally OID) number.

e•MMC bus data transfers are composed of command, response, and data block structure tokens. One data transfer is a *bus operation*. Operations always contain a command and a response token. In addition, some operations have a data token.

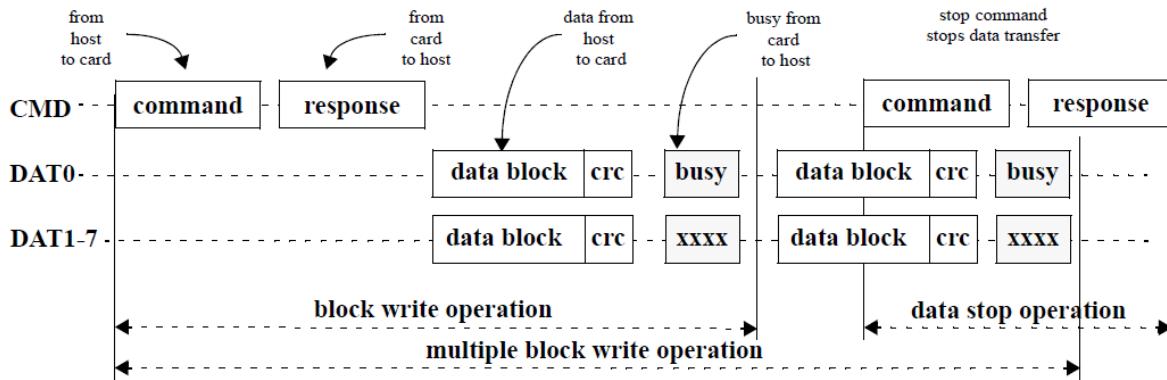
### 5.3.1 Bus Protocol (cont'd)

eMMC commands are Block-oriented commands: These commands send a data block succeeded by CRC bits. Both read and write operations allow either single or multiple block transmission. A multiple block transmission is terminated when a stop command follows on the CMD line similarly to the sequential read.

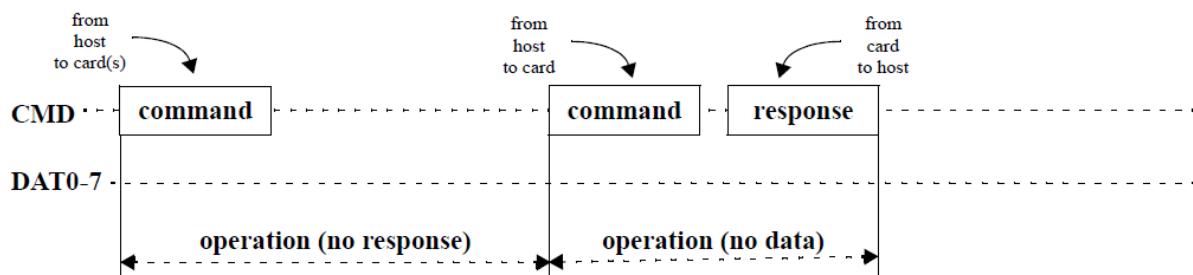


**Figure 2 — Multiple-block read operation**

The block write operation uses a simple busy signaling of the write operation duration on the data (DAT0) line. (See Figure 3)



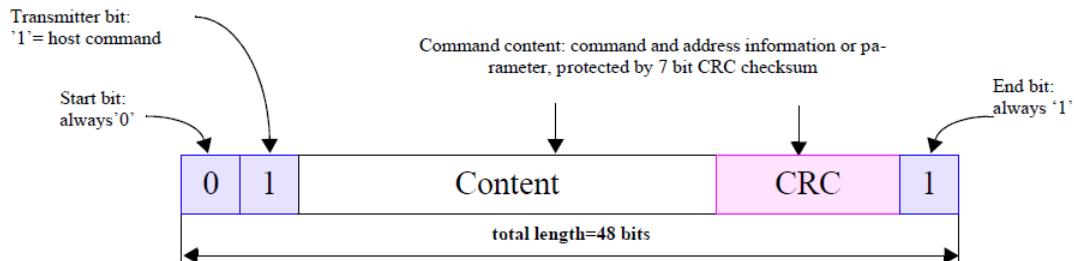
**Figure 3 — (Multiple) Block write operation**



**Figure 4 — "No response" and "no data" operations**

### 5.3.1 Bus Protocol (cont'd)

Command tokens have the following coding scheme:

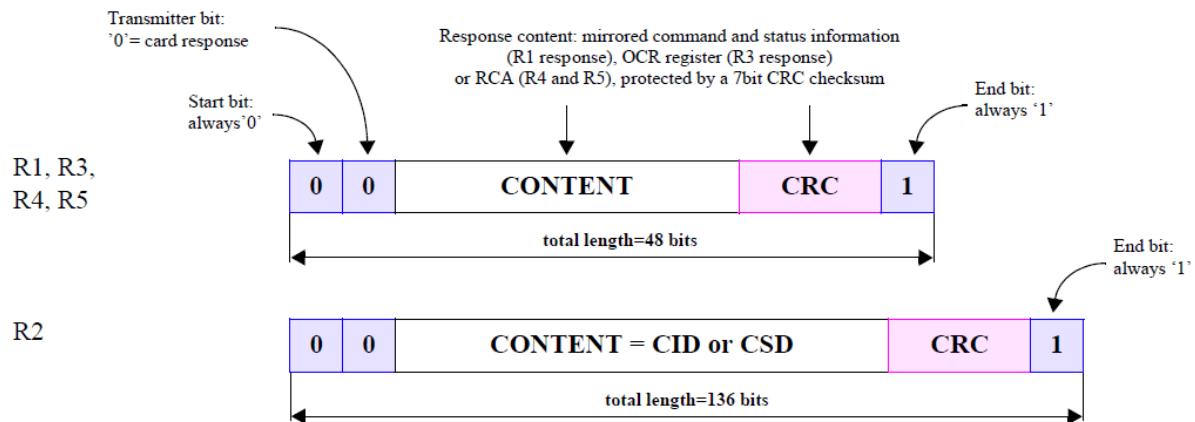


**Figure 5 — Command token format**

Each command token is preceded by a start bit ('0') and succeeded by an end bit ('1'). The total length is 48 bits. Each token is protected by CRC bits so that transmission errors can be detected and the operation may be repeated.

Response tokens have five coding schemes depending on their content. The token length is either 48 or 136 bits. The detailed command and response definitions are provided in 6.10 and 6.12.

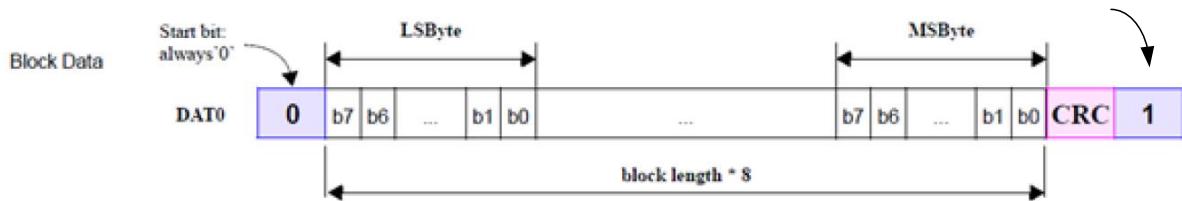
Due to the fact that there is no predefined end in sequential data transfer, no CRC protection is included in this case. The CRC protection algorithm for block data is a 16 bit CCITT polynomial. All used CRC types are described in 8.2.



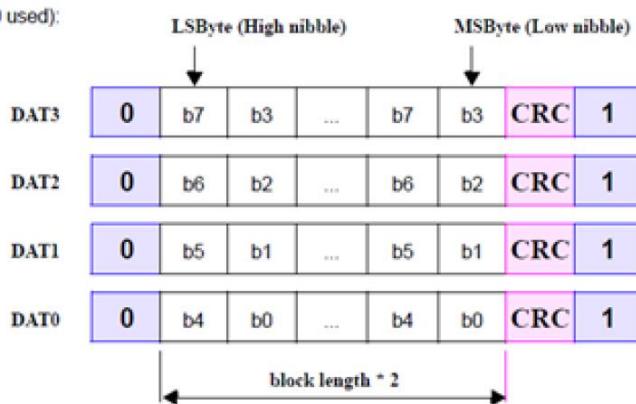
**Figure 6 — Response token format**

### 5.3.1 Bus Protocol (cont'd)

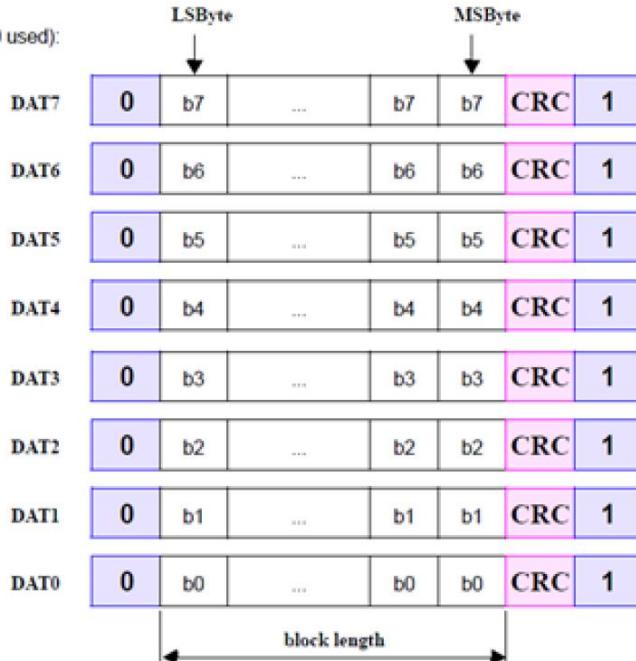
1 Bit bus (only DAT0 used):



4 Bits bus (DAT3-DAT0 used):



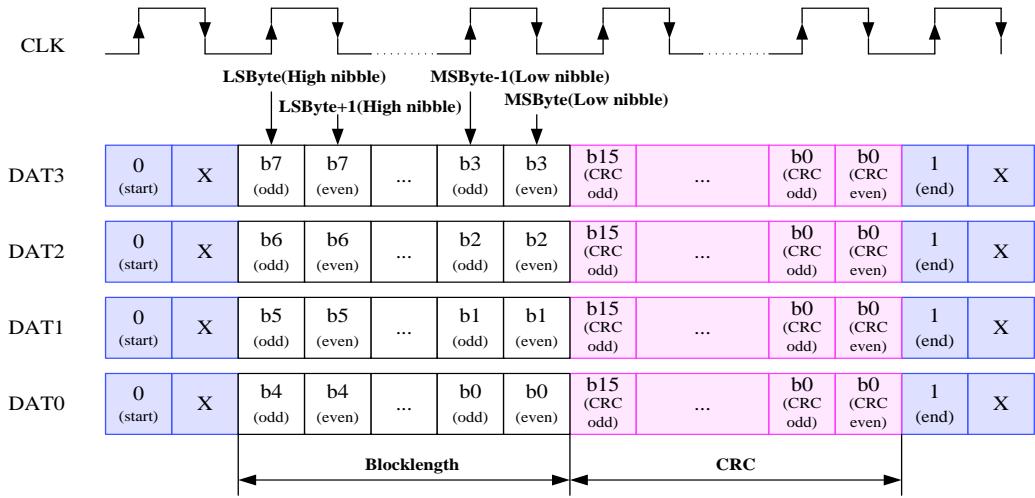
8 Bits bus (DAT7-DAT0 used):



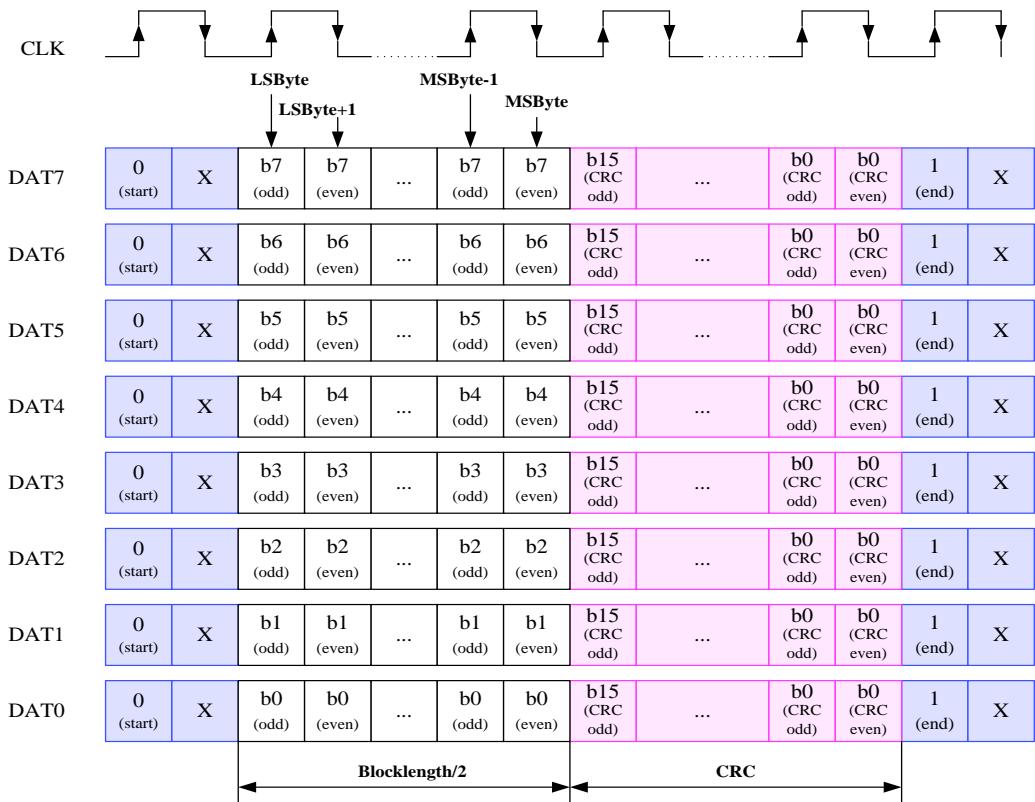
**Figure 7 — Data packet format for SDR**

### 5.3.1 Bus Protocol (cont'd)

4 Bits bus DDR (DAT3-DAT0 used):



8 Bits bus DDR (DAT7-DAT0 used):

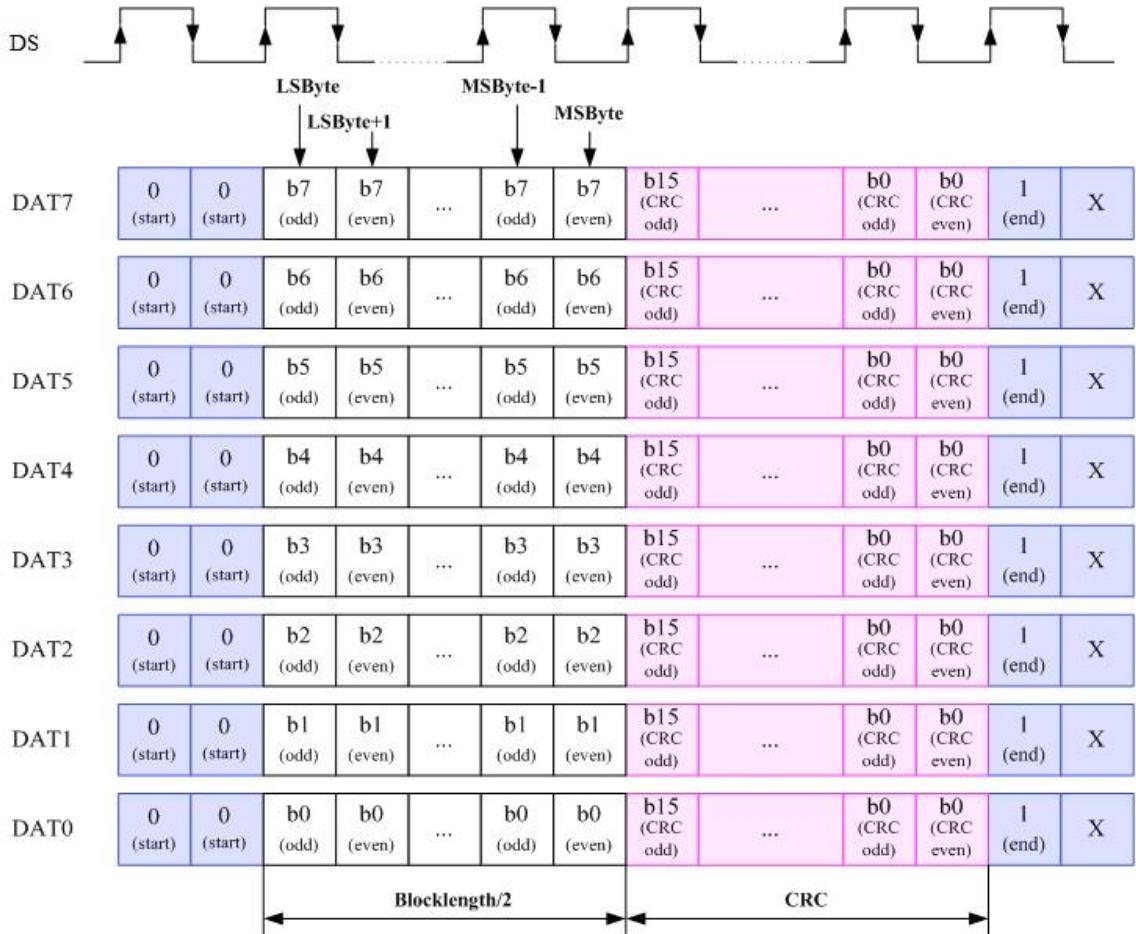


Notice that bytes data are not interleaved but CRC are interleaved  
Start and end bits are only valid on the rising edge. ('X': undefined)

**Figure 8 — Data packet format for DDR**

### 5.3.1 Bus Protocol (cont'd)

8bit bus DDR for HS400 (DAT7-DAT0 used) :



Notice that bytes data are not interleaved but CRC are interleaved

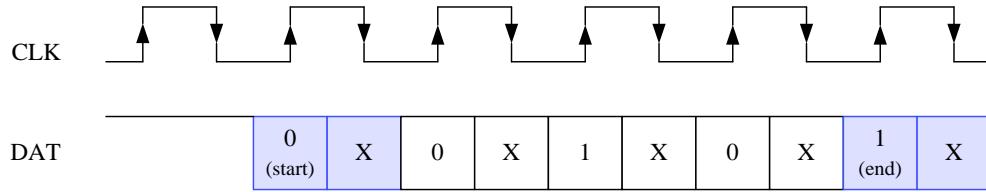
Start bits are valid on the rising and falling edge

End bits are only valid on the rising edge ("x" undefined)

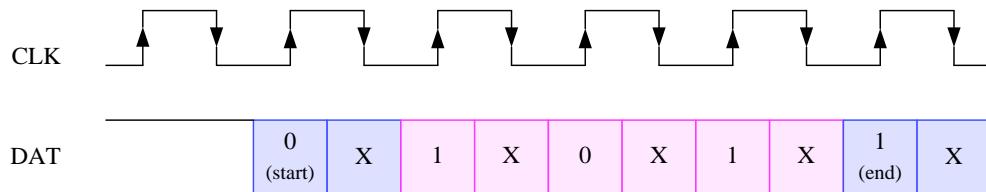
Figure 9 — Data packet format for DDR Read in HS400 mode

### 5.3.1 Bus Protocol (cont'd)

**Positive CRC status token ('010')/Boot acknowledge pattern:**



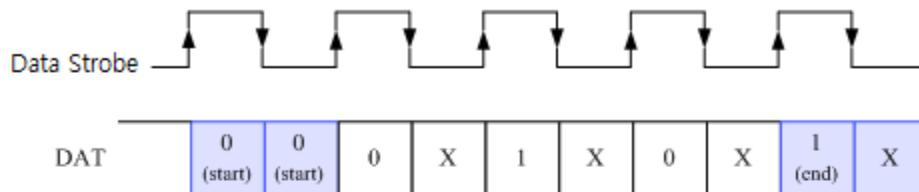
**Negative CRC status token ('101'):**



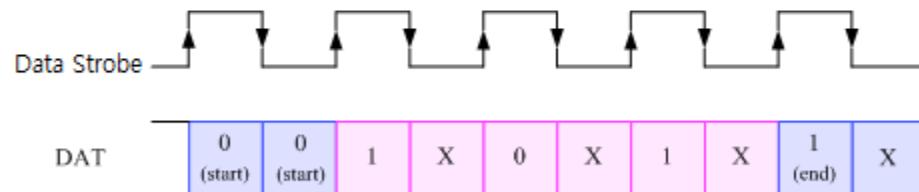
Start, end, CRC status and boot acknowledge bits are only valid on the rising edge ("x" is undefined)

**Figure 10 — DDR52 CRC token**

**Positive CRC status token('010') pattern**



**Negative CRC status token ('101'):**



Start bits are valid in the rising and falling edge  
CRC status and end bit are only valid on the rising edge

**Figure 11 — HS400 CRC token**

### 5.3.2 Bus Speed Modes

*e*MMC defines several bus speed modes. Table 4 — summarizes the various modes.

**Table 4 — Bus Speed Modes**

Mode Name	Data Rate	IO Voltage	Bus Width	Frequency	Max Data Transfer (implies x8 bus width)
Backwards Compatibility with legacy MMC card	Single	3/1.8/1.2V	1, 4, 8	0-26MHz	26MB/s
High Speed SDR	Single	3/1.8/1.2V	1,4, 8	0-52MHz	52MB/s
High Speed DDR	Dual	3/1.8/1.2V	4, 8	0-52MHz	104MB/s
HS200	Single	1.8/1.2V	4, 8	0-200MHz	200MB/s
HS400	Dual	1.8/1.2V	8	0-200MHz	400MB/s

### 5.3.3 HS200 Bus Speed Mode

The HS200 mode offers the following features:

- SDR Data sampling method
- CLK frequency up to 200MHz Data rate – up to 200MB/s
- 4 or 8-bits bus width supported
- Single ended signaling with 4 Drive Strengths
- Signaling levels of 1.8V and 1.2V
- Tuning concept for Read Operations

### 5.3.4 HS200 System Block Diagram

Figure 12 shows a typical HS200 Host and Device system. The host has a clock generator, which supplies CLK to the Device. For write operations, clock and data direction are the same, write data can be transferred synchronous with CLK, regardless of transmission line delay. For read operations, clock and data direction are opposite; the read data received by Host is delayed by round-trip delay, output delay and latency of Host and Device. For reads, the Host needs to have an adjustable sampling point to reliably receive the incoming data.

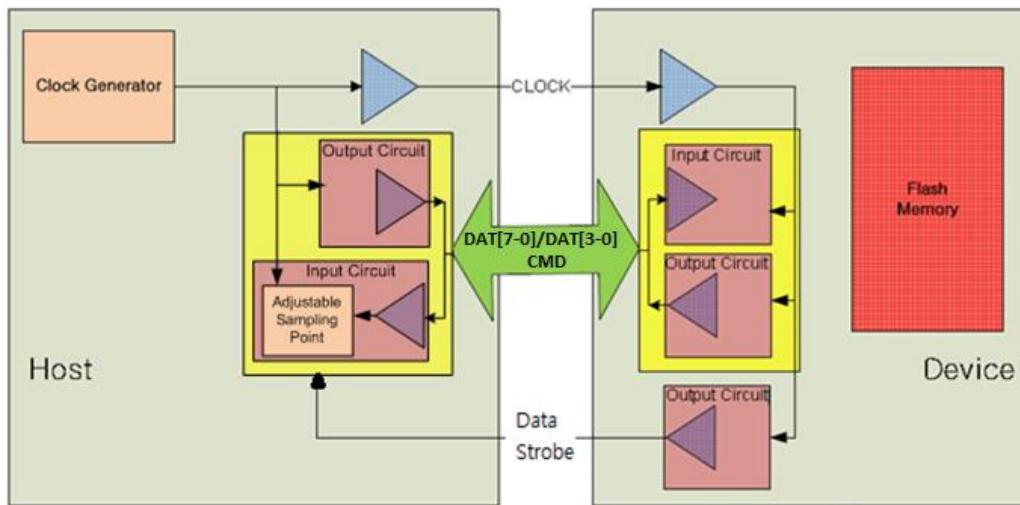


Figure 12 — Host and Device block diagram

### 5.3.5 HS200 Adjustable Sampling Host

The Host may use adjustable sampling to determine the correct sampling point. A predefined tuning block stored in Device may be used by the Host as an aid for finding the optimal data sampling point. The Host can use CMD21 tuning command to read the tuning block.

### 5.3.6 HS400 Bus Speed Mode

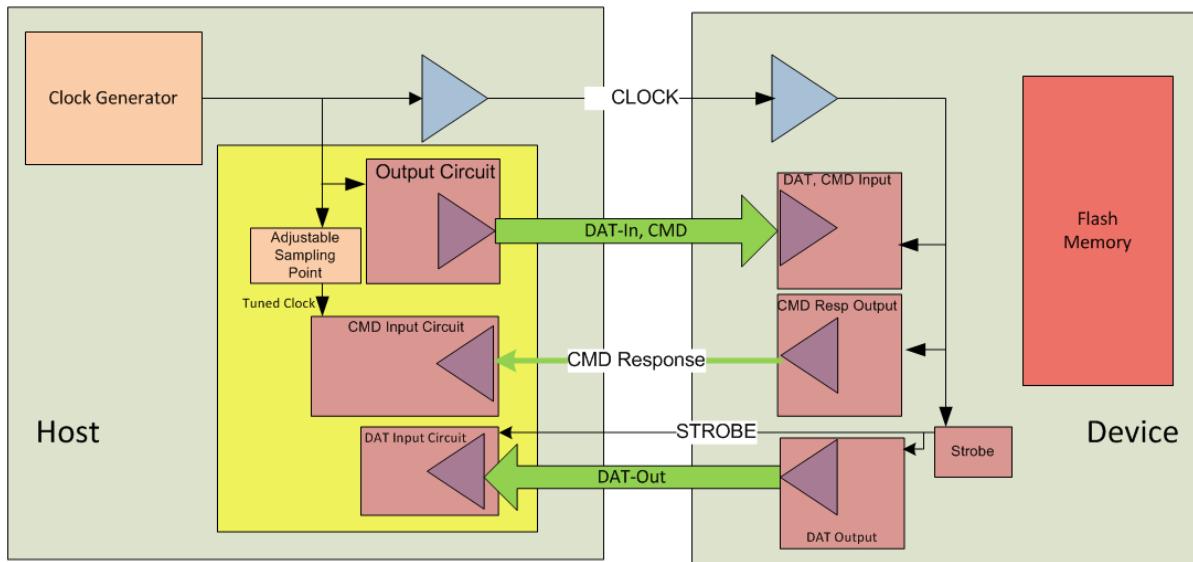
The HS400 mode has the following features

- DDR Data sampling method
- CLK frequency up to 200MHz, Data rate is up to 400MB/s
- Only 8-bit bus width supported
- Signaling levels of 1.8V and 1.2V
- Support up to 5 Drive Strengths
- Data strobe signal is toggled only for Data out and CRC response

### 5.3.7 HS400 System Block Diagram

Figure 13 shows a typical HS400 Host and Device system. The host has a clock generator which supplies CLK to the Device. For read operations, Data Strobe is generated by device output circuit. Host receives the data which is aligned to the edge of Data Strobe.

Clock Mechanism in HS400 using Strobe



**Figure 13 — HS400 Host and Device block diagram**

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## 6 e•MMC functional description

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### 6.1 e•MMC Overview

All communication between host and device are controlled by the host (master). The host sends a command, which results in a device response.

A general overview of the command flow is shown in Figure 22 for the device identification mode and in Figure 25 for the data transfer mode. The commands are listed in the command tables (Table 41 — to Table 50 — ). The dependencies between current state, received command and following state are listed in Table 51 — . Five operation modes are defined for the e•MMC system (hosts and devices):

- Boot mode:  
The device will be in boot mode after power cycle, reception of CMD0 with argument of 0xF0F0F0F0 or the assertion of hardware reset signal.
- Device identification mode  
The device will be in device identification mode after boot operation mode is finished or if host and /or device does not support boot operation mode. The device will be in this mode, until the SET\_RCA command (CMD3) is received.
- Interrupt mode  
Host and device enter and exit interrupt mode simultaneously. In interrupt mode there is no data transfer. The only message allowed is an interrupt service request from the device or the host.
- Data transfer mode  
The device will enter data transfer mode once an RCA is assigned to it. The host will enter data transfer mode after identifying the device on the bus.
- Inactive mode  
The device will enter inactive mode if either the device operating voltage range or access mode is not valid. The device can also enter inactive mode with GO\_INACTIVE\_STATE command (CMD15). The device will reset to *Pre-idle* state with power cycle.

Table 5 shows the dependencies between bus modes, operation modes and device states. Each state in the e•MMC state diagram (see Figure 22 and Figure 25) is associated with one bus mode and one operation mode.

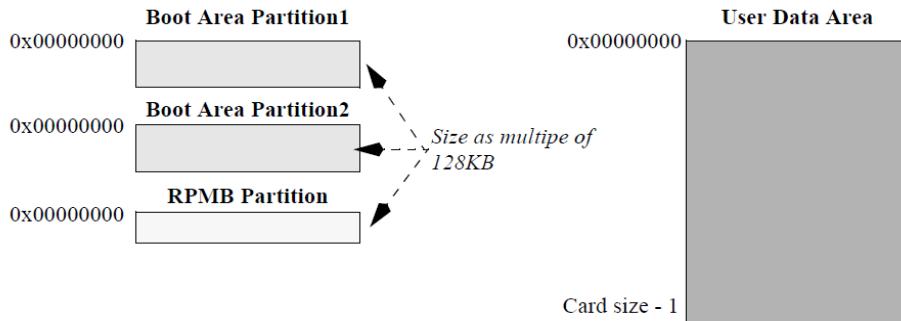
**Table 5 — Bus modes overview**

Device state	Operation mode	Bus mode
Inactive State	Inactive mode	Open-drain
Pre-Idle State	Boot mode	
Pre-Boot State		
Idle State	Device identification mode	
Ready State		
Identification State		
Stand-by State	Data transfer mode	Push-pull
Sleep State		
Transfer State		
Bus-Test State		
Sending-data State		
Receive-data State		
Programming State		
Disconnect State		
Boot State	Boot mode	
Wait-IRQ State	Interrupt mode	Open-drain

## 6.2 Partition Management

### 6.2.1 General

The default area of the memory device consists of a User Data Area to store data, two possible boot area partitions for booting (see 6.3.2) and the Replay Protected Memory Block Area Partition (see 6.6.25) to manage data in an authenticated and replay protected manner. The memory configuration initially consists (before any partitioning operation) of the User Data Area and RPMB Area Partitions and Boot Area Partitions (whose dimensions and technology features are defined by the memory manufacturer).



**Figure 14 — eMMC memory organization at time zero**

The embedded device also offers the host the possibility to configure additional local memory partitions with independent address spaces, starting from logical address 0x00000000, for different usage models.

Therefore the memory block areas can be classified as follows:

- Two Boot Area Partitions, whose size is multiple of 128 KB and from which booting from eMMC can be performed.
- One RPMB Partition accessed through a trusted mechanism, whose size is defined as multiple of 128 KB.
- Four General Purpose Area Partitions to store sensitive data or for other host usage models, whose sizes are a multiple of a Write Protect Group.

Each of the General Purpose Area Partitions can be implemented with enhanced or extended technological features (such as better reliability<sup>1</sup>) that distinguish them from the default storage media. If the enhanced storage media feature is supported by the device, boot and RPMB Area Partitions shall be implemented as enhanced storage media by default.

Boot and RPMB Area Partitions' sizes and attributes are defined by the memory manufacturer (read-only), while General Purpose Area Partitions' sizes and attributes can be programmed by the host only once in the device life-cycle (one-time programmable).

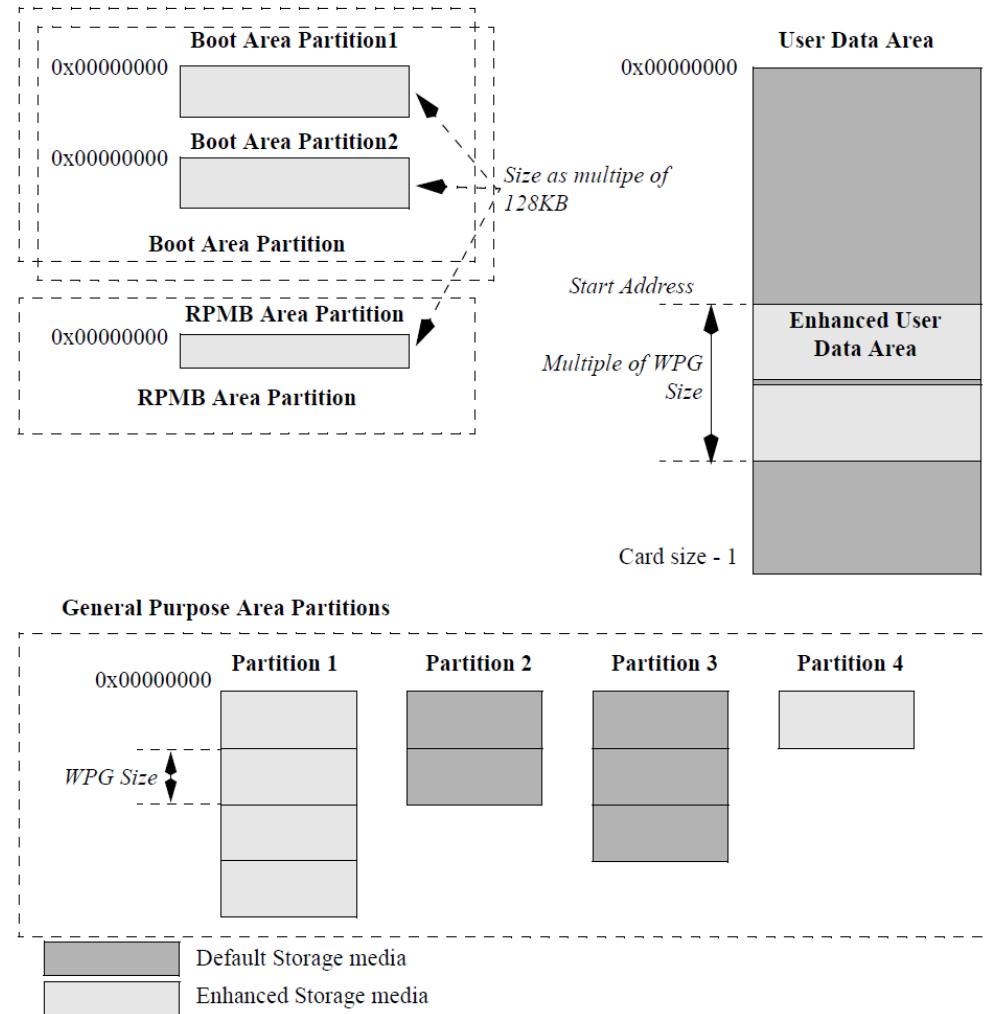
Moreover, the host is free to configure one segment in the User Data Area to be implemented as enhanced storage media, and to specify its starting location and size in terms of Write Protect Groups. The attributes of this Enhanced User Data Area can be programmed only once during the device life-cycle (one-time programmable).

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<sup>1</sup> This is cited as an example of an enhanced storage media characteristic, and should not be considered as a necessary definition of enhanced storage media technology. The definition of enhanced storage media should be decided upon by each system manufacturer, and is outside the scope of this standard.

### 6.2.1 General (cont'd)

A possible final configuration can be the following one:



**Figure 15 — Example of partitions and user data area configuration**

General Purpose Partitions and Enhanced User Data Area configuration by the host can have effects on data previously stored (they will be destroyed) and the device initialization time. In particular, the initialization time after first power cycle subsequent to the configuration can exceed the maximum initialization time defined by the specs since the internal controller could execute operations to set up the configurations stated by the host.

More generally also the following initialization phases can be affected by the new configuration. Max power up timings shall be specified in the device technical literature.

### 6.2.2 Command restrictions

Some restrictions for the commands that can be issued to each partition is defined:

- Boot Partitions
  - Command class 6 (Write Protect) and class 7 (Lock Device) not admitted.
- RPMB Partition
  - Only commands of classes Class0, Class2 and Class4 are admitted. Still usage of any other command than CMD0, CMD6, CMD8, CMD12, CMD13, CMD15 or commands defined in 6.6.25 shall be considered as illegal one.
- General Purpose Partitions
  - Command classes 0, 2, 4, 5, 6 are admitted.
  - Write protection can be set individually for each write protect group in each partition. So the host can set write protection types differently in each write protect group.

In the Enhanced User Data Area, all the commands belonging to the classes admitted in the User Data Area can be issued.

### 6.2.3 Extended Partitions Attribute

Each General Purpose Partition can have a different extended partition attribute. The list of attribute types includes:

- Default – no extended attribute is set
- System code – a partition that is rarely updated and contains important system files (e.g., containing the executable files of the host operating system)
- Non-Persistent – a partition that is used for temporary information (e.g., swap file to extend the host virtual memory space)

Using the extended attribute, the device can optimize the mixture of storage media characteristics to better suit the intended uses per partition.

A single partition cannot have both enhanced and extended attributes set for it.

#### 6.2.4 Configure partitions

Bit 0 (PARTITIONING\_EN) in PARTITIONING\_SUPPORT field of the Properties segment in the Extended CSD register indicate if the memory device supports partitioning features. Bit 1 (ENH\_ATTRIBUTE\_EN) in the same field indicates if the memory device supports enhanced features attribute in the General Purpose Partitions and in the Enhanced User Data Area. Bit 2 (EXT\_ATTRIBUTE\_EN) in the same field indicates if the memory device supports extended partitions attribute in the General Purpose Partitions. For e•MMC 5.0 Devices, Bit 2-0 in PARTITIONING\_SUPPORT shall be set to 1.

The attributes of General Purpose Partitions and Enhanced User Data Area can be programmed by the host setting the corresponding values in the Extended CSD registers only once in the device life-cycle. In particular, the host may issue a SWITCH command to set the R/W field of partition features containing the following parameters.

- General Purpose Partitions - size and attribute of max 4 partitions. The fields in the Modes segment of the EXT\_CSD register to be set are:
  - GP\_SIZE\_MULT\_GP0 - GP\_SIZE\_MULT\_GP3 for the size
  - PARTITIONS\_ATTRIBUTE for the Enhanced attribute
  - EXT\_PARTITIONS\_ATTRIBUTE for the extended attributes
- Enhanced User Data Area - start address and attribute of the region. The fields in the Modes segment of the EXT\_CSD register to be set are:
  - ENH\_START\_ADDR for the start address
  - ENH\_SIZE\_MULT for the size
  - PARTITIONS\_ATTRIBUTE for the Enhanced attribute

The Enhanced User Data Area start address (ENH\_START\_ADDR in the Extended CSD) shall be write protect group aligned. It is a group address in byte units, for densities up to 2GB, and in sector units for densities greater than 2GB. The device will ignore the LSBs below the write group size and will align the Enhanced User Data Area start address to the Write Protect Group the address (in bytes or sectors) belongs to. The address space of the enhanced user data area is continuous to the address for the rest of the user data area (there is no address gap between the enhanced user data area and the rest of the user data area).

The granularity of General Purpose Partitions and of the Enhanced User Data Area is in units of High Capacity Write Protect Group Sizes (see 7.4). When the partition parameters are configured, ERASE\_GROUP\_DEF bit in the Extended CSD shall be set to indicate that High Capacity Erase Group Sizes and High Capacity Write Protect Group Sizes are to be used. If the partition parameters are sent to a device by CMD6 before setting ERASE\_GROUP\_DEF bit, the slave shows SWITCH\_ERROR.

Once the device is partitioned and the configuration is stable, all the Command Class 5 and 6 commands will be referred to the high capacity erase groups and write protect groups.

In addition to partitioning parameters fields mentioned before, the host shall set Bit 0 in PARTITION\_SETTING\_COMPLETED in Modes segment: in this way the host notifies the device that the setting procedure has been successfully completed. This bit setting is to protect partitioning sequence against unexpected power loss event: if a sudden power loss occurs after that partitioning process has been only partially executed, at the next power up the device can detect and invalidate - being this bit not set - the previous incomplete partitioning process giving the host the possibility to repeat and correctly complete it.

#### 6.2.4 Configure partitions (cont'd)

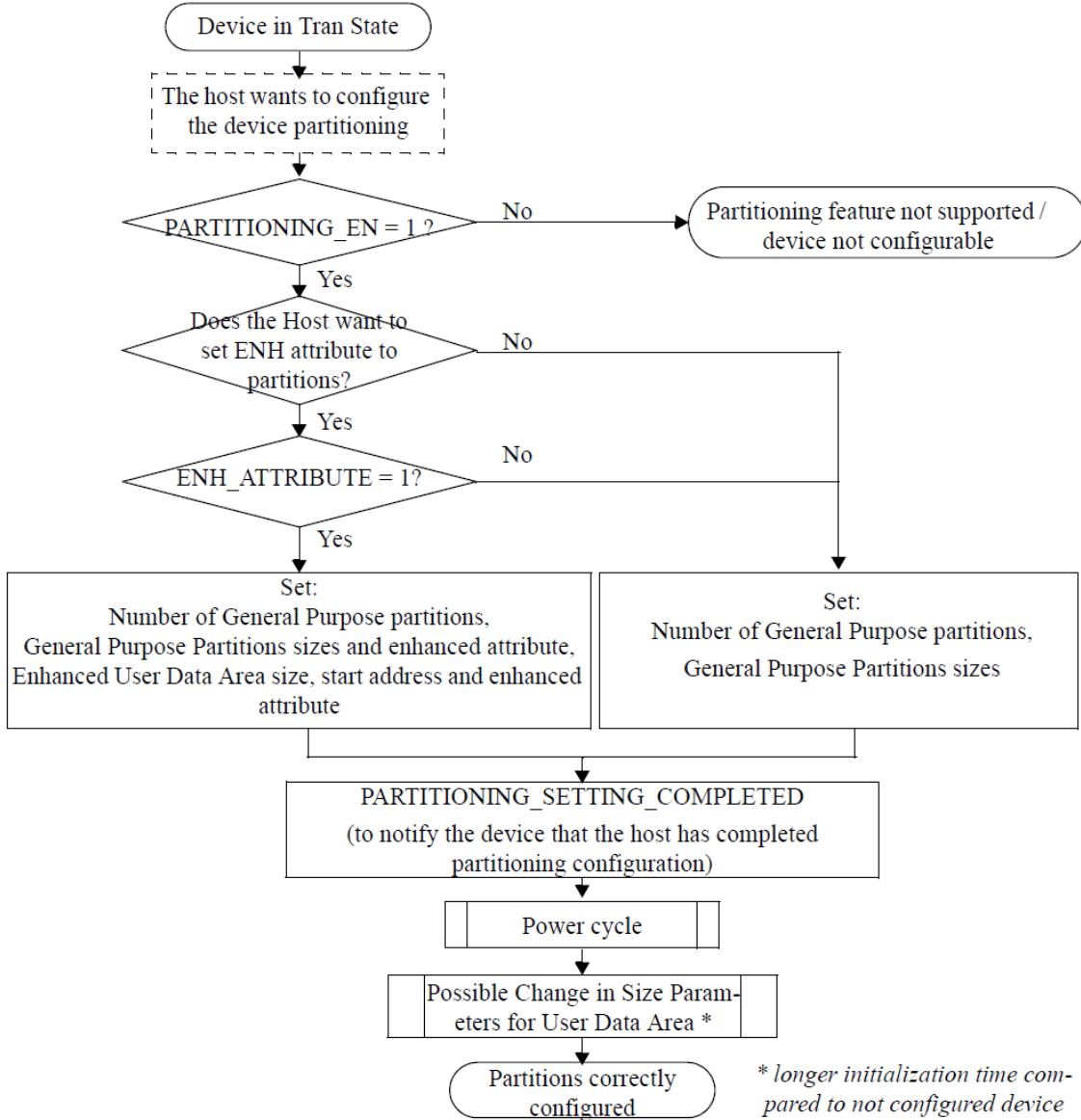


Figure 16 — Flow Chart for General Purpose Partitions & Enhanced User Data Area parameter setting

#### 6.2.4 Configure partitions (cont'd)

A CMD13 shall be issued by the host to make sure that all the parameters are correctly set. If any of the partitioning parameters is not correct a SWITCH\_ERROR will be raised by the device. Since the device will not know the total size of configured partitions and user area until PARTITION\_SETTING\_COMPLETED bit is set, device may show SWITCH\_ERROR when host set PARTITION\_SETTING\_COMPLETED bit, if the total size of the configured partitions and user data area does not fit in the available space of the device. In this case, all the setting will be cleared after the next power cycle. So the host needs to set proper values in each of partition configuration register bytes again.

The device will actually configure itself, according to the partition parameters in the Extended CSD, only after a power cycle. Any valid commands issued after PARTITION\_SETTING\_COMPLETED bit is set but before a power cycle takes place will be normally executed. Any previous incomplete partitioning configuration sequence before this bit is set will be cancelled upon a power cycle.

After the power cycle following the partition configuration, C-SIZE value for up to 2GB devices and SEC\_COUNT value for more than 2GB devices will be changed to indicate the size of user data area after the configuration. The size compared to 2GB shall be the size of user data area before configuring partitions (e.g., for more than 2GB devices before configuring partitions, SEC\_COUNT shall keep indicating the size of user data area after configuring partitions, even if the size is decreased to lower than or equal to 2GB). The size of the user data area includes the size of Enhanced User Data area in the user area. So host may need to read these values after the power cycle to calculate the size of the user data area. Access mode shall keep after configuring partitions.

If the host tries to change General Purpose partitions and Enhanced User Data Area features by using CMD6 after a power up following the configuration procedure, the device will assert the SWITCH\_ERROR bit in the status register of CMD 6 response without performing any internal action.

Partitions configuration parameters are stored in one time programmable fields of the Extended CSD register. The host can read them by a CMD8 even though the PARTITION\_SETTING\_COMPLETED has not yet been set but the execution of partitioning will take place only after the following power up. It is recommended to avoid changes on these parameters after reading them since they are one time programmable fields.

The host shall follow the flow chart in Figure 16 for configuring the parameters of General Purpose Area Partitions and Enhanced User Data Area; otherwise undefined behavior may result.

### 6.2.5 Access partitions

After every power up, when host uses a device in which partition(s) are configured, it must set the ERASE\_GROUP\_DEF bit to high before issuing read, write, erase and write protect commands, because this bit is reset after power up. Otherwise, these may not work correctly and it may leave the stored data in an unknown state.

Each time the host wants to access a partition the following flow shall be executed:

1. Set PARTITION\_ACCESS bits in the PARTITION\_CONFIG field of the Extended CSD register in order to address one of the partitions
2. Issue commands referred to the selected partition
3. Restore default access to the User Data Area or re-direction the access to another partition

All the reset events (CMD0 or hardware reset) will restore the access by default to the User Data Area. If an unwanted power loss occurs, the access will be by default restored to the User Data Area. When the host tries to access a partition which has not been created before, the devices sets the SWITCH\_ERROR bit in the status register and will not change the PARTITION\_ACCESS bits.

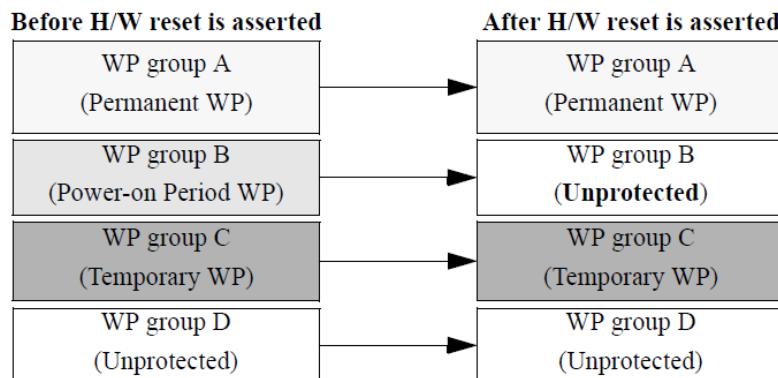
### 6.3 Boot operation mode

In boot operation mode, the master (*e*•MMC host) can read boot data from the slave (*e*•MMC device) by keeping CMD line low or sending CMD0 with argument + 0xFFFFFFFFA, before issuing CMD1. The data can be read from either boot area or user area depending on register setting.

#### 6.3.1 Device reset to Pre-idle state

The device may enter into *Pre-idle* state through any of the following four mechanisms:

- After power-on by the host, the device (even if it has been in *Inactive* state) is in *e*•MMC mode and in *Pre-idle* State.
- GO\_PRE\_IDLE\_STATE command (CMD0 with argument of 0xF0F0F0F0) is the software reset command and puts the device into *Pre-idle* State.
- Hardware reset may be used by host resetting a device , moving the device to *Pre-idle* state and disabling power-on period write protect on blocks which had been set as power-on write protect before the reset was asserted. When the device receives GO\_PRE\_IDLE\_STATE command (CMD0 with argument of 0xF0F0F0F0) or assertion of hardware reset signal during sleep state, the device also moves to *Pre-idle* state.

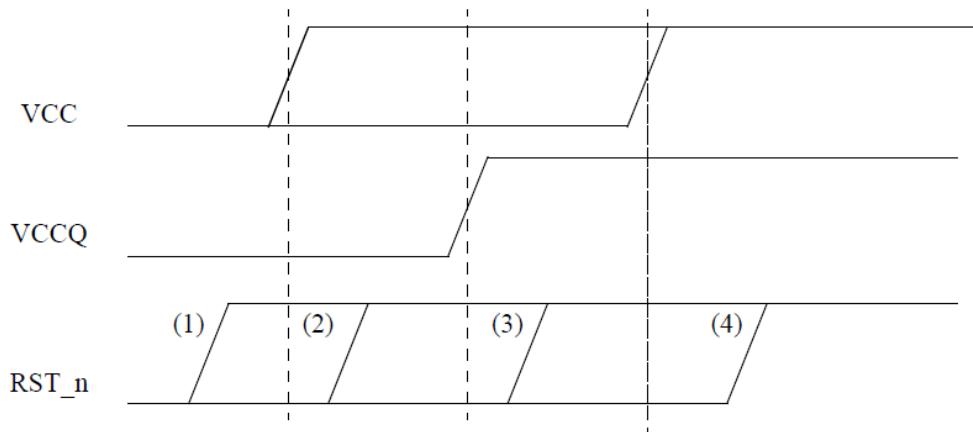


**Figure 17 — WP condition transition due to H/W reset assertion**

### 6.3.1 Device reset to Pre-idle state (cont'd)

GO\_PREIDLE\_STATE command or hardware RESET assertion, the device's output bus drivers are in high-impedance state and the device is initialized with a default relative device address (0x0001) and with a default driver stage register setting, as shown in 7.6.

When device powers up, RST\_n signal also rises with power source ramp up. So the device may detect rising edge of the RST\_n signal at the power up period (either (1), (2), (3) or (4) as shown in below). The device must handle this situation and work properly after the power up.



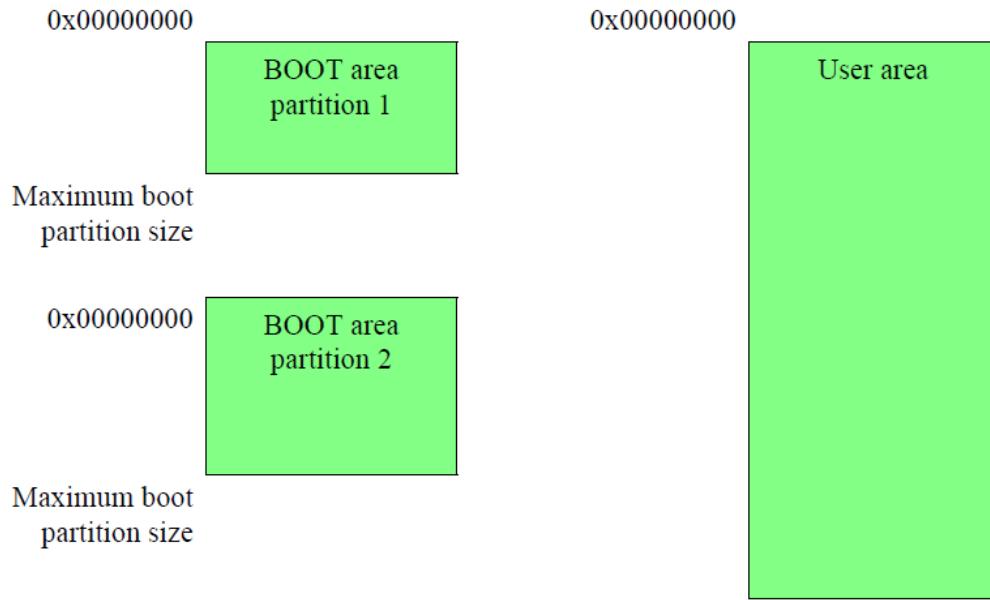
**Figure 18 — RST\_n signal at the power up period**

If the RST\_n signal falls before  $V_{CCQ}$  fully powers up, the  $V_{CCQ}$  rising edge is considered as the falling edge of RST\_n signal. In this case, the pulse width of RST\_n signal should be measured between the rising edge of RST\_n signal and the time  $V_{CCQ}$  powers up.

During the device internal initialization sequence right after power on, device may not be able to detect RST\_n signal, because the device may not complete loading RST\_n\_ENABLE bits of the extended CSD register into the controller yet. However the device already started internal initialization sequence due to power-up, which essentially includes the reset sequence asserted by RST\_n signal. The device may not have to do the reset sequence again but it should complete the internal initialization sequence within 1 second. In this case, the initialization delay should be the longest of 1msec, 74 clock cycles after RST\_n asserted or the supply ramp up time.

### 6.3.2 Boot partition

There are two partition regions. The minimum size of each boot partition is 128KB. Boot partition size is calculated as follows: Maximum boot partition size = 128K byte x BOOT\_SIZE\_MULT  
BOOT\_SIZE\_MULT: the value in Extended CSD register byte [226] The boot partitions are separated from the user area as shown in Figure 19.



**Figure 19 — Memory partition**

Slave has boot configuration in Extended CSD register byte [179]. The master can choose the configuration by setting the register using CMD6 (switch). Slave also can be configured to boot from the user area by setting the BOOT\_PARTITION\_ENABLE bits in the EXT\_CSD register, byte [179] to 111b.

### 6.3.3 Boot operation

If the CMD line is held LOW for 74 clock cycles and more after power-up or reset operation (either through CMD0 with the argument of 0xF0F0F0F0 or assertion of hardware reset for e•MMC, if it is enabled in Extended CSD register byte [162], bits [1:0]) before the first command is issued, the slave recognizes that boot mode is being initiated and starts preparing boot data internally.

The partition from which the master will read the boot data can be selected in advance using EXT\_CSD byte [179], bits [5:3]. The data size that the master can read during boot operation can be calculated as  $128\text{KB} \times \text{BOOT\_SIZE\_MULT}$  (EXT\_CSD byte [226]). Within 1 second after the CMD line goes LOW, the slave starts to send the first boot data to the master on the DAT line(s). The master must keep the CMD line LOW to read all of the boot data. The master must use push-pull mode until boot operation is terminated.

The master can choose to use single data rate mode with backward-compatible interface timing, single data rate with high-speed interface timing or dual data rate timing (if it supported) shown in 10.6 by setting a proper value in EXT\_CSD register byte [177] bits [4:3]. EXT\_CSD register byte [228], bit 2 tells the master if the high-speed timing during boot is supported by the device.

The master can also choose to use the dual data rate mode with interface shown in Table 188 — during boot by setting “10” in EXT\_CSD register byte [177], bits [4:3]. EXT\_CSD register byte [228], bit 1 tells the master if the dual data rate mode during boot is supported by the device.

HS200 & HS400 mode is not supported during boot operation.

The master can choose to receive boot acknowledge from the slave by setting “1” in EXT\_CSD register, byte [179], bit 6, so that the master can recognize that the slave is operating in boot mode.

If boot acknowledge is enabled, the slave has to send acknowledge pattern “010” to the master within 50ms after the CMD line goes LOW. If boot acknowledge is disabled, the slave will not send out acknowledge pattern “0-1-0.”

In the single data rate mode, data is clocked out by the device and sampled by the host with the rising edge of the clock and there is a single CRC per data line.

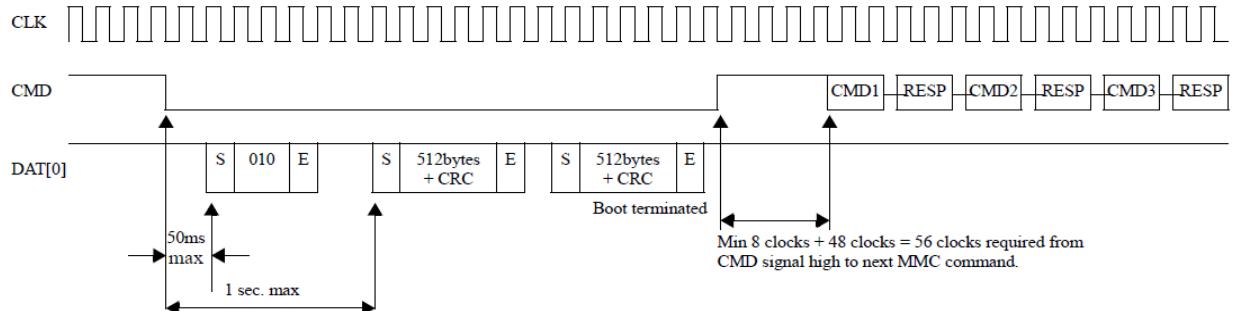
In the dual data rate mode, data is clocked out with both the rising edge of the clock and the falling edge of the clock and there are two CRC appended per data line. In this mode, the block length is always 512 bytes, and bytes come interleaved in either 4-bit or 8-bit width configuration. Bytes with odd number (1,3,5, ..., 511) shall be sampled on the rising edge of the clock by the host and bytes with even number (2,4,6, ..., 512) shall be sampled on the falling edge of the clock by the host. The device will append two CRC16 per each valid data line, one corresponding to the bits of the 256 odd bytes to be sampled on the rising edge of the clock by the host and the second for the remaining bits of the 256 even bytes of the block to be sampled on the falling edge of the clock by the host.

All timings on DAT lines shall follow DDR timing mode. The start bit, the end bit and Boot acknowledge bits are only valid on the rising edge of the clock. The value of the falling edge is not guaranteed.

The master can terminate boot mode with the CMD line HIGH. If the master pulls the CMD line HIGH in the middle of data transfer, the slave has to terminate the data transfer or acknowledge pattern within  $N_{ST}$  clock cycles (one data cycle and end bit cycle). If the master terminates boot mode between consecutive blocks, the slave must release the data line(s) within  $N_{ST}$  clock cycles.

Boot operation will be terminated when all contents of the enabled boot data are sent to the master. After boot operation is executed, the slave shall be ready for CMD1 operation and the master needs to start a normal MMC initialization sequence by sending CMD1.

### 6.3.3 Boot operation (cont'd)



**Figure 20 — e•MMC state diagram (boot mode)**

Detailed timings are shown in 6.15.5. Min 8 clocks + 48 clocks = 56 clocks required from CMD signal high to next e•MMC command. If the CMD line is held LOW for less than 74 clock cycles after power-up before CMD1 is issued, or the master sends any normal e•MMC command other than CMD0 with argument 0xFFFFFFFFFA before initiating boot mode, the slave shall not respond and shall be locked out of boot mode until the next power cycle or hardware reset, and shall enter Idle State.

When BOOT\_PARTITION\_ENABLE bits are set and master send CMD1 (SEND\_OP\_COND), slave must enter device Identification Mode and respond to the command. If the slave does not support boot operation mode, which is compliant with v4.2 or before, or BOOT\_PARTITION\_ENABLE bit is cleared, slave automatically enter Idle State after power-on.

### 6.3.4 Alternative boot operation

This boot function is mandatory for device from v4.4 standard. Device who follows v4.4 standard must show “1” bit 0 in the Extended CSD byte [228]. After power-up or reset operation (either assertion of CMD0 with the argument of 0xF0F0F0F0 or H/W reset if it is enabled), if the host issues CMD0 with the argument of 0xFFFFFFFFFA after 74 clock cycles, before CMD1 is issued or the CMD line goes low, the slave recognizes that boot mode is being initiated and starts preparing boot data internally. The partition from which the master will read the boot data can be selected in advance using EXT\_CSD byte [179], bits [5:3]. The data size that the master can read during boot operation can be calculated as  $128KB \times BOOT\_SIZE\_MULT$  (EXT\_CSD byte [226]). Within 1 second after CMD0 with the argument of 0xFFFFFFFFFA is issued, the slave starts to send the first boot data to the master on the DAT line(s). The master must use push-pull mode until boot operation is terminated. The master can choose to use single data rate mode with backward-compatible interface timing, single data rate with high-speed interface timing or dual data rate timing (if it is supported) shown in 10.7 by setting a proper value in EXT\_CSD register byte [177] bit[4:3]. EXT\_CSD register byte [228], bit 2 tells the master if the high-speed timing during boot is supported by the device.

The master can choose to receive boot acknowledge from the slave by setting “1” in EXT\_CSD register, byte [179], bit 6, so that the master can recognize that the slave is operating in boot mode. If boot acknowledge is enabled, the slave has to send the acknowledge pattern “010” to the master within 50ms after the CMD0 with the argument of 0xFFFFFFFFFA is received. If boot acknowledge is disabled, the slave will not send out acknowledge pattern “010.”

In the single data rate mode, data are clocked out by the device and sampled by the host with the rising edge of the clock and there is a single CRC per data line.

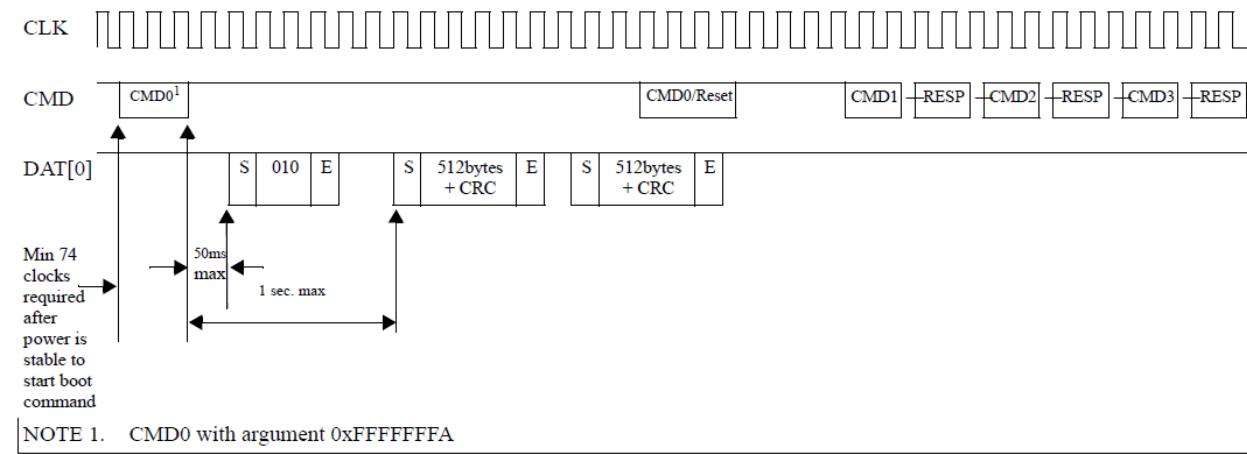
### 6.3.4 Alternative Boot operation (cont'd)

In the dual data rate mode, data are clocked out with both the rising edge of the clock and the falling edge of the clock and there are two CRC appended per data line. In this mode, the block length is always 512 bytes, and bytes come interleaved in either 4-bit or 8-bit width configuration. Bytes with odd number(1,3,5, ..., 511) shall be sampled on the rising edge of the clock by the host and bytes with even number (2,4,6, ..., 512) shall be sampled on the falling edge of the clock by the host. The device will append two CRC16 per each valid data line, one corresponding to the bits of the 256 odd bytes to be sampled on the rising edge of the clock by the host and the second for the remaining bits of the 256 even bytes of the block to be sampled on the falling edge of the clock by the host.

All timings on DAT lines shall follow DDR timing mode. The start bit, the end bit and Boot acknowledge bits are only valid on the rising edge of the clock. The value of the falling edge is not guaranteed.

The master can terminate boot mode by issuing CMD0 (Reset). If the master issues CMD0 (Reset) in the middle of a data transfer, the slave has to terminate the data transfer or acknowledge pattern within  $N_{st}$  clock cycles (one data cycle and end bit cycle). If the master terminates boot mode between consecutive blocks, the slave must release the data line(s) within  $N_{st}$  clock cycles.

Boot operation will be terminated when all contents of the enabled boot data are sent to the master. After boot operation is executed, the slave shall be ready for CMD1 operation and the master needs to start a normal MMC initialization sequence by sending CMD1.



**Figure 21 — eMMC state diagram (alternative boot mode)**

Detailed timings are shown in 6.15.5.

If the CMD line is held LOW for less than 74 clock cycles after power-up before CMD1 is issued, or the master sends any normal MMC command other than CMD1 and CMD0 with argument 0xFFFFFFFFA before initiating boot mode, the slave does not respond and will be locked out of boot mode until the next power cycle and enter *Idle State*.

When BOOT\_PARTITION\_ENABLE bits are set and master send CMD1 (SEND\_OP\_COND), slave must enter Device Identification Mode and respond to the command. If the slave does not support boot operation mode, which is compliant with v4.2 or before, or BOOT\_PARTITION\_ENABLE bit is cleared, slave automatically enter Idle State after power-on.

### 6.3.4 Alternative Boot operation (cont'd)

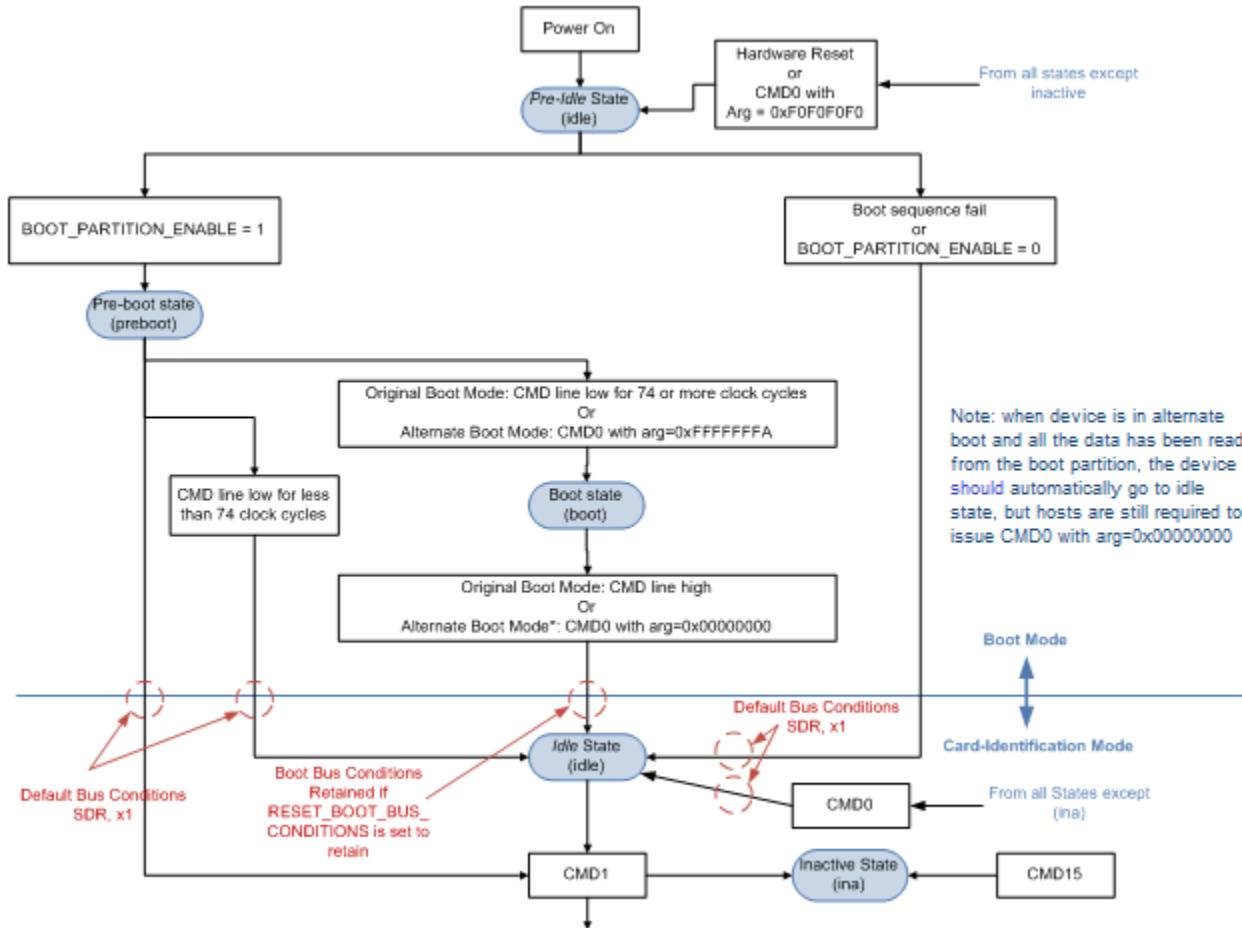
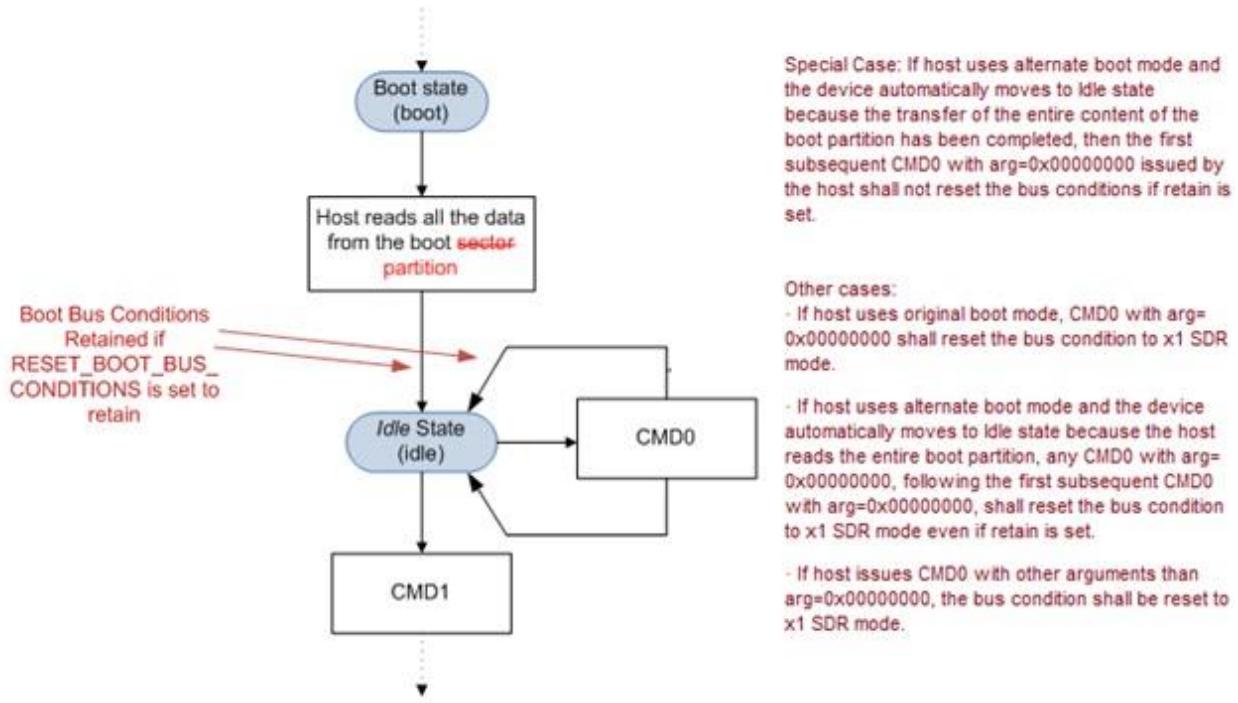


Figure 22 — eMMC state diagram (boot mode)

### 6.3.4 Alternative Boot operation (cont'd)



**Figure 23 — Clarification of RESET\_BOOT\_BUS\_CONDITIONS behavior when CMD0 is issued in IDLE**

### 6.3.5 Access to boot partition

After putting a slave into transfer state, master sends CMD6 (SWITCH) to set the PARTITION\_ACCESS bits in the EXT\_CSD register, byte [179]. After that, master can use normal MMC commands to access a boot partition.

Master can program boot data on DAT line(s) using CMD24 (WRITE\_BLOCK) or CMD25 (WRITE\_MULTIPLE\_BLOCK) with slave supported addressing mode i.e. byte addressing or sector addressing. If the master uses CMD25 (WRITE\_MULTIPLE\_BLOCK) and the writes past the selected partition boundary, the slave will report an “ADDRESS\_OUT\_OF\_RANGE” error. Data that is within the partition boundary will be written to the selected boot partition.

Master can read boot data on DAT line(s) using CMD17 (READ\_SINGLE\_BLOCK) or CMD18 (READ\_MULTIPLE\_BLOCK) with slave supported addressing mode i.e. byte addressing or sector addressing. If the master page uses CMD18 (READ\_MULTIPLE\_BLOCK) and then reads past the selected partition boundary, the slave will report an “ADDRESS\_OUT\_OF\_RANGE” error.

After finishing data access to the boot partition, the PARTITION\_ACCESS bits should be cleared. Then, non-volatile BOOT\_PARTITION\_ENABLE bits in the EXT\_CSD register should be set to indicate which partition is enabled for booting. This will permit the slave to read data from the boot partition during boot operation.

Master also can access user area by using normal command by clearing PARTITION\_ACCESS bits in the EXT\_CSD register, byte [179] to 000b. If user area is locked and enabled for boot, data will not be sent out to master during boot operation mode. However, if the user area is locked and one of the two partitions is enabled, data will be sent out to the master during boot operation mode.

### 6.3.6 Boot bus width and data access configuration

During boot operation, bus width can be configured by non-volatile configuration bits in the Extend CSD register byte[177] bit[0:1]. Bit2 in register byte[177] determines if the slave returns to x1 bus width and single data rate mode with backward compatible timing after a boot operation or if it remains in the configured boot-bus width during normal operation. Bits[4:3] in register byte[177] determines if the data lines are configured for single data rate using backward compatible or high speed timings or dual data rate mode during boot operation. If boot operation is not executed, the slave will initialize in normal x1 bus width, single data rate operation and backward compatible timing regardless of the register setting.

### 6.3.7 Boot Partition Write Protection

In order to allow the host to protect the boot area against erase or write, the *e*MMC shall support two levels of write protection for each of the boot areas: Permanent write protection or power-on write protection. This protection can be applied to each boot area individually or to both regions at the same time using the BOOT\_WP register (EXT\_CSD[173]).

The host must be aware of the following when writing the BOOT\_WP register:

- All the bits BOOT\_WP register, except the two R/W bits B\_PERM\_WP\_DIS (bit 4) and B\_PERM\_WP\_EN (bit 2), shall only be written once per power cycle. The protection mode intended for both boot areas will be set with a single write.
- Two bits in the register are type R/W, B\_PERM\_WP\_DIS (bit 4) and B\_PERM\_WP\_EN (bit 2) the first write to the boot register will permanently set these bits. The flow chart in Figure 24 should be followed for the first write to register BOOT\_WP to properly set these bits.
- If the B\_PERM\_WP\_EN bit is set for only one boot partition, the host should ensure that B\_SEC\_WP\_SEL (bit 7) and B\_PERM\_WR\_SEC\_SEL (bit 3) are set correctly to avoid accidentally permanently protecting the other boot Area.

The host has the ability to disable both permanent and power on write protection in the boot area by setting B\_PERM\_WP\_DIS (EXT\_CSD[173] bit 4) and B\_PWR\_WP\_DIS (EXT\_CSD[173] bit 6). If boot area protection is not required it is recommended that these bits be set in order to ensure that the boot area is not protected unintentionally or maliciously.

### 6.3.7 Boot Partition Write Protection (cont'd)

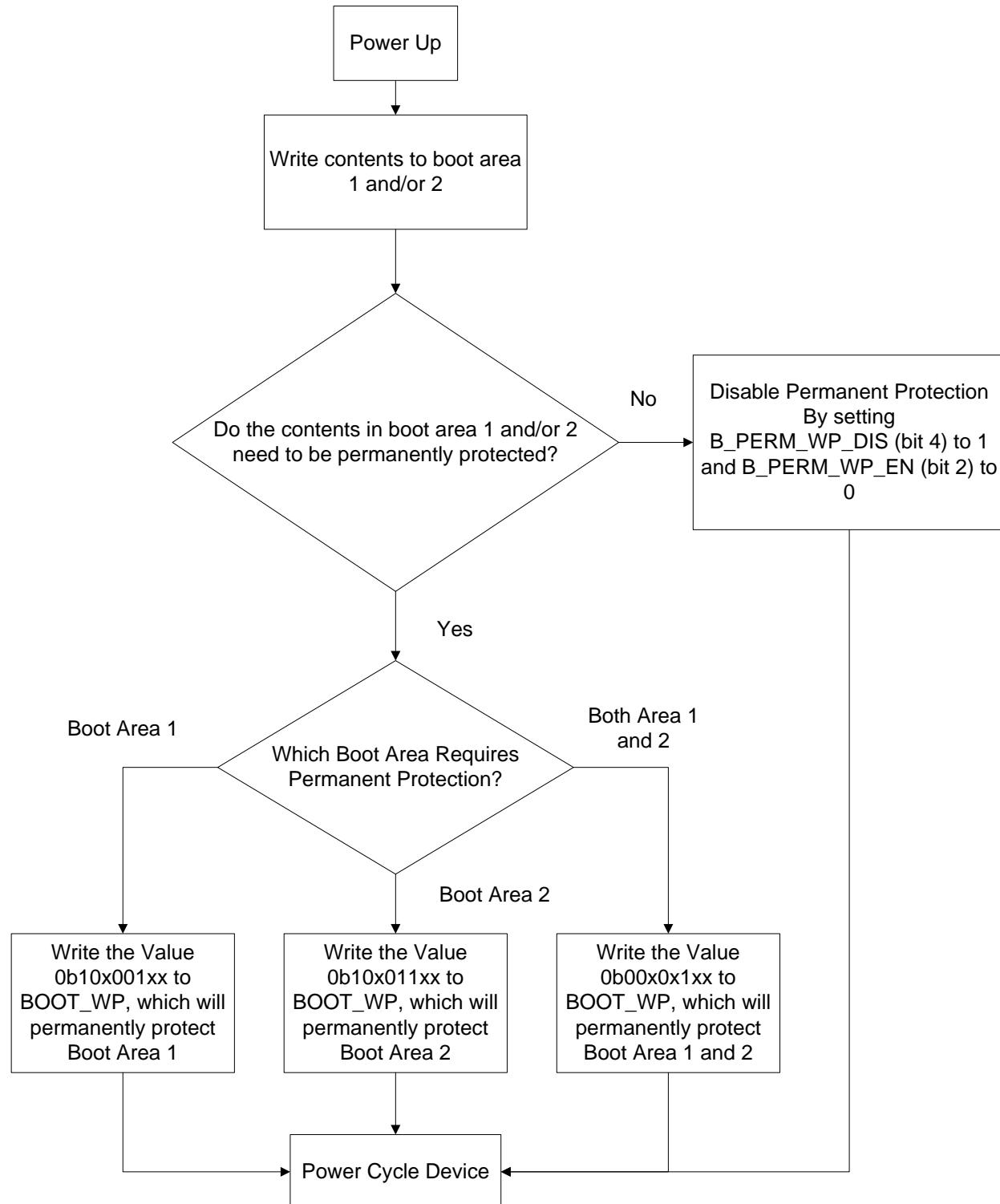


Figure 24 — Setting Ext CSD BOOT\_WP[173]

## 6.4 Device identification mode

While in device identification mode the host resets the device, validates operation voltage range and access mode, identifies the device and assigns a Relative device Address (RCA) to the device on the bus. All data communication in the Device Identification Mode uses the command line (CMD) only.

### 6.4.1 Device reset

After receiving Command GO\_IDLE\_STATE (CMD0 with argument of 0x00000000), the device s go to *Idle* State. Also below are the cases in which device move into *Idle* State.

- After completing boot operation
- After CMD line low for less than 74 clock in pre-boot state
- After power up if the device is not boot enabled

In this state, the device s' output bus drivers are in high-impedance state and the Device is initialized with a default relative Device address (0x0001) and with a default driver stage register setting, as shown in 7.6. The host clocks the bus at the identification clock rate  $f_{OD}$ , as described in 10.6. CMD0 with argument of 0x00000000 is valid in all states, with the exception of *Inactive* State. While in *Inactive* state the Device does not accept CMD0 with argument of 0x00000000.

For backward compatibility reason, if device receive CMD0 with argument of other than 0xFFFFFFF or 0xF0F0F0F0 in any state except *Inactive* state, device shall treat it as Device reset command and move to *Idle* state. CMD0 with argument of 0xFFFFFFF is a boot initiation command in *Pre-boot* state, but if host issue this command in any state except *Inactive* state and *Pre-boot* state, the device shall treat it as a rest command and move to *Idle* state.

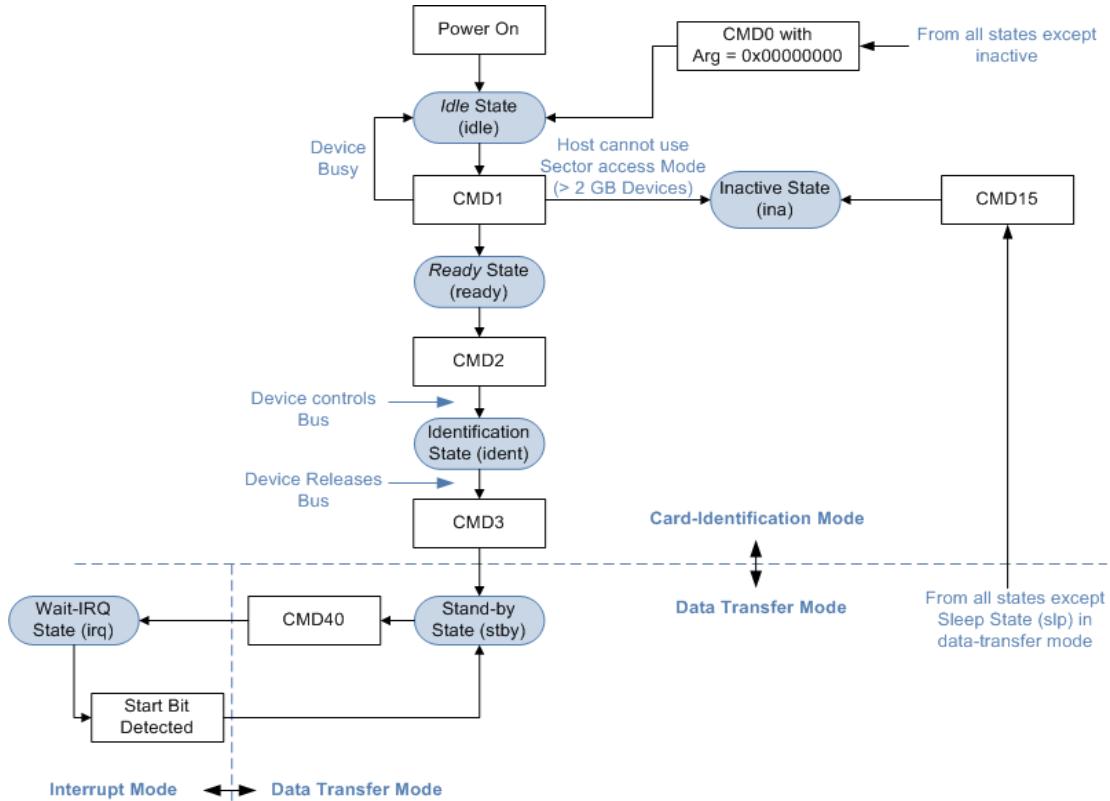


Figure 25 — eMMC state diagram (Device identification mode)

#### 6.4.2 Access mode validation (higher than 2GB of densities)

For *e*•MMC devices, the voltage range in CMD1 is no longer valid. Regardless of the voltage range indicated by the host, the *e*•MMC devices shall respond with a fixed pattern of either 0x00FF 8080 (capacity less than or equal to 2GB) or 0x40FF 8080 (capacity greater than 2GB) if device is busy, and they shall not move into *Inactive* state.

The SEND\_OP\_COND (CMD1) command and the OCR register include two bits for the indication of the supported access mode of the memory. The specifically set bits in the CMD1 command argument are indicating to a memory that the host is capable of handling sector type of addressing. The correspondingly set bits in the OCR register are indicating that the Device is requiring usage of sector type of addressing. These specific bits of the OCR register are valid only in the last response from the device for CMD1 (Device entering Ready state). This kind of two way handshaking is needed so that

- If there is no indication by a host to a memory that the host is capable of handling sector type of addressing the higher than 2GB of density of memory will change its state to *Inactive* (similarly to a situation in which there is no common voltage range to work with) (exception, if a host send 0x0000 0000 for voltage range validation, device shall not change its state to *Inactive* during voltage range validation stage) This will also be true if the operand generated by the host is 0x0000 0000, which does not represent any valid range.
- From the indication of the sector type of addressing requirement in the OCR register the host is able to separate the device from the byte access mode Devices and prepare itself.

The *e*•MMC devices shall respond with a fixed pattern of either 0x00FF 8080 or 0x40FF 8080 if device is busy, 0x80FF8080 (capacity less than or equal to 2GB) or 0xC0FF8080 (capacity greater than 2GB) if device is entering Ready state, and they shall not move into *Inactive* state. The host shall ignore the access mode bits if the device is busy.

Due to legacy reasons a host may need to change the voltage of a device. If the host changes the voltage range from one range to another range, the device shall be fully powered down and then powered up to the new voltage range. Dual voltage devices may fail if the voltage range 1.95V to 2.7 V is used.

The addressing mode should be reconfirmed by the host by reading the SEC\_COUNT information from the EXT\_CSD register.

#### 6.4.3 From busy to ready

The busy bit in the CMD1 response can be used by a device to tell the host that it is still working on its power-up/reset procedure (e.g., downloading the register information from memory field) and is not ready yet for communication. In this case the host must repeat CMD1 until the busy bit is cleared.

During the initialization procedure, the host is not allowed to change the operating voltage range or access mode setting. Such changes shall be ignored by the device. If there is a real change in the operating conditions, the host must reset the device (using CMD0 with argument of 0x00000000) and restart the initialization procedure. However, for accessing devices already in *Inactive* State, a hard reset must be done by switching the power supply off and back on.

The command GO\_INACTIVE\_STATE (CMD15) can be used to send an addressed device into the *Inactive* State. This command is used when the host explicitly wants to deactivate a device.

The command CMD1 shall be implemented by all devices defined by this standard.

#### 6.4.4 Device identification process

The following explanation refers to a Device working in a multi-Device environment, as defined in versions of this standard previous to v4.0, and it is maintained for backwards compatibility to those systems. The host starts the Device identification process in open-drain mode with the identification clock rate  $f_{OD}$ . (See 0) The open drain driver stages on the CMD line allow parallel Device operation during Device identification.

After the bus is activated, the host will request the Devices to send its valid operation conditions (CMD1). The response to CMD1 is the ‘wired and’ operation on the condition restrictions of all Devices in the system. Incompatible Devices are sent into *Inactive* State. The host then issues the broadcast command ALL\_SEND\_CID (CMD2), asking all Devices for its unique Device identification (CID) number. All unidentified Devices (i.e., those which are in *Ready* State) simultaneously start sending their CID numbers serially, while bit-wise monitoring their outgoing bit stream. Those Devices, whose outgoing CID bits do not match the corresponding bits on the command line in any one of the bit periods, stop sending their CID immediately and must wait for the next identification cycle (remaining in the *Ready* State). Since CID numbers are unique for each Device, there should be only one Device which successfully sends its full CID-number to the host. This Device then goes into *Identification* State. Thereafter, the host issues CMD3 (SET\_RELATIVE\_ADDR) to assign to this Device a relative Device address (RCA), which is shorter than CID and which will be used to address the Device in the future data transfer mode (typically with a higher clock rate than  $f_{OD}$ ). Once the RCA is received the Device state changes to the *Stand-by* State, and the Device does not react to further identification cycles. Furthermore, the Device switches its output drivers from open-drain to push-pull.

The host repeats the identification process, i.e., the cycles with CMD2 and CMD3, as long as it receives a response (CID) to its identification command (CMD2). If no more Devices responds to this command, all Devices have been identified. The time-out condition to recognize completion of the identification process is the absence of a start bit for more than  $N_{ID}$  clock cycles after sending CMD2. (See timing values in 6.15)

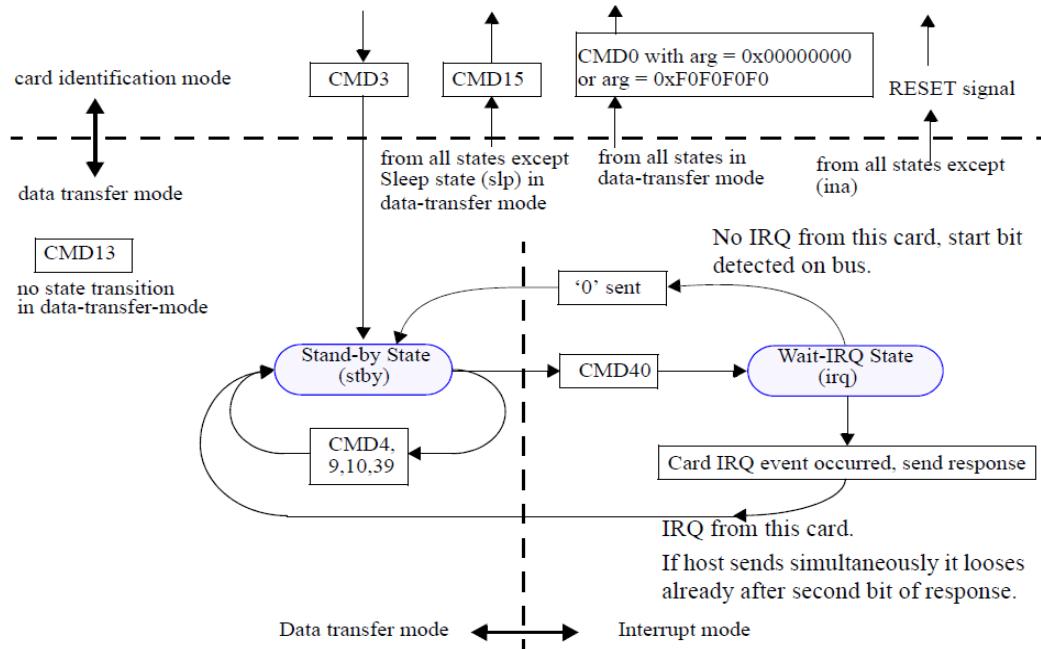
#### 6.5 Interrupt mode

The interrupt mode on the *e*•MMC system enables the master (*e*•MMC host) to grant the transmission allowance to the slaves (Device) simultaneously. This mode reduces the polling load for the host and hence, the power consumption of the system, while maintaining adequate responsiveness of the host to a Device request for service. Supporting *e*•MMC interrupt mode is an option, both for the host and the Device.

- The system behavior during the interrupt mode is described in the state diagram in Figure 26.
- The host must ensure that the Device is in *Stand-by* State before issuing the GO\_IRQ\_STATE (CMD40) command. While waiting for an interrupt response from the Device, the host must keep the clock signal active. Clock rate may be changed according to the required response time.
- The host sets the Device into interrupt mode using GO\_IRQ\_STATE (CMD40) command.
- A Device in Wait-IRQ-State is waiting for an internal interrupt trigger event. Once the event occurs, the Device starts to send its response to the host. This response is sent in the open-drain mode.
- While waiting for the internal interrupt event, the Device is also waiting for a start bit on the command line. Upon detection of a start bit, the Device will abort interrupt mode and switch to the *stand-by* state.

## 6.5 Interrupt mode(cont'd)

- Regardless of winning or losing bus control during CMD40 response, the device switches to *stand-by* state (as opposed to CMD2).
- After the interrupt response was received by the host, the host returns to the standard data communication procedure.



**Figure 26 — eMMC state transition diagram, interrupt mode**

- If the host wants to terminate the interrupt mode before an interrupt response is received, it can generate the CMD40 response by himself (with Device bit = 0) using the reserved RCA address 0x0000; this will bring the Device from Wait-IRQ-State back into the Stand-by-State. Now the host can resume the standard communication procedure.

## 6.6 Data transfer mode

When the Device is in *Stand-by State*, communication over the CMD and DAT lines will be performed in push-pull mode. Until the contents of the CSD register is known by the host, the  $f_{pp}$  clock rate must remain at  $f_{OD}$  (see 0). The host issues SEND\_CSD (CMD9) to obtain the Device Specific Data (CSD register), e.g., block length, Device storage capacity, maximum clock rate, etc.

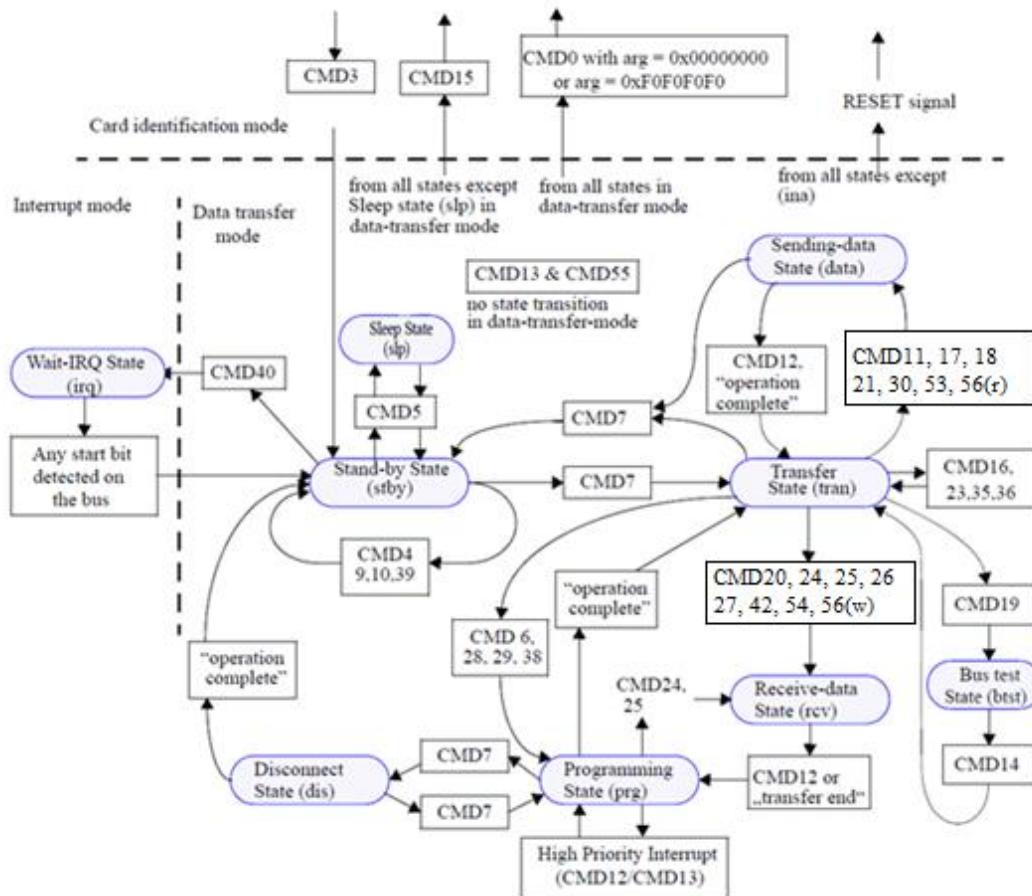


Figure 27 — eMMC state diagram (data transfer mode)

**NOTE** The busy (Dat0=low) is always active during the prg-state. Due to legacy reasons, a Device may still treat CMD24/25 during prg-state (while busy is active) as a legal or illegal command. A host should not send CMD24/25 while the Device is in the prg state and busy is active.

The broadcast command SET\_DSR (CMD4) configures the driver stages of the Device. It programs its DSR register corresponding to the application bus layout (length) and the data transfer frequency. The clock rate is also switched from  $f_{OD}$  to  $f_{pp}$  at that point.

## 6.6 Data transfer mode (cont'd)

While the Device is in *Stand-by* State, CMD7 is used to select the Device and put it into the *Transfer* State by including Device's relative address in the argument. If the Device was previously selected and was in *Transfer* State its connection with the host is released and it will move back to the *Stand-by* State when deselected by CMD7 with any address in the argument that is not equal to Device's own relative address. When CMD7 is issued with the reserved relative Device address "0x0000", the Device is put back to *Stand-by* State. Reception of CMD7 with Device's own relative address while the Device is in *Transfer* State is ignored by the Device and may be treated as an Illegal Command. After the Device is assigned an RCA it will not respond to identification commands — CMD1, CMD2, or CMD3 (see 0).

While the Device is in *Disconnect* State, CMD7 is used to select the Device and put it into the *Programming* State by including Device's relative address in the argument. If the Device was previously selected and was in *Programming* State its connection with the host is released and it will move back to the *Disconnect* State when deselected by CMD7 with any address in the argument that is not equal to Device's own relative address. Reception of CMD7 with Device's own relative address while the Device is in *Programming* State is ignored by the Device and may be treated as an Illegal Command.

All data communication in the Data Transfer Mode is point-to-point between the host and the selected Device (using addressed commands). All addressed commands get acknowledged by a response on the gCMD line.

The relationship between the various data transfer modes is summarized (see Figure 27):

- All data read commands can be aborted any time by the stop command (CMD12). The data transfer will terminate and the Device will return to the *Transfer* State. The read commands are: block read (CMD17), multiple block read (CMD18), send tuning block (CMD21 and send write protect (CMD30)).
- All data write commands can be aborted any time by the stop command (CMD12). The write commands must be stopped prior to deselecting the Device by CMD7. The write commands are: block write (CMD24 and CMD25), write CID (CMD26), and write CSD (CMD27).
- As soon as the data transfer is completed, the Device will exit the data write state and move either to the *Programming* State (transfer is successful) or *Transfer* State (transfer failed).
- If a block write operation is stopped and the block length and CRC of the last block are valid, the data will be programmed.
- The Device may provide buffering for block write. This means that the next block can be sent to the Device while the previous is being programmed.
- There is no buffering option for write CSD, write CID, write protection and erase. This means that while the Device is busy servicing any one of these commands, no other data transfer commands will be accepted. DAT0 line will be kept low as long as the Device is busy and in the *Programming* State.
- Parameter set commands are not allowed while Device is programming. Parameter set commands are: set block length (CMD16), and erase group selection (CMD35-36).
- Read commands are not allowed while Device is programming.
- Moving another Device from *Stand-by* to *Transfer* State (using CMD7) will not terminate a programming operation. The Device will switch to the *Disconnect* State and will release the DAT0 line.
- A Device can be reselected while in the *Disconnect* State, using CMD7. In this case the Device will move to the *Programming* State and reactivate the busy indication.

## 6.6 Data transfer mode (cont'd)

- Resetting a Device (using CMD0, CMD15, or hardware reset for e•MMC) or power failure will terminate any pending or active programming operation. This may leave some or all of the data addressed by the operation in an unknown state unless Reliable Write was enabled. It is the host's responsibility to prevent this.
- Prior to executing the bus testing procedure (CMD19, CMD14), it is recommended to set up the clock frequency used for data transfer. This way the bus test gives a true result, which might not be the case if the bus testing procedure is performed with lower clock frequency than the data transfer frequency.
- The following commands: bus testing (CMD19, CMD14), lock-unlock (CMD42) and set block-length (CMD16) are not allowed once the Device is configured to operate in dual data rate mode and shall not be executed but regarded as illegal commands.

In the following format definitions, all upper case flags and parameters are defined in the CSD (7.3), and the other status flags in the Device Status (6.13).

### 6.6.1 Command sets and extended settings

The Device operates in a given command set, by default, after a power cycle, reset by CMD0 with argument of 0x00000000 or after boot operation; it is the e•MMC standard command set, using a single data line, DAT0. The host can change the active command set by issuing the SWITCH command (CMD6) with the 'Command Set' access mode selected.

The supported command sets, as well as the currently selected command set, are defined in the EXT\_CSD register. The EXT\_CSD register is divided in two segments, a Properties segment and a Modes segment. The Properties segment contains information about the Device capabilities. The Modes segment reflects the current selected modes of the Device.

The host reads the EXT\_CSD register by issuing the SEND\_EXT\_CSD command. The Device sends the EXT\_CSD register as a block of data, 512 bytes long. Any reserved, or write only field, reads as '0'. The host can write the Modes segment of the EXT\_CSD register by issuing a SWITCH command and setting one of the access modes. All three modes access and modify one of the EXT\_CSD bytes, the byte pointed by the Index field.

**NOTE** The Index field can contain any value from 0–255, but only values 0–191 are valid values. If the Index value is in 192–255 range the Device does not perform any modification and the SWITCH\_ERROR status bit is set.

**Table 6 — EXT\_CSD access mode**

Access Bits	Access Name	Operation
00	Command Set	The command set is changed according to the Cmd Set field of the argument
01	Set Bits	The bits in the pointed byte are set, according to the '1' bits in the Value field.
10	Clear Bits	The bits in the pointed byte are cleared, according to the '1' bits in the Value field.
11	Write Byte	The Value field is written into the pointed byte.

The SWITCH command can be used either to write the EXT\_CSD register or to change the command set. If the SWITCH command is used to change the command set, the Index and Value field are ignored, and the EXT\_CSD is not written. If the SWITCH command is used to write the EXT\_CSD register, the Cmd Set field is ignored, and the command set remains unchanged.

The SWITCH command response is of type R1b, therefore, the host should read the Device status, using SEND\_STATUS command, after the busy signal is de-asserted, to check the result of the SWITCH operation.

### 6.6.2 High-speed modes selection

If host wants to operate a device with a clock above 26MHz it shall switch the timing mode to one of supported higher speed timing modes: “High Speed” for frequencies between 26MHz and 52MHz. “HS200” or “HS400” for frequencies above 52MHz up to 200MHz (“High Speed” and either “HS200” or “HS400” timing modes allow operation from 0 to 52MHz and 0 to 200MHz, respectively, as given in Table 4 — ). Note that while the actual timing change is done, the behavior of any command sent (like CMD13) cannot be guaranteed due to the asynchronous operation. Therefore it is not recommended to use CMD13 to check the busy completion of the timing change indication. In case CMD13 is used the host must ignore CRC errors, if appear. Following sections describes the mode selections in detail.

### 6.6.3 “High-speed” mode selection

After the host verifies that the Device complies with version 4.0, or higher, of this standard, it has to enable the high speed mode timing in the Device, before changing the clock frequency to a frequency between 26MHz and 52MHz.

After power-on, or software reset, the interface timing of the Device is set as specified in Table 176 — . For the host to change to a higher clock frequency, it has to enable the high speed interface timing. The host uses the SWITCH command to write 0x01 to the HS\_TIMING byte, in the Modes segment of the EXT\_CSD register.

The valid values for this register are defined in 7.4.60. If the host tries to write an invalid value, the HS\_TIMING byte is not changed, the high speed interface timing is not enabled, and the SWITCH\_ERROR bit is set.

### 6.6.4 “HS200” timing mode selection

HS200 is valid only at Vccq= 1.8V or 1.2V.

The bus width is set to 4 SDR or 8 SDR in HS200 mode.

After the host initializes the device, it must verify that the device supports the HS200 mode by reading the DEVICE\_TYPE field in the Extended CSD register. Then it may enable the HS200 timing mode in the device, before changing the clock frequency to a frequency higher than 52MHz.

After power-on or software reset(CMD0), the interface timing of the device is set as the default “Backward Compatible Timing”. Device shall select HS200 Timing mode if required and perform the Tuning process if needed.

To switch to HS200, host has to perform the following steps:

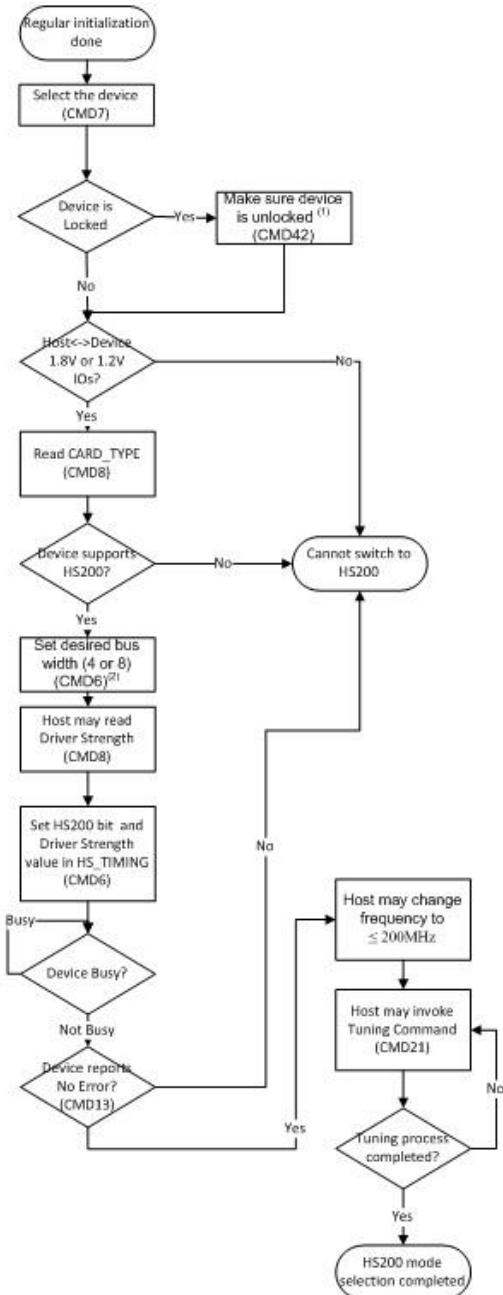
- 1) Select the device (through sending CMD7) and make sure it is unlocked (through CMD42)
- 2) Read the DEVICE\_TYPE [196] field of the Extended CSD register to validate if the device supports HS200 at the IO voltage appropriate for both host and device
- 3) Read the DRIVER\_STRENGTH [197] field of the Extended CSD register to find the supported device Driver Strengths. Note: This step can be skipped if changes of driver strength is not needed
- 4) Set HS200 bit and Driver Strength value in the HS\_TIMING [185] field of the Extended CSD register by issuing CMD6. If the host attempt to write an invalid value, the HS\_TIMING byte is not changed, the HS200 interface timing is not enabled, the Driver Strength is not changed, and the SWITCH\_ERROR bit is set. After the device responds with R1, it might assert Busy signal. Once the busy signal gets de-asserted, the host may send a SEND\_STATUS Command (CMD13) using the HS200 timing and after it receives a Trans State indication and No Error it means that the device is set to HS200 timing and the Driver Strength is set to the selected settings.
- 5) At this point, the host can set the frequency to ≤200MHz.

#### 6.6.4 “HS200” timing mode selection (cont’d)

- 6) The host may invoke the HS200 tuning sequence, by sending CMD21 to the device (see 6.6.8).

Note that the host should switch to the required bus width before starting the tuning operation to allow the tuning sequence to be done using the proper bus operating conditions.

Figure 28 illustrates the process described in 6.6.4



(1) Locked device does not support CMD21 therefore this check may be done any time before CMD21 is used.

(2) The switch to the required bus width may be done any time before the tuning process starts

**Figure 28 — HS200 Selection flow diagram**

### 6.6.5 “HS400” timing mode selection

The valid IO Voltage for HS400 is 1.8V or 1.2V for Vccq.

The bus width is set to only 8 DDR in HS400 mode.

HS400 supports the same commands as DDR52.

After the host initializes the device, host check whether the device supports the HS400 mode by reading the DEVICE\_TYPE field in the Extended CSD register. Then it enables the HS400 mode in the device before changing the clock frequency to a frequency higher than 52MHz.

After power-on or software reset (CMD0), the interface timing of the device is set as the default “Backward Compatible Timing”.

In order to switch to HS400 mode, host should perform the following steps:

- 1) Initialize device with “Backward Compatible Timings”
- 2) Select the device with CMD7.
- 3) Read the DEVICE\_TYPE [196] field of the Extended CSD register to validate whether the device supports HS400
- 4) Read the DRIVER\_STRENGTH [197] field of the Extended CSD register to find the supported device Driver Strengths. (Note: This step may be skipped if changes of driver strength is not needed)
- 5) Set the “Selected Driver Strength” parameter in the HS\_TIMING [185] field of the Extended CSD register to the appropriate driver strength for HS400 operation and set the “Timing Interface” parameter to 0x2 to switch to HS200 mode.
- 6) Perform the Tuning Process at the HS400 target operating frequency (Note: tuning process in HS200 mode is required to synchronize the command response on the CMD line to CLK for HS400 operation).
- 7) After the Tuning Process has completed, set the “Timing Interface” parameter in the HS\_TIMING [185] field of the Extended CSD register to 0x3 to switch to HS400 mode.

### 6.6.6 Power class selection

After the host verifies that the Device complies with v4.0, or higher, of this standard, it may change the power class of the Device. After power-on, or software reset, the Device power class is class 0, which is the default, minimum current consumption class for the Device type, either High Voltage or Dual voltage Device. The PWR\_CL\_ff\_vvv bytes, in the EXT\_CSD register, reflect the power consumption levels of the Device, for a 4 bits bus, an 8 bit bus, at the supported clock frequencies (26MHZ,52MHz or 200 MHz).

The host reads this information, using the SEND\_EXT\_CSD command, and determines if it will allow the Device to use a higher power class. If a power class change is needed, the host uses the SWITCH command to write the POWER\_CLASS byte, in the Modes segment of the EXT\_CSD register.

The valid values for this register are defined in 7.4.50 PWR\_CL\_ff\_vvv [203:200] , PWR\_CL\_ff\_vvv[237:236] , PWR\_CL\_DDR\_ff\_vvv [239:238] and PWR\_CL\_DDR\_FF\_vvv[253]. If the host tries to write an invalid value, the POWER\_CLASS byte is not changed and the SWITCH\_ERROR bit is set.

### 6.6.7 Bus testing procedure

By issuing commands CMD19 and CMD14 in single data rate mode the host can detect the functional pins on the bus. In the dual data rate mode, CMD19 and CMD14 are considered illegal commands. In a first step, the host sends CMD19 to the Device, followed by a specific data pattern on each selected data lines. The data pattern to be sent per data line is defined in the table below. As a second step, the host sends CMD14 to request the Device to send back the reversed data pattern. With the data pattern sent by the host and with the reversed pattern sent back by the Device, the functional pins on the bus can be detected.

**Table 7 — Bus testing pattern**

Start Bit	Data Pattern	End bit
0	1 0 x x x x ... x x	1

The Device ignores all but the two first bits of the data pattern. Therefore, the Device buffer size is not limiting the maximum length of the data pattern. The minimum length of the data pattern is two bytes, of which the first two bits of each data line are sent back, by the Device, reversed. The data pattern sent by the host may optionally include a CRC16 checksum, which is ignored by the Device.

The Device detects the start bit on DAT0 and synchronizes accordingly the reading of all its data inputs.

The host ignores all but the two first bits of the reverse data pattern. The length of the reverse data pattern is eight bytes and is always sent using all the Device's DAT lines (See Table 8 — through Table 10 — ). The reverse data pattern sent by the Device may optionally include a CRC16 checksum, which is ignored by the host.

The Device has internal pull ups in DAT1–DAT7 lines. In cases where the Device is connected to only a 1-bit or a 4-bit HS-MMC system, the input value of the upper bits (e.g., DAT1–DAT7 or DAT4–DAT7) are detected as logical “1” by the Device.

**Table 8 — 1-bit bus testing pattern**

Data line	Data pattern sent by the host	Reversed pattern sent by the Device	Notes
DAT0	0, 10xxxxxxxxxx, [CRC16], 1	0, 01000000, [CRC16], 1	Start bit defines beginning of pattern
DAT1		0, 00000000, [CRC16], 1	No data pattern sent
DAT2		0, 00000000, [CRC16], 1	No data pattern sent
DAT3		0, 00000000, [CRC16], 1	No data pattern sent
DAT4		0, 00000000, [CRC16], 1	No data pattern sent
DAT5		0, 00000000, [CRC16], 1	No data pattern sent
DAT6		0, 00000000, [CRC16], 1	No data pattern sent
DAT7		0, 00000000, [CRC16], 1	No data pattern sent

### 6.6.7 Bus testing procedure (cont'd)

**Table 9 — 4-bit bus testing pattern**

Data line	Data pattern sent by the host	Reversed pattern sent by the Device	Notes
DAT0	0, 10xxxxxxxxxx, [CRC16], 1	0, 01000000, [CRC16], 1	Start bit defines beginning of pattern
DAT1	0, 01xxxxxxxxxx, [CRC16], 1	0, 10000000, [CRC16], 1	
DAT2	0, 10xxxxxxxxxx, [CRC16], 1	0, 01000000, [CRC16], 1	
DAT3	0, 01xxxxxxxxxx, [CRC16], 1	0, 10000000, [CRC16], 1	
DAT4		0, 00000000, [CRC16], 1	No data pattern sent
DAT5		0, 00000000, [CRC16], 1	No data pattern sent
DAT6		0, 00000000, [CRC16], 1	No data pattern sent
DAT7		0, 00000000, [CRC16], 1	No data pattern sent

**Table 10 — 8-bit bus testing pattern**

Data line	Data pattern sent by the host	Reversed pattern sent by the Device	Notes
DAT0	0, 10xxxxxxxxxx, [CRC16], 1	0, 01000000, [CRC16], 1	Start bit defines beginning of pattern
DAT1	0, 01xxxxxxxxxx, [CRC16], 1	0, 10000000, [CRC16], 1	
DAT2	0, 10xxxxxxxxxx, [CRC16], 1	0, 01000000, [CRC16], 1	
DAT3	0, 01xxxxxxxxxx, [CRC16], 1	0, 10000000, [CRC16], 1	
DAT4	0, 10xxxxxxxxxx, [CRC16], 1	0, 01000000, [CRC16], 1	
DAT5	0, 01xxxxxxxxxx, [CRC16], 1	0, 10000000, [CRC16], 1	
DAT6	0, 10xxxxxxxxxx, [CRC16], 1	0, 01000000, [CRC16], 1	
DAT7	0, 01xxxxxxxxxx, [CRC16], 1	0, 10000000, [CRC16], 1	

### 6.6.8 Bus Sampling Tuning Concept

Optimal data sampling point in the Host may be found by performing tuning process executed by Host. After Device has entered HS200 mode, the tuning procedure may begin. Using this method, the best sampling point is found by scanning the whole UI with the tuning scheme.

The following is an example of a Host sampling point Tuning scheme (see 0 for conceptual block diagram of HS200):

1. Sampling Control Block of Host is reset.
2. ‘Send Tuning Block’ command is issued by Host, to read tuning block.
3. Tuning block is sent by Device as read data. The Host receives it and compares it with a known tuning block pattern.
4. Sampling Control Block of Host is incremented by one step.
5. A read command for the next tuning block is issued by Host.

Steps 3 to 5 should be repeated to cover full UI.

When the entire UI is covered, the Host is able to identify the available valid window. The Host decides the value of the Sampling Control Block (may be set to center of the valid window). After Host sampling point tuning has been completed, Read/Write operations execution may begin.

NOTE This example is given for concept explanation purpose. The Host may use any other implementation according to its design consideration.

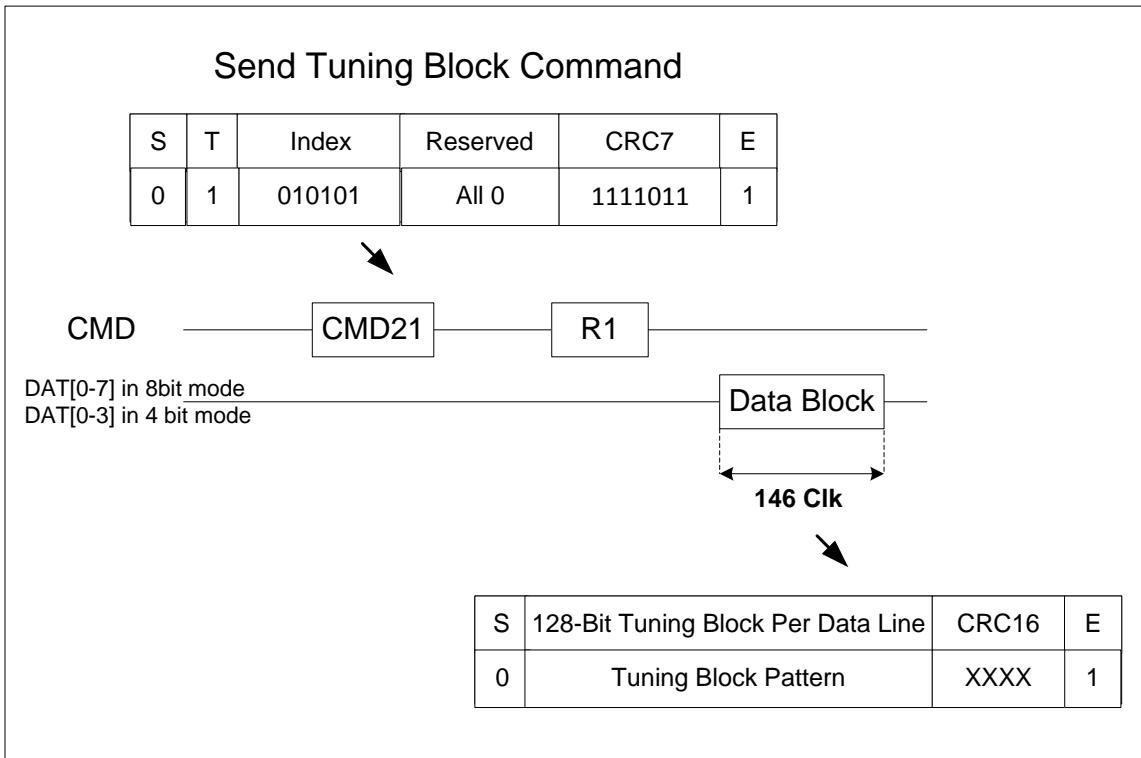
### 6.6.8.1 Sampling Tuning Sequence for HS200

A sampling-tuning sequence may be done by the host when switching to the HS200 mode, to compensate for timing variations due to different silicon processes, PCB loads, voltages, temperatures and other factors. The frequency of use and the implementation of the tuning process will be dependent on the implementation of the host and the system.

Upon host request, the device transmits 128 clocks of data bits containing 64 or 128-bytes block in case of 4 bit or 8 bit, respectively, with a known data pattern to the host, which in turn uses it to find the optimal sampling point for the data lines.

CMD21 (named “Send Tuning Block”) is used for sending the tuning block. CMD21 is followed by R1 type response. CMD21 is valid only in HS200 mode and only when the device is unlocked (Password Lock, see paragraph 6.6.22). In any other state, CMD21 is treated as illegal command. Since the data block following CMD21 is fixed, CMD16 is not required to precede CMD21.

CMD21 follows the timing of a single block read command as described in Figure 29.



**Figure 29 — Send Tuning Command**

The host may send a sequence of CMD21s until it has finished its tuning process.

The Device is guaranteed to complete a sequence of 40 times CMD21 executions within 150ms. This is exclusive of any host overhead.

### 6.6.8.1 Sampling Tuning Sequence for HS200 (cont'd)

Figure 30 defines the tuning block pattern for 8 bit mode. In 4 bit mode the same pattern is used as shown for the lower 4 bits (DAT[3:0]).

F	F	O	F	F	O	O	F	F	C	C	C	C	C	C	C	F	F	F	E	E	F	F	Byte #32																																																																																																								
F	F	O	F	F	O	O	F	F	C	C	C	C	C	C	C	F	F	F	E	E	F	F	Byte #33																																																																																																								
Byte #1	Byte #2	Byte #3	Byte #4	Byte #5	Byte #6	Byte #7	Byte #8	Byte #9	Byte #10	Byte #11	Byte #12	Byte #13	Byte #14	Byte #15	Byte #16	Byte #17	Byte #18	Byte #19	Byte #20	Byte #21	Byte #22	Byte #23	Byte #24	Byte #25	Byte #26	Byte #27	Byte #28	Byte #29	Byte #30	Byte #31	Byte #32	Byte #33	Byte #34	Byte #35	Byte #36	Byte #37	Byte #38	Byte #39	Byte #40	Byte #41	Byte #42	Byte #43	Byte #44	Byte #45	Byte #46	Byte #47	Byte #48	Byte #49	Byte #50	Byte #51	Byte #52	Byte #53	Byte #54	Byte #55	Byte #56	Byte #57	Byte #58	Byte #59	Byte #60	Byte #61	Byte #62	Byte #63	Byte #64	Byte #65	Byte #66	Byte #67	Byte #68	Byte #69	Byte #70	Byte #71	Byte #72	Byte #73	Byte #74	Byte #75	Byte #76	Byte #77	Byte #78	Byte #79	Byte #80	Byte #81	Byte #82	Byte #83	Byte #84	Byte #85	Byte #86	Byte #87	Byte #88	Byte #89	Byte #90	Byte #91	Byte #92	Byte #93	Byte #94	Byte #95	Byte #96	Byte #97	Byte #98	Byte #99	Byte #100	Byte #101	Byte #102	Byte #103	Byte #104	Byte #105	Byte #106	Byte #107	Byte #108	Byte #109	Byte #110	Byte #111	Byte #112	Byte #113	Byte #114	Byte #115	Byte #116	Byte #117	Byte #118	Byte #119	Byte #120	Byte #121	Byte #122	Byte #123	Byte #124	Byte #125	Byte #126	Byte #127	Byte #128

Figure 30 — Tuning block pattern for 8 bit mode

Figure 31 describes the way the known pattern is spread across DAT[7:0]. It includes only the first 16 bytes for illustration, and the fixed CRC16 value per data line. The order is Left->Right on each data line.

The tuning block purpose is to create "special" signal integrity cases on the bus. This causes high SSO noise, deterministic jitter, ISI and timing errors. Therefore host should switch to the desirable operational bus width before it performs the tuning process.

Therefore, the purpose is to create the worst case data valid window (minimal valid window) that the HS200 system should experience in a specific Host and Device combination.

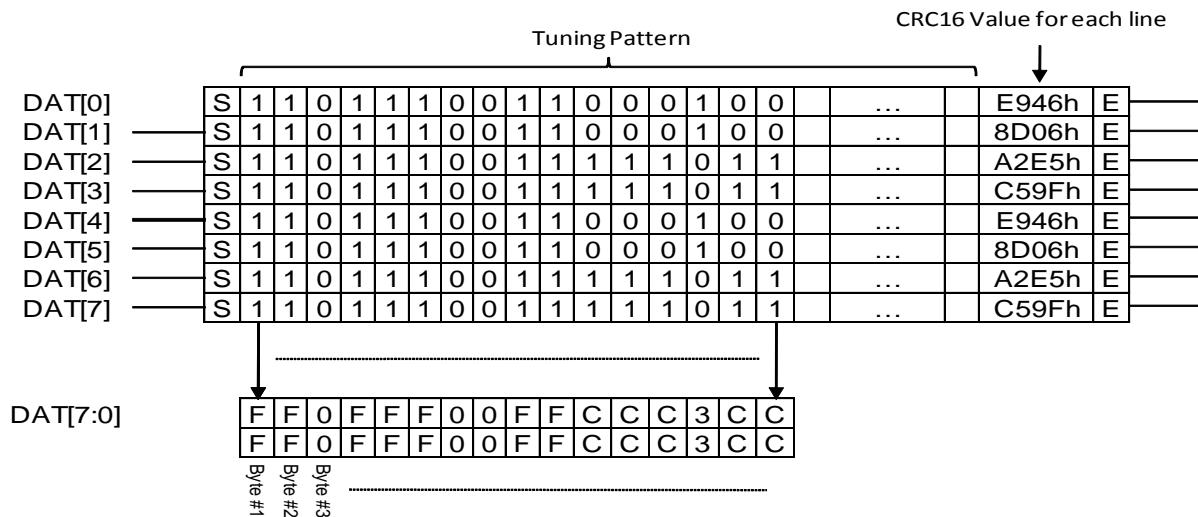


Figure 31 — Tuning block on DAT[7:0]/DAT[3:0] in 8bit/4bit bus width

### 6.6.9 Bus width selection

After the host has verified the functional pins on the bus it should change the bus width configuration accordingly, using the SWITCH command. The bus width configuration is changed by writing to the BUS\_WIDTH byte in the Modes Segment of the EXT\_CSD register (using the SWITCH command to do so). After power-on, or software reset, the contents of the BUS\_WIDTH byte is 0x00.

The valid values for this register are defined in 7.4.61. If the host tries to write an invalid value, the BUS\_WIDTH byte is not changed and the SWITCH\_ERROR bit is set. This register is write only.

### 6.6.10 Data read

The DAT0-DAT7 bus line levels are high when no data is transmitted. A transmitted data block consists of a start bit (LOW), on each DAT line, followed by a continuous data stream. The data stream contains the payload data (and error correction bits if an off-Device ECC is used). The data stream ends with an end bit (HIGH), on each DAT line. (See Figure 40, Figure 41, and Figure 47). The data transmission is synchronous to the clock signal for all interfaces other than HS400, and it is synchronous to the DS signal for HS400 interface.

The payload for block oriented data transfer is protected by one CRC check sum in single data rate mode or by two CRC check sums in dual data rate mode, on each DAT line (See 8.2).

#### 6.6.10.1 Block read

In single data rate mode the basic unit of data transfer is a block whose maximum size is defined in the CSD (READ\_BL\_LEN). If READ\_BL\_PARTIAL is set, smaller blocks whose starting and ending address are entirely contained within one physical block (as defined by READ\_BL\_LEN) may also be transmitted. A CRC is appended to the end of each block ensuring data transfer integrity. CMD17 (READ\_SINGLE\_BLOCK) initiates a block read and after completing the transfer, the Device returns to the *Transfer State*. In dual data rate mode, the data size of a block read is always 512 bytes, partial block data read is not supported, and at the end of each block is appended two CRC, one for even bytes and one for odd bytes. CMD18 (READ\_MULTIPLE\_BLOCK) starts a transfer of several consecutive blocks.

Two types of multiple block read transactions are defined (the host can use either one at any time):

- Open-ended Multiple block read  
The number of blocks for the read multiple block operation is not defined. The Device will continuously transfer data blocks until a stop transmission command is received.
- Multiple block read with pre-defined block count  
The Device will transfer the requested number of data blocks, terminate the transaction and return to *transfer state*. Stop command is not required at the end of this type of multiple block read, unless terminated with an error. In order to start a multiple block read with pre-defined block count the host must use the SET\_BLOCK\_COUNT command (CMD23) immediately preceding the READ\_MULTIPLE\_BLOCK (CMD18) command. Otherwise the Device will start an open-ended multiple block read which can be stopped using the STOP\_TRANSMISSION command.

### 6.6.10.1 Block read (cont'd)

The host can abort reading at any time, within a multiple block operation, regardless of the its type. Transaction abort is done by sending the stop transmission command. If either one of the following conditions occurs, the Device will reject the command, remain in *Tran* state and respond with the respective error bit set.

- The host provides an out of range address as an argument to either CMD17 or CMD18. ADDRESS\_OUT\_OF\_RANGE is set.
- The currently defined block length is illegal for a read operation. BLOCK\_LEN\_ERROR is set.
- The address/block-length combination positions the first data block misaligned to the Device physical blocks. ADDRESS\_MISALIGN is set.

If the Device detects an error (e.g., out of range, address misalignment, internal error, etc.) during a multiple block read operation (both types) it will stop data transmission and remain in the *Data State*. The host must then abort the operation by sending the stop transmission command. The read error is reported in the response to the stop transmission command.

If the host sends a stop transmission command after the Device transmits the last block of a multiple block operation with a pre-defined number of blocks, it is regarded as an illegal command, since the Device is no longer in *data* state.

If the host uses partial blocks whose accumulated length is not block aligned, and block misalignment is not allowed, the Device shall detect a block misalignment error condition during the transmission of the first misaligned block and the content of the further transferred bits is undefined. As the host sends CMD12 the Device will respond with the ADDRESS\_MISALIGN bit set and return to *Tran* state.

If the host sets the argument of the SET\_BLOCK\_COUNT command (CMD23) to all 0s, then the command is accepted; however, a subsequent read will follow the open-ended multiple block read protocol (STOP\_TRANSMISSION command - CMD12 - is required).

If a host had sent a CMD16 for password setting to a higher than 2GB of density of Device, then this host MUST re-send CMD16 before read data transfer; otherwise, the Device will response a BLK\_LEN\_ERROR and stay in TRANS state without data transfer since the data block (except in password application) transfer is sector unit (512B). Same error applies to up to 2GB of density of Devices in case partial read accesses are not supported.

### 6.6.11 Data write

The data transfer format of write operation is similar to the data read. For block oriented write data transfer, one CRC check bits in single data rate mode or by two CRC check bits in dual data rate mode are added to each data block. The Device performs a CRC parity check (see 8.2) for each received data block prior to the write operation. By this mechanism, writing of erroneously transferred data can be prevented.

In general, an interruption to a write process should not cause corruption in existing data at any other address. However, the risk of power being removed during a write operation is different in different applications. Also, for some technologies used to implement e•MMC, there is a tradeoff between protecting existing data (e.g., data written by the previous completed write operations), during a power failure, and write performance. The host has the ability to set the type of data reliability desired. When the write data reliability parameters (WR\_DATA\_REL\_USR, WR\_DATA\_REL\_1, WR\_DATA\_REL\_2, WR\_DATA\_REL\_3 and WR\_DATA\_REL\_4) in EXT\_CSD (WR\_REL\_SET) are set to 1 it will indicate to the host that the write mechanism in the associated partition has been implemented to protect existing data in that partition. This means that once a device indicates to the host that a write has successfully completed, the data that was written, along with all previous data written, shall not be corrupted by other operations that are host initiated, controller initiated or accidental. A value of 0 for these bits will indicate that there is some risk to previously written data in those partitions if power is removed. This reliability setting only impacts the reliability of the main user area and the general purpose partitions. The data in the boot partitions and the RPMB partition must have the same reliability that is implied by setting the WR\_DATA\_REL bit to 1. The reliability of these partitions is not impacted by the value of the WR\_DATA\_REL bit.

The host has the option of changing the reliability of the writes in one or more partitions on the device. The entire register is considered to be write once so the host has one opportunity to write all of the bits in the register. (Separate writes to change individual bits are not permitted) This write must happen as part of the partitioning process and must occur before the PARTITION\_SETTING\_COMPLETED bit is set. The changes made to the WR\_REL\_SET register will not have an impact until the partitioning process is complete (i.e. after the power cycle has occurred and the partitioning has completed successfully). Data reliability settings for partitions that do not exist in the device have no impact on the device.

All write operations must be completed in the order in which they arrive. The order restriction is applicable to each write command that a device receives and does not apply to the data within a specific write command.

### 6.6.11.1 Block write

In single data rate mode, during block write (CMD24 - 27) one or more blocks of data are transferred from the host to the Device with a CRC appended to the end of each block by the host. A Device supporting block write shall always be able to accept a block of data defined by WRITE\_BL\_LEN. If the CRC fails, the Device shall indicate the failure on the DAT0 line (see below); the transferred data will be discarded and not written, and all further transmitted blocks (in multiple block write mode) will be ignored. In dual data rate mode, the data size of a block write is always 512 bytes, partial block data write is not supported, and at the end of each block is appended two CRC, one for even bytes and one for odd bytes. CMD25 (WRITE\_MULTIPLE\_BLOCK) starts a transfer of several consecutive blocks. Three types of multiple-block write transactions are defined (the host can use any of these three types at any time):

- Open-ended Multiple-block write

The number of blocks for the write multiple block operation is not defined. The Device will continuously accept and program data blocks until a stop transmission command is received.

- Multiple-block write with pre-defined block count

The Device will accept the requested number of data blocks, terminate the transaction and return to *transfer* state. Stop command is not required at the end of this type of multiple block write, unless terminated with an error. In order to start a multiple block write with pre-defined block count the host must use the SET\_BLOCK\_COUNT command (CMD23) immediately preceding the WRITE\_MULTIPLE\_BLOCK (CMD25) command. Otherwise the Device will start an open-ended multiple-block write which can be stopped using the STOP\_TRANSMISSION command.

- Reliable Write: Multiple block write with pre-defined block count and Reliable Write parameters. This transaction is similar to the basic pre-defined multiple-block write (defined in previous bullet) with the following exceptions. The old data pointed to by a logical address must remain unchanged until the new data written to same logical address has been successfully programmed. This is to ensure that the target address updated by the reliable write transaction never contains undefined data. Data must remain valid even if a sudden power loss occurs during the programming.

- The block size defined by SET\_BLOCKLEN(CMD16) is ignored and all blocks are 512 B in length. The data transfers will be in multiple of 512 B sectors or in multiple of eight 512 B sectors if Large Sector size mode is activated. There is no limit on the size of the reliable write.
- The function is activated by setting the Reliable Write Request parameter (bit 31) to “1” in the SET\_BLOCK\_COUNT command (CMD23) argument.
- Reliable write transactions must be sector aligned, if a reliable write is not sector aligned the error bit 19 will be set and the transaction will not complete.
- If a power loss occurs during a reliable write, each sector being modified by the write is atomic. After a power failure sectors may either contain old data or new data. All of the sectors being modified by the write operation that was interrupted may be in one of the following states: all sectors contain new data, all sectors contain old data or some sectors contain new data and some sectors contain old data.
- In the case where a reliable write operation is interrupted by a high priority interrupt operation, the sectors that the register marks as completed will contain new data and the remaining sectors will contain old data.
- The REL\_WR\_SEC\_C [222] register shall be set to 1 and has no impact on the reliable write operation.

### 6.6.11.1 Block write (cont'd)

The host can abort writing at any time, within a multiple block operation, regardless of the its type. Transaction abort is done by sending the stop transmission command. If a multiple block write with predefined block count is aborted, the data in the remaining blocks is not defined.

If either one of the following conditions occurs, the Device will reject the command, remain in *Tran* state and respond with the respective error bit set.

- The host provides an out of range address as an argument to either CMD24 or CMD25. ADDRESS\_OUT\_OF\_RANGE is set.
- The currently defined block length is illegal for a write operation. BLOCK\_LEN\_ERROR is set.
- The address/block-length combination positions the first data block misaligned to the Device physical blocks. ADDRESS\_MISALIGN is set.

If the Device detects an error (e.g., write protect violation, out of range, address misalignment, internal error, etc.) during a multiple block write operation (both types) it will ignore any further incoming data blocks and remain in the *Receive State*. The host must then abort the operation by sending the stop transmission command. The write error is reported in the response to the stop transmission command.

If the host sends a stop transmission command after the Device received the last data block of a multiple block write with a pre-defined number of blocks, it is regarded as an illegal command, since the Device is no longer in *rcv* state.

If the host uses partial blocks whose accumulated length is not block aligned, and block misalignment is not allowed (CSD parameter WRITE\_BLK\_MISALIGN is not set), the Device shall detect the block misalignment error during the reception of the first misaligned block, abort the write operation, and ignore all further incoming data. As the host sends CMD12, the Device will respond with the ADDRESS\_MISALIGN bit set and return to *Tran* state.

If the host sets the argument of the SET\_BLOCK\_COUNT command (CMD23) to all 0s, then the command is accepted; however, a subsequent write will follow the open-ended multiple block write protocol (STOP\_TRANSMISSION command - CMD12 - is required).

Programming of the CID and CSD registers does not require a previous block length setting. The transferred data is also CRC protected. If a part of the CSD or CID register is stored in ROM, then this unchangeable part must match the corresponding part of the receive buffer. If this match fails, then the Device will report an error and not change any register contents.

Some Devices may require long and unpredictable times to write a block of data. After receiving a block of data and completing the CRC check, the Device will begin writing and hold the DAT0 line low. The host may poll the status of the Device with a SEND\_STATUS command (CMD13) at any time, and the Device will respond with its status (except in Sleep state). The status bit READY\_FOR\_DATA indicates whether the Device can accept new data or not. The host may deselect the Device by issuing CMD7 which will displace the Device into the *Disconnect State* and release the DAT0 line without interrupting the write operation. When reselecting the Device, it will reactivate busy indication by pulling DAT0 to low. See 6.15 for details of busy indication

If a host had sent a CMD16 for password setting to a higher than 2GB of density of Device, then this host MUST re-send CMD16 before write data transfer; otherwise, the Device will response a BLK\_LEN\_ERROR and stay in TRANS state without data transfer since the data block (except in password application) transfer is sector unit (512B). Same error applies to up to 2GB of density of devices in case partial write accesses are not supported.

### 6.6.12 Erase

In addition to the implicit erase executed by the Device as part of the write operation, provides a host explicit erase function. The erasable unit of the eMMC is the “Erase Group”; Erase group is measured in write blocks which are the basic writable units of the Device. The size of the Erase Group is a Device specific parameter and defined in the CSD when ERASE\_GROUP\_DEF is disabled, and in the EXT\_CSD when ERASE\_GROUP\_DEF is enabled. The content of an explicitly erased memory range shall be ‘0’ or ‘1’ depending on different memory technology. This value is defined in the EXT\_CSD.

Once the erase command completes successfully, the mapped device address range that was erased shall behave as if it was overwritten with all ‘0’ or all ‘1’ depending on the different memory technology. The impact of the erase command should be simply moving the mapped host address range to the unmapped host address range (note in some cases other flash management tasks may also be completed during the execution of this command).

The host can erase a contiguous range of Erase Groups. Starting the erase process is a three steps sequence. First the host defines the start address of the range using the ERASE\_GROUP\_START (CMD35) command, next it defines the last address of the range using the ERASE\_GROUP\_END (CMD36) command and finally it starts the erase process by issuing the ERASE (CMD38) command with argument bits set to zero. See Table 11 — for the arguments supported by CMD38. The address field in the erase commands is an Erase Group address, in byte units for densities up to 2GB, and in sector units for densities greater than 2GB. The Device will ignore all LSB's below the Erase Group size, effectively rounding the address down to the Erase Group boundary.

If an erase command (either CMD35, CMD36, CMD38) is received out of the defined erase sequence, the Device shall set the ERASE\_SEQ\_ERROR bit in the status register and reset the whole sequence. If the host provides an out of range address as an argument to CMD35 or CMD36, the Device will reject the command, respond with the ADDRESS\_OUT\_OF\_RANGE bit set and reset the whole erase sequence.

If an ‘non erase’ command (neither of CMD35, CMD36, CMD38 or CMD13) is received, the Device shall respond with the ERASE\_RESET bit set, reset the erase sequence and execute the last command.

Commands not addressed to the selected Device do not abort the erase sequence.

If the erase range includes write protected blocks, they shall be left intact and only the non-protected blocks shall be erased. The WP\_ERASE\_SKIP status bit in the status register shall be set. As described above for block write, the Device will indicate that an erase is in progress by holding DAT0 low. The actual erase time may be quite long, and the host may issue CMD7 to deselect the Device.

### 6.6.12 Erase (cont'd)

**Table 11 — Erase command (CMD38) Valid arguments**

CMD38 Arguments	Command Description	SEC_GB_CL_EN (EXT_CSD[231] bit 4)	SEC_ER_EN (EXT_CSD[231] bit 0)
0x00000000	<b>Erase</b> Erase the erase groups identified by CMD35&36. Controller can perform actual erase at a convenient time. (legacy implementation)	n/a	n/a
0x00000003	<b>Discard</b> the write blocks identified by CMD35 & 36. The controller can perform partial or full the actual erase at a convenient time.	n/a	n/a
0x80000000	<b>Secure Erase</b> Perform a secure purge according to Secure Removal Type in EXT_CSD on the erase groups identified by CMD35 &36 and any copies of those erase groups	n/a	Required
0x80008000	<b>Secure Trim Step 2</b> Perform a secure purge operation on the write blocks according to Secure Removal Type in EXT_CSD and copies of those write blocks that were previously identified using CMD 35,36 and 38 + argument 0x80000001.	Required	Required
0x80000001	<b>Secure Trim Step 1</b> Mark the write blocks, indicated by CMD35&36, for secure erase.	Required	Required
0x00000001	<b>Trim</b> Erase (aka Trim) the write blocks identified by CMD35&36. The controller can perform the actual erase at a convenient time.	Required	n/a

When executing the Erase command the host should note that an erase group contains multiple write blocks, which could each contain different pieces of information. When the Erase is executed it will apply to all write blocks within an erase group. Before the host executes the Erase command it should make sure that the information in the individual write blocks no longer needed. So to avoid the deletion of valid data by accident, the Erase command is best used to erase the entire device or a partition. If the host only wishes to purge a single write block a Trim command might be more appropriate.

### 6.6.13 TRIM

The Trim operation is similar to the default erase operation described in 6.6.12. The Trim function applies the erase operation to write blocks instead of erase groups. The Trim function allows the host to identify data that is no longer required so that the Device can erase the data if necessary during background erase events. The contents of a write block where the trim function has been applied shall be '0' or '1' depending on different memory technology. This value is defined in the EXT\_CSD.

Once the trim command completes successfully, the mapped device address range that was trimmed shall behave as if it was overwritten with all '0' or all '1' depending on the different memory technology. The impact of the trim command should be simply moving the mapped host address range to the unmapped host address range (note in some cases other flash management tasks may also be completed during the execution of this command).

Completing the TRIM process is a three steps sequence. First the host defines the start address of the range using the ERASE\_GROUP\_START (CMD35) command, next it defines the last address of the range using the ERASE\_GROUP\_END (CMD36) command and finally it starts the erase process by issuing the ERASE (CMD38) command with argument bit 0 set to one and the remainder of the arguments set to zero. In the case of a TRIM operation both CMD35 and CMD36 identify the addresses of write blocks rather than erase groups.

If an element of the Trim command (CMD35, CMD36 or CMD38) is received out of the defined erase sequence, the device shall set the ERASE\_SEQ\_ERROR bit in the status register and reset the whole sequence.

If the host provides an out of range address as an argument to CMD35 or CMD36, the Device will reject the command, respond with the ADDRESS\_OUT\_OF\_RANGE bit set and reset the whole erase sequence. If a “non erase” command (neither of CMD35, CMD36, CMD38 or CMD13) is received, the Device shall respond with the ERASE\_RESET bit set, reset the erase sequence and execute the last command. Commands not addressed to the selected Device do not abort the erase sequence.

If the trim range includes write protected blocks, they shall be left intact and only the non-protected blocks shall be erased. The WP\_ERASE\_SKIP status bit in the status register shall be set. As described above for block write, the Device will indicate that a Trim command is in progress by holding DAT0 low. The actual erase time may be quite long, and the host may issue CMD7 to deselect the Device.

The host should execute the Trim command with caution to avoid unintentional data loss.

Resetting a Device (using CMD0, CMD15, or hardware reset for e•MMC) or power failure will terminate any pending or active Trim command. This may leave the data involved in the operation in an unknown state

#### 6.6.14 Sanitize

The Sanitize operation is a feature, in addition to TRIM and Erase that is used to remove data from the device. The use of the Sanitize operation requires the device to physically remove data from the unmapped user address space. A Sanitize operation is initiated by writing a value to the extended CSD[165] SANITIZE\_START. While the device is performing the sanitize operation, the busy line is asserted. The device will continue the sanitize operation, with busy asserted, until one of the following events occurs:

- Sanitize operation is complete.
- An HPI is used to abort the operation
- A power failure.
- A hardware reset.

After the sanitize operation is completed, no data should exist in the unmapped host address space.

If the sanitize operation is interrupted, either by HPI, power failure, CMD0 or hardware reset, the state of the unmapped host address space cannot be guaranteed. The host must re-initiate the sanitize operation by writing to the SANITIZE\_START[165] and allow the operation to complete to be sure that unmapped host address space is clear.

Since the region being operated on is not accessible by the host, applications requiring this feature must work with individual device manufacturers to ensure this operation is performing properly and to understand the impact on device reliability.

#### 6.6.15 Discard

The Discard is similar operation to TRIM. The Discard function allows the host to identify data that is no longer required so that the device can erase the data if necessary during background erase events. The contents of a write block where the discard function has been applied shall be ‘don’t care’. After discard operation, the original data may be remained partially or fully accessible to the host dependent on device. The portions of data that are no longer accessible by the host may be removed or unmapped just as in the case of TRIM. The device will decide the contents of discarded write block.

The distinction between Discard and TRIM, is that a read to a region that was discarded may return some or all of the original data. However, in the case of Trim the entire region shall be unmapped or removed and will return ‘0’ or ‘1’ depending on the memory technology.

When Sanitize is executed, only the portion of data that was unmapped by a Discard command shall be removed by the Sanitize command. The device cannot guarantee that discarded data is completely removed from the device when Sanitize is applied.

Completing the Discard process is a three steps sequence. First the host defines the start address of the range using the ERASE\_GROUP\_START (CMD35) command, next it defines the last address of the range using the ERASE\_GROUP\_END (CMD36) command and finally it starts the erase process by issuing the ERASE (CMD38) command with argument bit 0 and bit 1 set to one and the remainder of the arguments set to zero. In the case of a Discard operation both CMD35 and CMD36 identify the addresses of write blocks rather than erase groups.

If an element of the Discard command (CMD35, CMD36 or CMD38) is received out of the defined erase sequence, the device shall set the ERASE\_SEQ\_ERROR bit in the status register and reset the whole sequence.

### **6.6.15 Discard (cont'd)**

If the host provides an out of range address as an argument to CMD35 or CMD36, the device will reject the command, respond with the ADDRESS\_OUT\_OF\_RANGE bit set and reset the whole erase sequence.

If a “non erase” command (neither of CMD35, CMD36, CMD38 or CMD13) is received, the device shall respond with the ERASE\_RESET bit set, reset the erase sequence and execute the last command. Commands not addressed to the selected device do not abort the erase sequence.

If the discard range includes write protected blocks, they shall be left intact and only the non-protected blocks shall be erased. The WP\_ERASE\_SKIP status bit in the status register shall be set.

As described above for block write, the device will indicate that a Discard command is in progress by holding DAT0 low. The actual erase time may be quite long, and the host may issue CMD7 to deselect the device.

The host should execute the Discard command with caution to avoid unintentional data loss.

Resetting a device (using CMD0, CMD15, or hardware reset for eMMC) or power failure will terminate any pending or active Discard command. This may leave the data involved in the operation in an unknown state.

### 6.6.16 Secure Erase

**NOTE** Secure Erase is included for backwards compatibility. New system level implementations (based on v4.51 devices and beyond) should use Erase combined with Sanitize instead of secure erase.

In addition to the standard Erase command there is also an optional Secure Erase command. The Secure Erase command differs from the basic Erase command (outlined in 6.6.12) in that it requires the device to execute the erase operation on the memory array when the command is issued and requires the device and host to wait until the operation is complete before moving to the next device operation. Also, the secure erase command requires the device to do a secure purge operation, according to Secure Removal Type in EXT\_CSD (outlined in 7.4.112), on the erase groups, and any copies of items in those erase groups, identified for erase.

This command allows applications that have high security requirements to request that the device perform secure operations, while accepting a possible erase time performance impact. The Secure Erase command is executed in the same way the erase command outlined in 6.6.12, except that the Erase (CMD38) command is executed with argument bit 31 set to 1 and the other argument bits set to zero. See Table 11 — for details on the argument combinations supported with the Erase (CMD 38) command and Table 12 — for the definition of the argument bits associated with the ERASE (CMD38) command.

The host should execute the Secure Erase command with caution to avoid unintentional data loss.

Resetting a device (using CMD0, CMD15, or hardware reset for eMMC) or power failure will terminate any pending or active Secure Erase command. This may leave the data involved in the operation in an unknown state.

**Table 12 — Erase command (CMD38) Valid arguments**

Bit	Argument	Arguments
31	Secure Request	'1' - Secure form of the command must be performed. '0' - Default in Secure Erase command is performed
15	Force Garbage Collection	'1' — CMD35 & 36 are ignored. Erase is performed on previously identified write blocks. '0' - Command uses the erase groups identified by CMD35&36
1	Discard Enable	'1' – Discard write blocks identified by CMD35 & 36. '0' – Execute an erase. NOTE Bit[0] is also required to be set to 0x1 (in addition to bit[1] being set to 0x1) for the Discard write blocks operation
0	Identify Write Blocks for Erase (or TRIM Enable)	'1' — Mark write block identified by CMD35&36 for erase (bit 31 set) or execute Trim operation (bit 31 cleared). Bit[0] shall be set to 0x1 for the Discard write blocks operation. '0' - Execute an erase.

### 6.6.17 Secure Trim

**NOTE: Secure TRIM is included for backwards compatibility. New system level implementations (based on v4.51 devices and beyond) should use TRIM combined with Sanitize instead of secure trim.**

The Secure Trim command is very similar to the Secure Erase command. The Secure Trim command performs a secure purge operation on write blocks instead of erase groups. To minimize the impact on the device's performance and reliability the Secure Trim operation is completed by executing two distinct steps.

In Secure Trim Step 1 the host defines the range of write blocks that it would like to mark for the secure purge. This step does not perform the actual purge operation. The blocks are marked by defining the start address of the range using the ERASE\_GROUP\_START (CMD35) command, followed by defining the last address of the range using the ERASE\_GROUP\_END (CMD36) command. In the case of Secure Trim, both ERASE\_GROUP\_START and ERASE\_GROUP\_END arguments are identifying write block addresses. Once the range of blocks has been identified the ERASE (CMD 38) with argument bit 31 and 0 set to 1 and the remainder of the argument bits set to 0 (See Table 11 — for the allowable arguments) is applied. This completes Secure Trim Step 1.

Secure Trim Step 1 can be repeated several times, with other commands being allowed in between, until all the write blocks that need to be purged have been identified. It is recommended that the Secure Trim Step 1 is done on as many blocks as possible to improve its efficiency of the secure trim operation.

Secure Trim Step 2 issues the ERASE\_GROUP\_START (CMD35) and ERASE\_GROUP\_END (CMD36) with addresses that are in range. Note the arguments used with these commands will be ignored. Then the ERASE (CMD 38) with bit 31 and 15 set to 1 and the remainder of the argument bits to 0 is sent. This step actually performs the secure purge on all the write blocks, according to Secure Removal Type(outlined in 7.4.112), as well as any copies of those blocks, that were marked during Secure Trim Step 1 and completes the secure trim operation. Other commands can be issued to the device in between Secure Trim Step 1 and Secure Trim Step 2.

The host may issue Secure Trim Step 2 without issuing Secure Trim Step 1. This may be required after a power failure event in order to complete unfinished secure trim operations. If Secure Trim Step 2 is done and there are no write blocks marked for erase then Secure Trim Step 2 again will have no impact on the device.

Once a write block is marked for erase using Secure Trim Step 1, it is recommended that the host consider this block as erased. However, if the host does write to a block after it has been marked for erase, then the last copy of the block, which occurred as a result of the modification, will not be marked for erase. All previous copies of the block will remain marked for erase.

If the host application wishes to use the secure TRIM command as the method to remove data from the device, then the host should make sure that it completes secure trim step 1 for a write block before using a write command to overwrite the block. This will ensure that the overwritten data is removed securely from the device the next time that secure Trim step 2 is issued.

If either CMD35, CMD36 or CMD38 is received out of the defined erase sequence, the device shall set the ERASE\_SEQ\_ERROR bit in the status register and reset the whole sequence for an individual step. If the host provides an out of range address as an argument to CMD35 or CMD36, the device will reject the command, respond with the ADDRESS\_OUT\_OF\_RANGE bit set and reset the whole erase sequence.

### 6.6.17 Secure Trim (cont'd)

If a 'non erase' command (neither of CMD35, CMD36, CMD38 or CMD13) is received, while the device is performing the operations in Secure Trim Step 1 or Secure Trim Step 2, the device shall respond with the ERASE\_RESET bit set, and reset the individual step without completing the operation and execute the last command. Commands not addressed to the selected device do not abort the sequence. Other commands may occur in between the multiple iterations of Secure Trim Step 1 and/or before Secure Trim Step 2 is sent. However, the sequence during each of the steps cannot be interrupted.

If a power failure or reset occurs in between Secure Trim Step 1 and Secure Trim Step 2. The blocks that were identified for the secure purge operation will remain marked. The next time the device sees Secure Trim Step 2 it will purge the blocks that were marked prior to the power failure or reset and along with any blocks that have been identified since that point.

The host should execute the Secure Trim command with caution to avoid unintentional data loss. Resetting a device (using CMD0, CMD15, or hardware reset for *e*•MMC) or power failure during either step 1 or step2 will terminate any pending or active secure trim command. This may leave the data involved in the operation in an unknown state. If the erase range includes write protected blocks, they shall be left intact and only the non-protected blocks shall be erased. The WP\_ERASE\_SKIP status bit in the status register shall be set.

If the device needs a write block that is marked for Secure Erase and Secure Trim Step 2 has not been issued, the device can issue a secure purge operation on that write block as a background task. As described above for block write, the device will indicate that either Secure Trim Step 1 or Secure Trim Step 2 are in progress by holding DAT0 low. The actual time for the operation may be quite long, and the host may issue CMD7 to deselect the device. If the write block size is changed in between Secure Trim Step 1 and Secure Trim Step 2 then the write block size used during step 1 of the operation will apply.

### 6.6.18 Write protect management

In order to allow the host to protect data against erase or write, the *e*•MMC shall support two levels of write protect commands:

- The entire Device (including the Boot Area Partitions, General Purpose Area Partition, RPMB, and User/Enhanced User Data Area Partition) may be write-protected by setting the permanent or temporary write protect bits in the CSD. When permanent protection is applied to the entire Device it overrides all other protection mechanisms that are currently enabled on the entire Device or in a specific segment. CSD Register bits and Extended CSD Register bits are not impacted by this protection. When temporary write protection is enabled for the entire Device it only applies to those segments that are not already protected by another mechanism. See Table 13 — for details.
- Specific segments of the Devices may be permanent, power-on or temporarily write protected. ERASE\_GROUP\_DEF in EXT\_CSD decides the segment size. When set to 0, the segment size is defined in units of WP\_GRP\_SIZE erase groups as specified in the CSD. When set to 1, the segment size is defined in units of HC\_WP\_GRP\_SIZE erase groups as specified in the EXT\_CSD. If host does not set ERASE\_GROUP\_DEF bit for a device of which high capacity write protect was already set in some of the area in the previous power cycle, then the device may show unknown behavior when host issue write or erase commands to the device, because the write protect group size previously set mismatches the current write protect group size. Similarly if host set ERASE\_GROUP\_DEF bit for a device of which default write protect was already set in some of the area in the previous power cycle, then the device may show unknown behavior when host issue write or erase commands to the device. In application, it is mandatory for host to use same ERASE GROUP DEF value to the device all the time.

### 6.6.18 Write protect management (cont'd)

- The SET\_WRITE\_PROT command sets the write protection of the addressed write-protect group, group to the type of write protection dictated by the US\_PERM\_WP\_EN (EXT\_CSD[171] bit 2) and US\_PWR\_WP\_EN (EXT\_CSD[171] bit 0). See Table 13 — for the result of the SET\_WRITE\_PROT(CMD28) command when protection is already enabled in a segment and Table 14 — for impact of the different combinations of the protection enable bits. The CLR\_WRITE\_PROT command clears the temporary write protection of the addressed write-protect group. If the CLR\_WRITE\_PROT command is applied to a write protection group that has either permanent or power-on write protection then the command will fail.

The ability for the host to set permanent protection for the entire Device and permanent power-on protection for specific segments can be disabled by setting the CD\_PERM\_WP\_DIS, US\_PERM\_WP\_DIS and US\_PWR\_WP\_DIS bit in the EXT\_CSD USER\_WP byte. It is recommended to disable all protection modes that are not needed to prevent unused write protection modes from being set maliciously or unintentionally.

The host has the ability to check the write protection status of a given segment or segments by using the SEND\_WRITE\_PROT\_TYPE command (CMD31). When full Device protection is enabled all the segments will be shown as having permanent protection.

The SEND\_WRITE\_PROT and SEND\_WRITE\_PROT\_TYPE commands are similar to a single block read command. The Device shall send a data block containing 32 or 64 write protection bits, respectively, (representing 32 write protect groups starting at the specified address) followed by 16 CRC bits. The address field in the write protect commands is a group address in byte units, for densities up to 2GB, and in sector units for densities greater than 2GB.

The Device will ignore all LSBs below the group size for densities up to 2GB. If the host provides an out of range address as an argument to CMD28, CMD29 or CMD30, the Device will reject the command, respond with the ADDRESS\_OUT\_OF\_RANGE bit set and remain in the *Tran* state.

**Table 13 — Write Protection Hierarchy (when disable bits are clear)**

Current Protection mode	CSD[12]	Action	Resulting Protection mode
Permanent	N/A	Power failure or hardware reset	Permanent
Permanent	N/A	SET_WRITE_PROT (US_PERM_WP_EN = 0)	Permanent
Power-On	1	Power failure or hardware reset	Temporary
Power-On	0	Power failure or hardware reset	None
Power-On	N/A	SET_WRITE_PROT (US_PERM_WP_EN = 1)	Permanent
Power-On	N/A	SET_WRITE_PROT (US_PERM_WP_EN = 0 and US_PWR_WP_EN = 0)	Power-On
Temporary	1	Power failure or hardware reset	Temporary
Temporary	1	SET_WRITE_PROT (US_PERM_WP_EN = 1)	Permanent
Temporary	1	SET_WRITE_PROT (US_PERM_WP_EN = 0 and US_PWR_WP_EN = 1)	Power-On

**Table 14 — Write Protection Types (when disable bits are clear)**

US_PERM_WP_EN	US_PWR_WP_EN	Type of protection set by SET_WRITE_PROT command
0	0	Temporary
0	1	Power-On
1	0	Permanent
1	1	Permanent

### 6.6.19 Extended Security Protocols Pass Through Commands

The extended protocol pass through commands is a feature that allows the host to communicate with an *e*MMC device with other commonly used security protocols over *e*MMC protocol using two pass through commands – CMD53 and CMD54.

In order to support Extended Security Protocols communication with the device the following three requirements are essential:

1. Discovery whether the extended protocol pass through commands (CMD53-PROTOCOL\_RD and CMD54-PROTOCOL\_WR) supported in the device
2. Receive Extended Protocol data from the device
3. Send Extended Protocol data to the device

In order to discover whether the extended protocol pass through commands are supported the host should verify that Command Class 10 is supported by the device (in CCC field in CSD Register).

In order to receive and send extended protocol information CMD53 and CMD54 shall be used.

NOTE CMD53 and CMD54 are the basic infrastructure in *e*MMC standard that allows the pass through transfer of other protocols. The other protocols that may be implemented over *e*MMC are referenced in a separate JEDEC Security Extension Standard.

#### 6.6.19.1 PROTOCOL\_RD - CMD53

This command works in similar fashion to the Read Multiple Block command (CMD18) and retrieves security protocol related information from the device. The Security Protocol being referenced is passed in the command arguments. The number of blocks to be transferred shall be provided in advance by using CMD23 (SET\_BLOCK\_COUNT). Sector size is fix 512Bytes regardless of the NATIVE\_SECTOR\_SIZE or DATA\_SECTOR\_SIZE defined in EXT\_CSD. Refer to Table 50 — for the detailed description of CMD53 fields.

#### 6.6.19.2 PROTOCOL\_WR - CMD54

This command works in similar fashion to the multi block Write Multiple Block command (CMD25) and sends security protocol related information to the device. The Security Protocol being referenced is passed in the command arguments. The number of blocks to be transferred shall be provided in advance by using CMD23 (SET\_BLOCK\_COUNT). Sector size is fix 512Bytes regardless of the NATIVE\_SECTOR\_SIZE or DATA\_SECTOR\_SIZE defined in EXT\_CSD. The Busy Programming timeout for this command is defined as max 10Sec and it is non interruptible with HPI. In case HPI is used during the Busy Programming time of CMD54 it shall be ignored by device.

Refer to Table 50 — for the detailed description of CMD54 fields.

#### 6.6.19.3 Security Protocol Type

The meaning and coding of the Security Protocol argument fields in CMD53 and CMD54 shall be identical to the SECURITY PROTOCOL field in the definition of the SCSI commands SECURITY PROTOCOL IN and SECURITY PROTOCOL OUT respectively, as defined in the T10 SPC-4 specification. For further information on the Extended Security supported protocols refer to a separate JEDEC Security Extension Standard.

#### 6.6.19.4 Security Protocol Information

When received PROTOCOL\_RD (CMD53) with Security protocol value equal to 00h device shall return the list of supported protocols as described in Table 15 — .

**Table 15 — Security Protocol Information**

Byte Number	Value
0	Reserved
1	Reserved
2	Reserved
3	Reserved
4	Reserved
5	Reserved
6	List length (MSB)
7	List length (LSB)
8	Supported security protocols list
...	
M	Padding
M+1	
...	Padding
N	

The values shall be in ascending order starting with 00h. Pad Bytes shall have value ‘0’.

NOTE Devices that support several Security Systems may not support them simultaneously during the same power on session.

#### 6.6.19.5 Error handling

Bit4 of EXCEPTION\_EVENTS\_STATUS field in the EXT\_CSD named EXTENDED\_SECURITY\_FAILURE indicates error occurrence while usage of PROTOCOL\_RD and PROTOCOL\_WR commands or in relation to the Extended Protocols usage. In case of such error the host may read the detailed cause of the error in EXT\_SECURITY\_ERR[505] field of EXT\_CSD.

### 6.6.20 Production State Awareness

eMMC device could utilize the information of whether it is in production environment and operate differently than it operates in the field.

For example, content which was loaded into the storage device prior to soldering might get corrupted, at higher probability, during device soldering. The eMMC device could use “special” internal operations for loading content prior to device soldering which would reduce production failures and use “regular” operations post-soldering.

PRODUCTION\_STATE\_AWARENESS [133] field in extended CSD is used as a mechanism through which the host should report to the device whether it is pre or post soldering state.

This standard defines two methods, Manual Mode and Auto Mode, to manage the device production state.

### 6.6.20 Production State Awareness (cont'd)

The trigger for starting or re-starting the process is setting correctly PRE\_LOADING\_DATA\_SIZE field. Before setting this field the host is expected to make sure that the device is clean and any data which was written before to the device is expected to be erased using CMD35, CMD36 and CMD38.

In case the host erased data, override existing data or preformed re-partition during production state awareness it should restart the production state awareness process by re-setting PRE\_LOADING\_DATA\_SIZE.

#### 6.6.20.1 Manual Mode

Using Manual Mode method the host explicitly sets the production state by changing the PRODUCTION\_STATE\_AWARENESS field. The host should to PRE\_SOLDERING\_WRITES state when the device is in production prior soldering and before the host loaded content to the device. When loading of content is complete the host should set to PRE\_SOLDERING\_POST\_WRITES state. In this state the host should not write content to the device until soldering is performed. Once soldered, the host should set PRODUCTION\_STATE\_AWARENESS to Normal state.

In this mode the host is not expected to write any data to the device until PRODUCTION\_STATE\_AWARENESS is set to PRE\_SOLDERING\_WRITES.

In case the feature is enabled and the host writes to the device not in PRE\_SOLDERING\_WRITES state the device may response with an error.

PRODUCTION\_STATE\_AWARENESS state change may exceed the switch command timeout. The maximum timeout for PRODUCTION\_STATE\_AWARENESS state change is defined by the device manufacturer in PRODUCTION\_STATE\_AWARENESS\_TIMEOUT [218].

#### 6.6.20.2 Auto Mode

Using Auto Method the host sets the amount of data which would be loaded to the device prior to soldering. The host sets PRODUCTION\_STATE\_AWARENESS to AUTO\_PRE\_SOLDERING to signal the device that the Auto mode is used. Once all data have been loaded, the device automatically changes the PRODUCTION\_STATE\_AWARENESS back to Normal state.

In this mode the host is expected to write data to the device only after it sets PRODUCTION\_STATE\_AWARENESS to AUTO\_PRE\_SOLDERING. In case the feature is enabled and the host writes to the device not in AUTO\_PRE\_SOLDERING state the device may response with an error.

After PRE\_LOADING\_DATA\_SIZE amount of data has been loaded the device switches automatically PRODUCTION\_STATE\_AWARENESS to Normal.

If the host continues to write data in Normal state (after it wrote PRE\_LOADING\_DATA\_SIZE amount of data) and before soldering occurred device may respond with an error.

If a power cycle is occurred during the data transfer, the amount of data written to device is not clear. Therefore in this case, host should erase the entire pre-loaded data and set PRE\_LOADING\_DATA\_SIZE to the desired size.

### 6.6.20.2 Auto Mode (cont'd)

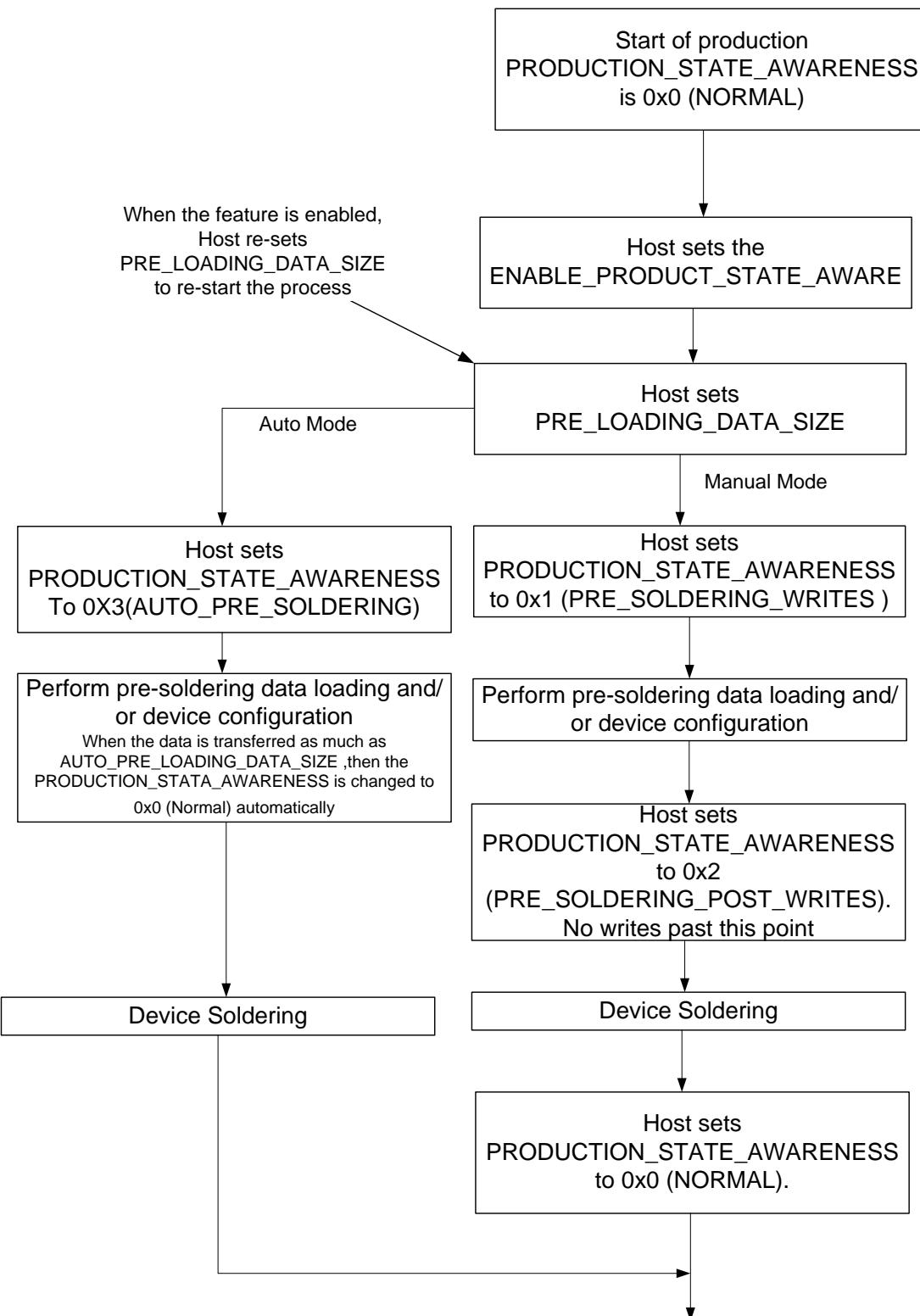


Figure 32 — Recommended Soldering procedure

### 6.6.21 Field Firmware Update

Field Firmware Updates (FFU) enables features enhancement in the field. Using this mechanism the host downloads a new version of the firmware to the *e*•MMC device and, following a successful download, instructs the *e*•MMC device to install the new downloaded firmware into the device.

In order to start the FFU process the host first checks if the *e*•MMC device supports FFU capabilities by reading SUPPORTED\_MODES and FW\_CONFIG fields in the EXT\_CSD. If the *e*•MMC device supports the FFU feature the host may start the FFU process. The FFU process starts by switching to FFU Mode in MODE\_CONFIG field in the EXT\_CSD. In FFU Mode host should use closed-ended or open ended commands for downloading the new firmware and reading vendor proprietary data. In this mode, the host should set the argument of these commands to be as defined in FFU\_ARG field. In case these commands have a different argument the device behavior is not defined and the FFU process may fail. The host should set Block Length to be DATA\_SECTOR\_SIZE. Downloaded firmware bundle must be DATA\_SECTOR\_SIZE size aligned (internal padding of the bundle might be required).

Once in FFU Mode the host may send the new firmware bundle to the device using one or more write commands.

The host could regain regular functionality of write and read commands by setting MODE\_CONFIG field in the EXT\_CSD back to Normal state. Switching out of FFU Mode may abort the firmware download operation. When switched back-in to FFU Mode, the host should check the FFU Status to get indication about the number of sectors which were downloaded successfully by reading the NUMBER\_OF\_FW\_SECTORS\_CORRECTLY\_PROGRAMMED in the extended CSD. In case the number of sectors which were downloaded successfully is zero the host should re-start downloading the new firmware bundle from its first sector. In case the number of sectors which were downloaded successfully is positive the host should continue the download from the next sector, which would resume the firmware download operation.

In case MODE\_OPERATION\_CODES field is supported by the device (defined in SUPPORTED\_MODE\_OPERATION\_CODES bit in FFU\_FEATURES field in extended CSD) the host may abort the firmware download process by setting MODE\_OPERATION\_CODES to FFU\_ABORT to inform the device the FFU operation has been aborted. In response the device shall set NUMBER\_OF\_FW\_SECTORS\_CORRECTLY\_PROGRAMMED field to zero and be ready to receive a new firmware bundle. If the host finished downloading successfully the firmware bundle to the device it may set MODE\_OPERATION\_CODES to FFU\_INSTALL, the device shall set NUMBER\_OF\_FW\_SECTORS\_CORRECTLY\_PROGRAMMED field to zero, install the new firmware and set MODE\_CONFIG to Normal state which would regain regular operation of read and write commands. The host should set MODE\_OPERATION\_CODES to FFU\_INSTALL. If the host performs a CMD0/HW\_Reset/Power cycle through the FFU process, prior to successful execution of the FFU\_INSTALL command, device may abort the download process.

In case MODE\_OPERATION\_CODES field is not supported by the device the host sets to NORMAL state and initiates a CMD0/HW\_Reset/Power cycle to install the new firmware. In such case the device doesn't need to use NUMBER\_OF\_FW\_SECTORS\_CORRECTLY\_PROGRAMMED.

In both cases occurrence of a CMD0/HW\_Reset/Power occurred before the host successfully downloaded the new firmware bundle to the device may cause the firmware download process to be aborted.

When in FFU\_MODE and host sends other commands which are not part of the recommended flow, device behavior may be undefined.

### 6.6.22 Device lock/unlock operation

The password protection feature enables the host to lock the Device by providing a password, which later will be used for unlocking the Device. The password and its size are kept in a 128 bit PWD and 8 bit PWD\_LEN registers, respectively. These registers are non-volatile so that a power cycle will not erase them.

The password protection feature can be disabled permanently by setting the permanent password disable bit in the extended CSD (PERM\_PSWD\_DIS bit in the EXT\_CSD byte [171]). If the host attempts to permanently disable CMD42 features on an eMMC having a password set, the action will fail and the ERROR (bit 19) error bit will be set by the memory device in the Device status register. It is recommended to disable the password protection feature on the Device, if it is not required, to prevent it being set unintentionally or maliciously.

An attempt to use password protection features (CMD42) on a Device having password permanently disabled will fail and the LOCK\_UNLOCK\_FAILED (bit 24) error bit will be set in the status register.

A locked Device responds to (and executes) all commands in the “basic” command class (class 0) and “lock Device” command class. Thus the host is allowed to reset, initialize, select, query for status, etc., but not to access data on the Device. If the password was previously set (the value of PWD\_LEN is not ‘0’) the Device will be locked automatically after power on.

On v4.3 and later version devices, the Lock command can be applied to user data area only. So the host can still access the boot partitions, RPMB and General partition area after Lock command is issued to the devices.

Similar to the existing CSD and CID register write commands the lock/unlock command is available in “transfer state” only. This means that it does not include an address argument and the Device has to be selected before using it.

The Device lock/unlock command (CMD42) has the structure and bus transaction type of a regular single block write command. The transferred data block includes all the required information of the command (password setting mode, PWD itself, Device lock/unlock etc.). The following table describes the structure of the command data block.

The Device lock/unlock command (CMD42) can only be performed when the Device operates in single data rate mode. CMD42 is an illegal command in dual data rate mode.

Table 16 — Lock Device data structure

Byte #	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
0	Reserved				ERASE	LOCK_UNLOCK	CLR_PWD	SET_PWD
1	PWD_LEN							
2	Password data							
...								
PWD_LEN +1								

- **ERASE:** ‘1’ Defines Forced Erase Operation (all other bits shall be ‘0’) and only the cmd byte is sent.
- **LOCK/UNLOCK:** ‘1’ = Locks the Device. ‘0’ = Unlock the Device (note that it is valid to set this bit together with SET\_PWD but it is not allowed to set it together with CLR\_PWD).
- **CLR\_PWD:** ‘1’ = Clears PWD.
- **SET\_PWD:** ‘1’ = Set new password to PWD
- **PWD\_LEN:** Defines the following password length (in bytes). Valid password lengths are 1 to 16 bytes.
- **PWD:** The password (new or currently used depending on the command).

### 6.6.22 Device lock/unlock operation (cont'd)

The data block size shall be defined by the host before it sends the Device lock/unlock command. This will allow different password sizes.

The following paragraphs define the various lock/unlock command sequences:

#### Setting the password:

- Select the Device (CMD7), if not previously selected already
- Define the block length (CMD16), given by the 8bit Device lock/unlock mode, the 8 bits password size (in bytes), and the number of bytes of the new password. In case that a password *replacement* is done, then the block size shall consider that both passwords, the old and the new one, are sent with the command.
- Send Device Lock/Unlock command (CMD42) with the appropriate data block size on the data line including 16 bit CRC. The data block shall indicate the mode (SET\_PWD), the length (PWD\_LEN) and the password itself. In case that a password *replacement* is done, then the length value (PWD\_LEN) shall include both passwords, the old and the new one, and the PWD field shall include the old password (currently used) followed by the new password. Each of the old and the new password length should not exceed 16 Bytes. In case that the new password length exceeds 16 Bytes, the LOCK\_UNLOCK\_FAILED error bit is set in the status register and the old password is not changed.
- In case that a password replacement is attempted with PWD\_LEN set to the length of the old password only, the LOCK\_UNLOCK\_FAILED error bit is set in the status register and the old password is not changed.
- In case that the sent old password is not correct (not equal in size and content) then LOCK\_UNLOCK\_FAILED error bit will be set in the status register and the old password does not change. In case that PWD matches the sent old password then the given new password and its size will be saved in the PWD and PWD\_LEN fields, respectively.

NOTE The password length register (PWD\_LEN) indicates if a password is currently set. When it equals '0' there is no password set. If the value of PWD\_LEN is not equal to zero, the Device will lock itself after power up. It is possible to lock the Device immediately in the current power session by setting the LOCK/UNLOCK bit (while setting the password) or sending additional command for Device lock.

#### Reset the password:

- Select the Device (CMD7), if not previously selected already
- Define the block length (CMD16), given by the 8 bit Device lock/unlock mode, the 8 bit password size (in bytes), and the number of bytes of the currently used password.
- Send the Device lock/unlock command (CMD42) with the appropriate data block size on the data line including 16 bit CRC. The data block shall indicate the mode CLR\_PWD, the length (PWD\_LEN) and the password (PWD) itself (LOCK/UNLOCK bit is don't care). If the PWD and PWD\_LEN content match the sent password and its size, then the content of the PWD register is cleared and PWD\_LEN is set to 0. If the password is not correct then the LOCK\_UNLOCK\_FAILED error bit will be set in the status register.

### 6.6.22 Device lock/unlock operation (cont'd)

#### Locking the Device:

- Select the Device (CMD7), if not previously selected already
- Define the block length (CMD16), given by the 8 bit Device lock/unlock mode, the 8 bit password size (in bytes), and the number of bytes of the currently used password.
- Send the Device lock/unlock command (CMD42) with the appropriate data block size on the data line including 16 bit CRC. The data block shall indicate the mode LOCK, the length (PWD\_LEN) and the password (PWD) itself.
- If the PWD content equals to the sent password then the Device will be locked and the Device-locked status bit will be set in the status register. If the password is not correct then LOCK\_UNLOCK\_FAILED error bit will be set in the status register.

NOTE It is possible to set the password and to lock the Device in the same sequence. In such case the host shall perform all the required steps for setting the password (as described above) including the bit LOCK set while the new password command is sent.

If the password was previously set (PWD\_LEN is not '0'), then the Device will be locked automatically after power on reset. An attempt to lock a locked Device or to lock a Device that does not have a password will fail and the LOCK\_UNLOCK\_FAILED error bit will be set in the status register.

#### Unlocking the Device:

- Select the Device (CMD7), if not previously selected already.
- Define the block length (CMD16), given by the 8 bit Device lock/unlock mode, the 8 bit password size (in bytes), and the number of bytes of the currently used password.
- Send the Device lock/unlock command (CMD42) with the appropriate data block size on the data line including 16 bit CRC. The data block shall indicate the mode UNLOCK, the length (PWD\_LEN) and the password (PWD) itself.

If the PWD content equals to the sent password then the Device will be unlocked and the Device-locked status bit will be cleared in the status register. If the password is not correct then the LOCK\_UNLOCK\_FAILED error bit will be set in the status register.

NOTE The unlocking is done only for the current power session. As long as the PWD is not cleared the Device will be locked automatically on the next power up. The only way to unlock the Device is by clearing the password. An attempt to unlock an unlocked Device will fail and LOCK\_UNLOCK\_FAILED error bit will be set in the status register.

### 6.6.22 Device lock/unlock operation (cont'd)

#### Forcing erase:

- In case that the user forgot the password (the PWD content) it is possible to erase all the Device data content along with the PWD content. This operation is called *Forced Erase*.
- Select the Device (CMD7), if not previously selected already.

Define the block length (CMD16) to 1 byte (8bit Device lock/unlock command). Send the Device lock/unlock command (CMD42) with the appropriate data block of one byte on the data line including 16 bit CRC. The data block shall indicate the mode ERASE (the ERASE bit shall be the only bit set).

If the ERASE bit is not the only bit in the data field then the LOCK\_UNLOCK\_FAILED error bit will be set in the status register and the erase request is rejected. If the command was accepted then ALL THE DEVICE CONTENT WILL BE ERASED including the PWD and PWD\_LEN register content and the locked Device will get unlocked. In addition, if the Device is temporary write protected it will be unprotected (write enabled), the temporary-write-protect bit in the CSD and all temporary Write-Protect-Groups will be cleared.

If a force erase command is issued on power-on protected or a permanently-write-protected write protect group the command will fail (Device stays locked) and the LOCK\_UNLOCK\_FAILED error bit will be set in the status register

An attempt to force erase on an unlocked Device will fail and LOCK\_UNLOCK\_FAILED error bit will be set in the status register. If a force erase command is issued on a permanently-write-protect media the command will fail (Device stays locked) and the LOCK\_UNLOCK\_FAILED error bit will be set in the status register.

The Force Erase time-out is specified in 6.8.2. On v4.3 and later version devices, when host issues the Force erase, only the data stored in user data area (including enhanced attribute area) will be erased. The Force erase will not applied to Boot, RPMB and General partition area.

### 6.6.23 Application-specific commands

The e•MMC system is designed to provide a standard interface for a variety applications types. In this environment, it is anticipated that there will be a need for specific customers/applications features. To enable a common way of implementing these features, two types of generic commands are defined in the standard:

- Application-specific command—APP\_CMD (CMD55)

This command, when received by the Device, will cause the Device to interpret the following command as an application specific command, ACMD. The ACMD has the same structure as of regular e•MMC standard commands and it may have the same CMD number. The Device will recognize it as ACMD by the fact that it appears after APP\_CMD. The only effect of the APP\_CMD is that if the command index of the, immediately, following command has an ACMD overloading, the non standard version will be used. If, as an example, a Device has a definition for ACMD13 but not for ACMD7 then, if received immediately after APP\_CMD command, Command 13 will be interpreted as the non standard ACMD13 but, command 7 as the standard CMD7.

### 6.6.23 Application-specific commands (cont'd)

In order to use one of the manufacturers specific ACMD's the host will:

- Send APP\_CMD. The response will have the APP\_CMD bit (new status bit) set signaling to the host that ACMD is now expected.
- Send the required ACMD. The response will have the APP\_CMD bit set, indicating that the accepted command was interpreted as ACMD. If a non-ACMD is sent then it will be respected by the Device as normal eMMC command and the APP\_CMD bit in the Device Status stays clear.

If a non valid command is sent (neither ACMD nor CMD) then it will be handled as a standard eMMC illegal command error. From the eMMC protocol point of view the ACMD numbers will be defined by the manufacturers without any restrictions.

- General command—GEN\_CMD (CMD56)

The bus transaction of the GEN\_CMD is the same as the single block read or write commands (CMD24 or CMD17). The difference is that the argument denotes the direction of the data transfer (rather than the address) and the data block is not a memory payload data but has a vendor specific format and meaning. The Device shall be selected ('*tran\_state*') before sending CMD56. If the Device operates in the single data rate mode, the data block size is the BLOCK\_LEN that was defined with CMD16. If the Device operates in the dual data rate mode, the data block size is 512 bytes. The response to CMD56 will be R1.

### 6.6.24 Sleep (CMD5)

A Device may be switched between a Sleep state and a Standby state by SLEEP/AWAKE (CMD5). In the Sleep state the power consumption of the memory device is minimized. In this state the memory device reacts only to the commands RESET (CMD0 with argument of either 0x00000000 or 0xF0F0F0F0 or H/W reset) and SLEEP/AWAKE (CMD5). All the other commands are ignored by the memory device. The timeout for state transitions between Standby state and Sleep state is defined in the EXT\_CSD register S\_A\_timeout. The maximum current consumptions during the Sleep state are defined in the EXT\_CSD registers S\_A\_VCC and S\_A\_VCCQ.

Sleep command: The bit 15 as set to 1 in SLEEP/AWAKE (CMD5) argument. Awake command: The bit 15 as set to 0 in SLEEP/AWAKE (CMD5) argument.

The Sleep command is used to initiate the state transition from Standby state to Sleep state. The memory device indicates the transition phase busy by pulling down the DAT0 line. No further commands should be sent during the busy. The Sleep state is reached when the memory device stops pulling down the DAT0 line.

The Awake command is used to initiate the transition from Sleep state to Standby state. The memory device indicates the transition phase busy by pulling down the DAT0 line. No further commands should be sent during the busy. The Standby state is reached when the memory device stops pulling down the DAT0 line.

During the Sleep state the Vcc power supply may be switched off. This is to enable even further system power consumption saving. The Vcc supply is allowed to be switched off only after the Sleep state has been reached (the memory device has stopped to pull down the DAT0 line). The Vcc supply have to be ramped back up at least to the min operating voltage level before the state transition from Sleep state to Standby state is allowed to be initiated (Awake command).

#### **6.6.24 Sleep (CMD5) (cont'd)**

A locked Device may be placed into Sleep state by first deselecting the Device through CMD7, which is a Class 0 command that can be executed in the locked state, and then issuing the Sleep command. This would allow the Device to save power consumption while it is locked. The locked Device can subsequently exit sleep and be placed into Standby state through the Awake command.

The reverse sequence, locking the device after it has already entered sleep, is not allowed.

#### **6.6.25 Replay Protected Memory Block**

A signed access to a Replay Protected Memory Block is provided. This function provides means for the system to store data to the specific memory area in an authenticated and replay protected manner. This is provided by first programming authentication key information to the *e*•MMC memory (shared secret).

As the system cannot be authenticated yet in this phase the authentication key programming have to take in a secure environment like in an OEM production. Further on the authentication key is utilized to sign the read and write accesses made to the replay protected memory area with a Message Authentication Code (MAC).

Usage of random number generation and count register are providing additional protection against replay of messages where messages could be recorded and played back later by an attacker

### 6.6.25.1 The Data Frame for Replay Protected Memory Block Access

The data frame to access the replay protected memory area is including following fields of data.

**Table 17 — Data Frame Files for RPMB**

Start	Stuff Bytes	Key/ (MAC)	Data	Nonce	Write Counter	Address	Block Count	Result	Req/ Resp	CRC16	
1bit	196Byte	32Byte (256b)	256Byte	16Byte	4Byte	2Byte	2Byte	2Byte	2Byte	2Byte	
	[511:316]	[315:284]	[283:28]	[27:12]	[11:8]	[7:6]	[5:4]	[3:2]	[1:0]		

Byte order of the RPMB data frame is MSB first, e.g., Write Counter MSB [11] is storing the upmost byte of the counter value.

**Name: Request/Response Type**

- Length: 2B
- Direction: Request (to the memory), Response (from the memory)
- Description: defines the type of request and response to/from the memory. Table 18 is listing the defined requests and responses. The response type is corresponding to the previous Replay Protected Memory Block read/write request.

**Table 18 — RPMB Request/Response Message Types**

Request Message Types	
0x0001	Authentication key programming request
0x0002	Reading of the Write Counter value -request
0x0003	Authenticated data write request
0x0004	Authenticated data read request
0x0005*	Result read request
Response Message Types	
0x0100	Authentication key programming response
0x0200	Reading of the Write Counter value -response
0x0300	Authenticated data write response
0x0400	Authenticated data read response

NOTE There is no corresponding response type for the Result read request because the reading of the result with this request is always relative to previous programming access.

**Name: Authentication Key / Message Authentication Code (MAC)**

- Length: 32Bytes (256bits)
- Direction: Request (key or MAC) / Response (MAC)
- Description: the authentication key or the message authentication code (MAC) depending on the request/response type. The MAC will be delivered in the last (or the only) block of data.

**Name: Operation Result**

- Length: 2B
- Direction: Response
- Description: includes information about the status of the write counter (valid, expired) and successfulness of the access made to the Replay Protected Memory Block. Table 19 is listing the defined results and possible reasons for failures.

### 6.6.25.1 The Data Frame for Replay Protected Memory Block Access (cont'd)

**Table 19 — RPMB Operation Results data structure**

Bit[15:8]	Bit[7]	Bit[6:0]
reserved	Write Counter Status	Operation Result

**Table 20 — RPMB Operation Results**

<b>Operation Results</b>	
0x0000 (0x0080)*	Operation OK
0x0001 (0x0081)	General failure
0x0002 (0x0082)	Authentication failure (MAC comparison not matching, MAC calculation failure)
0x0003 (0x0083)	Counter failure (counters not matching in comparison, counter incrementing failure)
0x0004 (0x0084)	Address failure (address out of range, wrong address alignment)
0x0005 (0x0085)	Write failure (data/counter/result write failure)
0x0006 (0x0086)	Read failure (data/counter/result read failure)
0x0007**	Authentication Key not yet programmed

\* The values in parenthesis are valid in case the Write Counter has expired i.e. reached its max value  
 \*\* This value is the only valid Result value until the Authentication Key has been programmed  
 (after which it can never occur again)

#### Name: Write Counter

- Length: 4Bytes
- Direction: Request and Response.
- Description: Counter value for the total amount of the successful authenticated data write requests made by the host.

#### Name: Data Address

- Length: 2B
- Direction: Request and Response.
- Description: Address of the data to be programmed to or read from the Replay Protected Memory Block. Address is the serial number of the accessed half sector (256B). Address argument in CMD 18 and CMD 25 will be ignored.

#### Name: Nonce

- Length: 16B
- Direction: Request and Response.
- Description: Random number generated by the host for the Requests and copied to the Response by the eMMC Replay Protected Memory Block engine.

#### Name: Data

- Length: 256B
- Direction: Request and Response.
- Description: Data to be written or read by signed access.

#### Name: Block Count

- Length: 2B
- Direction: Request.
- Description: Number of blocks (half sectors, 256B) requested to be read/programmed. This value is equal to the count value in CMD23 argument.

### 6.6.25.2 Memory Map of the Replay Protected Memory Block

The Replay Protected Memory Block is including following registers and memory partition:

#### Name: Authentication Key

- Size: 32B
- Type: Write once
- Description: One time programmable authentication key register. This register cannot be overwritten, erased or read. The key is used by the *e*•MMC Replay Protected Memory Block engine to authenticate the accesses when MAC is calculated.

#### Name: Write Counter

- Size: 4B
- Type: Read only
- Description: Counter value for the total amount of successful authenticated data write requests made by the host. Initial value after *e*•MMC production is 0x0000 0000. Value will be incremented by one automatically by the *e*•MMC Replay Protected Memory Block engine along with successful programming accesses. The value cannot be reset. After the counter has reached its maximum value 0xFFFF FFFF it will not be incremented anymore (overflow prevention) and the bit [7] in Operation Result value will be permanently set.

#### Name: Data

- Size: 128kB min (RPMB\_SIZE\_MULT x 128kB)
- Type: Read/Write
- Description: Data which can only be read and written via successfully authenticated read/write access. This data may be overwritten by the host but can never be erased.

### 6.6.25.3 Message Authentication Code Calculation

The message authentication code (MAC) is calculated using HMAC SHA-256 as defined in [HMAC-SHA]. The HMAC SHA-256 calculation takes as input a key and a message. The resulting MAC is 256 bits (32Byte), which are embedded in the data frame as part of the request or response.

The key used for the MAC calculation is always the 256 bit Authentication Key stored in the *e*MMC. The message used as input to the MAC calculation is the concatenation of the fields in the data frames excluding stuff bytes, the MAC itself, start bit, CRC16, and end bit. That is, the MAC is calculated over bytes [283:0] of the data frame in that order.

If several data frames are sent as part of one request or response then the input message to MAC is the concatenation of bytes [283:0] of each data frame in the order in which the data frames are sent. The MAC is added only to the last data frame.

Example: Assume that the write counter is 0x12345678. The host wants to write at address 0x0010 two sectors of where the first sector is 256 bytes of 0xAA and the second sector is 256 bytes of 0xBB. The host must then send to following two requests frames: Where the MAC in the second request frame is an HMAC. See Table 21 — for an illustration.

**Table 21 — MAC Example**

Start	Stuff Bytes	Key/ (MAC)	Data	Nonce	Write Counter	Address	Block Count	Result	Req/ Resp	CRC16	End
1bit	196Byte	32Byte (256b)	256Byte	16Byte	4Byte	2Byte	2Byte	2Byte	2Byte	2Byte	1bit
	[511:316]	[315:284]	[283:28]	[27:12]	[11:8]	[7:6]	[5:4]	[3:2]	[1:0]		
<b>Request frame 1</b>											
	0x0000...	0x0000...	0xAA...	0x000 0...	0x12345 678	0x0010	0x000 2	0x000 0	0x000 3		
<b>Request frame 2</b>											
	0x0000...	MAC	0xBB...	0x000 0...	0x12345 678	0x0010	0x000 2	0x000 0	0x000 3		

SHA-256 calculated over the following message:

0xAA... (total 256 times) ... 0xAA  
 0x0000 0x0000 0x0000 0x0000 0x0000 0x0000 0x0000  
 0x1234 0x5678 0x0010 0x0002 0x0000 0x0003  
 0xBB... (total 256 times) ... 0xBB  
 0x0000 0x0000 0x0000 0x0000 0x0000 0x0000 0x0000  
 0x1234 0x5678 0x0010 0x0002 0x0000 0x0003

The key used for the HMAC SHA-256 calculation is the authentication key stored in the *e*MMC.

**Reference:**

[HMAC-SHA] Eastlake, D. and T. Hansen, "US Secure Hash Algorithms (SHA and HMAC-SHA)", RFC 4634, July 2006.

#### 6.6.25.4 Accesses to the Replay Protected Memory Block

After putting a slave into transfer state, master sends CMD6 (SWITCH) to set the PARTITION\_ACCESS bits in the EXT\_CSD register, byte [179]. After that, master can use the Multiple Block read and Multiple Block Write commands (CMD23, CMD18 and CMD25) to access the Replay Protected Memory Block partition. The defined accesses are listed in following sections.

Any undefined set of parameters or sequence of commands, or High Priority Interrupt during Authenticated Write will result in a failed access.

- In Data Programming case the data shall not be programmed
- In Data Read case the data read shall be “0x00” (in multiple block case in all frames)”

A General Failure (0x01) will be indicated in the Results register (in multiple block case in all frames). If there are more than one failure related to an access then the first type of error shall be indicated in the Results register. The order of the error checking is defined under each access below. After finishing data access to the Replay Protected Memory Block partition, the PARTITION\_ACCESS bits should be cleared.

##### 6.6.25.4.1 Programming of the Authentication Key

The Authentication Key is programmed with the Write Multiple Block command, CMD25. In prior to the command CMD25 the block count is set to 1 by CMD23, with argument bit [31] set as 1 to indicate Reliable Write type of programming. If block count has not been set to 1 and/or argument bit [31] has not been set to 1 then the subsequent Write Multiple Block command must fail and General Failure shall be indicated.

The key information itself is delivered in data packet. The packet is size of 512B and it is including the request type information and the Authentication Key. The request type value 0x0001 indicates programming of the Authentication Key.

**Table 22 — Authentication Key Data Packet**

Start	Stuff Bytes	Key/ (MAC)	Data	Nonce	Write Counter	Address	Block Count	Result	Req/ Resp	CRC 16	End
1bit	196Byte	32Byte (256b)	256Byte	16Byte	4Byte	2Byte	2Byte	2Byte	2Byte	2Byte	1bit
	[511:316]	[315:284]	[283:28]	[27:12]	[11:8]	[7:6]	[5:4]	[3:2]	[1:0]		
0b	0x0000...		0x00	0x00	0x00	0x00	0x00	0x00	0x0001		1b

The busy signaling in the Dat0 line after the CRC status by the eMMC is indicating programming busy of the key. The status can also be polled with CMD13. The status response received in R1 is indicating the generic status condition, excluding the status of successful programming of the key.

The successfulness of the programming of the key should be checked by reading the result register of the Replay Protected Memory Block. The result read sequence is initiated by Write Multiple Block command, CMD25. Prior to CMD25, the block count is set to 1 by CMD23. If block count has not been set to 1 then the subsequent Write Multiple Block command must fail and General Failure shall be indicated.

The request type information is delivered in data packet. The packet is size of 512B and is including the request type information. The request type value 0x0005 indicates Result register read request initiation.

#### 6.6.25.4.1 Programming of the Authentication Key (cont'd)

**Table 23 — Result Register Read Request Packet**

Start	Stuff Bytes	Key/ (MAC)	Data	Nonce	Write Counter	Address	Block Count	Result	Req/ Resp	CRC16	End
1bit	196Byte	32Byte (256b)	256Byte	16Byte	4Byte	2Byte	2Byte	2Byte	2Byte	2Byte	1bit
	[511:316]	[315:284]	[283:28]	[27:12]	[11:8]	[7:6]	[5:4]	[3:2]	[1:0]		
0b	0x0000...	0x00	0x00	0x00	0x00	0x00	0x00	0x00	0x0000 5		1b

The busy signaling in the Dat0 line after the CRC status by the *e*MMC is indicating request busy. The result itself is read out with the Read Multiple Block command, CMD18. Prior to the read command, the block count is set to 1 by CMD23. If block count has not been set to 1 then the Read Multiple Block command must fail and General Failure shall be indicated.

The result information itself is delivered in the read data packet. The packet size is 512B and is including the response type information and result of the key programming operation. The response type value 0x0100 corresponds to the key programming request.

**Table 24 — Response for Key Programming Result Request**

Start	Stuff Bytes	Key/ (MAC)	Data	Nonce	Write Counter	Address	Block Count	Result	Req/ Resp	CRC16	End
1bit	196Byte	32Byte (256b)	256Byte	16Byte	4Byte	2Byte	2Byte	2Byte	2Byte	2Byte	1bit
	[511:316]	[315:284 ]	[283:28]	[27:12]	[11:8]	[7:6]	[5:4]	[3:2]	[1:0]		
0b	0x0000...	0x00	0x00	0x00	0x00	0x00	0x00		0x010 0		1b

Access to Reply Protected Memory Block is not allowed and not possible before Authentication Key is programmed. The state of the device can be checked by trying to write/read data to/from the Replay Protected Memory Block and then reading the result register. If the Authentication Key is not yet programmed then message 0x07 (Authentication Key not yet programmed) is returned in result field.

If programming of Authentication Key fails then returned result is 0x05 (Write failure). If some other error occurs during Authentication Key programming then returned result is 0x01 (General failure).

#### 6.6.25.4.2 Reading of the Counter Value

The counter read sequence is initiated by Write Multiple Block command, CMD25. Prior to CMD25, the block count is set to 1 by CMD23. If block count has not been set to 1 then the subsequent Write Multiple Block command must fail and General Failure shall be indicated.

The request type information is delivered in data packet. The packet is size of 512B and it is including the request type information and the nonce. The request type value 0x0002 indicates counter value read request initiation.

**Table 25 — Counter Read Request Packet**

Start	Stuff Bytes	Key/(MAC)	Data	Nonce	Write Counter	Address	Block Count	Result	Req/Resp	CRC16	End
1bit	196Byte	32Byte (256b)	256Byte	16Byte	4Byte	2Byte	2Byte	2Byte	2Byte	2Byte	1bit
	[511:316]	[315:284]	[283:28]	[27:12]	[11:8]	[7:6]	[5:4]	[3:2]	[1:0]		
0b	0x0000...	0x00	0x00		0x00	0x00	0x00	0x00	0x0002		1b

The busy signaling in the Dat0 line after the CRC status by the e•MMC is indicating request busy. The counter value itself is read out with the Read Multiple Block command, CMD18. Prior to the command CMD18, the block count is set to 1 by CMD23. If block count has not been set to 1 then the Read Multiple Block command must fail and General Failure shall be indicated.

The counter value itself is delivered in the read data packet. The packet size is 512B and it is including the response type information, a copy of the nonce received in the request, the write counter value, the MAC and the Result.

**Table 26 — Counter Value Response**

Start	Stuff Bytes	Key/(MAC)	Data	Nonce	Write Counter	Address	Block Count	Result	Req/Resp	CRC16	End
1bit	196Byte	32Byte (256b)	256Byte	16Byte	4Byte	2Byte	2Byte	2Byte	2Byte	2Byte	1bit
	[511:316]	[315:284]	[283:28]	[27:12]	[11:8]	[7:6]	[5:4]	[3:2]	[1:0]		
0b	0x0000..		0x00			0x00	0x00		0x0200		1b

If reading of the counter value fails then returned result is 0x06 (Read failure). If some other error occurs then Result is 0x01 (General failure). If counter has expired also bit 7 is set to 1 in returned results (Result values 0x80,0x86 and 0x81, respectively).

#### 6.6.25.4.3 Authenticated Data Write

Data to the Replay Protected Memory Block is programmed with the Write Multiple Block command, CMD25. In prior to the command CMD25 the block count is set by CMD23, with argument bit [31] set as 1 to indicate Reliable Write type of programming access. The block count is the number of the half sectors (256B) to be programmed. Note that the size of the access cannot exceed the size REL\_WR\_SEC\_C x 512B.

- two different sizes are supported in case of RPMB partition: 256B (single 512B frame) and 512B (two 512B frames) - as REL\_WR\_SEC\_C=1 is fixed setting per this version of the standard

If block count has not been set and/or argument bit[31] has not been set to 1 and/or the size exceeds the max size of Reliable Write access then the subsequent Write Multiple Block command must fail and General Failure shall be indicated.

Data itself is delivered in data packet. The packet is size of 512B and it is including the request type information, the block count, the counter value, the start address of the data, the data itself and the MAC. In multiple block write case the MAC is included only to the last packet n, the n-1 packets will include value 0x00. In every packet the address is the start address of the full access (not address of the individual half a sector) and the block count is the total count of the half sectors (not the sequence number of the half a sector). The request type value 0x0003 indicates programming of the data.

**Table 27 — Program Data Packet**

Start	Stuff Bytes	Key/ (MAC)	Data	Nonce	Write Counter	Address	Block Count	Result	Req/ Resp	CRC16	End
1bit	196Byte	32Byte (256b)	256Byte	16Byte	4Byte	2Byte	2Byte	2Byte	2Byte	2Byte	1bit
	[511:316]	[315:284]	[283:28]	[27:12]	[11:8]	[7:6]	[5:4]	[3:2]	[1:0]		
0b	0x0000...			0x00				0x00	0x000 3		1b

The busy signaling in the Dat0 line after the CRC status by the *e*MMC is indicating buffer busy between the sent blocks (in multiple block write case) and programming busy of the key after the last block (or in single block case). The status can also be polled with CMD13. The status response received in R1 is indicating the generic access status condition (e.g., state transitions), excluding the status of successfulness of programming of the data.

When the *e*MMC receives this message it first checks whether the write counter has expired. If the write counter is expired then *e*MMC sets the result to 0x85 (write failure, write counter expired). No data is written to the *e*MMC

Next the address is checked. If there is an error in the address (out of range) then the result is set to 0x04 (address failure). In case of multiple block write, if the Data Address is set to an odd address (i.e. wrong address alignment, the address is not the start address of the full access) then the result is set to 0x04 (address failure). No data are written to the *e*MMC. If the write counter was not expired then the MAC is calculated over bytes [283:0] (request type, result = 0x00, block count, write counter, address, nonce = 0x00 and data), and compares this with the MAC in the request. If the two MAC's are different then *e*MMC sets the result to 0x02 (authentication failure). No data are written to the *e*MMC.

If the MAC in the request and the calculated MAC are equal then the *e*MMC compares the write counter in the request with the write counter stored in the *e*MMC. If the two counters are different then *e*MMC sets the result to 0x03 (counter failure). No data are written to the *e*MMC.

#### 6.6.25.4.3 Authenticated Data Write (cont'd)

If the MAC and write counter comparisons are successful then the write request is considered to be authenticated. The data from the request are written to the address indicated in the request and the write counter is incremented by 1.

If write fails then returned result is 0x05 (write failure). If some other error occurs during the write procedure then returned result is 0x01 (General failure). The successfulness of the programming of the data should be checked by the host by reading the result register of the Replay Protected Memory Block. The result read sequence is initiated by Write Multiple Block command, CMD 25. Prior to CMD25, the block count is set to 1 by CMD23. If block count has not been set to 1 then the subsequent Write Multiple Block command must fail and General Failure shall be indicated.

The request type information is delivered in data packet. The packet is size of 512B and is including the request type information. The request type value 0x0005 indicates result register read request initiation.

**Table 28 — Result Register Read Request Packet**

Start	Stuff Bytes	Key/ (MAC)	Data	Nonce	Write Counter	Address	Block Count	Result	Req/ Resp	CRC 16	End
1bit	196Byte	32Byte (256b)	256Byte	16Byte	4Byte	2Byte	2Byte	2Byte	2Byte	2Byte	1bit
	[511:316]	[315:284]	[283:28]	[27:12]	[11:8]	[7:6]	[5:4]	[3:2]	[1:0]		
0b	0x00000... ..	0x00	0x00	0x00	0x00	0x00	0x00	0x00	0x0005		1b

The busy signaling in the Dat0 line after the CRC status by the e•MMC is indicating request busy. The result itself is read out with the Read Multiple Block command, CMD18. Prior to the read command, the block count is set to 1 by CMD23. If block count has not been set to 1 then the Read Multiple Block command must fail and General Failure shall be indicated. The result information itself is delivered in the read data packet. The packet size is 512B and includes the response type information, the incremented counter value, the data address, the MAC and result of the data programming operation.

**Table 29 — Response for Data Programming Result Request**

Start	Stuff Bytes	Key/ (MAC)	Data	Nonce	Write Counter	Address	Block Count	Result	Req/ Resp	CRC16	End
1bit	196Byte	32Byte (256b)	256Byte	16Byte	4Byte	2Byte	2Byte	2Byte	2Byte	2Byte	1bit
	[511:316]	[315:284]	[283:28]	[27:12]	[11:8]	[7:6]	[5:4]	[3:2]	[1:0]		
0b	0x00000... ..		0x00	0x00			0x00		0x0300		1b

#### 6.6.25.4.4 Authenticated Data Read

Data read sequence is initiated by Write Multiple Block command, CMD25. Prior to CMD25, the block count is set to 1 by CMD23. If block count has not been set to 1 then the subsequent Write Multiple Block command must fail and General Failure shall be indicated.

The request type information is delivered in the data packet. The packet is size of 512B and it is including the request type information, the nonce and the data address. The request type value 0x0004 indicates data read request initiation.

**Table 30 — Data Read Request Initiation Packet**

Start	Stuff Bytes	Key/ (MAC)	Data	Nonce	Write Counter	Address	Block Count	Result	Req/ Resp	CRC16	End
1bit	196Byte	32Byte (256b)	256Byte	16Byte	4Byte	2Byte	2Byte	2Byte	2Byte	2Byte	1bit
	[511:316]	[315:284] ]	[283:28]	[27:12]	[11:8]	[7:6]	[5:4]	[3:2]	[1:0]		
0b	0x0000...	0x00	0x00		0x00		0x00	0x00	0x000 4		1b

The busy signaling in the Dat0 line after the CRC status by the *e*•MMC is indicating request busy.

When the *e*•MMC receives this request it first checks the address. If there is an error in the address (out of range) then result is set to 0x04 (address failure). In case of multiple block read, if the Data Address is set to an odd address (i.e., wrong address alignment, the address is not the start address of the full access) then the result is set to 0x04 (address failure). The data read is not valid. The data itself is read out with the Read Multiple Block command, CMD18. Prior to the read command, the block count is set by CMD23.

**NOTE** The block count of the RPMB read operation is not indicated in the original RPMB Data Read Request packet. Block count set in CMD23 for reading out the RPMB data also indicates the block count for the RPMB read operation. This is intentional for RPMB implementation in *e*•MMC standard which may be different from implementations in other protocol standards.

The block count is the number of the half sectors (256B) to be read. If block count has not been set then the Read Multiple Block command must fail and General Failure shall be indicated. MAC is calculated over bytes [283:0] (response type, nonce, address, block count, write counter = 0x00, data and result). If the MAC calculation fails then returned result is 0x02 (Authentication failure).

The data information itself is delivered in the read data packet. The packet size is 512B and it is including the response type information, the block count, a copy of the nonce received in the request, the data address, the data itself, the MAC and the result. In multiple block read case the MAC is included only to the last packet n, the n-1 packets will include value 0x00. In every packet the address is the start address of the full access (not address of the individual half a sector) and the block count is the total count of the half sectors (not the sequence number of the half a sector).

**Table 31 — Read Data Packet**

Start	Stuff Bytes	Key/ (MAC)	Data	Nonce	Write Counter	Address	Block Count	Result	Req/ Resp	CRC16	End
1bit	196Byte	32Byte (256b)	256Byte	16Byte	4Byte	2Byte	2Byte	2Byte	2Byte	2Byte	1bit
	[511:316]	[315:284] ]	[283:28]	[27:12]	[11:8]	[7:6]	[5:4]	[3:2]	[1:0]		
0b	0x0000...				0x00				0x040 0		1b

If data fetch from addressed location inside *e*•MMC fails then returned result is 0x06 (Read failure). If some other error occurs during the read procedure then returned result is 0x01 (General failure).

### 6.6.26 Dual Data Rate mode selection

After the host verifies that the Device complies with version 4.4, or higher, of this standard, and supports dual data rate mode, it may enable the dual data rate data transfer mode in the Device. After power-on, hardware reset, or software reset, the operating mode of the Device is single data rate, except when the Device begins by performing boot operation, in which case the selection between single or dual data rate mode is determined by EXT\_CSD register byte [177] (BOOT\_BUS\_CONDITIONS) settings specified in Table 133 — . For the host to change to dual data rate mode, HS\_TIMING[3:0] shall be set to 0x1. For the host to change to HS400 mode, HS\_TIMING[3:0] shall be set to 0x3 (see 6.6.2) and the Device shall supports this mode as defined in EXT\_CSD register [196] (DEVICE\_TYPE) specified in Table 124 — .

The host uses the SWITCH command to write 0x05 (4-bit data width) or 0x06 (8-bit data width) to the BUS\_WIDTH byte, in the Modes segment of the EXT\_CSD register byte [183]. In HS400 mode, the host is expect to write 0x06(8-bit data width) to the BUS\_WIDTH byte, in the Modes segment of the EXT\_CSD register byte [183]. The valid values for this register are defined in Table 131 — . If the host tries to write an invalid value, the BUS\_WIDTH byte is not changed, the dual data rate mode is not enabled, and the SWITCH\_ERROR bit is set.

Conversely, a Device in the dual data mode may be switched back to single data rate mode by writing new values in the BUS\_WIDTH byte.

### 6.6.27 Dual Data Rate mode operation

After the Device has been enabled for dual data rate operating mode, the block length parameter of CMD17, CMD18, CMD24, CMD25 and CMD56 automatically default to 512 bytes and cannot be changed by CMD16 (SET\_BLOCKLEN) command which becomes illegal in this mode.

Therefore, all single or multiple block data transfer read or write will operates on a fixed block size of 512 bytes while the Device remains in dual data rate mode.

CMD 30 and CMD 31 are used in dual data rate mode with their native data size. Additionally to CMD16, CMD42 (LOCK\_UNLOCK), CMD14 (BUSTEST\_R), CMD19 (BUSTEST\_W), CMD11 (READ\_DAT\_UNTIL\_STOP) and CMD 20 (WRITE\_DAT\_UNTIL\_STOP) are considered illegal in the dual data rate mode. If any of these commands are required, the Device shall be switched to operate in single data rate mode before using these. CMD26 and CMD27 are supported in dual data rate mode if EXT\_CSD register [130] (PROGRAM\_CID\_CSD\_DDR\_SUPPORT) is set.

### 6.6.28 Background Operations

Devices have various maintenance operations need to perform internally. In order to reduce latencies during time critical operations like read and write, it is better to execute maintenance operations in other times - when the host is not being serviced. Operations are then separated into two types:

Foreground operations – operations that the host needs serviced such as read or write commands;

Background operations – operations that the device executes while not servicing the host; In order for the device to know when the host does not need it and it can execute background operations, host shall write any value to BKOPS\_START (EXT\_CSD byte [164]) to manually start background operations. Device will stay busy till no more background processing is needed.

Since foreground operations are of higher priority than background operations, host may interrupt ongoing background operations using the High Priority Interrupt mechanism (see 6.6.29). In order for the device to know if host is going to periodically start background operations, host shall set bit 0 of BKOPS\_EN (EXT\_CSD byte [163]) to indicate that it is going to write to BKOPS\_START periodically. The device may then delay some of its maintenance operations to when host writes to BKOPS\_START.

The device reports its background operation status in bits [1:0] of BKOPS\_STATUS (EXT\_CSD byte [246]), which can be in one of four possible levels: 0x0: No operations required 0x1: Operations outstanding – non critical 0x2: Operations outstanding – performance being impacted 0x3: Operations outstanding – critical

Host shall check the status periodically and start background operations as needed, so that the device has enough time for its maintenance operations, to help reduce the latencies during foreground operations. If the status is at level 3 ("critical"), some operations may extend beyond their original timeouts due to maintenance operations which cannot be delayed anymore. The host should give the device enough time for background operations to avoid getting to this level in the first place.

To allow hosts to quickly detect the higher levels, the URGENT\_BKOPS bit in the EXCEPTION\_EVENTS\_STATUS is set whenever the levels is either 2 or 3. That automatically sets the EXCEPTION\_BIT in Device Status. This allows hosts to detect urgent levels on every R1 type response. Hosts shall still read the full status from the BKOPS\_STATUS byte periodically and start background operations as needed.

The background operations feature is mandatory for *e*MMC 5.0 Devices. Bit 0 of BKOPS\_SUPPORT (EXT\_CSD byte [502]) shall be set.

### 6.6.29 High Priority Interrupt (HPI)

In some scenarios, different types of data on the device may have different priorities for the host. For example, writing operation may be time consuming and therefore there might be a need to suppress the writing to allow demand paging requests in order to launch a process when requested by the user.

The high priority interrupt (HPI) mechanism enables servicing high priority requests, by allowing the device to interrupt a lower priority operation before it is actually completed, within OUT\_OF\_INTERRUPT\_BUSY\_TIME timeout. Host may need to repeat the interrupted operation or part of it to complete the original request.

The HPI command may have one of two implementations in the device:

- CMD12 – based on STOP\_TRANSMISSION command when the HPI bit in its argument is set.
- CMD13 – based on SEND\_STATUS command when the HPI bit in its argument is set.

Host shall check the read-only HPI\_IMPLEMENTATION bit in HPI\_FEATURES (EXT\_CSD byte [503]) and use the appropriate command index accordingly.

If CMD12 is used with HPI bit set, it differs from the non-HPI command in the allowed state transitions. See Device state transition table (Table 51 — ) for the specific transitions for both cases.

HPI shall only be executed during prg-state. Then, it indicates the device that a higher priority command is pending and therefore it should interrupt the current operation and return to tran-state as soon as possible, with a different timeout value.

If HPI is received in states other than prg-state, the device behavior is defined by the Device state transition table (Table 51 — ). If the state transition is allowed, response is sent but the HPI bit is ignored. If the state transition is not allowed, the command is regarded as an illegal command.

HPI command is accepted as a legal command in prg-state. However, only some commands may be interrupted by HPI. If HPI is received during commands which are not interruptible, a response is sent but the HPI command has no effect and the original command is completed normally, possibly exceeding the OUT\_OF\_INTERRUPT\_TIME timeout. Table 32 — shows which commands are interruptible and which are not.

**Table 32 — Interruptible commands**

CMD Index	Name	Is interruptible?
CMD24	WRITE_BLOCK	Yes
CMD25	WRITE_MULTIPLE_BLOCK	Yes
CMD38	ERASE	Yes
CMD6	SWITCH, byte BKOPS_START, any value	Yes
CMD6	SWITCH, byte SANITIZE_START, any value	Yes
CMD6	SWITCH, byte POWER_OFF_NOTIFICATION, value POWER_OFF_LONG or SLEEP_NOTIFICATION	Yes
CMD6	SWITCH, byte POWER_OFF_NOTIFICATION, other values	No
CMD6	CACHE_CTRL when used for turning the cache OFF	Yes
CMD6	FLUSH_CACHE	Yes
CMD6	SWITCH, other bytes, any value	No
All others		No

### 6.6.29 High Priority Interrupt (HPI) (cont'd)

Following a WRITE\_MULTIPLE\_BLOCK command (CMD25), the device updates the CORRECTLY\_PRG\_SECTORS\_NUM field (EXT\_CSD bytes [245:242]) with the number of 512B sectors successfully written to the device. Host may use this information when repeating an interrupted write command – it does not need to re-write again all data sectors, it may skip the correctly programmed sectors and continue writing only the rest of the data that wasn't yet programmed.

In case HPI is interrupting a CMD25 which is part of a packed write command (see 6.6.32), the CORRECTLY\_PRG\_SECTORS\_NUM field will reflect the accumulated packed sectors that were transferred (plus header) – host may calculate from this number the index of the interruptible individual command and the offset of interruption for it.

If HPI is received during a reliable-write command, the first CORRECTLY\_PRG\_SECTORS\_NUM sectors shall contain the new data and all the rest of the sectors shall contain the old data.

The HPI mechanism shall be enabled before it may be used, by setting the HPI\_EN bit in the HPI\_MGMT field (EXT\_CSD byte [161]). The HPI feature is mandatory for e•MMC 5.0 devices. All devices shall have the HPI\_SUPPORT bit in HPI\_FEATURES field (EXT\_CSD byte [503]) set.

### 6.6.30 Context Management

To better differentiate between large sequential operations and small random operations, and to improve multitasking support, contexts can be associated with groups of read or write commands. Associating a group of commands with a single context allows the device to optimize handling of the data.

A context can be seen as an active session, configured for a specific read/write pattern (e.g., sequential in some granularity). Multiple read or write commands are associated with this context to create some logical association between them, to allow device to optimize performance. For example, a large sequential write pattern may have better performance by allowing the device to improve internal locality and reduce some overheads (e.g., if some large unit of data is allowed to be affected by a power failure as a whole while it is being written to, all of the commands that fill this unit can work faster because they can reduce the overhead usually required to protect each write individually in case of a power failure). Furthermore, handling of multiple concurrent contexts allows the device to better recognize each of the write patterns without getting confused when they are all mixed together.

Device may support one or more concurrent contexts, defined by a context-ID. Context ID #0 always exists for backward compatibility and for context-less data. Each context ID (besides #0) has a configuration field in EXT\_CSD to control its behavior.

To use a context, an available context ID shall be picked. Then, it shall be initialized by writing the configuration register. Then, data can be read/written associated to the context by specifying the context ID and the number of blocks (> 0) in SET\_BLOCK\_COUNT command (CMD23) before sending the read/write command. When the context is no longer used, the configuration register should be updated to close the context ID. A context shall be closed prior to re-configuring it for another configuration/use.

**NOTE** A Read/Write command using context shall be close-ended command. In case the host uses an open-ended command the device may consider the read/write command a context-less command.

### 6.6.30.1 Context configuration

Before any context can be used it shall be configured, except for context #0 which is always pre-configured and cannot be changed.

Configuration is done by writing to the configuration register of the specific context ID required. Then, all read commands or write commands that are associated with this context ID shall be sent with the ID. When the context is no longer needed, it should be closed by writing a zero byte to the configuration register.

The configuration registers are an array of 15 byte registers, one for each context (except the fixed, pre-defined #0). To configure a context, the following fields shall be written to the configuration register of the specific context needed:

- Activation and direction mode (read-only, write-only or read/write)  
The direction indicates if all following accesses to this context would be either read-only, write-only or both read/write.  
Writing a non-zero direction to this field is the ‘activation code’ for the context. A zero in this field means a closed context which can no longer be addressed by its ID until re-configured.
- Large Unit context flag  
This indicates if the context is following Large Unit rules or not
  - If Large Unit context flag is set, then the Large Unit multiplier may be used to specify a larger unit to be used instead of the Large Unit itself
- Reliability mode Controls how data written to a context should respond to interruptions

### 6.6.30.2 Context direction

A non-zero context can be configured as a read-only context, a write-only context or a read/write context. Context #0 is always treated as a read/write context.

Any read command from any context (including #0) to an address that is part of an active write-only context is not allowed, and may either fail the command or return dummy data.

Any write command from any context (including #0) to an address that is part of an active read-only context is not allowed, and may either fail the command, ignore the data written or cause unexpected data to return in the read commands.

A context that is configured as read/write context may be read while written, as long as the writing follows the context rules. Note that read/write context may have reduced performance compared to read-only or write-only contexts.

### 6.6.30.3 Large-Unit

The Large Unit is the smallest unit that can be used for large sequential read/write operations, in order to reduce internal overheads and improve performance.

Accessing a Large Unit (both read & write) shall:

- Use a context-ID configured to operate in Large Units
- Always access a full Large Unit, in order and from beginning to end
  - Multiple read/write commands may be used to read or write the Large Unit and they may be interleaved with other accesses and commands, as long as the specific Large Unit is being accessed with its own separate context ID
  - A Large Unit that is being written to shall not be modified outside the scope of the context (e.g., no other writes from other contexts to the address range of the Large Unit shall be used, no erases/trims to that range, etc.)
  - Different Large Units belonging to the same context may be located in non-consecutive addresses on the media, as long as alignment is kept (a Large Unit shall be accessed in order from beginning to end, but only within the range of the specific Large Unit – the next Large Unit can be non-consecutive and even in a lower address)
- When writing a Large Unit context, data shall always be aligned and in multiples of SUPER\_PAGE\_SIZE

When writing a Large Unit context, last Large Unit before closing the context may be partially written, as long as it is written from the beginning, in order and up to a specific point where it is closed. Host should be aware that the rest of the Large Unit may be padded (by the device) to the end of the Large Unit with some data (may be random).

#### 6.6.30.4 Context Writing Interruption

In case a write command to a context-ID other than #0 is interrupted, the device behaves as if all the writes to the context from its configuration were written in one large write command.

In case of a power failure, RST\_n assertion or CMD0 before closing an active context – even if not in the middle of a write command to the specific context (even if not in the middle of any command) – is considered as if the event occurred during writing the entire context.

During a context write operation to a partition with WR\_REL\_SET set to ‘1’, reliability mode of context would be according to the context Reliability Mode. It means that data written inside a context may be lost by power loss even if WR\_REL\_SET is set to ‘1’; whereas during a context write operation to a partition with WR\_REL\_SET set to ‘0’, reliability mode of the context would be ignored (regardless of the context Reliability Mode).

In any case, once the context is closed the data would be protected according to WR\_REL\_SET.

The reliable write bit in CMD23 is ignored when context-ID is non-zero. Instead, the context behavior is determined as part of its configuration and is applied to all writes to this context until it is closed.

Interruption during any of the writes to a non-zero context may cause some of the data not to be fully programmed on the device. Still no partial sector shall exist – any sector written as part of the non-zero context shall contain either the new data written or its old data before the context was configured. The scope of data that may be affected by the interruption depends on the mode configured:

- For non-Large Unit contexts:
  - MODE0 – Normal mode – Any data written to the context from the time it was configured may be affected
  - MODE1 – Non-Large Unit, reliable mode – Only data written by a specifically interrupted write command (CMD25) may be affected. Any previously completed write to the context shall not be changed because of any interruption.
- For Large Unit contexts:

NOTE1 The unit N refers to the current Large Unit which is being written to when interruption occurs, unit N-1 refers to the last Large Unit of the context that was written completely before the current one and unit N-2 and earlier are Large Units that were completed before the N-1 unit.

NOTE 2 Data stored in a large unit which is affected may be partially or entirely invalid

  - MODE0 – Normal mode – Any unit may be affected: Any data written to the context from the time it was configured may be affected
  - MODE1 – Large Unit, unit-by-unit mode – Unit N may be affected, units N-1 and earlier are not: Any data written to a Large Unit context may affect the entire specific Large Unit accessed. Any previously completed Large Units in the context shall not be changed because of any interruption.
  - MODE2 – Large Unit, one-unit-tail mode – Unit N and N-1 may be affected, units N-2 and earlier are not: Any data written to a Large Unit context may affect the entire specific Large Unit accessed and the entire completed Large Unit that was accessed before the current one. Any other completed Large Units in the context shall not be changed because of any interruption.

In case HPI is used during a write to a non-zero context, the write may still be interrupted like any context-less write. In case HPI is interrupting a write to a Large Unit context (including one that is packed inside a packed-write command), the device shall always stop writing on a SUPER\_PAGE\_SIZE boundary (and report CORRECTLY\_PRG\_SECTORS\_NUM accordingly), so host may later continue the stopped write from an address that is aligned to SUPER\_PAGE\_SIZE as required for Large Unit contexts. See also 0.

### 6.6.30.5 Large-Unit Multipliers

In order to allow increased performance by parallelism, the device may allow reading or writing in units larger than Large Unit.

The device reports in EXT\_CSD the maximum multiplier that is supported.

In order to use a multiplier beyond one, the context should be configured with the multiplier, and all alignment and unit sizes are multiplied by the multiplier.

For example, if the Large Unit size is 1MB, reading data from a Large Unit context configured with a multiplier of 2 shall be done in full units of 2MB and aligned to 2MB. Inside each such unit, same rules apply as if it was a normal Large Unit context with a Large Unit size of 2MB.

### 6.6.31 Data Tag Mechanism

The mechanism permits the device to receive from the host information about specific data types (for instance file system metadata, time-stamps, configuration parameters, etc.). The information is conveyed before a write multiple blocks operation at well defined addresses. By receiving this information the device can improve the access rate during the following read and update operations and offer a more reliable and robust storage.

The host should manage the tags accountability (tags allocation, tags – device logical addresses mapping, etc.)

If the SYSTEM\_DATA\_TAG\_SUPPORT (EXT\_CSD[499]) field is set to 1, the device supports the functionality on all the ‘Default’ type partitions (user data area in the area that’s not defined as enhanced user data area and general purpose partitions configured with the ‘Default’ attribute)

The host can mark a data segment (Tag Unit) in the addressable space whose length, in bytes, is expressed by the Extended CSD parameter TAG\_UNIT\_SIZE (always multiple of the sector size). The marking operation shall be Tag Unit aligned and have the granularity of a Tag Unit. If the address of the Write Multiple Blocks command is not Tag Unit aligned but falls in the middle of a Tag Unit, the entire Tag Unit will be marked in order to contain System Data.

The request to mark a Tag Unit or a sequence of Tag Units is based on the use of the SET\_BLOCK\_COUNT command (CMD23).

Any command that updates data (for instance a Trim, Erase, regular/reliable write, etc.) sent on the logical addresses containing a System Data previously written by the Tagging mechanism determines that the new data will not be opportunely managed to behave as a System Data. Those commands shall be sent in order to cover a single Tag Unit or a multiple of Tag Units.

The resources allocated by the device to accommodate data marked as System Data Tag can be limited. This condition is indicated by the device raising the EXCEPTION\_EVENT bit in the Device Status register provided as response to the first R1, R1b command following the internal resource exhaustion event; after receiving this indication the host retrieves the specific information about the exhaustion of resources allocated for the tagging mechanism by checking the EXCEPTION\_EVENTS\_STATUS field in Extended CSD byte. Note that SYSPOOL\_EVENT\_EN bit in EXCEPTION\_EVENTS\_CTRL field in Extended CSD shall be set to get the exception event indication in this case.

The data shall still be written to the device regardless of the resources exhaustion; however, it may not have the improved characteristics.

The host should manage the tag operation counting in order to avoid resources exhaustion. If it happens the host should execute operations having the final effect of freeing some of the resources (for instance by issuing a Trim command on some of the addresses containing System Data).

### 6.6.32 Packed Commands

Read and write commands can be packed in groups of commands (either all read or all write) that transfer the data for all commands in the group in one transfer on the bus, to reduce overheads.

Packed write command can group several write multiple block commands by using SET\_BLOCK\_COUNT command (CMD23) with the PACKED flag set. Then, WRITE\_MULTIPLE\_BLOCK (CMD25) shall follow, with the first block containing the packed-command header as described below. Then, all data sectors of the individual packed commands are sent appended together after the header, in the order of appearance in the header. The block count specified in CMD23 in this case shall be the sum of all block counts of the individual writes plus one for the header.

Packed read command can group several read multiple block commands by using SET\_BLOCK\_COUNT command (CMD23) with the PACKED flag set and a block count of one. Then, WRITE\_MULTIPLE\_BLOCK (CMD25) shall follow with just the header. Then, CMD23 may be sent again with the packed flag set and a block count equal to the sum of all block counts of the individual reads (CMD23 here is optional – open-ended reading is allowed). Then a READ\_MULTIPLE\_BLOCK (CMD18) shall follow to read the packed data. Host should not send any other command (except for CMD13 SEND\_STATUS) until the packed read command sequence is completed (i.e. inserting command(s) between sending the header and reading the data is not permitted), otherwise device behavior is undefined.

In both cases of read and write, the argument for CMD25 (both for packed write and in case of the header of a packed read) and for CMD18 shall be the same address that is specified by the first individual read or write command in the packed group. If the argument does not match the address of the first individual command, device behavior is undefined.

The maximum number of read or write commands that can be packed in a single packed command is reported by the device in MAX\_PACKED\_READS and MAX\_PACKED\_WRITES fields in EXT\_CSD respectively.

MAX\_PACKED\_READS and MAX\_PACKED\_WRITES may be larger than the number of commands which one block is able to include if the device is 4kB native device. In emulation mode for 4kB native sector device, host can pack commands into only one block and send the block as header. After disabling the emulation mode, host can pack commands into 8 blocks and send the blocks as header.

### 6.6.32.1 Packed Command Header

The packed command header is sent on the first block (if DATA\_SECTOR\_SIZE[62] = 0x00) or the first 8 blocks (if DATA\_SECTOR\_SIZE[62] = 0x01) of the data in case of packed write command and as a separated write command sent before reading the packed data in case of a packed read command.

The structure contains:

- Version of structure – a byte to indicate version for future compatibility; shall be set to 0x01
- R/W flag – 0x01 for packed read, 0x02 for packed write
- Number of entries in the table
- Then, for each entry:
  - Argument of CMD23 of the individual command (4 bytes), formatted as in CMD23, including both the ‘count’ field and the various flags fields (high bits), with the ‘packed’ bit always ‘0’ (except for the ‘packed’ bit, all other CMD23 argument bits are still allowed in the header). Each individual read and write command shall not be open-ended. If any bit[15:0] of argument of CMD23 in the header is set to 0, device behavior is undefined.”
  - Argument of CMD18 or CMD25 (4 bytes) – the address read/written by the individual command

The structure contains (in little-endian format, padding shall be all zeros):

**Table 33 — Packed Command Structure**

Entry index	Offset (Bytes)	Name	Length (Bytes)
-	+0	VERSION	1
	+1	R/W	1
	+2	NUM_ENTRIES (=N)	1
	+3	padding to 8B	5
1	+8	CMD23_ARG_1	4
	+12	CMDxx_ARG_1	4
2	+16	CMD23_ARG_2	4
	+20	CMDxx_ARG_2	4
3	+24	CMD23_ARG_3	4
	+28	CMDxx_ARG_3	4
...			
N	+8N	CMD23_ARG_N	4
	+8N+4	CMDxx_ARG_N	4
-	+8N+8	Padding	till block ends

### 6.6.32.2 Packed Commands Error Handling

If one of the individual commands causes a failure, the following individual commands within the same packed command are not executed. For packed read, the device may transfer some data (may be random) for the non-executed commands – to complete the number of blocks specified (as host is waiting for all blocks). Alternatively it can stop transferring the data at the point of failure, causing a timeout. For packed write, the device shall ignore the transfer of the non-executed commands.

In any case of failure, the generic error flag in the PACKED\_COMMAND\_STATUS field in EXT\_CSD is set (e.g., bad header, more commands in the pack than device supports, etc.). In case of any error during one of the individual commands within the packed command, the ‘error index’ flag shall be set as well as the generic error, and the PACKED\_FAILURE\_INDEX field in EXT\_CSD shall report the index in the header block of the failed command.

Additionally, an exception event bit may report a non-zero status in PACKED\_COMMAND\_STATUS if host enables it by writing a value of ‘1’ to PACKED\_EVENT\_EN to the EXCEPTION\_EVENTS\_CTRL. Once enabled, the exception bit in the Device Status (reported on every R1 response) shall be set if PACKED\_COMMAND\_STATUS is non-zero.

When packed commands are used, reporting of errors in command responses may be deferred to the command after the actual packed read/write transfer (the CMD25 or CMD18 that transfers the packed data). For example, the ADDRESS\_OUT\_OF\_RANGE error may be deferred in case one of the packed commands accessed an address that is out of range.

### 6.6.33 Exception Events

The exception events allow device to report some exceptions quickly to the host by setting the EXCEPTION\_EVENT bit in Device Status. The exception event bit remains set until its cause is cleared.

To control which events may set this bit, a 16 bit EXCEPTION\_EVENTS\_CTRL field in EXT\_CSD is defined – each bit enables a specific event to set the EXCEPTION\_EVENT bit. The EXCEPTION\_EVENT bit is therefore a logical-or between all exception events which have their relevant enable-bit set in EXCEPTION\_EVENTS\_CTRL.

To make it easier to detect the specific exceptions, a 16 bit EXCEPTION\_EVENTS\_STATUS field in EXT\_CSD holds a bit per exception to indicate which one is currently set. The status bit is set only for exceptions that are enabled in EXCEPTION\_EVENTS\_CTRL.

### 6.6.34 Cache

Cache is a temporary storage space in an *e*•MMC device. The cache should in typical case reduce the access time (compared to an access to the main non-volatile storage) for both write and read. The cache is not directly accessible by the host. This temporary storage space may be utilized also for some implementation specific operations like as an execution memory for the memory controller and/or as storage for an address mapping table etc. but which definition is out of scope of this specification.

The cache is expected to be volatile by nature. Implementation of such volatile cache has some significant effects on some of the ground rules of this standard as follows:

- Caching of data shall apply only for the single block read/write (CMD17/24), pre-defined multiple block read/write (CMD23+CMD18/25) and open ended multiple block read/write (CMD18/25+CMD12) commands and excludes any other access e.g., to the register space (e.g., CMD6).
- Data0 busy and status response bit [8] after CMD24, CMD23+CMD25 or CMD25+CMD12 does not anymore necessarily indicate the programming status to the non-volatile memory but may indicate programming status to the volatile cache (exceptions defined later),
- A Flush operation refers to the requirement, from the host to the device, to write the cached data to the non-volatile memory. Prior to a flush, the device may autonomously write data to the non-volatile memory, but after the flush operation all data in the volatile area must be written to non-volatile memory.
- Data in the cache may (and most probably will) be lost due to a sudden power down. If there was a flush operation ongoing when the power was lost then also any such data may be lost.
- Accesses to the RPMB and Boot partitions while the cache is ON shall still be directed to the non-volatile storage with same rules as defined elsewhere in this specification.
- When the cache is turned ON it applies to the *e*•MMC device as whole (When flushing the cache the data for all partitions shall be flushed, this operation is independent of the active partition)
- There is no requirement for flush due to switching between the partitions. (Note: This also implies that the cache data shall not be lost when switching between partitions) Cached data may be lost in SLEEP state, so host should flush the cache before placing the device into SLEEP state.
- The device may invalidate the data in the cache in case of RST\_n or CMD0 received.

Support of the cache function and size of the cache are indicated in the CACHE\_SIZE byte (EXT\_CSD byte [252:249]).

The cache shall be OFF by default after power up, RST\_n assertion or CMD0. All accesses shall be directed to the non-volatile storage like defined elsewhere in this specification. The cache function can be turned ON and OFF by writing to the CACHE\_CTRL byte (EXT\_CSD byte [33]). Turning the cache ON shall enable behavior model defined in this Section. Turning the cache OFF shall trigger flushing of the data to the non-volatile storage.

The cache may be flushed to the non-volatile storage by writing to FLUSH\_CACHE byte (EXT\_CSD byte [32]). The R1b response result shall reflect the status of programming of cached data to the non-volatile storage. Any error resulted can be read from the status register by CMD13 after the completion of the programming as defined for normal write. If a flush error occurs during the execution of the FLUSH\_CACHE or while turning off the cache using the CACHE\_CTRL operation, the device shall set the generic error bit, STATUS BIT[19]. If an error occurs as a result of flush operation the device has no responsibility to isolate the error to a specific data area. The error could affect any data written to the cache since the previous flush operation.

### 6.6.34 Cache (cont'd)

There is no maximum timeout for flushing of the cache as flushing a large amount of cached data may take very unpredictably long time. This applies both for the FLUSH\_CACHE and CACHE\_CTRL (turning the cache OFF) operations. Host may use the HPI function to interrupt the flush operation. In this case the cache shall not be considered as fully flushed and host should re-initiate the flush.

There are two ways to force data to be programmed directly to the non-volatile storage while the cache is turned ON:

- A Reliable Write access shall force the data to be written to the non-volatile storage and Data0 busy indication reflects the status of the programming like defined elsewhere in this specification
- Another way is by setting the argument bit [24] in the CMD23 in prior to the actual write command. In case the cache is turned OFF then this bit shall be ignored by the memory device. If this bit is set together with the Reliable Write bit in CMD23 then this bit shall be ignored also by the device.

A logical block may or may not be removed from the cache after the flush operation. The data may also be stored to the cache in case of Reliable Write access and access with CMD23 bit [24] set. These are left for the implementation.

If the cache gets totally full and/or the cache is not able to receive the data of the next access (per block count indicated in CMD23 or per initiated single / open ended multiple block write in general) then it shall still be responsibility of the *e*MMC device to store data of the next access within timeouts specified elsewhere in this specification. The actual algorithm to handle the new data and possible flush of some older cached data is left for the implementation.

ERASE, TRIM and DISCARD commands shall have effect on data in the cache accordingly so that any following read will reflect the Erased, Trimmed or Discarded state of data. There may be copies of an old data in the cache and these are expected to be cleared during power down. The SANITIZE operation shall clean up the unmapped data in the cache.

All functions related to a certain address should still be considered as sequential and ordered, just like with a device without the cache. For example if there is some old data in an address and then some new data is written (potentially cached) to this address. Next there is the write protection set to the very same address and write protect is not a cached operation as such. Still the write protection shall in all cases apply to the new data, not to the old data which may still have been in the non-volatile memory in this particular time. There is no requirement that the cache in general should be first-in-first-out -type, this is left for the implementation.

In between consecutive flush operations the device is free to write data into the non-volatile memory out of order. If the host wants to preserve the order it must flush the cache at the point where order is important; the device can only ensure data was written in order after the flush operation has completed.

It shall never be possible to read stale data from the *e*MMC device due to the cached operation.

The cache feature is optional for an *e*MMC device.

### 6.6.35 Features cross matrix

This section summarizes rules and limitations on simultaneous activations of features that are controlled through CMD23 argument, Cache and Partitions.

The following rules are derived from Extended Partition Attributes, Reliable Write, Context Management, Data Tag, Packed Commands and Cache features:

- If CMD23 Reliable Write [31] bit is set then Forced Prg [24] is ignored
  - CMD23 bits for Data Tag [29] and ContextID [28:25] cannot be set in the same command argument
  - In case of Packed Command, in the encapsulating CMD23, packed [30] bit and number of blocks [15:0] are valid; all other parameter bits are ‘0’ and are included in the header (see the “Packed Command” and “Non-Packed Command” description in Table 44 — )
  - Enhanced and Extended partition settings cannot co-exist in same partition
  - Data Tagging works only for default partitions
  - ContextID overrides Reliable Write
  - Cache mode does not apply for Boot and RPMB partitions

**Table 34 — Features Cross Reference Table**

<b>Cache On</b>							
Ok	<b>Packed Commands</b>						
Ok	Ok, in header (1)	<b>Context ID</b>					
Ok	Ok, in header (1)	Not valid	<b>Data Tag</b>				
If Reliable Write bit is set, cache is bypassed	Ok, in header (1)	Reliable Write bit is ignored if a Context is open	Ok	<b>Reliable Write</b>			
No caching on Boot and RPMB Partitions	Ok	Ok	Data tag is valid on default memory type only	Ok	<b>Partitions (all)</b>		
If Force programming bit is set, cache is bypassed (2)	Ok, in header (1)	Ok	Ok	If Reliable Write bit is set, Forced Programming bit is ignored	Ok	<b>Forced programming</b>	
-	No	No	No	-	Switch to FFU mode could be done from any partition except boot and RPMB	-	<b>FFU Mode</b>

### 6.6.36 Dynamic Capacity Management

Extensive memory usage and aging of Flash could result in bad blocks. Dynamic Capacity Management provides a mechanism for the memory device to reduce its reported capacity and extend the device life time.

The mechanism to manipulate dynamic capacity is based on: memory array partitioning and the granularity of WP groups (see 6.14). Reducing the capacity is done by releasing of WP-Groups anywhere within the address space of the user area. A released WP-Group will behave as a permanently write protected group and it shall not be read from: Writing to an address within a released WP-Group returns a WP error; Reading from an address within a released WP-Group is forbidden and may return an error; Checking write protection (using CMD30) and write protect type (using CMD31) shall report protected groups and permanent write protection accordingly.

Write protected groups cannot be released – they shall be unprotected first before they may be released.

Write protect groups from general purpose partitions cannot be released – only groups from the user area may be released.

The device keeps an indication DYNCAP\_NEEDED in EXT\_CSD byte [58] to notify the host how many WP-Groups host should release. Host should monitor this byte and release as many WP-Groups as requested for the device to continue to be functional.

If device reports a non-zero DYNCAP\_NEEDED and host doesn't release WP-Groups accordingly, the device may degrade in performance and eventually become non-functional.

Additionally, an exception event bit may report the status of DYNCAP\_NEEDED if host enables it by writing a value of '1' to DYNCAP\_EVENT\_EN to the EXCEPTION\_EVENTS\_CTRL. Once enabled, the exception bit in the Device Status (reported on every R1 response) shall be set if DYNCAP\_NEEDED is non-zero.

In order to release WP-Groups and query status of groups, host shall first set CLASS\_6\_CTRL in EXT\_CSD byte [59] to 0x01 (see Table 158 — ) and then use class 6 commands (CMD28-31) to release and/or query the status of WP-Groups. Host shall write 0x00 back to CLASS\_6\_CTRL before using class 6 command for write protection manipulation.

When CLASS\_6\_CTRL is set to 0x01:

- CMD28 is used to release a WP-Group
- CMD29 is ignored (no-operation)
- CMD30 returns the status of released or not released WP-Groups
- CMD31 returns a fixed pattern of 64-bit zeros

The dynamic capacity commands and statuses are only supported for high capacity devices and are based on the high capacity write protect group size.

The device user area size shall never change while a device is powered up even if WP-Groups from the end of the user area were released. The device may update its user area following the release of WP-Groups from the end of its address space only after passing through CMD1 after a power cycle, assertion of RST\_n signal or CMD0. In any case, the addressing mode of the device doesn't change (devices stays in high capacity sector based addressing).

### 6.6.37 Large sector size

The native sector size is the smallest unit of information that the device manages internally. For a high capacity device, two options may exist for its native sector size:

- Small 512B sectors (supported by devices up to and including 256GB total capacity)
- Large 4KB sectors (supported by all devices)

The device reports its native sector size in NATIVE\_SECTOR\_SIZE field of EXT\_CSD [63].

For backward compatibility, large sectors devices shall work in emulation mode when shipped. The actual sector size host may access and address in any mode is reported by DATA\_SECTOR\_SIZE. In emulation mode, DATA\_SECTOR\_SIZE is still 512B, but the device is emulating the 512B operations internally which may affect performance. The emulation mode may be disabled by the host. Once emulation mode is disabled, the sector size is set permanently to the native sector size.

All devices with capacities higher than 256GB shall have native sector size of 4KB.

For non high capacity devices the fields NATIVE\_SECTOR\_SIZE, DATA\_SECTOR\_SIZE, USE\_NATIVE\_SECTOR andINI\_TIMEOUT\_EMU are read only and shall be zero and should be ignored.

Internal sizes reported by the device shall always be a full multiple of the native sector size even in emulation mode, e.g., device capacity, write protect group size, erase group size, super page size, etc.

The units of the internal sizes in the emulation mode and the one after disabling emulation mode shall be same except Tag Unit size. Table 36 — shows a list of granularities and units for all internal sizes.

### 6.6.37 Large sector size (cont'd)

Table 35 — eMMC internal sizes and related Units / Granularities

Parameter		Definition	Unit		Granularity	
			512 B Native Sector	4 KB Native Sector	512 B Native Sector	4 KB Native Sector
Device Capacity	Emulation	Disable Emulation	Emulation	Disable Emulation	Emulation	Disable Emulation
	> 2GB	SEC_COUNT · 512B	512B	512B	512B	4KB
Erase Group Size		(ERASE_GRP_SIZE+ 1) · (ERASE_GRP_MULT + 1)	512B	512B	512B	4KB
Write Protect Group Size		WP_GRP_SIZE	Erase group	Erase group	Erase Group	Erase Group
High Capacity Erase Size	HC_ERASE_GRP_SIZE · 512KB	512KB	512KB	512 KB	512KB	512KB
High Capacity Write Protect size	HC_ERASE_GRP_SIZE · HC_WP_GRP_SIZE · 512KB	512KB	512KB	512KB	512KB	512KB
Super page size	$2^{(\text{SUPER\_PAGE\_SIZE}-1)} \cdot 512B$	512B	512B	512B	4KB	4KB
Boot partition size	BOOT_SIZE_MULT · 128KB	128KB	128KB	128KB	128KB	128KB
RPMB partitionsize	RPMB_SIZE_MULT · 128KB	128KB	128KB	128KB	128KB	128KB
Tag Unit Size	$2^{\text{TAG\_UNIT\_SIZE}} \cdot \text{Sector Size}$	512B	512B	4KB	512B	512B
Tag Resource Size	((N · TAG_UNIT_SIZE) · $2^{\text{TAG\_RES\_SIZE}}$ ) / $2^{10}$	Tag Unit Size	Tag Unit Size	Tag Unit Size	Tag Unit Size	Tag Unit Size
Large Unit size	1MB · (LARGE_UNIT_SIZE_M 1 + 1)	1MB	1MB	1MB	1MB	1MB
Cache size	CACHE_SIZE · 1Kb	1Kb	1Kb	1Kb	32Kb (=4KB)	32Kb (=4KB)
Reliable Write Sector size	REL_WR_SEC_C	512B	512B	512B	4KB	4KB
Max Enhanced area size	MAX_ENH_SIZE_MULT · HC_WP_GRP_SIZE · HC_ERASE_GRP_SIZE · 512KB	512 KB	512KB	512KB	512KB	512KB

Parameter	Definition	Unit			Granularity		
		512 B Native Sector	4 KB Native Sector		512 B Native Sector	4 KB Native Sector	
			Emulation	Disable Emulation		Emulation	Disable Emulation
General purpose partition size	(GP_SIZE_MULT_X_2·2 <sup>16</sup> + GP_SIZE_MULT_X_1·2 <sup>8</sup> + GP_SIZE_MULT_X_0·2 <sup>0</sup> ) ·HC_WP_GRP_SIZE ·HC_ERASE_GRP_SIZE ·512KB	512 KB	512KB		512KB	512KB	
Enhanced user data area size	(ENH_SIZE_MULT_2·2 <sup>16</sup> + ENH_SIZE_MULT_1·2 <sup>8</sup> + ENH_SIZE_MULT_0·2 <sup>0</sup> ) ·HC_WP_GRP_SIZE ·HC_ERASE_GRP_SIZE ·512KB	512KB	512KB		512KB	512KB	

A large sector device shall not support partial access.

#### 6.6.37.1 Disabling emulation mode

To disable the emulation mode for large 4KB sector devices, host may write 0x01 to the USE\_NATIVE\_SECTOR field in EXT\_CSD [62] and then go through a power cycle, passing through CMD1.

Setting USE\_NATIVE\_SECTOR does not immediately change the DATA\_SECTOR\_SIZE. Only after a power cycle following setting of USE\_NATIVE\_SECTOR to 0x01 shall the device change DATA\_SECTOR\_SIZE. The following initialization timeout for CMD1 is then defined by the INI\_TIMEOUT\_NATIVE.

Any valid commands issued after USE\_NATIVE\_SECTOR is set to 0x01 but before a power cycle takes place will be normally executed.

Disabling emulation mode is only supported on devices that do not support partitions or before partitions are configured. Once partitions are configured, disabling of emulation mode is no longer allowed.

Setting Bit 0 in PARTITIONING\_SETTING\_COMPLETED and writing 0x01 in USE\_NATIVE\_SECTOR without a power cycle between the two operations is not allowed.

Some internal sizes reported by the device may change after successfully disabling of the emulation mode.

After a successful disabling of the emulation mode, the content of the User Data Area is undefined.

### 6.6.37.2 Native 4KB sector behavior

The following restrictions apply for a 4KB sector device that is in native mode (not emulation mode):

- Data transfers on the bus are still using 512B CRC-protected blocks, but data shall only be transferred in multiple of 8 such blocks (always multiples of 4KB)
- Sector addressing is still used, but sector addresses shall always be aligned to 8 (4KB)
- Sector counts shall be multiples of 8 (4KB), e.g., in SET\_BLOCK\_COUNT (CMD23), and CORRECTLY\_PRG\_SECTORS\_NUM field in EXT\_CSD
- Single block Write and Read Command (CMD17 and CMD24) are not supported. If the host attempts to issue CMD17 or CMD24 the device behavior is undefined
- Arguments for read multiple block command (CMD18) and multiple block write command (CMD25) shall always be aligned to 8 (4KB)
- If a power loss occurs during a reliable write, each 4KB sector being modified by the write is atomic. After a power failure sectors may either contain old data or new data . All of the sectors being modified by the write operation that was interrupted may be in one of the following states: all sectors contain new data, all sectors contain old data or some sectors contain new data and some sectors contain old data
- Start and end addresses in erase/trim/discard commands shall always be aligned to 8 (4KB)
- RPMB partition, if exists, is an exception to the above: Since read/write commands to the RPMB partition are data frames packets and not actual read/write operations, access to RPMB partition shall still be done in 512B blocks

Not following any of the above restrictions may result in undefined behavior.

Table 36 — summarizes data sector size, address mode and reliable write granularity depending on the device density range, device sector size and emulation mode enablement state:

**Table 36 — Admitted Data Sector Size, Address Mode and Reliable Write granularity**

Device density range	Native Sector size	Emulation mode	Data Sector size	Address mode	Reliable Write granularity
$\leq 2\text{GB}$	N/A	N/A	512B	Byte	512B
$2\text{GB} < \text{Density} \leq 256\text{GB}$	512B	N/A	512B	Sector (512B)	512B
$2\text{GB} < \text{Density} \leq 256\text{GB}$	4KB	On (when device is shipped)	512B	Sector (512B)	512B
$2\text{GB} < \text{Density} \leq 256\text{GB}$	4KB	Off	4KB	Sector (512B) (1)	4KB
Density $> 256\text{GB}$	4KB (mandatory)	On (when device is shipped)	512B	Sector (512B)	512B
Density $> 256\text{GB}$	4KB (mandatory)	Off	4KB	Sector (512B) (1)	4KB

NOTE 1 Each data transfer has a minimum length of 8 Sectors (4KB) and the addresses shall be aligned to 8 (4KB)

### 6.6.38 Real Time Clock Information

Providing real time clock information to the device may be useful for internal maintenance operations.

Host may provide either absolute time (based on UTC) if available, or relative time. This feature provides a mechanism for the host to update both real time clock and relative time updates (see CMD49).

The host should send the time information on the following events:

- After power up, as early as possible
- After waking up from sleep state, as early as possible
- Periodically (hourly, daily, ...)

To set the real time clock, CMD49 command (SET\_TIME) shall be used. This command which behaves like CMD24 (WRITE\_BLOCK) in its state transitions and timeouts and shall always be configured to transfer a 512B information block using CMD16 (SET\_BLOCKLEN). The information block is formatted as little-endian block with the following structure:

**Table 37 — Real Time Clock Information Block Format**

Bytes	Field Name
1	Version of Structure: Shall be set to 0x01
1	RTC_INFO_TYPE
8	SECONDS_PASSED
10-511	Reserved (shall be set to all ‘0’)

The meaning of the SECONDS\_PASSED field is determined by the RTC\_INFO\_TYPE field:

**Table 38 — RTC\_INFO\_TYPE Field Description**

Value	Name	Description
0x01	Absolute time	SECONDS_PASSED is the number of seconds that passed from January 1st, year 0 AD till the current time in UTC (universal time coordinated)
0x02	Set-base for relative time	SECONDS_PASSED is ignored, and the time of sending the SET_TIME command with this parameter is set as a reference for future relative time
0x03	Relative time	SECONDS_PASSED is the number of seconds that passed since the most recent call to SET_TIME with the parameter RTC_INFO_TYPE=2 (set-base)
0x00, 0x04-0xFF	-	Reserved, not allowed

#### **6.6.38.1 Periodic Wake-up**

Host may update the PERIODIC\_WAKEUP register (EXT\_CSD[131]) to indicate to the device how often host shall wake it up. Host shall then repeat the following sequence at least as often as configured by PERIODIC\_WAKEUP register: Power up the device and execute at least one background operation (by writing to BKOPS\_START) that is run until completion (without interruptions), before powering down the device. Host may execute other operations before powering down the device as long as the device is not powered down for a period longer than that configured in PERIODIC\_WAKEUP.

Host may only increase the frequency in the PERIODIC\_WAKEUP register.

### 6.6.39 Power Off Notification

The host should notify the device before it powers the device off. This allows the device to better prepare itself for being powered off. Power the device off means to turn off all its power supplies. In particular, the host should issue a power off notification (POWER\_OFF\_LONG, POWER\_OFF\_SHORT) if it intends to turn off both VCC and VCCQ power supplies or it may use to a power off notification (SLEEP\_NOTIFICATION) if it intends to turn-off VCC after moving the device to Sleep state.

To indicate to the device that power off notification is supported by the host, a supporting host shall first set the POWER\_OFF\_NOTIFICATION byte in EXT\_CSD [34] to POWERED\_ON (0x01). To execute a power off, before powering the device down the host changes the value to either POWER\_OFF\_SHORT (0x02) or POWER\_OFF\_LONG (0x03). Host waits for the busy line to be de-asserted. Once the setting has changed to either 0x02 or 0x03, host may safely power off the device.

The host may issue SLEEP\_AWAKE (CMD5) to enter or to exit from Sleep state if POWER\_OFF\_NOTIFICATION byte is set to POWERED\_ON. Before moving to Standby state and then to Sleep state, the host sets POWER\_OFF\_NOTIFICATION to SLEEP\_NOTIFICATION and waits for the DAT0 line de-assertion. While in Sleep (slp) state VCC (Memory supply) may be turned off as defined in 6.6.21. Removing power supplies other than VCC while the device is in the Sleep (slp) state may result in undefined device behavior. Before removing all power supplies, the host should transition the device out of Sleep (slp) state back to Transfer state using CMD5 and CMD7 and then execute a power off notification setting POWER\_OFF\_NOTIFICATION byte to either POWER\_OFF\_SHORT or POWER\_OFF\_LONG.

If host continues to send commands (e.g., CMD8) to the device after switching to the power off setting (POWER\_OFF\_LONG, POWER\_OFF\_SHORT or SLEEP\_NOTIFICATION) or performs HPI during its busy condition, the device shall restore the POWER\_OFF\_NOTIFICATION byte to POWERED\_ON.

If host tries to change POWER\_OFF\_NOTIFICATION to 0x00 after writing another value there, a SWITCH\_ERROR is generated.

The difference between the two power-off modes is how urgent the host wants to turn power off. The device should respond to POWER\_OFF\_SHORT quickly under the generic CMD6 timeout. If more time is acceptable, POWER\_OFF\_LONG may be used and the device shall respond to it within the POWER\_OFF\_LONG\_TIME timeout.

While POWER\_OFF\_NOTIFICATION is set to POWERED\_ON, the device expects the host to :

- Keep the device power supplies alive (both Vcc and Vccq) and in their active mode
- Not power off the device intentionally before changing POWER\_OFF\_NOTIFICATION to either POWER\_OFF\_LONG or POWER\_OFF\_SHORT
- Not power off VCC intentionally before changing POWER\_OFF\_NOTIFICATION to SLEEP\_NOTIFICATION and before moving the device to Sleep state

Before moving to Sleep state hosts may set the POWER\_OFF\_NOTIFICATION byte to SLEEP\_NOTIFICATION (0x04) if aware that the device is capable of autonomously initiating background operations for possible performance improvements. Host should wait for the busy line to be de-asserted. Busy line may be asserted up the period defined in SLEEP\_NOTIFICATION\_TIME byte in EXT\_CSD [216]. Once the setting has changed to 0x04 host may set the device into Sleep mode (CMD7+CMD5). After getting out from Sleep the POWER\_OFF\_NOTIFICATION byte will restore its value to POWERED\_ON. HPI may interrupt the SLEEP\_NOTIFICATION operation. In that case POWER\_OFF\_NOTIFICATION byte will restore to POWERED\_ON.

## 6.7 Clock control

The *e*•MMC bus clock signal can be used by the host to put the Device into energy saving mode, or to control the data flow (to avoid under-run or over-run conditions) on the bus. The host is allowed to lower the clock frequency or shut it down.

There are a few restrictions the host must follow:

- The bus frequency can be changed at any time (under the restrictions of maximum data transfer frequency, defined by the Device, and the identification frequency defined by the standard document).

It is an obvious requirement that the clock must be running for the Device to output data or response tokens. After the last *e*•MMC bus transaction, the host is required, to provide 8 (eight) clock cycles for the Device to complete the operation before shutting down the clock. Following is a list of the various bus transactions:

- A command with no response. 8 clocks after the host command end bit.
- A command with response. 8 clocks after the Device response end bit.
- A read data transaction. 8 clocks after the end bit of the last data block.
- A write data transaction. 8 clocks after the CRC status token.

The host is allowed to shut down the clock of a “busy” Device. The Device will complete the programming operation regardless of the host clock. However, the host must provide a clock edge for the Device to turn off its busy signal. Without a clock edge the Device (unless previously disconnected by a deselect command (CMD7) will force the DAT0 line down, forever.

## 6.8 Error conditions

### 6.8.1 CRC and illegal command

All commands are protected by CRC (cyclic redundancy check) bits. If the addressed Device’s CRC check fails, the Device does not respond, and the command is not executed; the Device does not change its state, and COM\_CRC\_ERROR bit is set in the status register.

Similarly, if an illegal command has been received, the Device shall not change its state, shall not respond and shall set the ILLEGAL\_COMMAND error bit in the status register. Only the non-erroneous state branches are shown in the state diagrams, (see Figure 25 to Figure 27). Table 51 — contains a complete state transition description.

There are different kinds of illegal commands:

- Commands which belong to classes not supported by the Device (e.g., write commands in read only Devices).
- Commands not allowed in the current state (e.g., CMD2 in Transfer State).
- Commands which are not defined (e.g., CMD44).

**NOTE** The COM\_CRC\_ERROR and ILLEGAL\_COMMAND errors are detected during the command interpretation and validation phase (Response Mode). However, since the Device does not respond to commands with COM\_CRC\_ERROR or ILLEGAL\_COMMAND error, the errors are reported in the response of the following valid command.

### 6.8.2 Time-out conditions

The times after which a time-out condition for read/write/erase operations occurs are (Device independent) 10 times longer than the typical access/program times for these operations given below. A Device shall complete the command within this time period, or give up and return an error message. If the host does not get a response within the defined time-out it should assume the Device is not going to respond anymore and try to recover (e.g., reset the Device, power cycle, reject, etc.). The typical access and program times are defined as follows:

- Read

The read access time is defined as the sum of the two times given by the CSD parameters TAAC and NSAC (see 6.15). These Device parameters define the typical delay between the end bit of the read command and the start bit of the data block. This number is Device dependent.

- Write

The R2W\_FACTOR field in the CSD is used to calculate the typical block program time obtained by multiplying the read access time by this factor. It applies to all write/erase commands (e.g., SET(CLEAR)\_WRITE\_PROTECT, PROGRAM\_CSD(CID) and the block write commands).

- Erase / Secure Erase

The duration of an erase command will be (order of magnitude) the number of Erase blocks to be erased multiplied by the block write delay. If ERASE\_GROUP\_DEF (EXT\_CSD byte [175]) is enabled, ERASE\_TIMEOUT\_MULT should be used to calculate the duration.

Secure Erase timeout is calculated based on the Erase Timeout and additional SEC\_ERASE\_MULT factor (EXT\_CSD byte [230]).

- TRIM/DISCARD/Secure TRIM

The TRIM/DISCARD function timeout is calculated based on the TRIM\_MULT factor (EXT\_CSD byte [232]). Secure TRIM timeout is calculated based on the Erase Timeout and additional SEC\_TRIM\_MULT factor (EXT\_CSD byte [229]).

- Force erase

The duration of the Force Erase command using CMD42 is specified to be a fixed time-out of 3 minutes.

- High-Priority Interrupt (HPI)

OUT\_OF\_INTERRUPT\_TIME (EXD\_CSD byte[198]) defines the maximum time between the end bit of CMD12/13, arg[0]=1 to the DAT0 release by the device.

- Partition Switch

PARTITION\_SWITCH\_TIME (EXD\_CSD byte[199]) defines the maximum time between the end bit of the SWITCH command (CMD6) to the DAT0 release by the device, when switching partitions by changing PARTITION\_ACCESS bits in PARTITION\_CONFIG field (EXT\_CSD byte [179]).

### 6.8.3 Read ahead in multiple block read operation

In multiple block, read operations, in order to avoid data under-run condition or improve read performance, the Device may fetch data from the memory array, ahead of the host. In this case, when the host is reading the last addresses of the memory, the Device attempts to fetch data beyond the last physical memory address and generates an ADDRESS\_OUT\_OF\_RANGE error.

Therefore, even if the host times the stop transmission command to stop the Device immediately after the last byte of data was read, The Device may already have generated the error, and it will show in the response to the stop transmission command. The host should ignore this error.

## 6.9 Minimum performance

An *e*•MMC Device has to fulfill the requirements set for the read and write access performance.

### 6.9.1 Speed class definition

The speed class definition is for indication of the minimum performance of a Device. The classes are defined based on respectively the 150kB/s base value for single data rate operation (normal mode) and 300kB/s base value for dual data rate operation. The minimum performance of the Device can then be marked by defined multiples of the base value e.g., 2.4MB/s (SDR) or 4.8MB/s (DDR). Only following speed classes are defined. . Speed class is not defined and is not applicable for *e*•MMC operating in HS200 mode & HS400 mode.

NOTE *e*•MMC Devices always including 8bit data bus and the categories below states the configuration with which the Device is operated.

Low bus category classes (26MHz clock with 4bit data bus operation)

- 2.4 MB/s (sdr) or 4.8MB/s (ddr) Class A
- 3.0 MB/s (sdr) or 6.0MB/s (ddr) Class B
- 4.5 MB/s (sdr) or 9.0MB/s (ddr) Class C
- 6.0 MB/s (sdr) or 12.0MB/s (ddr) Class D
- 9.0 MB/s (sdr) or 18.0MB/s (ddr) Class E

Mid bus category classes (26MHz clock with 8bit data bus or 52MHz clock with 4bit data bus operation):

- 12.0 MB/s (sdr) or 24.0MB/s (ddr) Class F
- 15.0 MB/s (sdr) or 30.0MB/s (ddr) Class G
- 18.0 MB/s (sdr) or 36.0MB/s (ddr) Class H
- 21.0MB/s (sdr) or 42.0MB/s (ddr) Class J

High bus category classes (52MHz clock with 8bit data bus operation):

- 24.0MB/s (sdr) or 48.0MB/s (ddr) Class K
- 30.0MB/s (sdr) or 60.0MB/s (ddr) Class M
- 36.0MB/s (sdr) or 72.0MB/s (ddr) Class O
- 42.0MB/s (sdr) or 84.0MB/s (ddr) Class R
- 48.0MB/s (sdr) or 96.0MB/s (ddr) Class T

The performance values for both write and read accesses are stored into the EXT\_CSD register for electrical reading (see 7.4). Only the defined values and classes are allowed to be used.

### 6.9.2 Measurement of the performance

Initial state of the memory in prior to the test is: filled with random data. The test is performed by writing/reading a 64kB chunk of data to/from random logical addresses (aligned to physical block boundaries) of the Device. A predefined multiple block write/read is used with block count of 128 (64kB as 512B blocks are used). The performance is calculated as average out of several 64kB accesses. Same test is performed with all applicable clock frequency and bus width options as follows:

- 52MHz, 8bit bus in the dual data mode (if 52MHz clock frequency and dual data mode is supported by the Device)
- 52MHz, 8bit bus (if 52MHz clock frequency is supported by the Device)
- 52MHz, 4bit bus (if 52MHz clock frequency is supported by the Device)
- 26MHz, 8bit bus
- 26MHz, 4bit bus

In case the minimum performance of the Device exceeds the physical limit of one of the above mentioned options the Device has to also fulfill accordingly the performance criteria as defined in `MIN_PERF_a_b_ff`.

## 6.10 Commands

### 6.10.1 Command types

There are four kinds of commands defined to control the *e*•MMC:

- broadcast commands (bc), no response
- broadcast commands with response (bcr)
- addressed (point-to-point) commands (ac), no data transfer on DAT lines
- addressed (point-to-point) data transfer commands (adtc), data transfer on DAT lines

All commands and responses are sent over the CMD line of the *e*•MMC bus. The command transmission always starts with the left bit of the bit string corresponding to the command codeword.

### 6.10.2 Command format

All commands have a fixed code length of 48 bits, needing a transmission time of 0.92 micro second @ 52 MHz.

**Table 39 — Command Format**

Description	Start Bit	Transmissio n Bit	Command Index	Argument	CRC7	End Bit
Bit position	47	46	[45:40]	[39:8]	[7:1]	0
Width (bits)	1	1	6	32	7	1
Value	“0”	“1”	x	x	x	“1”

A command always starts with a start bit (always ‘0’), followed by the bit indicating the direction of transmission (host = ‘1’). The next 6 bits indicate the index of the command, this value being interpreted as a binary coded number (between 0 and 63). Some commands need an argument (e.g., an address), which is coded by 32 bits. A value denoted by ‘x’ in the table above indicates this variable is dependent on the command. All commands are protected by a CRC (see 8.2 for the definition of CRC7). Every command codeword is terminated by the end bit (always ‘1’). All commands and their arguments are listed in Table 40 — through Table 50 — .

### 6.10.3 Command classes

The command set of the *e*•MMC system is divided into several classes. (See Table 40 — )

Each class supports a subset of Device functions.

Class 0 is mandatory and shall be supported by all Devices. The other classes are either mandatory only for specific Device types or optional (refer to Section 11, for detailed description of supported command classes as a function of Device type). By using different classes, several configurations can be chosen (e.g., a block writable Device). The supported Device Command Classes (CCC) are coded as a parameter in the Device specific data (CSD) register of each Device, providing the host with information on how to access the Device.

**Table 40 — Supported Device command classes (0–56)**

(1) Mandatory only for devices that supports HS200 mode

## (2) Obsolete

#### 6.10.4 Detailed command description

The following tables define in detail all e•MMC bus commands. The responses R1-R5 are defined in 6.12. The registers CID, CSD, EXT\_CSD and DSR are described in clause 7.

**Table 41 — Basic commands (class 0 and class 1)**

CMD INDEX	Type	Argument	Resp	Abbreviation	Command Description
CMD0	bc	[31:0] 00000000	—	GO_IDLE_STATE	Resets the Device to <i>idle</i> state
	bc	[31:0] F0F0F0F0	—	GO_PRE_IDLE_STATE	Resets the Device to <i>pre-idle</i> state
	—	[31:0] FFFFFFFA	—	BOOT_INITIATION	Initiate alternative boot operation
CMD1	bcr	[31:0] OCR without busy	R3	SEND_OP_COND	Asks the Device, in <i>idle</i> state, to send its Operating Conditions Register contents in the response on the CMD line.
CMD2	bcr	[31:0] stuff bits	R2	ALL_SEND_CID	Asks the Device to send its CID number on the CMD line
CMD3	ac	[31:16] RCA [15:0] stuff bits	R1	SET_RELATIVE_ADDR	Assigns relative address to the Device
CMD4	bc	[31:16] DSR [15:0] stuff bits	-	SET_DSR	Programs the DSR of the Device
CMD5	ac	[31:16] RCA [15:0] Sleep/Awake [14:0] stuff bits	R1b	SLEEP_AWAKE	Toggles the Device between Sleep state and Standby state. (See 6.6.24).
CMD6	ac	[31:26] Set to 0 [25:24] Access [23:16] Index [15:8] Value [7:3] Set to 0 [2:0] Cmd Set	R1b	SWITCH	Switches the mode of operation of the selected Device or modifies the EXT_CSD registers. (See 6.6.1)
CMD7	ac	[31:16] RCA [15:0] stuff bits	R1/R1b1	SELECT/DESELECT_CARD	Command toggles a device between the standby and transfer states or between the programming and disconnect states. In both cases the Device is selected by its own relative address and gets deselected by any other address; address 0 deselects the Device.
CMD8	adtc	[31:0] stuff bits	R1	SEND_EXT_CSD	The Device sends its EXT_CSD register as a block of data.
CMD9	ac	[31:16] RCA [15:0] stuff bits	R2	SEND_CSD	Addressed Device sends its Device-specific data (CSD) on the CMD line.
CMD10	ac	[31:16] RCA [15:0] stuff bits	R2	SEND_CID	Addressed Device sends its Device identification (CID) on CMD the line.
CMD11			obsolete		The response to CMD11 will be undefined.
CMD12	ac	[31:16] RCA3 [15:1] stuff bits [0] HPI	R1/R1b4	STOP_TRANSMISSION	Forces the Device to stop transmission. If HPI flag is set the device shall interrupt its internal operations in a well defined timing.
CMD13	ac	[31:16] RCA [15:1] stuff bits [0] HPI	R1	SEND_STATUS	Addressed Device sends its status register. If HPI flag is set the device shall interrupt its internal operations in a well defined timing.
CMD14	adtc	[31:0] stuff bits	R1	BUSTEST_R	A host reads the reversed bus testing data pattern from a Device.
CMD15	ac	[31:16] RCA [15:0] stuff bits	-	GO_INACTIVE_STATE	Sets the Device to <i>inactive</i> state
CMD19	adtc	[31:0] stuff bits	R1	BUSTEST_W	A host sends the bus test data pattern to a Device.
NOTE 1	R1 while selecting from Stand-By State to Transfer State; R1b while selecting from Disconnected State to Programming State.				
NOTE 2	Data address for media =<2GB is a 32bit byte address and data address for media > 2GB is a 32bit sector (512B) address.				
NOTE 3	RCA in CMD12 is used only if HPI bit is set. The argument does not imply any RCA check on the device side.				
NOTE 4	R1 for read cases and R1b for write cases.				

#### 6.10.4 Detailed command description (cont'd)

**Table 42 — Block-oriented read commands (class 2)**

CMD INDEX	Type	Argument	Resp	Abbreviation	Command Description
CMD16	ac	[31:0] block length	R1	SET_BLOCKLEN	Sets the block length (in bytes) for all following block commands (read and write). Default block length is specified in the CSD.
CMD17	adtc	[31:0] data address1	R1	READ_SINGLE_BLOCK	Reads a block of the size selected by the SET_BLOCKLEN command. <sup>2</sup>
CMD18	adtc	[31:0] data address1	R1	READ_MULTIPLE_BLOCK	Continuously transfers data blocks from Device to host until interrupted by a stop command, or the requested number of data blocks is transmitted. If sent as part of a packed read command, the argument shall contain the first read data address in the pack (address of first individual read command inside the pack). (See 6.6.30.1)
CMD21	adtc	[31:0] stuff bits	R1	SEND_TUNING_BLOCK	128 clocks of tuning pattern (64byte in 4 bit mode or 128byte in 8 bit mode) is sent for HS200 optimal sampling point detection.

NOTE 1 Data address for media =<2GB is a 32bit byte address and data address for media > 2GB is a 32bit sector (512B) address.

NOTE 2 The transferred data must not cross a physical block boundary, unless READ\_BLK\_MISALIGN is set in the CSD register.

**Table 43 — Class 3 commands**

CMD INDEX	Type	Argument	Resp	Abbreviation	Command Description
CMD20				Obsolete	The response to CMD20 will be undefined.
CMD22	Reserved				

#### 6.10.4 Detailed command description (cont'd)

**Table 44 — Block-oriented write commands (class 4)**

CMD INDEX	Type	Argument	Resp	Abbreviation	Command Description
CMD23 (default)	ac	[31] Reliable Write Request [30] '0' non-packed [29] tag request [28:25] context ID [24]: forced programming [23:16] set to 0 [15:0] number of blocks	R1	SET_BLOCK_COUN T	<p><b>non-packed command version</b></p> <p>Defines the number of blocks (read/write) and the reliable writer parameter (write) for a block read or write command. (See 6.6.10 and 6.6.11)</p> <p>May contain a tag request (see 6.6.31) or a context ID (see 6.6.30). Tag and Context ID cannot be used together in the same command, if one is used the other must be set to zero.</p> <p>The context ID is an identifier (0 to 15) that associates the read/write command with the specific context.</p> <p>When bit 24 is set to 1, forced programming enabled, data shall be forcefully programmed to non-volatile storage instead of volatile cache while cache is turned ON.</p>
CMD23 (packed)	ac	[31] set to 0 [30] '1' packed [29:16] set to 0 [15:0] number of blocks	R1	SET_BLOCK_COUNT	<p><b>packed command version</b></p> <p>Defines the number of blocks (read/write) for the following packed write command or for the header of the following packed read command. (See 6.6.30.1).</p> <p>For packed write commands, the number of blocks should include the total number of blocks all packed commands plus one for the header block.</p> <p>For packed read commands, the number of blocks should equal one as only the header is sent inside the following CMD25. After that, a separate normal read command is sent to get the packed data.</p>
CMD24	adtc	[31:0] data address1	R1	WRITE_BLOCK	Writes a block of the size selected by the SET_BLOCKLEN command.2
CMD25	adtc	[31:0] data address1	R1	WRITE_MULTIPLE_BLOCK	<p>Continuously writes blocks of data until a STOP_TRANSMISSION follows or the requested number of block received.</p> <p>If sent as a packed command (either packed write, or the header of packed read) the argument shall contain the first read/write data address in the pack (address of first individual command inside the pack). (See 6.6.30.1)</p>
CMD26	adtc	[31:0] stuff bits	R1	PROGRAM_CID	Programming of the Device identification register. This command shall be issued only once. The Device contains hardware to prevent this operation after the first programming. Normally this command is reserved for the manufacturer.
CMD27	adtc	[31:0] stuff bits	R1	PROGRAM_CSD	Programming of the programmable bits of the CSD.
CMD49	adtc	[31:0] stuff bits	R1	SET_TIME	Sets the real time clock according to the RTC information in the 512B data block.
NOTE 1 Data address for media =<2GB is a 32bit byte address and data address for media > 2GB is a 32bit sector (512B) address.					
NOTE 2 The transferred data must not cross a physical block boundary unless WRITE_BLK_MISALIGN is set in the CSD.					

#### 6.10.4 Detailed command description (cont'd)

**Table 45 — Block-oriented write protection commands (class 6)**

CMD INDEX	Type	Argument	Resp	Abbreviation	Command Description
CMD28	ac	[31:0] data address1	R1b	SET_WRITE_PROT	<p><b>If CLASS_6_CTRL=0x00:</b> If the Device has write protection features, this command sets the write protection bit of the addressed group. The properties of write protection are coded in the Device specific data (WP_GRP_SIZE or HC_WP_GRP_SIZE).</p> <p><b>If CLASS_6_CTRL=0x01:</b> This command releases the specified addressed group.</p>
CMD29	ac	[31:0] data address1	R1b	CLR_WRITE_PROT	<p><b>If CLASS_6_CTRL=0x00:</b> If the Device provides write protection features, this command clears the write protection bit of the addressed group.</p> <p><b>If CLASS_6_CTRL=0x01:</b> This command is ignored.</p>
CMD30	adtc	[31:0] write protect data address	R1	SEND_WRITE_PROT	<p><b>If CLASS_6_CTRL=0x00:</b> If the Device provides write protection features, this command asks the Device to send the status of the write protection bits.<sup>2</sup></p> <p><b>If CLASS_6_CTRL=0x01:</b> This command asks the device to send the status of released groups. A bit '0' means the specific group is valid and accessible, a bit '1' means the specific group was released and it cannot be used.<sup>3</sup></p>
CMD31	adtc	[31:0] write protect data address	R1	SEND_WRITE_PROT_TYPE	<p><b>If CLASS_6_CTRL=0x00:</b> This command sends the type of write protection that is set for the different write protection groups<sup>4</sup>.</p> <p><b>If CLASS_6_CTRL=0x01:</b> This command returns a fixed pattern of 64-bit zeros in its payload.</p>
NOTE 1	Data address for media =<2GB is a 32bit byte address and data address for media > 2GB is a 32bit sector (512B) address.				
NOTE 2	32 write protection bits (representing 32 write protect groups starting at the specified address) followed by 16 CRC bits are transferred in a payload format via the data lines. The last (least significant) bit of the protection bits corresponds to the first addressed group. If the addresses of the last groups are outside the valid range, then the corresponding write protection bits shall be set to zero.				
NOTE 3	32 released status bits (representing 32 write protect groups starting at the specified address) followed by 16 CRC bits are transferred in a payload format via the data lines. The last (least significant) bit of the released bits corresponds to the first addressed group. If the addresses of the last groups are outside the valid range, then the corresponding released bits shall be set to zero.				
NOTE 4	64 write protection bits (representing 32 write protect groups starting at the specified address) followed by 16 CRC bits are transferred in a payload format via the data lines. Each set of two protection bits shows the type of protection set for each of the write protection groups. The definition of the different bit settings are shown below. The last (least significant) two bits of the protection bits correspond to the first addressed group. If the addresses of the last groups are outside the valid range, then the corresponding write protection bits shall be set to zero. "00" Write protection group not protected "01" Write protection group is protected by temporary write protection "10" Write protection group is protected by power-on write protection "11" Write protection group is protected by permanent write protection				

#### 6.10.4 Detailed command description (cont'd)

**Table 46 — Erase commands (class 5)**

CMD INDEX	Type	Argument	Resp	Abbreviation	Command Description
CMD32 ... CMD34	Reserved. These command indexes cannot be used in order to maintain backwards compatibility with older versions of <i>e</i> •MMCs				
CMD35	ac	[31:0] data address1,2	R1	ERASE_GROUP_STAR T	Sets the address of the first erase group within a range to be selected for erase
CMD36	ac	[31:0] data address1,2	R1	ERASE_GROUP_END	Sets the address of the last erase group within a continuous range to be selected for erase
CMD37	Reserved. This command index cannot be used in order to maintain backwards compatibility with older versions of <i>e</i> •MMCs				
CMD38	ac	[31] Secure request <sup>4</sup> [30:16] set to 0 [15] Force Garbage Collect request <sup>4</sup> [14:2] set to 0 [1] Discard Enable [0] Identify Write Blocks for Erase (or TRIM Enable)	R1b	ERASE	<p>Erases all previously selected write blocks according to argument bits<sup>3</sup>.</p> <p>When all argument bits are zero CMD38 will perform an erase on erase group(s).</p> <p>When Bit 0 = 1 and Bit 1=0 then CMD38 will perform a TRIM on the sector(s).</p> <p>When Bit 0 =1 and Bit 1=1 then CMD38 will perform a DISCARD on the sector(s).</p> <p>To maintain backward compatibility the device must not report an error if bits 31 and 15 are set. The device behavior when these are set is undefined.</p> <p>All other argument settings should trigger an ERROR.</p>
NOTE 1	Data address for media =<2GB is a 32bit byte address and data address for media > 2GB is a 32bit sector (512B) address.				
NOTE 2	The Device will ignore all LSB's below the Erase Group size, effectively rounding the address down to the Erase Group boundary.				
NOTE 3	Table 11 — and Table 12 — give a description of the argument bits and a list of supported argument combinations.				
NOTE4	Argument bit 15 is an optional feature that is only supported if SEC_GB_CL_EN (EXT_CSD[231] bit 4) is set. Argument bit 31 is an optional feature that is only supported if SEC_ER_EN (EXT_CSD[231] bit 0) is set				

All future reserved commands, and their responses (if there are any), shall have a codeword length of 48 bits.

#### 6.10.4 Detailed command description (cont'd)

**Table 47 — I/O mode commands (class 9)**

CMD INDEX	Type	Argument	Resp	Abbreviation	Command Description
CMD39	ac	[31:16] RCA [15:15] register write flag [14:8] register address [7:0] register data	R4	FAST_IO	Used to write and read 8 bit (register) data fields. The command addresses a Device and a register and provides the data for writing if the write flag is set. The R4 response contains data read from the addressed register if the write flag is cleared to 0. This command accesses application dependent registers which are not defined in the e•MMC standard.
CMD40	bcr	[31:0] stuff bits	R5	GO_IRQ_STATE	Sets the system into interrupt mode
CMD41	Reserved				

**Table 48 — Lock Device commands (class 7)**

CMD INDEX	Type	Argument	Resp	Abbreviation	Command Description
CMD42	adtc	[31:0] stuff bits.	R1	LOCK_UNLOCK	Used to set/reset the password or lock/unlock the Device. The size of the data block is set by the SET_BLOCK_LEN command.
CMD43	Reserved				
CMD48					

**Table 49 — Application-specific commands (class 8)**

CMD INDEX	Type	Argument	Resp	Abbreviation	Command Description
CMD55	ac	[31:16] RCA [15:0] stuff bits	R1	APP_CMD	Indicates to the Device that the next command is an application specific command rather than a standard command
CMD56	adtc	[31:1] stuff bits. [0]: RD/WR1	R1	GEN_CMD	Used either to transfer a data block to the Device or to get a data block from the Device for general purpose / application specific commands. The size of the data block shall be set by the SET_BLOCK_LEN command.
CMD57	reserved				
CMD59					
CMD60	reserved for manufacturer				
CMD63					
NOTE 1 RD/WR: "1" the host gets a block of data from the Device. "0" the host sends block of data to the Device.					

#### 6.10.4 Detailed command description (cont'd)

**Table 50 — Security Protocols (class 10)**

CMD INDEX	Type	Argument	Resp	Abbreviation	Command Description
CMD50 -52	Reserved				
CMD53	adtc	[16:31] Security Protocol Specific [15:8] Security Protocol [7:0] reserved	R1	PROTOCOL_RD	Continuously transfers data blocks from device to host. Number of data blocks shall be defined by a preceding CMD23. Data Transfer may be interrupted by a STOP_TRANSMISSION command, This command is not supported if sent as a packed command. Block size is always 512bytes.
CMD54	adtc	[16:31] Security Protocol Specific [15:8] Security Protocol [7:0] reserved	R1	PROTOCOL_WR	Continuously transfers data blocks from host to device. Number of data blocks shall be defined by a preceding CMD23. Data Transfer may be interrupted by a STOP_TRANSMISSION command, This command is not supported if sent as a packed command. Block size is always 512bytes.

## 6.11 Device state transition table

Table 51 — defines the Device state transitions in dependency of the received command.

**Table 51 — Device state transitions**

## 6.12 Device state transition table (cont'd)

## 6.12 Device state transition table (cont'd)

Command	Current State												
	idle	ready	ident	stby	tran	data	btst	rcv	prg	dis	ina	slp	irq
CMD41; CMD43...CMD52, CMD57...CMD59	Changes to												
CMD60...CMD63	Reserved for Manufacturer												
NOTE 1	Due to legacy considerations, a Device may treat CMD24/25 during a prg state—while busy is active—as a legal or an illegal command. A Device that treats CMD24/25 during a prg-state—while busy is active—as an illegal command will not change its state to the rcv state. A host should not send CMD24/25 while the Device is in prg state and busy is active.												
NOTE 2	Due to legacy considerations, a Device may treat CMD24/25 during a prg state—while busy is active—as a legal or an illegal command. A Device that treats CMD24/25 during a prg state—while busy is active—as an illegal command will not change its state to the rcv state. A host should not send CMD24/25 while the Device is in prg state and busy is active												
NOTE 3	As there is no way to obtain state information in boot mode, boot-mode states are not shown in this table.												

## 6.12 Responses

All responses are sent via the command line CMD. The response transmission always starts with the left bit of the bit string corresponding to the response codeword. The code length depends on the response type. A response always starts with a start bit (always '0'), followed by the bit indicating the direction of transmission (Device = '0'). A value denoted by 'x' in the tables below indicates a variable entry. All responses, except for the type R3 (see below), are protected by a CRC (see 8.2 for the definition of CRC7). Every command codeword is terminated by the end bit (always '1').

There are five types of responses. Their formats are defined as follows:

- **R1** (normal response command): code length 48 bit. The bits 45:40 indicate the index of the command to be responded to, this value being interpreted as a binary coded number (between 0 and 63). The status of the Device is coded in 32 bits. The Device status is described in 6.13.

**Table 52 — R1 response**

Bit position	47	46	[45:40]	[39:8]	7	0
Width (bits)	1	1	6	32	x	1
Value	"0"	"0"	x	x	CRC7	"1"
Description	Start bit	Transmission bit	Command index	Device status	CRC7	End bit

- **R1b** is identical to R1 with an optional busy signal transmitted on the data line DAT0. The Device may become busy after receiving these commands based on its state prior to the command reception. Refer to 6.15 for detailed description and timing diagrams.
- **R2** (CID, CSD register): code length 136 bits. The contents of the CID register are sent as a response to the commands CMD2 and CMD10. The contents of the CSD register are sent as a response to CMD9. Only the bits [127...1] of the CID and CSD are transferred, the reserved bit [0] of these registers is replaced by the end bit of the response.

## 6.12 Responses (cont'd)

**Table 53 — R2 response**

Bit position	135	134	[133:128]	[127:1]	0
Width (bits)	1	1	6	127	1
Value	“0”	“0”	111111	x	“1”
Description	Start bit	Transmission bit	Check bits	CID or CSD register incl. internal CRC7	End bit

- **R3** (OCR register): code length 48 bits. The contents of the OCR register is sent as a response to CMD1. The level coding is as follows: restricted voltage windows=LOW, Device busy=LOW.

**Table 54 — R3 Response**

Bit position	47	46	[45:40]	[39:8]	[7:1]	0
Width (bits)	1	1	6	32	7	1
Value	“0”	“0”	“111111”	x	“1111111”	“1”
Description	Start bit	Transmission bit	Check bits	OCR register	Check bits	End bit

- **R4** (Fast I/O): code length 48 bits. The argument field contains the RCA of the addressed Device, the register address to be read out or written to, and its contents. The status bit in the argument is set if the operation was successful.

**Table 55 — R4 response**

Bit position	47	46	[45:40]	[39:8] Argument field				[7:1]	0
Width (bits)	1	1	6	16	1	7	8	7	1
Value	“0”	“0”	“100111”	x	x	x	x	x	“1”
Description	Start bit	Transmission bit	CMD39	RCA [31:16]	Status [15]	Register address [14:8]	Read register contents [7:0]	CRC 7	End bit

- **R5** (Interrupt request): code length 48 bits. If the response is generated by the host, the RCA field in the argument shall be 0x0.

**Table 56 — R5 response**

Bit position	47	46	[45:40]	[39:8] Argument field				[7:1]	0
Width (bits)	1	1	6	16	16	16	16	7	1
Value	“0”	“0”	“101000”	x	x	x	x	x	“1”
Description	Start bit	Transmission bit	CMD40	RCA [31:16] of winning Device or of the host	[15:0] Not defined. May be used for IRQ data	CRC 7	End bit		

### 6.13 Device status

The response format R1 contains a 32-bit field named *Device status*. This field is intended to transmit the Device's status information. Two different attributes are associated with each one of the Device status bits:

- Bit type. Two types of Device status bits are defined:
  - (a) Error bit. Signals an error condition was detected by the device. These bits are cleared as soon as the response (reporting the error) is sent out. Clear Cond. B
  - (b) Status bit. These bits serve as information fields only, and do not alter the execution of the command being responded to. These bits are persistent; they are set and cleared in accordance with the Device status. Clear Cond. A

The “Type” field of Table 57 — defines the type of each bit in the Device status register. The symbol “E” is used to denote an Error bit while the symbol “S” is used to denote a Status bit.

- Detection mode of Error bits.

Exceptions are detected by the Device either during the command interpretation and validation phase (Response Mode) or during command execution phase (Execution Mode). Response mode exceptions are reported in the response to the command that raised the exception. Execution mode exceptions are reported in the response to a STOP\_TRANSMISSION command used to terminate the operation or in the response to a GET\_STATUS command issued while the operation is being carried out or after the operation is completed. The “Det Mode” field of Table 57 — defines the detection mode of each bit in the Device status register. The symbol “R” is used to denote a Response Mode detection while the symbol “X” is used to denote an

- Execution Mode detection.

When an error bit is detected in “R” mode the Device will report the error in the response to the command that raised the exception. The command will not be executed and the associated state transition will not take place. When an error is detected in “X” mode the execution is terminated. The error will be reported in the response to the next command.

The ADDRESS\_OUT\_OF\_RANGE and ADDRESS\_MISALIGN exceptions may be detected both in Response and Execution modes. The conditions for each one of the modes are explicitly defined in the table.

### 6.13 Device status (cont'd)

**Table 57 — Device status**

Bits	Identifier	Type	Det Mode	Value	Description	Clear Cond
31	ADDRESS_OUT_OF_RANGE	E	R	“0” = no error “1” = error	The command’s address argument was out of the allowed range for this Device.	B
			X		A multiple block operation is (although started in a valid address) attempting to read or write beyond the Device capacity	
30	ADDRESS_MISALIGN	E	R	“0” = no error “1” = error	The command’s address argument (in accordance with the currently set block length) positions the first data block misaligned to the Device physical blocks.	B
			X		A multiple block read/write operation (although started with a valid address/block length combination) is attempting to read or write a data block which does not align with the physical blocks of the Device.	
29	BLOCK_LEN_ERROR	E	R	“0” = no error “1” = error	Either the argument of a SET_BLOCKLEN command exceeds the maximum value allowed for the Device, or the previously defined block length is illegal for the current command (e.g., the host issues a write command, the current block length is smaller than the Device’s maximum and write partial blocks is not allowed)	B
28	ERASE_SEQ_ERROR	E	R	“0” = no error “1” = error	An error in the sequence of erase commands occurred.	B
27	ERASE_PARAM	E	X	“0” = no error “1” = error	An invalid selection of erase groups for erase occurred.	B
26	WP_VIOLATION	E	X	“0” = no error “1” = error	Attempt to program a write protected block	B
25	DEVICE_IS_LOCKED	S	R	“0” = Device unlocked “1” = Device locked	When set, signals that the Device is locked by the host	A
24	LOCK_UNLOCK_FAILED	E	X	“0” = no error “1” = error	Set when a sequence or password error has been detected in lock/unlock Device command	B
23	COM_CRC_ERROR	E	R	“0” = no error “1” = error	The CRC check of the command failed.	B
22	ILLEGAL_COMMAND	E	R	“0” = no error “1” = error	Command not legal for the Device state	B
21	DEVICE_ECC_FAILED	E	X	“0” = success “1” = failure	Device internal ECC was applied but failed to correct the data.	B
20	CC_ERROR	E	R	“0” = no error “1” = error	(Undefined by the standard) A Device error occurred, which is not related to the host command.	B
19	ERROR	E	X	“0” = no error “1” = error	(Undefined by the standard) A generic Device error related to the (and detected during) execution of the last host command (e.g., read or write failures).	B
18	obsolete				Hosts should ignore this bit	
17	obsolete				Hosts should ignore this bit	

<b>Bits</b>	<b>Identifier</b>	<b>Type</b>	<b>Det Mode</b>	<b>Value</b>	<b>Description</b>	<b>Clear Cond</b>
16	CID/CSD_OVERWRITE	E	X	"0" = no error "1" = error	Can be either one of the following errors: - The CID register has been already written and cannot be overwritten - The read only section of the CSD does not match the Device content. - An attempt to reverse the copy (set as original) or permanent WP (unprotected) bits was made.	B
15	WP_ERASE_SKIP	E	X	"0" = not protected "1" = protected	Only partial address space was erased due to existing write protected blocks.	B
14	Reserved, must be set to 0					
13	ERASE_RESET	E	R	"0" = cleared "1" = set	An erase sequence was cleared before executing because an out of erase sequence command was received (commands other than CMD35, CMD36, CMD38 or CMD13)	B
12:9	CURRENT_STATE	S	R	0 = Idle 1 = Ready 2 = Ident 3 = Sby 4 = Tran 5 = Data 6 = Rcv 7 = Prg 8 = Dis 9 = Btst 10 = Slp 11–15 = reserved	The state of the Device when receiving the command. If the command execution causes a state change, it will be visible to the host in the response on the next command. The four bits are interpreted as a binary number between 0 and 15.  NOTE As there is no way to obtain state information in boot mode, boot-mode states are not shown in this table.	A
8	READY_FOR_DATA	S	R	"0" = not ready "1" = ready	Corresponds to buffer empty signaling on the bus	A
7	SWITCH_ERROR	E	X	"0" = no error "1" = switch error	If set, the Device did not switch to the expected mode as requested by the SWITCH command	B
6	EXCEPTION_EVENT	S	R	"0" = no event "1" = an exception event has occurred	If set, one of the exception bits in field EXCEPTION_EVENTS_STATUS was set to indicate some exception has occurred. Host should check that field to discover which exception has occurred to understand what further actions are needed in order to clear this bit.	A
5	APP_CMD	S	R	"0" = Disabled "1" = Enabled	The Device will expect ACMD, or indication that the command has been interpreted as ACMD	A
4	Reserved					
3:2	Reserved for Application Specific commands					
1:0	Reserved for Manufacturer Test Mode					

### 6.13 Device status (cont'd)

Table 58 defines, for each command responded by a R1 response, the affected bits in the status field. A “R” or a “X” mean the error/status bit may be affected by the respective command (using the R or X detection mechanism respectively). The Status bits are valid in any R1 response and are marked with “S” symbol in the table.

**Table 58 — Device Status field/command - cross reference**

CMD#	Response 1 Format – Status bit #																						
	31	30	29	28	27	26	25	24	23*	22*	21	20	19	18	17	16	15	13	12:9	8	7	6	5
0							S	R			R	X						S	S	S	S		
1								R	R			X											
2								R	R			X											
3							S	R	R		R	X						S	S	S	S		
4							S	R	R		R	X						S	S	S	S		
5							S	R	R		R	X					R	S	S	S	S		
6							S	R	R		R	X					R	S	S	X	S		
7							S	R	R		R	X					R	S	S	S	S		
8							S	R	R		R	X					R	S	S	S	S		
9							S	R	R		R	X					R	S	S	S	S		
10							S	R	R		R	X					R	S	S	S	S		
11 (1)																							
12							S	R	R		R	X						S	S	S	S		
13							S	R	R		R	X						S	S	S	S		
14							S	R	R		R	X					R	S	S	S	S		
15							S	R			R	X					R	S	S	S	S		
16			R				S	R	R		R	X					R	S	S	S	S		
17	R	R	R				S	R	R	X	R	X					R	S	S	S	S		
18	R	R	R				S	R	R	X	R	X					R	S	S	S	S		
19							S	R	R		R	X					R	S	S	S	S		
20 (1)																							
21							S	R	R	X	R	X					R	S	S	S	S		
23							S	R	R		R	X					R	S	S	S	S		
24	R	R	R				S	R	R		R	X					R	S	S	S	S		
25	R	R	R				S	R	R		R	X					R	S	S	S	S		
26							S	R	R		R	X					R	S	S	S	S		
27							S	R	R		R	X					R	S	S	S	S		
28	R						S	R	R		R	X					R	S	S	S	S		
29	R						S	R	R		R	X					R	S	S	S	S		
30	R			R	X		S	R	R		R	X					R	S	S	S	S		
35	R			R	X		S	R	R		R	X						S	S	S	S		
36			R				S	R	R		R	X						S	S	S	S		
38							S	R	R		R	X						X	S	S	S		
39							S	R	R		R	X					R	S	S	S	S		
40							S	R	R		R	X					R	S	S	S	S		
42							S	X	R	R		R	X				R	S	S	S	S		
53	R	R	R				S	R	R	X	R	X					R	S	S	S	S		
54	R	R	R				S	R	R		R	X					R	S	S	S	S		
55							S	R			R	X					R	S	S	S	S		
56							S	R	R		R	X					R	S	S	S	S		

NOTE 1 Commands are obsolete

### 6.13 Device status (cont'd)

**Table 59 — Response 1 Status Bit Valid**

CMD#	Response 1 Format – Status bit #																							
	31	30	29	28	27	26	25	24	23*	22*	21	20	19	18	17	16	15	13	12:9	8	7	6	5	
Bit is valid for classes	1, 2, 3, 4, 5, 6, 10	2, 4, 7, 10	2, 4, 10	5	3, 4, 10	A L W	7 L W	A L W	A L W	A L W	1, 2, 10	A L W	A L W	1 W	3 A Y	5 L Y	A L Y							
						A Y S	A Y S	A Y S	A Y S	A Y S		A Y S	A Y S		A Y S									

\* The COM\_CRC\_ERROR and ILLEGAL\_COMMAND errors are detected during the command interpretation and validation phase (Response Mode). However, since the Device does not respond to commands with COM\_CRC\_ERROR or ILLEGAL\_COMMAND error, the errors are reported in the response of the following valid command.

Not all Device status bits are meaningful all the time. Depending on the classes supported by the Device, the relevant bits can be identified. If all the classes that affect a status bit, or an error bit, are not supported by the Device, the bit is not relevant and can be ignored by the host.

### 6.14 Memory array partitioning

The basic unit of data transfer to/from the e•MMC is one byte. All data transfer operations which require a block size always define block lengths as integer multiples of bytes. Some special functions need other partition granularity.

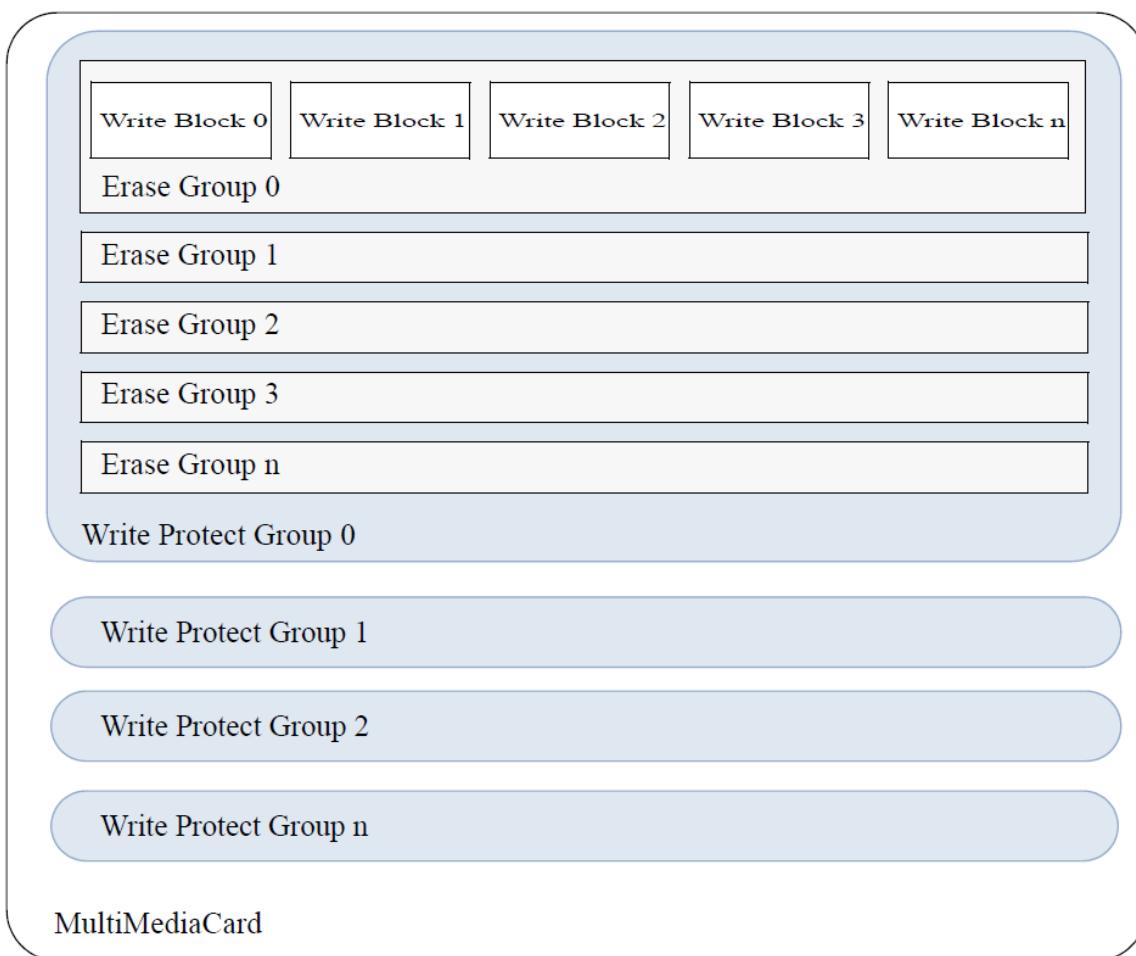
For block oriented commands, the following definition is used:

- **Block:** is the unit which is related to the block oriented read and write commands. Its size is the number of bytes which will be transferred when one block command is sent by the host. The size of a block is either programmable or fixed. The information about allowed block sizes and the programmability is stored in the CSD.

Special erase and write protect commands are defined:

- The granularity of the erasable units is the **Erase Group:** The smallest number of consecutive write blocks which can be addressed for erase. The size of the Erase Group is Device specific and stored in the CSD when ERASE\_GROUP\_DEF is disabled, and in the EXT\_CSD when ERASE\_GROUP\_DEF is enabled.
- The granularity of the Write Protected units is the **WP-Group:** The minimal unit which may be individually write protected. Its size is defined in units of erase groups. The size of a WP-group is Device specific and stored in the CSD when ERASE\_GROUP\_DEF is disabled, and in the EXT\_CSD when ERASE\_GROUP\_DEF is enabled.

## 6.14 Memory array partitioning (cont'd)



**Figure 33 — Memory array partitioning**

## 6.15 Timings

All timing diagrams use the following schematics and abbreviations:

S	Start bit (= “0”)
T	Transmitter bit (Host = “1,” Device = “0”)
P	One-cycle pull-up (= “1”)
E	End bit (= “1”)
L	One-cycle pull-down (= “0”)
Z	High impedance state (-> = “1”)
X	Driven value, “1” or “0”
D	Data bits
*	Repetition
CRC	Cyclic redundancy check bits (7 bits)
	Device active
	Host active

The difference between the P-bit and Z-bit is that a P-bit is actively driven to HIGH by the Device respectively host output driver, while Z-bit is driven to (respectively kept) HIGH by the pull-up resistors  $R_{CMD}$  respectively  $R_{DAT}$ . Actively-driven P-bits are less sensitive to noise.

All timing values are defined in Table 60 —

### 6.15.1 Command and response

Both host command and Device response are clocked out with the rising edge of the host clock in either the single data rate or dual data rate modes.

- Device identification and Device operation conditions timing

The Device identification (CMD2) and Device operation conditions (CMD1) timing are processed in the open-drain mode. The Device response to the host command starts after exactly  $N_{ID}$  clock cycles.

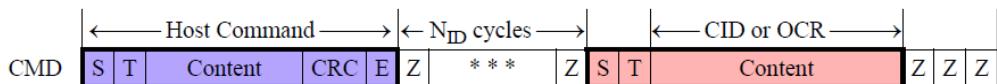


Figure 34 — Identification timing (Device identification mode)

- Assign a Device relative address

The SET\_RCA (CMD 3) is also processed in the open-drain mode. The minimum delay between the host command and Device response is  $N_{CR}$  clock cycles.

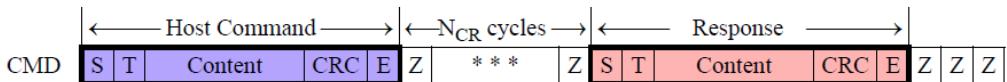
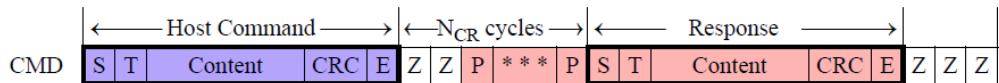


Figure 35 — SET\_RCA timing (Device identification mode)

### 6.15.1 Command and response (cont'd)

- Data transfer mode.

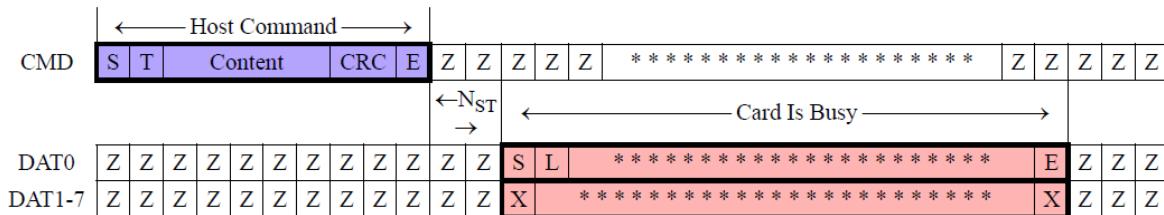
After a Device receives its RCA it will switch to data transfer mode. In this mode the CMD line is driven with push-pull drivers. The command is followed by a period of two Z bits (allowing time for direction switching on the bus) and then by P bits pushed up by the responding Device. This timing diagram is relevant for all responded host commands except CMD1, 2 and 3:



**Figure 36 — Command response timing (data transfer mode)**

- R1b responses

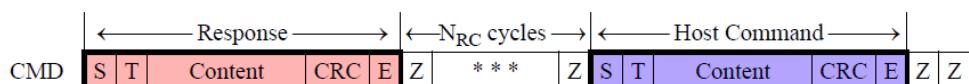
Some commands, like CMD6, may assert the BUSY signal and respond with R1. If the busy signal is asserted, it is done two clock cycles after the end bit of the command. The DAT0 line is driven low, DAT1-DAT7 lines are driven by the Device though their values are not relevant.



**Figure 37 — R1b response timing**

- Last Device response—next host command timing

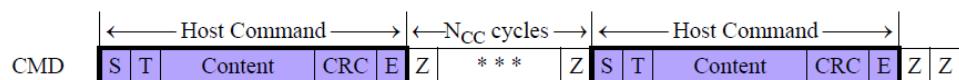
After receiving the last Device response, the host can start the next command transmission after at least  $N_{RC}$  clock cycles. This timing is relevant for any host command.



**Figure 38 — Timing response end to next command start (data transfer mode)**

- Last host command—next host command timing

After the last command has been sent, the host can continue sending the next command after at least  $N_{CC}$  clock periods.



**Figure 39 — Timing of command sequences (all modes)**

If the ALL\_SEND\_CID command is not responded by the Device after  $N_{ID} + 1$  clock periods, the host can conclude there is no Device present in the bus.

### 6.15.2 Data read

Data read can be made in single data rate mode or in dual rate mode.

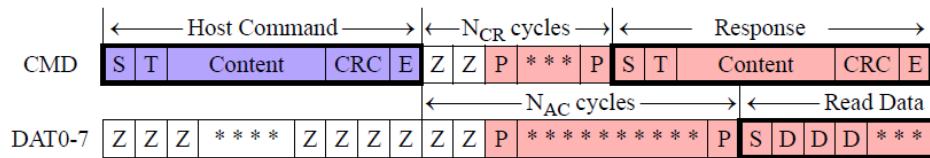
In the single data rate mode, data are clocked out by the Device and sampled by the host with the rising edge of the clock and there is a single CRC per data line.

In the dual data rate mode, data are clocked out with both the rising edge of the clock and the falling edge of the clock and there are two CRC appended per data line. In this mode, the block length is always 512 bytes, and bytes come interleaved in either 4-bit or 8-bit width configuration. Bytes with odd number (1,3,5, ..., 511) shall be sampled on the rising edge of the clock by the host and bytes with even number (2,4,6, ..., 512) shall be sampled on the falling edge of the clock by the host. The Device will append two CRC16 per each valid data line, one corresponding to the bits of the 256 odd bytes to be sampled on the rising edge of the clock by the host and the second for the remaining bits of the 256 even bytes of the block to be sampled on the falling edge of the clock by the host.

Remark: only the data block and the two CRC use both edges of the clock. Start and end bits are only valid on the rising edge of the clock. The value on the falling edge is not guaranteed.<sup>2</sup>

- Single block read

The host selects one Device for data read operation by CMD7, and sets the valid block length for block oriented data transfer by CMD16(CMD16 only applies to single data rate mode). The basic bus timing for a read operation is given in Figure 40. The sequence starts with a single block read command (CMD17) which specifies the start address in the argument field. The response is sent on the CMD line as usual.



**Figure 40 — Single-block read timing**

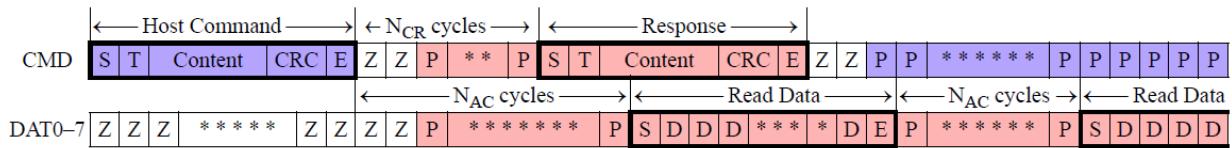
Data transmission from the Device starts after the access time delay N<sub>AC</sub> beginning from the end bit of the read command. After the last data bit, the CRC check bits are suffixed to allow the host to check for transmission errors.

- Multiple block read

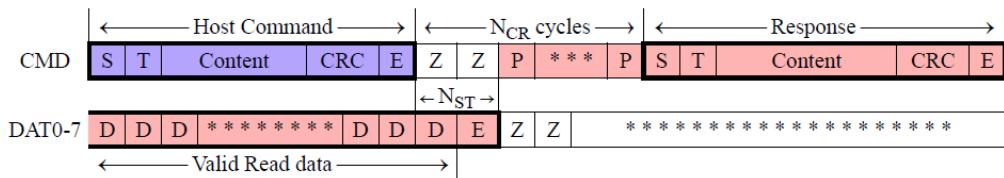
In multiple block read mode, the Device sends a continuous flow of data blocks following the initial host read command. The data flow is terminated by a stop transmission command (CMD12). Figure 41 describes the timing of the data blocks and Figure 42 the response to a stop command. The data transmission stops two clock cycles after the end bit of the stop command.

<sup>2</sup> Due to ambiguity of previous versions of standard, start and end bits may either be valid for both the rising and falling edge or only for the rising edge. To ensure backward compatibility, the standard allows for both interpretations and does not mandate the value on the falling edge

### 6.15.2 Data read (cont'd)



**Figure 41**—Multiple-block read timing



**Figure 42** — Stop command timing (CMD12, data transfer mode)

### 6.15.3 Data write

Data write can be made in single data rate mode or in dual rate mode.

In the single data rate mode, data are clocked out by the host and sampled by the Device with the rising edge of the clock and there is a single CRC per data line. In the dual data rate mode, data are clocked out with both the rising edge of the clock and the falling edge of the clock and there are two CRC appended per data line. In this mode, the block length is always 512 bytes, and bytes come interleaved in either 4-bit or 8-bit width configuration. Bytes with odd number (1,3,5,...,511) shall be sampled on the rising edge of the clock by the Device and bytes with even number (2,4,6,...,512) shall be sampled on the falling edge of the clock by the Device. The host will append two CRC16 per valid data line, one corresponding to bits of the 256 odd bytes to be sampled on the rising edge of the clock by the Device and the second for the remaining bits of the 256 even bytes of the block to be sampled on the falling edge of the clock by the Device.

Remark: In a similar manner to the data read, only the data block and the two CRC use both edges of the clock. Start, end and the 3-bit CRC token status bits are only valid on the rising edge of the clock. The value on the falling edge is not guaranteed.<sup>3</sup>

- Single block write

The host selects the Device for data write operation by CMD7.

The host sets the valid block length for block oriented data transfer by CMD16 (CMD16 only applies to single data rate mode).

The basic bus timing for a write operation is given in Figure 43. The sequence starts with a single block write command (CMD24) which determines (in the argument field) the start address. It is responded by the Device on the CMD line as usual. The data transfer from the host starts  $N_{WR}$  clock cycles after the Device response was received.

<sup>3</sup> Due to ambiguity of previous versions of standard, start and end bits may either be valid for both the rising and falling edge or only for the rising edge. To ensure backward compatibility, the standard allows for both interpretations and does not mandate the value on the falling edge

### 6.15.3 Data write (cont'd)

The data is suffixed with CRC check bits to allow the Device to check it for transmission errors. The Device sends back the CRC check result as a CRC status token on DAT0. In the case of transmission error, occurring on any of the active data lines, the Device sends a negative CRC status ('101') on DAT0. In the case of successful transmission, over all active data lines, the Device sends a positive CRC status ('010') on DAT0 and starts the data programming procedure.

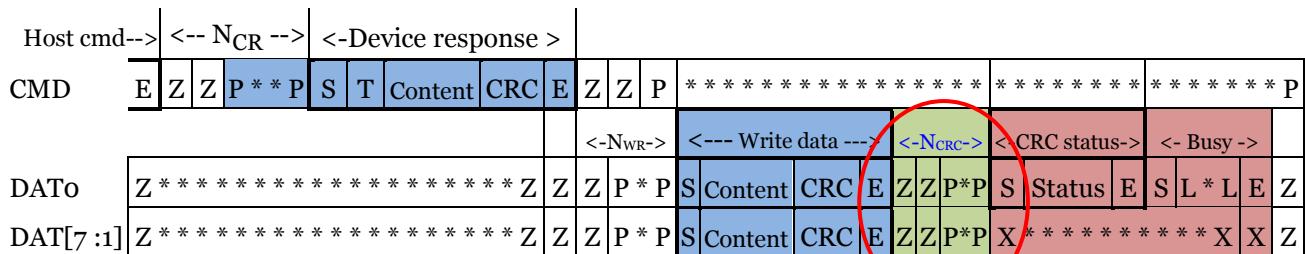


Figure 43 — Block write command timing

$N_{CRC}$ , is a timing parameter defined for HS200 and HS400. HS200 and HS400 device shall support  $N_{CRC}$ .  $N_{CRC}$  specifies timing from the end bit of data block in a Write operation, till the start bit of the CRC status.

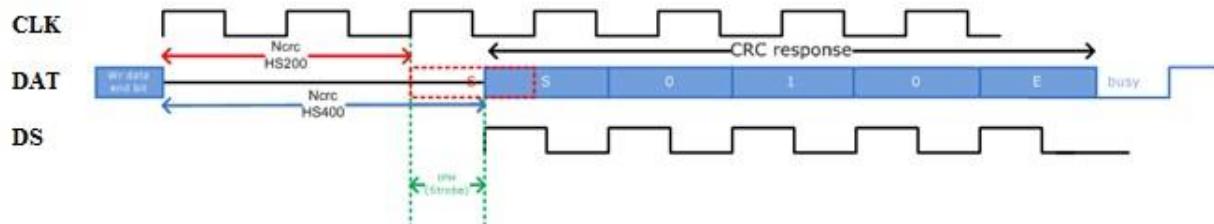


Figure 44 —  $N_{CRC}$  timing

For HS400, after CRC Status Response, the Device outputs the BUSY signal on DAT0 after  $t_{PH\_DATASTRBOE} + t_{PERIOD} + t_{RQ}$  from CLK rising edge which generates End Bit. After this time, the host may start sampling safely the BUSY signal.

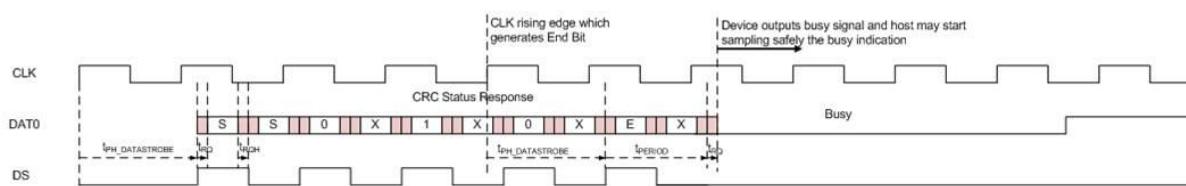


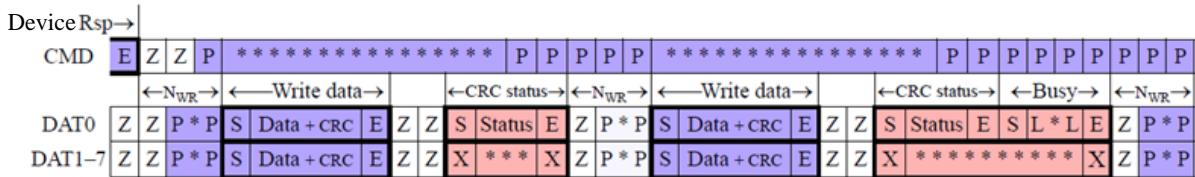
Figure 45 — BUSY Signal after CRC Status Response

### 6.15.3 Data write (cont'd)

While the Device is programming it indicates busy by pulling down the Dat0 line. This busy status is directly related to Programming state. As soon as the Device completes the programming it stops pulling down the Dat0 line.

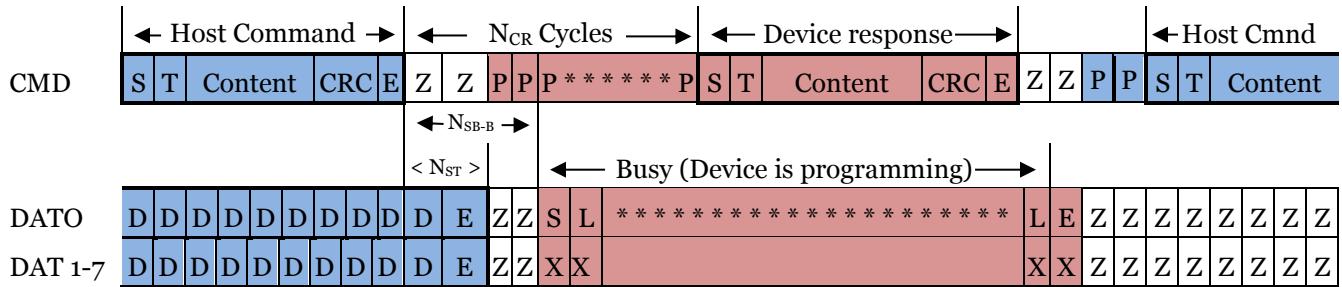
- Multiple block write

In multiple block write mode, the Device expects continuous flow of data blocks following the initial host write command. The data flow is terminated by a stop transmission command (CMD12). Figure 46 describes the timing of the data blocks with and without Device busy signal.



**Figure 46 — Multiple-block write timing**

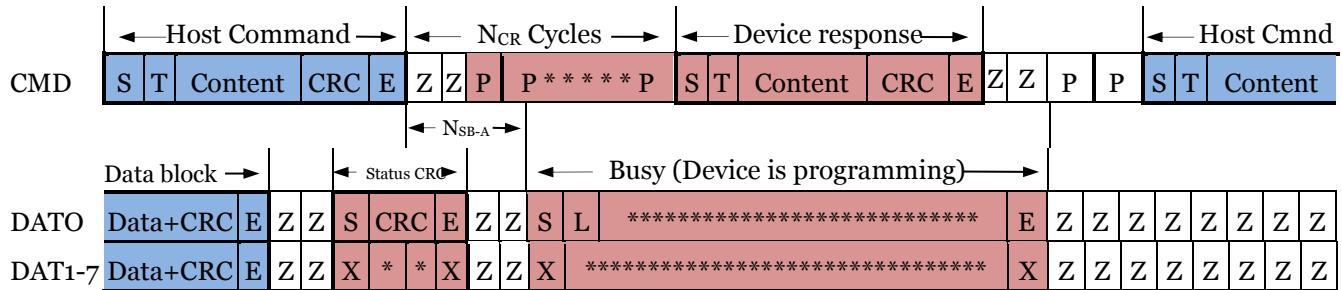
The stop transmission command works similar as in the read mode. Figure 47 thru Figure 50 describe the timing of the stop command in different Device states.



**Figure 47 — Stop transmission during data transfer from the host**

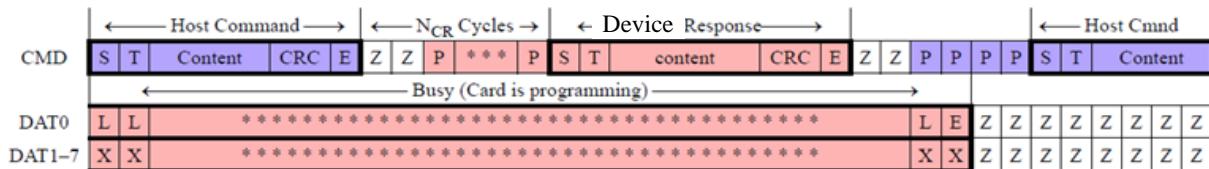
The Device will treat a data block as successfully received and ready for programming only if the CRC data of the block was validated and the CRC status tokens sent back to the host. 0 is an example of an interrupted (by a host stop command) attempt to transmit the CRC status block. The sequence is identical to all other stop transmission examples. The end bit of the host command is followed, on the data lines, with one more data bit, an end bit and two Z clocks for switching the bus direction (number of Z clocks may vary from 2 to 4 in HS200 and HS400 as described in 6.15.8.1). The received data block, in this case is considered incomplete and will not be programmed.

### 6.15.3 Data write (cont'd)

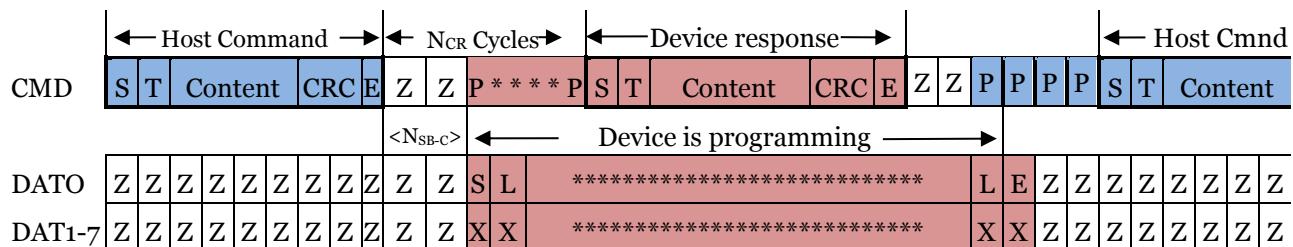


**Figure 48 — Stop transmission during CRC status transfer from the Device**

All previous examples dealt with the scenario of the host stopping the data transmission during an active data transfer. The following two diagrams describe a scenario of receiving the stop transmission between data blocks. In the first example the Device is busy programming the last block while in the second the Device is idle. However, there are still unprogrammed data blocks in the input buffers. These blocks are being programmed as soon as the stop transmission command is received and the Device activates the busy signal.



**Figure 49 — Stop transmission after last data block; Device is busy programming**



**Figure 50 — Stop transmission after last data block; Device becomes busy**

In an open-ended multiple block write case the busy signal between the data blocks should be considered as buffer busy signal. As long as there is no free data buffer available the Device should indicate this by pulling down the Dat0 line. The Device stops pulling down DAT0 as soon as at least one receive buffer for the defined data transfer block length becomes free. After the Device receives the stop command (CMD12), the following busy indication should be considered as programming busy and being directly related to the Programming state. As soon as the Device completes the programming, it stops pulling down the Dat0 line.

### 6.15.3 Data write (cont'd)

In pre-defined multiple block write case the busy signal between the data blocks should be considered as buffer busy signal similar to the open-ended multiple block case. After the Device receives the last data block the following busy indication should be considered as programming busy and being directly related to the Programming state. The meaning of busy signal (from buffer busy to programming busy) changes when the state changes (from rcv to prg). The busy signal remains “low” all the time during the process and is not released by the device between the rcv to prg states. As soon as the Device completes the programming, it stops pulling down the Dat0 line.

- Erase, set, and clear write protect timing

The host must first select the erase groups to be erased using the erase start and end command (CMD35, CMD36). The erase command (CMD38), once issued, will erase all selected erase groups. Similarly, set and clear write protect commands start a programming operation as well. The Device will signal “busy” (by pulling the DAT0 line low) for the duration of the erase or programming operation. The bus transaction timings are identical to the variation of the stop transmission described in Figure 50.

- Reselecting a busy Device

When a busy Device which is currently in the dis state is reselected it will reinstate its busy signaling on the data line DAT0. The timing diagram for this command / response / busy transaction is given in Figure 50.

### 6.15.4 Bus test procedure timing

After reaching the Tran-state in the single data rate mode a host can initiate the Bus Testing procedure. The Bus Testing procedure is invalid in dual data rate mode. If there is no response to the CMD19 sent by the host, the host should read the status from the Device with CMD13. If there was no response to CMD19, the host may assume that this function is not supported by the Device.

CMD	<b>CMD19</b>	<b>RSP19</b>		<b>CMD14</b>	<b>RSP14</b>		<b>CMD6</b>	<b>RSP6</b>
			↔N <sub>WR</sub> ↔		↔N <sub>RC</sub> ↔	↔N <sub>AC</sub> ↔		↔N <sub>RC</sub> ↔
DAT0	Z Z * * * * * Z Z Z	S   10   XXX   E		Z Z * * * * * Z Z Z	S   01   00000   CRC16   E		Z Z * * * * * Z Z Z	
DAT1	Z Z * * * * * Z Z Z	S   01   XXX   E		Z Z * * * * * Z Z Z	S   10   00000   CRC16   E		Z Z * * * * * Z Z Z	
DAT2	Z Z * * * * * Z Z Z	S   10   XXX   E		Z Z * * * * * Z Z Z	S   01   00000   CRC16   E		Z Z * * * * * Z Z Z	
DAT3	Z Z * * * * * Z Z Z	S   01   XXX   E		Z Z * * * * * Z Z Z	S   10   00000   CRC16   E		Z Z * * * * * Z Z Z	
DAT4-7	Z Z * * * * * Z Z Z	Z Z * * * Z Z Z		Z Z * * * * * Z Z Z	S   00   00000   CRC16   E		Z Z * * * * * Z Z Z	

Stuff bits optional

**Figure 51 — Bus test procedure timing**

### 6.15.5 Boot operation

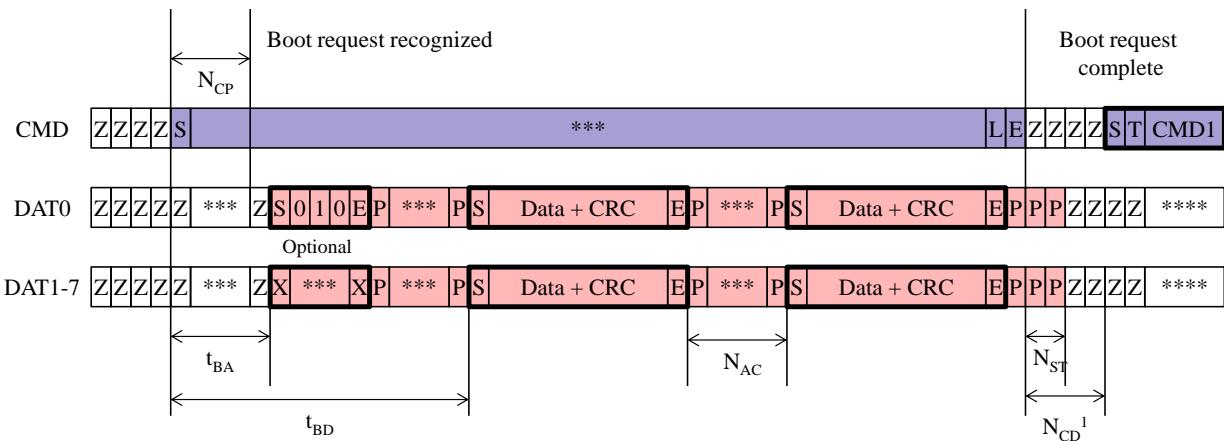
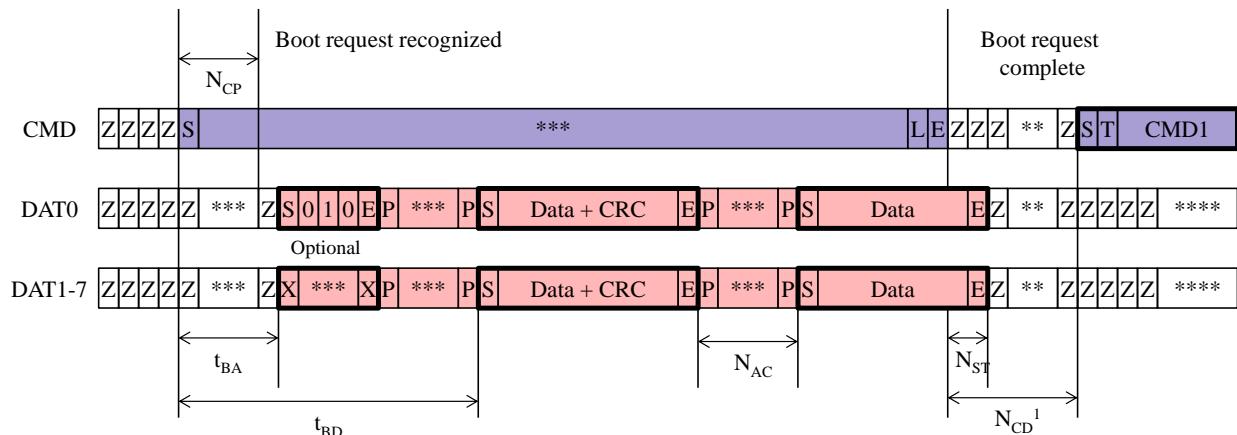


Figure 52 — Boot operation, termination between consecutive data blocks



NOTE 1 Also refer to Figure 54.

Figure 53 — Boot operation, termination during transfer

Boot operation complete      Clock =  $\leq 400$  kHz

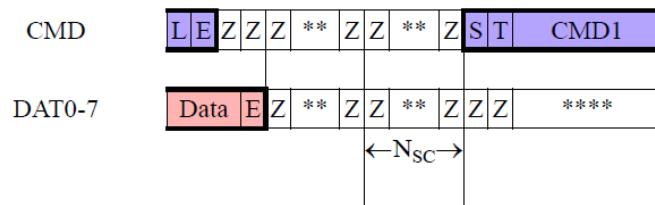
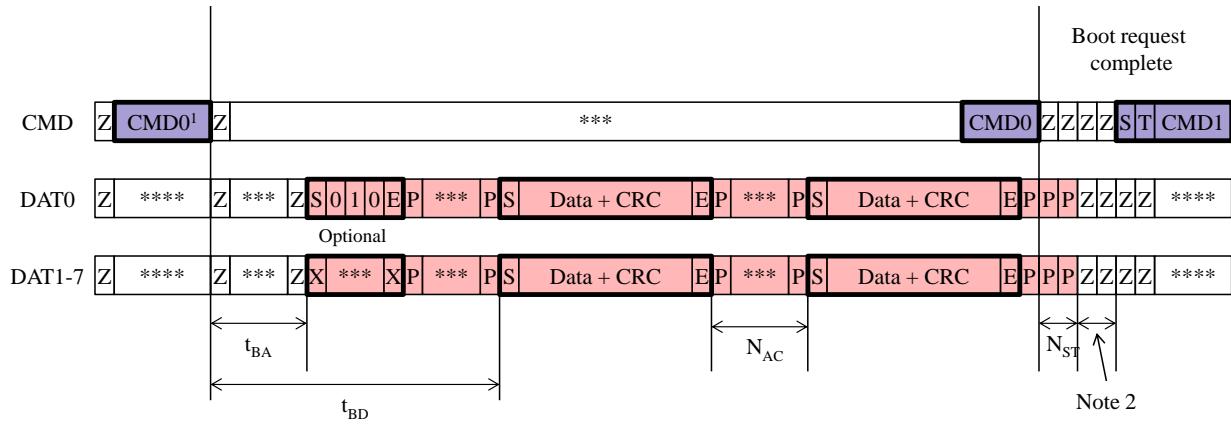


Figure 54 — Bus mode change timing (push-pull to open-drain)

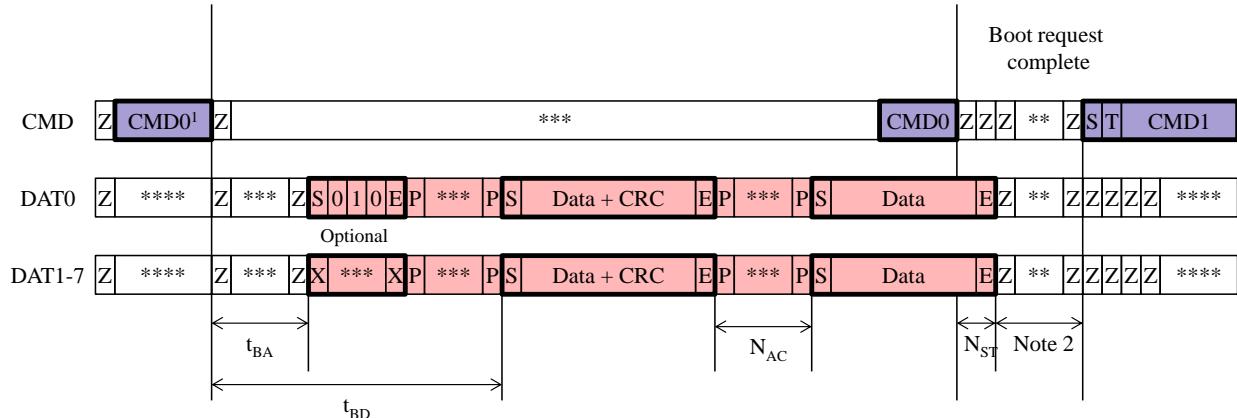
### 6.15.6 Alternative boot operation



NOTE 1 CMD0 with argument 0xFFFFFFFFA.

NOTE 2 Refer to Figure 54.

**Figure 55 — Alternative boot operation, termination between consecutive data blocks**



NOTE 1 CMD0 with argument 0xFFFFFFFFA.

NOTE 2 Refer to Figure 54.

**Figure 56 — Alternative boot operation, termination during transfer**

### 6.15.7 Timing Values

**Table 60 — Timing Parameters**

Symbol	Min	Max	Unit
N <sub>AC</sub>	2	10 * (TAAC * FOP + 100 * NSAC) <sup>1</sup>	Clock cycles
N <sub>CC</sub>	8	-	Clock cycles
N <sub>CD</sub>	56	-	Clock cycles
N <sub>CP</sub>	74	-	Clock cycles
N <sub>CR</sub>	2	64	Clock cycles
N <sub>ID</sub>	5	5	Clock cycles
N <sub>RC</sub>	8	-	Clock cycles
N <sub>SC</sub>	8	-	Clock cycles
N <sub>ST</sub>	2	2	Clock cycles
N <sub>WR</sub>	2	-	Clock cycles
N <sub>SB-A<sup>(2)</sup></sub>	4	4	Clock cycles
N <sub>SB-B<sup>(2)</sup></sub>	4	4	Clock cycles
N <sub>SB-C<sup>(2)</sup></sub>	2	2	Clock cycles
t <sub>BA</sub>	-	50	ms
t <sub>BD</sub>	-	1	s

NOTE 1  
FOP is the MMC clock frequency the host is using for the read operation.  
Following is a calculation example:  
CSD value for TAAC is 0x26; this is equal to 1.5mSec;  
CSD value for NSAC is 0;  
The host frequency FOP is 10MHz  
 $NAC = 10 \times (1.5 \times 10^{-3} \times 10 \times 10^6 + 0) = 150,000$  clock cycles

NOTE 2  
NSB-A: Device is driving DAT0 (e.g., CRC response) – no need in direction change (see 0)  
NSB-B: Host is transmitting DAT0 (e.g., during write data transfer) – need to allow direction change (see Figure 47)  
NSB-C: DAT0 in Tri State – no need in direction change (see Figure 50)

## 6.15.8 Timing changes in HS200 & HS400 mode

### 6.15.8.1 Timing values

Table 61 — describes the differences and additions in timing parameters compared to Table 60 — .

The difference regarding  $N_{ST}$  and  $N_{SB}$  are caused by the phase variation between CLK and DAT that is defined as  $t_{PH}$  (0 - 2 UI) in HS200. The phase variation between CLK and DataStrobe is defined as  $t_{PH\_DATASTROBE}$  (0 - 4 UI) in HS400.

**Table 61 — Timing Parameters for HS200 & HS400 mode**

Parameter	Min.	Max.	Unit
$N_{AC}$	8	-	clock cycles
$N_{CRC}$		(See note.1)	
$N_{ST}$	2	4	clock cycles
$N_{SB-A}$	4	6	
$N_{SB-B}$	4	6	clock cycles
$N_{SB-C}$	2	4	

NOTE 1  $N_{CRC}$  shall be between 2 to 8 clock cycles in HS200 and (2 x tPeriod) to (8 x tPeriod +  $t_{PH\_dataStrobe}$ ) in HS400.

### 6.15.8.2 Read Block Gap

The host may suspend read data transfer from the device by stopping CLK, and resume data transfer by resuming CLK. In HS200 & HS400, the  $t_{PH}$  variation requires that DAT[7:0] will be considered asynchronous to CLK. As a result, it takes a few clock cycles to stop CLK by detecting the end bit of a data block, because synchronization is required.

Therefore, the host shall stop CLK between data blocks rather than within a data block. The minimum gap between two consecutive blocks ( $N_{AC}$ ) is defined as 8, leaving room for the host to stop CLK before the device starts to transfer the next block of data.

Figure 57 describes an example of stopping CLK at the Read Block Gap. In that case  $t_{PH}$  is more than 1UI. Clock position 0 is a trigger point, which outputs the end bit of data block. The device starts to count  $N_{AC}$  based on CLK cycles from clock position 0. The number indicated above CLK is the counter value. The device shall wait until at least clock 9 to output the next data block. Then host needs to stop CLK before clock 9.  $N_{AC}(\min.)=8$  provides enough timing for the host to stop CLK.

NOTE The host is advised to take a special care when command or response is communicated at the time when the host stops the clock in a Read Block Gap. Due to the asynchronism of the lines, stopping the clock while command or response are displayed may result in an uncertain behavior

### 6.15.8.2 Read Block Gap (cont'd)

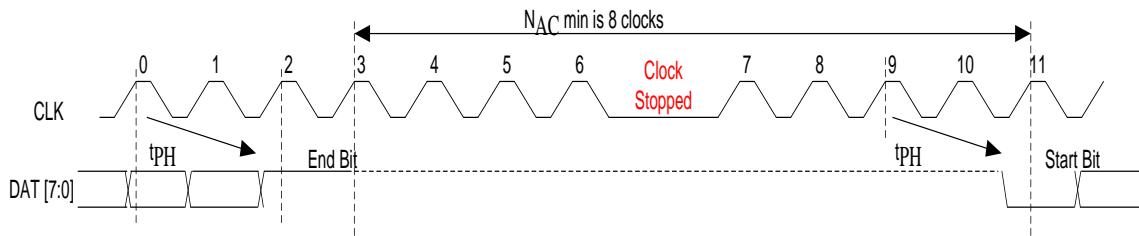


Figure 57 — Clock Stop Timing at Block Gap in Read Operation

#### Implementation Guide:

If the host stops the clock during read data block transfer, it should recognize the number of correctly-transferred data bits, assuming that sampling timing has drifted during the clock suspension.

### 6.15.8.3 CMD12 Timing Modification in Write Operation

In HS200 & HS400 mode, the output delay from the device to the host may vary more than 1 clock cycle. The host needs to take special care about the relations between CMD and Data. This applies specifically to the relations between CMD12 (STOP\_TRANSMISSION) and the Data CRC Status response.

In order to assure that the last data block in a Multiple Block Write operation is written successfully, the host shall not interrupt the data CRC Status response sent by the device. It requires that the host will output the end bit of CMD12 after it has received the end bit of the data CRC response from the device.

In case where the device detects the end bit of CMD12 prior to outputting the end bit of the CRC status response, the last data block is not assured to be written to the non volatile memory of the device.

Figure 58 describes border timing that assures write block is written successfully. Host needs to output the end bit of CMD12 after host receive the end bit of CRC Status.

Adjusting end bit of CMD12 to CRC status requires specific hardware. Alternatively, the host can take a simpler approach, and start issuing CMD12 after receiving the CRC status of the last data block.

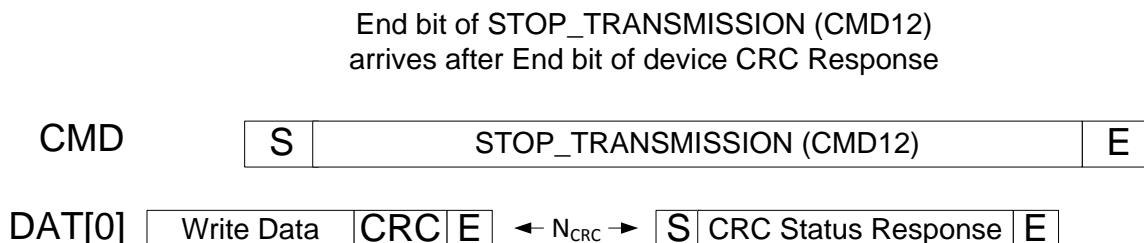


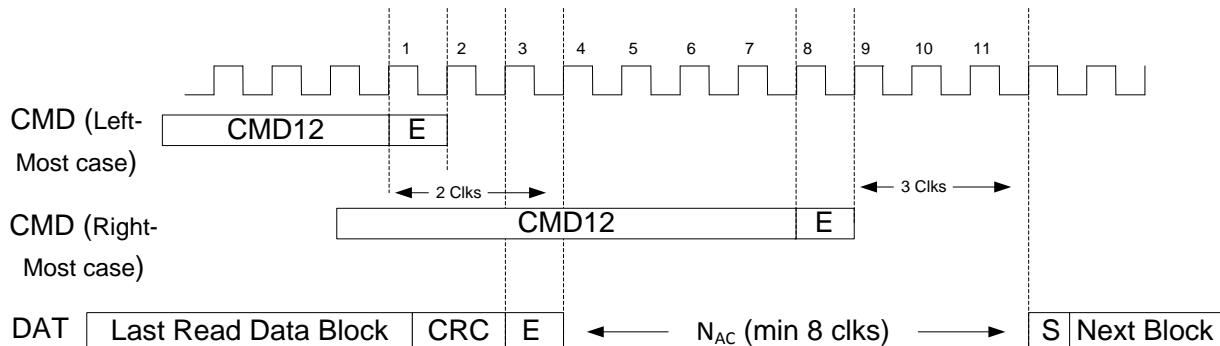
Figure 58 — Border Timing of CMD12 in Write Operation

#### 6.15.8.4 CMD12 Timing Modification in Read Operation

Figure 59 describes CMD12 border timing in read operation. The minimum Read Block Gap length  $N_{AC}$  is 8 clocks. In order to allow the device to output the entire last read data block successfully, the end bit of CMD12 (clock #1 in the figure) shall not arrive earlier than 2 clocks before the end bit of the last data block (clock #3). If CMD12 is issued earlier than this timing, the last read data block may be misinterpreted (for example, end bit of data block is not indicated).

To avoid transferring of the following data block (after the last block the host intends to read), or OUT\_OF\_RANGE error (in case the last block the host reads is near the last logical block of the partition), the end bit of CMD12 shall arrive no later than 3 clocks before the end of  $N_{AC}$  clocks after the end of the last data block read by the host. If the end bit of CMD12 arrives after that clock cycle, the device may start transferring the next data block.

Adjusting end bit of CMD12 to read data block requires specific hardware. Host may take another method to stop multiple-block read operation, for example issue CMD12 after receiving the last data block. By this method, next data block may start to output and aborted by CMD12. The last block read indicates out of range error.



**Figure 59 — Border Timing of CMD12 in Read Operation**

#### 6.15.8.5 R1B Timing

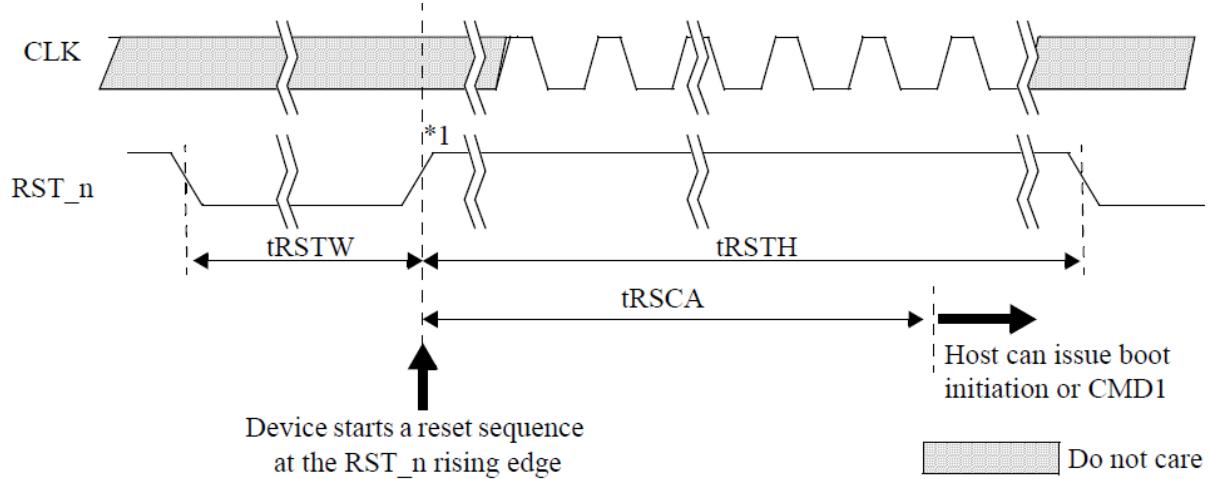
"Busy" signaling (by pulling DAT0 line low) during an R1b command execution adheres to the same bus timing as described in Figure 49. In all legacy modes other than HS200 or HS400 mode, R1b busy indication starts 2 clocks after the end bit of the command. In HS200 & HS400 mode, R1b busy indication starts 2 to 4 clocks after the end bit of the command.

#### 6.15.8.6 Reselecting a Busy Device

When a busy device that is currently in the disconnect state is reselected it will reinstate its busy signaling on DAT0. The bus timing of reselecting a device is the same as described in Figure 49.

In non HS200 or HS400 mode, the selected device starts indicating busy 2 clocks after the end bit of CMD7. In HS200 & HS400 mode, the selected device starts indicating busy 2 to 4 clocks after the end bit of CMD7.

### 6.15.9 H/W Reset Operation



Note1: Device will detect the rising edge of RST<sub>n</sub> signal to trigger internal reset sequence

**Figure 60 — H/W reset waveform**

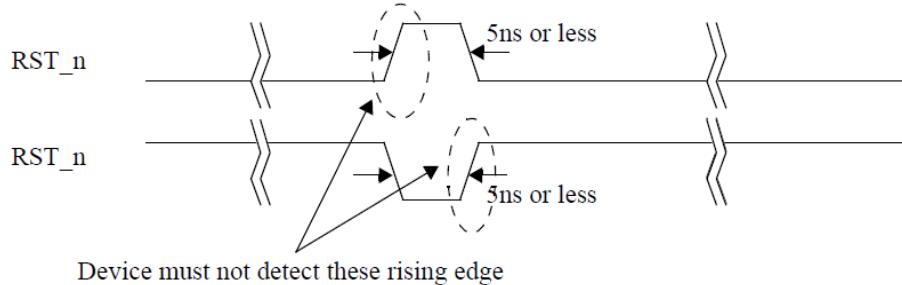
**Table 62 — H/W reset timing parameters**

Symbol	Comment	Min	Max	Unit
tRSTW	RST <sub>n</sub> pulse width	1		[us]
tRSCA	RST <sub>n</sub> to Command time	200 <sup>1</sup>		[us]
tRSTH	RST <sub>n</sub> high period (interval time)	1		[us]

NOTE 1 74 cycles of clock signal required before issuing CMD1 or CMD0 with argument 0xFFFFFFFFFA

### 6.15.10 Noise filtering timing for H/W Reset

Device must filter out 5ns or less pulse width for noise immunity



**Figure 61 — Noise filtering timing for H/W reset**

Device must not detect 5ns or less of positive or negative RST<sub>n</sub> pulse. Device must detect more than or equal to 1us of positive or negative RST<sub>n</sub> pulse width.

### 6.15.11 Additional Timing changes in HS400 mode

#### 6.15.11.1 Write Timing

In HS400 mode, default Start Bit position is valid at rising edge. In addition, the host should not stop CLK during transfer of data within a data block. The Data Strobe is used only in read operation. The Data Strobe is always “High-Z or Low” in write operation.

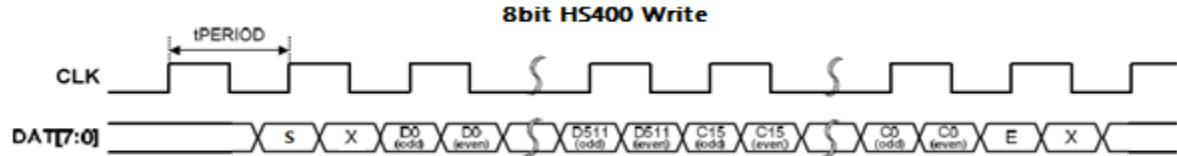


Figure 62 — HS400 Write Timing

#### 6.15.11.2 Read Timing

The Data Strobe is toggled only during data valid period(Start bit, Data, CRC16, End bit, CRC status token). In HS400 mode, Start Bit position is valid at both rising and falling edge. In addition, the host may stop CLK between data blocks rather than within a data block.

Data Strobe shall be driven  $t_{RPRE}$  prior to the first Data Strobe rising edge and  $t_{RPST}$  after the last falling edge.

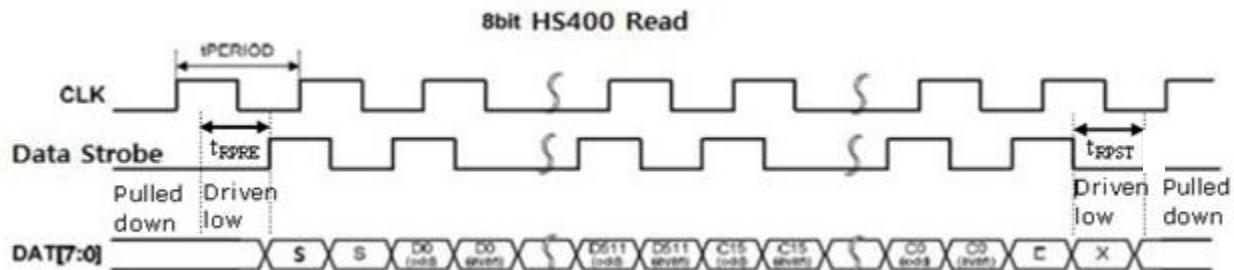


Figure 63 — HS400 Read Timing

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## 7 Device Registers

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Within the Device interface six registers are defined: OCR, CID, CSD, EXT\_CSD, RCA and DSR. These can be accessed only by corresponding commands (see 6.10). The OCR, CID and CSD registers carry the Device/content specific information, while the RCA and DSR registers are configuration registers storing actual configuration parameters. The EXT\_CSD register carries both, Device specific information and actual configuration parameters.

### 7.1 OCR register

The 32-bit operation conditions register (OCR) stores the  $V_{DD}$  voltage profile of the Device and the access mode indication. In addition, this register includes a status information bit. This status bit is set if the Device power up procedure has been finished. The OCR register shall be implemented by all Devices.

**Table 63 — OCR register definitions**

OCR bit	VDD voltage window	High Voltage MultimediaCard	Dual voltage MultimediaCard and e•MMC
[6:0]	Reserved	000 0000b	000 0000b
[7]	1.70 – 1.95V	0b	1b
[14:8]	2.0 – 2.6V	000 0000b	000 0000b
[23:15]	2.7 – 3.6V	1 1111 1111b	1 1111 1111b
[28:24]	Reserved	0 0000b	0 0000b
[30:29]	Access Mode	00b (byte mode) 10b (sector mode)	00b (byte mode) 10b (sector mode)
[31]	(Card power up status bit (busy)) <sup>1</sup>		
This bit is set to LOW if the Device has not finished the power up routine			

The supported voltage range is coded as shown in Table 63 for e•MMC devices. As long as the Device is busy, the corresponding bit (31) is set to LOW, the ‘wired-and’ operation, described in 6.4.4 yields LOW, if at least one Device is still busy.

## 7.2 CID register

The Device IDentification (CID) register is 128 bits wide. It contains the Device identification information used during the Device identification phase (*e*•MMC protocol). Every individual flash or I/O Device shall have an unique identification number. Every type of *e*•MMC Device shall have a unique identification number. Table 64 — lists these identifiers.

The structure of the CID register is defined in the following sections.

**Table 64 — CID Fields**

Name	Field	Width	CID-Slice
Manufacturer ID	MID	8	[127:120]
Reserved		6	[119:114]
Device/BGA	CBX	2	[113:112]
OEM/Application ID	OID	8	[111:104]
Product name	PNM	48	[103:56]
Product revision	PRV	8	[55:48]
Product serial number	PSN	32	[47:16]
Manufacturing date	MDT	8	[15:8]
CRC7 checksum	CRC	7	[7:1]
not used, always "1"	-	1	[0:0]

### 7.2.1 MID [127:120]

MID is an 8 bit binary number that identifies the device manufacturer. The MID number is controlled, defined and allocated to an *e*•MMC manufacturer by the MMCA/JEDEC. This procedure is established to ensure uniqueness of the CID register.

### 7.2.2 CBX [113:112]

CBX indicates the device type.

**Table 65 — Device Types**

[113:112]	Type
00	Device (removable)
01	BGA (Discrete embedded)
10	POP
11	Reserved

### 7.2.3 OID [111:104]

OID is an 8-bit binary number that identifies the Device OEM and/or the Device contents (when used as a distribution media either on ROM or FLASH Devices). The OID number is controlled, defined and allocated to an *e*•MMC manufacturer by the MMCA/JEDEC. This procedure is established to ensure uniqueness of the CID register.

### 7.2.4 PNM [103:56]

The product name, PNM, is a string, 6 ASCII characters long.

### 7.2.5 PRV [55:48]

The product revision, PRV, is composed of two Binary Coded Decimal (BCD) digits, four bits each, representing an “n.m” revision number. The “n” is the most significant nibble and “m” is the least significant nibble. As an example, the PRV binary value field for product revision “6.2” will be: 0110 0010.

### 7.2.6 PSN [47:16]

PSN is a 32-bit unsigned binary integer.

### 7.2.7 MDT [15:8]

The manufacturing date, MDT, is composed of two hexadecimal digits, four bits each, representing a two digits date code m/y; The “m” field, most significant nibble, is the month code. 1 = January. The “y” field, least significant nibble, is the year code. 0 = 1997. As an example, the binary value of the MDT field for production date “April 2000” will be: 0100 0011

For e•MMC 4.41 and later devices, indicated by a value larger than 4 in EXT\_CSD\_REV [192], the 4-bit “y” field shall roll over after 2012, so that y=0 shall be used for 2013. See Table 66 — for a list of valid y values for specific e•MMC versions.

**Table 66 — Valid MDT “y” Field Values**

MDT y Field [11:8]	Year
0000	1997, or 2013 if EXT_CSD_REV [192] > 4
0001	1998, or 2014 if EXT_CSD_REV [192] > 4
0010	1999, or 2015 if EXT_CSD_REV [192] > 4
0011	2000, or 2016 if EXT_CSD_REV [192] > 4
0100	2001, or 2017 if EXT_CSD_REV [192] > 4
0101	2002, or 2018 if EXT_CSD_REV [192] > 4
0110	2003, or 2019 if EXT_CSD_REV [192] > 4
0111	2004, or 2020 if EXT_CSD_REV [192] > 4
1000	2005, or 2021 if EXT_CSD_REV [192] > 4
1001	2006, or 2022 if EXT_CSD_REV [192] > 4
1010	2007, or 2023 if EXT_CSD_REV [192] > 4
1011	2008, or 2024 if EXT_CSD_REV [192] > 4
1100	2009, or 2025 if EXT_CSD_REV [192] > 4
1101	2010 only
1110	2011 only
1111	2012 only

### 7.2.8 CRC [7:1]

The CRC7 checksum (7 bits). This is the checksum of the CID contents computed according to 8.2.

### 7.3 CSD register

The Device-Specific Data (CSD) register provides information on how to access the Device contents. The CSD defines the data format, error correction type, maximum data access time, data transfer speed, whether the DSR register can be used etc. The programmable part of the register (entries marked by W or E, see below) can be changed by CMD27. The type of the CSD Registry entries below is coded as follows:

- R: Read only.
- W: One time programmable and not readable.
- R/W: One time programmable and readable.
- W/E: Multiple writable with value kept after power failure, H/W reset assertion and any CMD0 reset and not readable.
- R/W/E: Multiple writable with value kept after power failure, H/W reset assertion and any CMD0 reset and readable.
- R/W/C\_P: Writable after value cleared by power failure and HW/rest assertion (the value not cleared by CMD0 reset) and readable.
- R/W/E\_P: Multiple writable with value reset after power failure, H/W reset assertion and any CMD0 reset and readable.
- W/E\_P: Multiple writable with value reset after power failure, H/W reset assertion and any CMD0 reset and not readable.

### 7.3CSD Register (cont'd)

**Table 67 — CSD Fields**

Name	Field	Width	Cell Type	CSD-slice
CSD structure	CSD_STRUCTURE	2	R	[127:126]
System specification version	SPEC_VERS	4	R	[125:122]
Reserved	-	2	R	[121:120]
Data read access-time 1	TAAC	8	R	[119:112]
Data read access-time 2 in CLK cycles (NSAC*100)	NSAC	8	R	[111:104]
Max. bus clock frequency	TRAN_SPEED	8	R	[103:96]
Device command classes	CCC	12	R	[95:84]
Max. read data block length	READ_BL_LEN	4	R	[83:80]
Partial blocks for read allowed	READ_BL_PARTIAL	1	R	[79:79]
Write block misalignment	WRITE_BLK_MISALIGN	1	R	[78:78]
Read block misalignment	READ_BLK_MISALIGN	1	R	[77:77]
DSR implemented	DSR_IMP	1	R	[76:76]
Reserved	-	2	R	[75:74]
Device size	C_SIZE	12	R	[73:62]
Max. read current @ VDD min	VDD_R_CURR_MIN	3	R	[61:59]
Max. read current @ VDD max	VDD_R_CURR_MAX	3	R	[58:56]
Max. write current @ VDD min	VDD_W_CURR_MIN	3	R	[55:53]
Max. write current @ VDD max	VDD_W_CURR_MAX	3	R	[52:50]
Device size multiplier	C_SIZE_MULT	3	R	[49:47]
Erase group size	ERASE_GRP_SIZE	5	R	[46:42]
Erase group size multiplier	ERASE_GRP_MULT	5	R	[41:37]
Write protect group size	WP_GRP_SIZE	5	R	[36:32]
Write protect group enable	WP_GRP_ENABLE	1	R	[31:31]
Manufacturer default ECC	DEFAULT_ECC	2	R	[30:29]
Write speed factor	R2W_FACTOR	3	R	[28:26]
Max. write data block length	WRITE_BL_LEN	4	R	[25:22]
Partial blocks for write allowed	WRITE_BL_PARTIAL	1	R	[21:21]
Reserved	-	4	R	[20:17]
Content protection application	CONTENT_PROT_APP	1	R	[16:16]
File format group	FILE_FORMAT_GRP	1	R/W	[15:15]
Copy flag (OTP)	COPY	1	R/W	[14:14]
Permanent write protection	PERM_WRITE_PROTECT	1	R/W	[13:13]
Temporary write protection	TMP_WRITE_PROTECT	1	R/W/E	[12:12]
File format	FILE_FORMAT	2	R/W	[11:10]
ECC code	ECC	2	R/W/E	[9:8]
CRC	CRC	7	R/W/E	[7:1]
Not used, always'1'	-	1	—	[0:0]

The following sections describe the CSD fields and the relevant data types. If not explicitly defined otherwise, all bit strings are interpreted as binary coded numbers starting with the left bit first.

### 7.3.1 CSD\_STRUCTURE [127:126]

CSD\_STRUCTURE describes the version of the CSD structure.

**Table 68 — CSD register structure**

CSD_STRUCTURE	CSD Structure version	Valid for System Specification Version
0	CSD version No. 1.0	Allocated by MMCA
1	CSD version No. 1.1	Allocated by MMCA
2	CSD version No. 1.2	Version 4.1–4.2–4.3–4.41–4.5–4.51–5.0
3	Version is coded in the CSD_STRUCTURE byte in the EXT_CSD register	

### 7.3.2 SPEC\_VERS [125:122]

SPEC\_VERS defines the *e*MMC System Specification version supported by the Device.

**Table 69 — System specification version**

SPEC_VERS	System Specification Version
0	Allocated by MMCA
1	Allocated by MMCA
2	Allocated by MMCA
3	Allocated by MMCA
4	Version 4.1–4.2–4.3–4.4–4.41–4.5–4.51–5.0
5–15	Reserved

### 7.3.3 TAAC [119:112]

TAAC defines the asynchronous part of the data access time.

**Table 70 — TAAC access-time definition**

TAAC bit position	Code
2:0	Time unit 0 = 1ns, 1 = 10ns, 2 = 100ns, 3 = 1μs, 4 = 10μs, 5 = 100μs, 6 = 1ms, 7 = 10ms
6:3	Multiplier factor 0 = reserved, 1 = 1.0, 2 = 1.2, 3 = 1.3, 4 = 1.5, 5 = 2.0, 6 = 2.5, 7 = 3.0, 8 = 3.5, 9 = 4.0, A = 4.5, B = 5.0, C = 5.5, D = 6.0, E = 7.0, F = 8.0
7	Reserved

### 7.3.4 NSAC [111:104]

NSAC defines the typical case for the clock dependent factor of the data access time. The unit for NSAC is 100 clock cycles. Therefore, the maximal value for the clock dependent part of the data access time is 25.5k clock cycles.

The total access time  $N_{AC}$  as expressed in Table 60 — is calculated based on TAAC and NSAC. It has to be computed by the host for the actual clock rate. The read access time should be interpreted as a typical delay for the first data bit of a data block or stream.

### 7.3.5 TRAN\_SPEED [103:96]

The following table defines the clock frequency when not in high speed mode. For Devices supporting version 4.0, 4.1, and 4.2 of the standard, the value shall be 20MHz (0x2A). For Devices supporting version 4.3, the value shall be 26 MHz (0x32).

**Table 71 — Maximum bus clock frequency definition**

TRAN_SPEED bit	Code
2:0	Frequency unit 0 = 100KHz, 1 = 1MHz, 2 = 10MHz, 3 = 100MHz, 4...7 = reserved
6:3	Multiplier factor 0 = reserved, 1 = 1.0, 2 = 1.2, 3 = 1.3, 4 = 1.5, 5 = 2.0, 6 = 2.6, 7 = 3.0, 8 = 3.5, 9 = 4.0, A = 4.5, B = 5.2, C = 5.5, D = 6.0, E = 7.0, F = 8.0
7	reserved

### 7.3.6 CCC [95:84]

The *e*•MMC command set is divided into subsets (command classes). The Device command class register CCC defines which command classes are supported by this Device. A value of ‘1’ in a CCC bit means that the corresponding command class is supported. For command class definition refer to Table 72 — .

**Table 72 — Supported Device command classes**

CCC Bit	Supported Device Command Class
0	class 0
1	class 1
...	
11	class 11

### 7.3.7 READ\_BL\_LEN [83:80]

The data block length is computed as  $2^{\text{READ\_BL\_LEN}}$ . The block length might therefore be in the range 1B, 2B, 4B...16kB. (See 6.13 for details.) Note that the support for 512B read access is mandatory for all Devices. And that the Devices has to be in 512B block length mode by default after power-on, or software reset. The purpose of this register is to indicate the supported maximum read data block length:

**Table 73 — Data block length**

READ_BL_LEN	Block length	Remark
0	$2^0 = 1 \text{ Byte}$	
1	$2^1 = 2 \text{ Bytes}$	
...		
11	$2^{11} = 2048 \text{ Bytes}$	
12	$2^{12} = 4096 \text{ Bytes}$	
13	$2^{13} = 8192 \text{ Bytes}$	
14	$2^{14} = 16 \text{ kBytes}$	
15	$2^{15} = \text{Extension}$	New register TBD to EXT_CSD

### 7.3.8 READ\_BL\_PARTIAL [79]

READ\_BL\_PARTIAL defines whether partial block sizes can be used in block read commands.

Up to 2GB of density (byte access mode):

READ\_BL\_PARTIAL=0 means that only the 512B and the READ\_BL\_LEN block size can be used for block oriented data transfers.

READ\_BL\_PARTIAL=1 means that smaller blocks can be used as well. The minimum block size will be equal to minimum addressable unit (one byte).

Higher than 2GB of density (sector access mode):

READ\_BL\_PARTIAL=0 means that only the 512B and the READ\_BL\_LEN block sizes can be used for block oriented data transfers.

READ\_BL\_PARTIAL=1 means that smaller blocks than indicated in READ\_BL\_LEN can be used as well. The minimum block size will be equal to minimum addressable unit, one sector (512B).

- WRITE\_BLK\_MISALIGN [78]

Defines if the data block to be written by one command can be spread over more than one physical block of the memory device. The size of the memory block is defined in WRITE\_BL\_LEN.

WRITE\_BLK\_MISALIGN=0 signals that crossing physical block boundaries is invalid.

WRITE\_BLK\_MISALIGN=1 signals that crossing physical block boundaries is allowed.

- READ\_BLK\_MISALIGN [77]

Defines if the data block to be read by one command can be spread over more than one physical block of the memory device. The size of the memory block is defined in READ\_BL\_LEN.

READ\_BLK\_MISALIGN=0 signals that crossing physical block boundaries is invalid.

READ\_BLK\_MISALIGN=1 signals that crossing physical block boundaries is allowed.

### 7.3.9 DSR\_IMP [76]

DSR\_IMP defines if the configurable driver stage is integrated on the Device. If set, a driver stage register (DSR) must be implemented also. (See 7.6.)

**Table 74 — DSR implementation code table**

CCC Bit	Supported Device Command Class
0	DSR is not implemented
1	DSR is implemented

### 7.3.10 C\_SIZE [73:62]

The C\_SIZE parameter is used to compute the device capacity for devices up to 2GB of density. See 7.4.48, SEC\_COUNT [215:212], for details on calculating densities greater than 2GB. When the device density is greater than 2GB, the maximum possible value should be set to this register (0xFFFF). This parameter is used to compute the device capacity.

The memory capacity of the device is computed from the entries C\_SIZE, C\_SIZE\_MULT and READ\_BL\_LEN as follows:

$$\text{Memory capacity} = \text{BLOCKNR} * \text{BLOCK\_LEN} \text{ where } \text{BLOCKNR} = (\text{C\_SIZE}+1) * \text{MULT}$$

$$\text{MULT} = 2^{\text{C\_SIZE\_MULT}+2} \quad (\text{C\_SIZE\_MULT} < 8)$$

$$\text{BLOCK\_LEN} = 2^{\text{READ\_BL\_LEN}}, \quad (\text{READ\_BL\_LEN} < 12)$$

Therefore, the maximal capacity which can be coded is  $4096*512*2048 = 4$  GBytes.

Example: A 4 MByte device with BLOCK\_LEN = 512 can be coded by C\_SIZE\_MULT = 0 and C\_SIZE = 2047. When the partition configuration is executed by host, device will re-calculate the C\_SIZE value which can indicate the size of user data area after the partition.

### 7.3.11 VDD\_R\_CURR\_MIN [61:59] and VDD\_W\_CURR\_MIN [55:53]

The maximum values for read and write currents at the minimal power supply  $V_{DD}$  are coded as follows:

**Table 75 —  $V_{DD}$  (min) current consumption**

<b>VDD_R_CURR_MIN</b>	<b>Code for current consumption @ <math>V_{DD}</math></b>
<b>VDD_W_CURR_MIN</b>	
2:0	0 = 0.5mA; 1 = 1mA; 2 = 5mA; 3 = 10mA; 4 = 25mA; 5 = 35mA; 6 = 60mA; 7 = 100mA

The values in these fields are valid when the Device is not in high speed modes. When the Device is in one of the high speed modes, the current consumption is chosen by the host, from the power classes defined in the PWR\_ff\_vvv registers, in the EXT\_CSD register.

### 7.3.12 VDD\_R\_CURR\_MAX [58:56] and VDD\_W\_CURR\_MAX [52:50]

The maximum values for read and write currents at the maximal power supply  $V_{DD}$  are coded as follows:

**Table 76 —  $V_{DD}$  (max) current consumption**

<b>VDD_R_CURR_MAX</b>	<b>Code for current consumption @ <math>V_{DD}</math></b>
<b>VDD_W_CURR_MAX</b>	
2:0	0 = 1mA; 1 = 5mA; 2 = 10mA; 3 = 25mA; 4 = 35mA; 5 = 45mA; 6 = 80mA; 7 = 200mA

The values in these fields are valid when the Device is not in high speed mode. When the Device is in high speed mode, the current consumption is chosen by the host, from the power classes defined in the PWR\_ff\_vvv registers, in the EXT\_CSD register.

### 7.3.13 C\_SIZE\_MULT [49:47]

This parameter is used for coding a factor MULT for computing the total device size (see ‘C\_SIZE’). The factor MULT is defined as  $2^{\text{C\_SIZE\_MULT}+2}$ .

If the density of the device is higher than 2GB, the maximum possible value should be set to this register (i.e., 0x7).

**Table 77 — Multiplier factor for device size**

C_SIZE_MULT	MULT	Remarks
0	$2^2 = 4$	
1	$2^3 = 8$	
2	$2^4 = 16$	
3	$2^5 = 32$	
4	$2^6 = 64$	
5	$2^7 = 128$	
6	$2^8 = 256$	
7	$2^9 = 512$	

### 7.3.14 ERASE\_GRP\_SIZE [46:42]

The content of this register is a 5 bit binary coded value, used to calculate the size of the erasable unit of the Device. The size of the erase unit (also referred to as erase group) is determined by the ERASE\_GRP\_SIZE and the ERASE\_GRP\_MULT entries of the CSD, using the following equation: size of erasable unit = (ERASE\_GRP\_SIZE + 1) \* (ERASE\_GRP\_MULT + 1) This size is given as minimum number of write blocks that can be erased in a single erase command.

### 7.3.15 ERASE\_GRP\_MULT [41:37]

ERASE\_GRP\_MULT is a 5 bit binary coded value used for calculating the size of the erasable unit of the Device. See ERASE\_GRP\_SIZE section for detailed description.

### 7.3.16 WP\_GRP\_SIZE [36:32]

WR\_GRP\_SIZE is the minimum size of a write protected region. The content of this register is a 5 bit binary coded value, defining the number of erase groups which can be write protected. The actual size is computed by increasing this number by one. A value of zero means 1 erase group, 31 means 32 erase groups.

### 7.3.17 WP\_GRP\_ENABLE [31]

WP\_GRP\_ENABLE indicates whether write protection of regions is possible. A value of ‘0’ means no group write protection possible.

### 7.3.18 DEFAULT\_ECC [30:29]

DEFAULT\_ECC is set by the Device manufacturer. It defines the ECC code which is recommended for use. The field definition is the same as for the ECC field described later.

### 7.3.19 R2W\_FACTOR [28:26]

R2W\_FACTOR defines the typical block program time as a multiple of the read access time. Table 78 defines the field format.

**Table 78 — R2W\_FACTOR**

R2W_FACTOR	Multiples of read access time
0	1
1	2 (write half as fast as read)
2	4
3	8
4	16
5	32
6	64
7	128

### 7.3.20 WRITE\_BL\_LEN [25:22]

WRITE\_BL\_LEN defines the block length for write operations. See READ\_BL\_LEN for field coding. Support for 512B write access is mandatory for all devices and the device must be in 512B block length mode by default after power-on, or software reset. The purpose of this register is to indicate the supported maximum write data block length.

### 7.3.21 WRITE\_BL\_PARTIAL[21]

WRITE\_BL\_PARTIAL defines whether partial block sizes can be used in block write commands.

Up to 2GB of density (byte access mode):

WRITE\_BL\_PARTIAL='0' means that only the 512B and the WRITE\_BL\_LEN block size can be used for block oriented data write.

WRITE\_BL\_PARTIAL='1' means that smaller blocks can be used as well. The minimum block size is one byte.

Higher than 2GB of density (sector access mode):

WRITE\_BL\_PARTIAL='0' means that only the 512B and the WRITE\_BL\_LEN block size can be used for block oriented data write.

WRITE\_BL\_PARTIAL='1' means that smaller blocks can be used as well. The minimum block size will be equal to minimum addressable unit, one sector (512B).

### 7.3.22 CONTENT\_PROT\_APP [16]

This field in the CSD indicates whether the content protection application is supported. e•MMC devices which implement the content protection application will have this bit set to '1';

### 7.3.23 FILE\_FORMAT\_GRP [15]

FILE\_FORMAT\_GRP indicates the selected group of file formats. This field is read-only for ROM. The usage of this field is shown in Table 79 — . (See FILE\_FORMAT)

### 7.3.24 COPY [14]

COPY defines if the contents is original (= '0') or has been copied (= '1'). The COPY bit for OTP and MTP devices, sold to end consumers, is set to '1' which identifies the device contents as a copy. The COPY bit is a one time programmable bit.

### 7.3.25 PERM\_WRITE\_PROTECT [13]

This register permanently protects the whole device (boot, RPMB and all user area partitions) content against overwriting or erasing (all data write and erase commands for the device are permanently disabled). The default value is ‘0’, i.e., not permanently write protected.

Setting permanent write protection for the entire Device will take precedence over any other write protection mechanism currently enabled on the Device. The ability to permanently protect the Device by setting PERM\_WRITE\_PROTECT(CSD[13]) can be disabled by setting CD\_PERM\_WP\_DIS (EXT\_CSD[171] bit 6). If CD\_PERM\_WP\_DIS is set and the master attempts to set PERM\_WRITE\_PROTECT(CSD[13]) the operation will fail and the ERROR (bit 19) error bit will be set in the status register.

### 7.3.26 TMP\_WRITE\_PROTECT [12]

Temporarily protects the whole Device content from being overwritten or erased (all write and erase commands for this Device are temporarily disabled). This bit can be set and reset. The default value is ‘0’, i.e., not write protected.

Temporary write protection only applies to the write protection groups on the Device where another write protection mechanism (Password, Permanent or Power-On) has not already been enabled.

### 7.3.27 FILE\_FORMAT [11:10]

FILE\_FORMAT indicates the file format on the Device. This field is read-only for ROM. The following formats are defined:

**Table 79 — File formats**

FILE_FORMAT_GRP	FILE_FORMAT	Remarks
0	0	Hard disk-like file system with partition table
0	1	DOS FAT (floppy-like) with boot sector only (no partition table)
0	2	Universal File Format
0	3	Others / Unknown
1	0, 1, 2, 3	Reserved

### 7.3.28 ECC [9:8]

ECC defines the ECC code that was used for storing data on the Device. This field is used by the host (or application) to decode the user data. The following table defines the field format.

**Table 80 — ECC type**

ECC	type	Maximum number of correctable bits per block
0	None (default)	none
1	BCH (542, 512)	3
2-3	reserved	—

### 7.3.29 CRC [7:1]

The CRC field carries the check sum for the CSD contents. It is computed according to 8.2. The checksum has to be recalculated by the host for any CSD modification. The default corresponds to the initial CSD contents. The following table lists the correspondence between the CSD entries and the command classes. A '+' entry indicates that the CSD field affects the commands of the related command class.

**Table 81 — CSD field command classes**

#### 7.4 Extended CSD register

The Extended CSD register defines the Device properties and selected modes. It is 512 bytes long. The most significant 320 bytes are the Properties segment, which defines the Device capabilities and cannot be modified by the host. The lower 192 bytes are the Modes segment, which defines the configuration the Device is working in. These modes can be changed by the host by means of the SWITCH command

- R: Read only.
  - W: One time programmable and not readable.
  - R/W: One time programmable and readable.
  - W/E: Multiple writable with value kept after power failure, H/W reset assertion and any CMD0 reset and not readable.
  - R/W/E: Multiple writable with value kept after power failure, H/W reset assertion and any CMD0 reset and readable.
- 
- R/W/C\_P: Writable after value cleared by power failure and HW/rest assertion (the value not cleared by CMD0 reset) and readable.
  - R/W/E\_P: Multiple writable with value reset after power failure, H/W reset assertion and any CMD0 reset and readable.
  - W/E\_P: Multiple writable with value reset after power failure, H/W reset assertion and any CMD0 reset and not readable.

#### 7.4 Extended CSD register (cont'd)

**Table 82 — Extended CSD**

Name	Field	Size (Bytes)	Cell Type	CSD-slice
<b>Properties Segment</b>				
Reserved <sup>1</sup>		6	TBD	[511:506]
Extended Security Commands Error	EXT_SECURITY_ERR	1	R	[505]
Supported Command Sets	S_CMD_SET	1	R	[504]
HPI features	HPI_FEATURES	1	R	[503]
Background operations support	BKOPS_SUPPORT	1	R	[502]
Max packed read commands	MAX_PACKED_READS	1	R	[501]
Max packed write commands	MAX_PACKED_WRITES	1	R	[500]
Data Tag Support	DATA_TAG_SUPPORT	1	R	[499]
Tag Unit Size	TAG_UNIT_SIZE	1	R	[498]
Tag Resources Size	TAG_RES_SIZE	1	R	[497]
Context management capabilities	CONTEXT_CAPABILITIES	1	R	[496]
Large Unit size	LARGE_UNIT_SIZE_M1	1	R	[495]
Extended partitions attribute support	EXT_SUPPORT	1	R	[494]
Supported modes	SUPPORTED_MODES	1	R	[493]
FFU features	FFU_FEATURES	1	R	[492]
Operation codes timeout	OPERATION_CODE_TIME_OUT	1	R	[491]
FFU Argument	FFU_ARG	4	R	[490:487]
Reserved <sup>1</sup>		181	TBD	[486:306]
Number of FW sectors correctly programmed	NUMBER_OF_FW_SECTORS_CORRECTLY_PROGRAMMED	4	R	[305:302]
Vendor proprietary health report	VENDOR_PROPRIETARY_HEALTH_REPORT	32	R	[301:270]
Device life time estimation type B	DEVICE_LIFE_TIME_EST_TYP_B	1	R	[269]
Device life time estimation type A	DEVICE_LIFE_TIME_EST_TYP_A	1	R	[268]
Pre EOL information	PRE_EOL_INFO	1	R	[267]
Optimal read size	OPTIMAL_READ_SIZE	1	R	[266]
Optimal write size	OPTIMAL_WRITE_SIZE	1	R	[265]
Optimal trim unit size	OPTIMAL_TRIM_UNIT_SIZE	1	R	[264]
Device version	DEVICE_VERSION	2	R	[263:262]
Firmware version	FIRMWARE_VERSION	8	R	[261:254]
Power class for 200MHz, DDR at VCC=3.6V	PWR_CL_DDR_200_360	1	R	[253]
Cache size	CACHE_SIZE	4	R	[252:249]
Generic CMD6 timeout	GENERIC_CMD6_TIME	1	R	[248]
Power off notification(long) timeout	POWER_OFF_LONG_TIME	1	R	[247]
Background operations status	BKOPS_STATUS	1	R	[246]
Number of correctly programmed sectors	CORRECTLY_PRG_SECTORS_NUM	4	R	[245:242]
1st initialization time after partitioning	INI_TIMEOUT_AP	1	R	[241]

Name	Field	Size (Bytes)	Cell Type	CSD-slice
Reserved <sup>1</sup>		1	TBD	[240]
Power class for 52MHz, DDR at V <sub>CC</sub> = 3.6V	PWR_CL_DDR_52_360	1	R	[239]
Power class for 52MHz, DDR at V <sub>CC</sub> = 1.95V	PWR_CL_DDR_52_195	1	R	[238]
Power class for 200MHz at V <sub>CCQ</sub> = 1.95V, V <sub>CC</sub> = 3.6V	PWR_CL_200_195	1	R	[237]
Power class for 200MHz, at V <sub>CCQ</sub> = 1.3V, V <sub>CC</sub> = 3.6V	PWR_CL_200_130	1	R	[236]
Minimum Write Performance for 8bit at 52MHz in DDR mode	MIN_PERF_DDR_W_8_52	1	R	[235]
Minimum Read Performance for 8bit at 52MHz in DDR mode	MIN_PERF_DDR_R_8_52	1	R	[234]
Reserved <sup>1</sup>		1	TBD	[233]
TRIM Multiplier	TRIM_MULT	1	R	[232]
Secure Feature support	SEC_FEATURE_SUPPORT	1	R	[231]
Secure Erase Multiplier	SEC_ERASE_MULT	1	R	[230]
Secure TRIM Multiplier	SEC_TRIM_MULT	1	R	[229]
Boot information	BOOT_INFO	1	R	[228]
Reserved <sup>1</sup>		1	TBD	[227]
Boot partition size	BOOT_SIZE_MULTI	1	R	[226]
Access size	ACC_SIZE	1	R	[225]
High-capacity erase unit size	HC_ERASE_GRP_SIZE	1	R	[224]
High-capacity erase timeout	ERASE_TIMEOUT_MULT	1	R	[223]
Reliable write sector count	REL_WR_SEC_C	1	R	[222]
High-capacity write protect group size	HC_WP_GRP_SIZE	1	R	[221]
Sleep current (VCC)	S_C_VCC	1	R	[220]
Sleep current (VCCQ)	S_C_VCCQ	1	R	[219]
Production state awareness timeout	PRODUCTION_STATE_AWARENESS_TIMEOUT	1	R	[218]
Sleep/awake timeout	S_A_TIMEOUT	1	R	[217]
Sleep Notification Timeout <sup>1</sup>	SLEEP_NOTIFICATION_TIMER	1	R	[216]
Sector Count	SEC_COUNT	4	R	[215:212]
Reserved <sup>1</sup>		1	TBD	[211]
Minimum Write Performance for 8bit at 52MHz	MIN_PERF_W_8_52	1	R	[210]
Minimum Read Performance for 8bit at 52MHz	MIN_PERF_R_8_52	1	R	[209]
Minimum Write Performance for 8bit at 26MHz, for 4bit at 52MHz	MIN_PERF_W_8_26_4_52	1	R	[208]
Minimum Read Performance for 8bit at 26MHz, for 4bit at 52MHz	MIN_PERF_R_8_26_4_52	1	R	[207]
Minimum Write Performance for 4bit at 26MHz	MIN_PERF_W_4_26	1	R	[206]
Minimum Read Performance for 4bit at 26MHz	MIN_PERF_R_4_26	1	R	[205]

Name	Field	Size (Bytes)	Cell Type	CSD-slice
Reserved <sup>1</sup>		1	R	[204]
Power class for 26MHz at 3.6V 1 R	PWR_CL_26_360	1	R	[203]
Power class for 52MHz at 3.6V 1 R	PWR_CL_52_360	1	R	[202]
Power class for 26MHz at 1.95V 1 R	PWR_CL_26_195	1	R	[201]
Power class for 52MHz at 1.95V 1 R	PWR_CL_52_195	1	R	[200]
Partition switching timing	PARTITION_SWITCH_TIME	1	R	[199]
Out-of-interrupt busy timing	OUT_OF_INTERRUPT_TIMING	1	R	[198]
I/O Driver Strength	DRIVER_STRENGTH	1	R	[197]
Device type	DEVICE_TYPE		R	[196]
Reserved <sup>1</sup>		1	TBD	[195]
CSD STRUCTURE	CSD_STRUCTURE	1	R	[194]
Reserved <sup>1</sup>		1	TBD	[193]
Extended CSD revision	EXT_CSD_REV	1	R	[192]
<b>Modes Segment</b>				
Command set	CMD_SET	1	R/W/E_P	[191]
Reserved <sup>1</sup>		1	TBD	[190]
Command set revision	CMD_SET_REV	1	R	[189]
Reserved <sup>1</sup>		1	TBD	[188]
Power class	POWER_CLASS	1	R/W/E_P	[187]
Reserved <sup>1</sup>		1	TBD	[186]
High-speed interface timing	HS_TIMING	1	R/W/E_P	[185]
Reserved <sup>1</sup>		1	TBD	[184]
Bus width mode	BUS_WIDTH	1	W/E_P	[183]
Reserved <sup>1</sup>		1	TBD	[182]
Erased memory content	ERASED_MEM_CONT	1	R	[181]
Reserved <sup>1</sup>		1	TBD	[180]
Partition configuration	PARTITION_CONFIG	1	R/W/E & R/W/E_P	[179]
Boot config protection	BOOT_CONFIG_PROT	1	R/W & R/W/C_P	[178]
Boot bus Conditions	BOOT_BUS_CONDITIONS	1	R/W/E	[177]
Reserved <sup>1</sup>		1	TBD	[176]
High-density erase group definition	ERASE_GROUP_DEF	1	R/W/E_P	[175]
Boot write protection status registers	BOOT_WP_STATUS	1	R	[174]
Boot area write protection register	BOOT_WP	1	R/W & R/W/C_P	[173]
Reserved <sup>1</sup>		1	TBD	[172]
User area write protection register	USER_WP	1	R/W, R/W/C_P & R/W/E_P	[171]
Reserved <sup>1</sup>		1	TBD	[170]
FW configuration	FW_CONFIG	1	R/W	[169]
RPMB Size	RPMB_SIZE_MULT		R	[168]
Write reliability setting register	WR_REL_SET		R/W	[167]
Write reliability parameter register	WR_REL_PARAM		R	[166]
Start Sanitize operation	SANITIZE_START	1	W/E_P	[165]

Name	Field	Size (Bytes)	Cell Type	CSD-slice
Manually start background operations	BKOPS_START	1	W/E_P	[164]
Enable background operations handshake	BKOPS_EN		R/W	[163]
H/W reset function	RST_n_FUNCTION	1	R/W	[162]
HPI management	HPI_MGMT	1	R/W/E_P	[161]
Partitioning Support	PARTITIONING_SUPPORT	1	R	[160]
Max Enhanced Area Size	MAX_ENH_SIZE_MULT	3	R	[159:157]
Partitions attribute	PARTITIONS_ATTRIBUTE	1	R/W	[156]
Partitioning Setting	PARTITION_SETTING_COMPLETED	1	R/W	[155]
General Purpose Partition Size	GP_SIZE_MULT	12	R/W	[154:143]
Enhanced User Data Area Size	ENH_SIZE_MULT	3	R/W	[142:140]
Enhanced User Data Start Address	ENH_START_ADDR	4	R/W	[139:136]
Reserved <sup>1</sup>		1	TBD	[135]
Bad Block Management mode	SEC_BAD_BLK_MGMT	1	R/W	[134]
Production state awareness	PRODUCTION_STATE_AWARENESS	1	R/W/E	[133]
Package Case Temperature is controlled	TCASE_SUPPORT	1	W/E_P	[132]
Periodic Wake-up	PERIODIC_WAKEUP	1	R/W/E	[131]
Program CID/CSD in DDR mode support	PROGRAM_CID_CSD_DD_R_SUPPORT	1	R	[130]
Reserved <sup>1</sup>		2	TBD	[129:128]
Vendor Specific Fields	VENDOR_SPECIFIC_FIELD	64	<vendor specific>	[127:64]
Native sector size	NATIVE_SECTOR_SIZE	1	R	[63]
Sector size emulation	USE_NATIVE_SECTOR	1	R/W	[62]
Sector size	DATA_SECTOR_SIZE	1	R	[61]
1st initialization after disabling sector size emulation	INI_TIMEOUT_EMU	1	R	[60]
Class 6 commands control	CLASS_6_CTRL	1	R/W/E_P	[59]
Number of addressed group to be Released	DYNCAP_NEEDED	1	R	[58]
Exception events control	EXCEPTION_EVENTS_CTRL	2	R/W/E_P	[57:56]
Exception events status	EXCEPTION_EVENTS_STATUS	2	R	[55:54]
Extended Partitions Attribute	EXT_PARTITIONS_ATTRIBUTE	2	R/W	[53:52]
Context configuration	CONTEXT_CONF	15	R/W/E_P	[51:37]
Packed command status	PACKED_COMMAND_STATUS	1	R	[36]
Packed command failure index	PACKED_FAILURE_INDEX	1	R	[35]
Power Off Notification	POWER_OFF_NOTIFICATION	1	R/W/E_P	[34]
Control to turn the Cache ON/OFF	CACHE_CTRL	1	R/W/E_P	[33]
Flushing of the cache	FLUSH_CACHE	1	W/E_P	[32]

Name	Field	Size (Bytes)	Cell Type	CSD-slice
Reserved <sup>1</sup>		1	TBD	[31]
Mode config	MODE_CONFIG	1	R/W/E_P	[30]
Mode operation codes	MODE_OPERATION_CODES	1	W/E_P	[29]
Reserved <sup>1</sup>		1	TBD	[28:27]
FFU status	FFU_STATUS	1	R	[26]
Pre loading data size	PRE_LOADING_DATA_SIZE	4	R/W/E_P	[25:22]
Max pre loading data size	MAX_PRE_LOADING_DATA_SIZE	4	R	[21:18]
Product state awareness enablement	PRODUCT_STATE_AWARENESS_ENABLEMENT	1	R/W/E & R	[17]
Secure Removal Type	SECURE_REMOVAL_TYPE	1	R/W & R	[16]
Reserved <sup>1</sup>		16	TBD	[15:0]
NOTE 1 Reserved bits should read as "0."				
NOTE 2 Obsolete values should be don't care.				

#### 7.4.1 EXT\_SECURITY\_ERR [505]

This field is a read only field through which the device indicates to the host the extended security error which occurred in relation to the Extended Security Protocol usage (this byte should be read in case that Bit4, EXTENDED\_SECURITY\_FAILURE, of the EXCEPTION\_EVENTS\_STATUS field in the EXT\_CSD is set). The error bits are cleared by the given clear condition.

**Table 83 — EXT\_SECURITY\_ERR byte description**

Bit #	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name	Reserved				ACCESS_DENIED (3)	SEC_INVALID_COMMAND_PARAMETERS		
Cler Cond.					(2)	(1)		

- (1) Cleared by next valid PROTOCOL\_RD/WR command acceptance
- (2) Cleared by next valid WR/RD command acceptance
- (3) ACCESS\_DENIED error indication that the host attempts to access an area without the proper access rights, using a regular RD/WR command

#### 7.4.2 S\_CMD\_SET [504]

This field defines the command sets supported by the Device.

**Table 84 — Device-supported command sets**

Bit	Command Set
7-5	Reserved
4	Allocated by MMCA
3	Allocated by MMCA
2	Allocated by MMCA
1	Allocated by MMCA
0	Standard MMC

### 7.4.3 HPI\_FEATURES [503]

This field indicates if the HPI feature is supported and which implementation is used by the device.

**Table 85 — HPI features**

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
						HPI_IMPLEMENTATION	HPI_SUPPORT

Bit[7:2]: Reserved

Bit[1]: HPI\_IMPLEMENTATION

0x0 : HPI mechanism implementation based on CMD13

0x1 : HPI mechanism implementation based on CMD12

Bit[0]: HPI\_SUPPORT

0x0 : Obsolete

0x1 : HPI mechanism supported (default)

### 7.4.4 BKOPS\_SUPPORT [502]

This field indicates if the background operations feature is supported by the device.

**Table 86 — Background operations support**

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
							SUPPORTED

Bit[7:1]: Reserved

Bit[0]: SUPPORTED

0x0 : Obsolete

0x1 : Background operations are supported. The fields BKOPS\_STATUS, BKOPS\_EN, BKOPS\_START and URGENT\_BKOPS are supported. (default)

### 7.4.5 MAX\_PACKED\_READS [501]

This field describes the maximum number of commands that can be packed inside a packed read command. The mandatory minimum value for this field is 5 (MAX\_PACKED\_READS shall be 5 or higher)

### 7.4.6 MAX\_PACKED\_WRITES [500]

This field describes the maximum number of commands that can be packed inside a packed write command. The mandatory minimum value for this field is 3 (MAX\_PACKED\_WRITES shall be 3 or higher)

### 7.4.7 DATA\_TAG\_SUPPORT [499]

This field indicates if the Data Tag mechanism features are supported.

Bit[7-1]: Reserved

Bit[0]: SYSTEM\_DATA\_TAG\_SUPPORT

0x0 : System Data Tag mechanism not supported (default)

0x1 : System Data Tag mechanism supported

#### 7.4.8 TAG\_UNIT\_SIZE [498]

This field is used by the host to calculate the size of a Tag Unit in Bytes.

$$\text{Tag Unit Size} = 2^{\text{TAG\_UNIT\_SIZE}} \cdot \text{Sector Size}$$

The ranges that can be covered by the parameter are:

- From 512 Bytes to 128 Kbytes in case of Sector Size = 512 Bytes
- From 4Kbytes to 1 Mbytes in case of Sector Size = 4 Kbytes

#### 7.4.9 TAG\_RES\_SIZE [497]

This field is defined to inform the host about the maximum quantity of resources in bytes allocated by the device to allocate system data by the tagging mechanism:

$$\text{System Data Tag Resources Size} = [(N \cdot \text{Tag Unit Size}) \cdot 2^{\text{TAG\_RES\_SIZE}}]/2^{10}$$

(N · Tag Unit Size) represents the device capacity in terms of Tag Unit Size

The range of valid TAG\_RES\_SIZE values is from 0 to 6; Values in range of 7 to 0xFF are reserved.

The formula covers a range from about 0.1% to 6.25% of the device capacity

#### 7.4.10 CONTEXT\_CAPABILITIES [496]

This field describes the capabilities of context management.

**Table 87 — Context Management Context Capabilities**

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Reserved	LARGE_UNIT_MAX_MULTIPLIER_M1					MAX_CONTEXT_ID	

MAX\_CONTEXT\_ID is the highest context ID that may be used in contexts.

The mandatory minimum value for this field is 5 plus the default ID #0 (MAX\_CONTEXT\_ID shall be 5 or higher)

LARGE\_UNIT\_MAX\_MULTIPLIER\_M1 is the highest multiplier that can be configured for Large Unit contexts, minus one. Large Unit contexts may be configured to have a multiplier in the range:

$$1 \leq \text{multiplier} \leq (\text{LARGE\_UNIT\_MAX\_MULTIPLIER\_M1} + 1)$$

#### 7.4.11 LARGE\_UNIT\_SIZE\_M1 [495]

This field describes the size of the Large Unit, minus one.

$$\text{Large Unit size} = 1\text{MB} * (\text{LARGE\_UNIT\_SIZE\_M1} + 1)$$

#### 7.4.12 EXT\_SUPPORT [494]

This field describes the extended partitions attribute support.

A bit value of '1' denotes a supported type. An eMMC 5.0 device shall have bits 0 and 1 set.

**Table 88 — Extended CSD Register Support**

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Reserved					Non-persistent		System code

#### **7.4.13 SUPPORTED\_MODES [493]**

Bit [0]: ‘0’ FFU is not supported by the device. ‘1’ FFU is supported by the device.

Bit [1]: ‘0’ Vendor Specific Mode (VSM) is not supported by the device. ‘1’ Vendor Specific mode is supported by the device.

**Table 89 — SUPPORTED\_MODES**

Others	Bit 1	Bit 0
Reserved	VSM	FFU

#### **7.4.14 FFU\_FEATURES [492]**

**Table 90 — FFU FEATURES**

Others	Bit 0
Reserved	SUPPORTED_MODE_OPERATION_CODES

SUPPORTED\_MODE\_OPERATION\_CODES:

- ‘0’ – Device does not support MODE\_OPERATION\_CODES field
- ‘1’ – Device support MODE\_OPERATION\_CODES field

#### **7.4.15 OPERATION\_CODES\_TIMEOUT [491]**

This field indicates the maximum timeout for the SWITCH command (CMD6) when setting a value to the MODE\_OPERATION\_CODES field.

The formula to calculate the max timeout value is:

$$\text{Production State Timeout} = 100\text{us} * 2^{\text{OPERATION_CODES_TIMEOUT}}$$

Max register value defined is 0x17 which equals 838.86s timeout. Values between 0x18 and 0xFF are reserved.

**Table 91 — MODE\_OPERATION\_CODES timeout definition**

Value	Timeout Values
0x00	Not defined
0x01	$100\text{us} \times 2^1 = 200\text{us}$
0x02	$100\text{us} \times 2^2 = 400\text{us}$
..	..
0x17	$100\text{us} \times 2^{23} = 838.86\text{s}$
0x18 – 0xFF	Reserved

#### **7.4.16 FFU\_ARG [490-487]**

Using this field the device reports to the host which value the host should set as an argument for the read and write commands in FFU mode.

#### **7.4.17 NUMBER\_OF\_FW\_SECTORS\_CORRECTLY\_PROGRAMMED [305-302]**

Using this field the device reports the number of sectors, from the firmware bundle, which were programmed correctly into the device. The value is in terms of 512 Bytes or in multiple of eight 512Bytes sectors (4KBytes) depending on the value of the DATA\_SECTOR\_SIZE field.

**7.4.18 VENDOR\_PROPRIETARY\_HEALTH\_REPORT [301-270]**

This Fields reserved for vendor proprietary health report.

**7.4.19 DEVICE\_LIFE\_TIME\_EST\_TYP\_B [269]**

This field provides an estimated indication about the device life time which is reflected by the averaged wear out of memory of Type B relative to its maximum estimated device life time.

**Table 92 — Device life time estimation type B value**

Value	Description
0x00	Not defined
0x01	0% - 10% device life time used
0x02	10% -20% device life time used
0x03	20% -30% device life time used
0x04	30% - 40% device life time used
0x05	40% - 50% device life time used
0x06	50% - 60% device life time used
0x07	60% - 70% device life time used
0x08	70% - 80% device life time used
0x09	80% - 90% device life time used
0x0A	90% - 100% device life time used
0x0B	Exceeded its maximum estimated device life time
Others	Reserved

#### 7.4.20 DEVICE\_LIFE\_TIME\_EST\_TYP\_A [268]

This field provides an estimated indication about the device life time which is reflected by the averaged wear out of memory of Type A relative to its maximum estimated device life time.

**Table 93 — Device life time estimation type A value**

Value	Description
0x00	Not defined
0x01	0% - 10% device life time used
0x02	10% -20% device life time used
0x03	20% -30% device life time used
0x04	30% - 40% device life time used
0x05	40% - 50% device life time used
0x06	50% - 60% device life time used
0x07	60% - 70% device life time used
0x08	70% - 80% device life time used
0x09	80% - 90% device life time used
0x0A	90% - 100% device life time used
0x0B	Exceeded its maximum estimated device life time
Others	Reserved

#### 7.4.21 PRE\_EOL\_INFO [267]

This field provides indication about device life time reflected by average reserved blocks.

**Table 94 — Pre EOL info value**

Value	Pre-EOL Info.	Description
0x00	Not Defined	
0x01	Normal	Normal
0x02	Warning	Consumed 80% of reserved block
0x03	Urgent	
0x04 ~ 0xFF	Reserved	

#### 7.4.22 OPTIMAL\_READ\_SIZE [266]

This field provides the minimum optimal (for the device) read unit size for the different partitions.

**Table 95 — Optimal read size value**

Value	Optimal Read Size
0x00	Not defined
0x01	4KB x 1 = 4KB
0x02	4KB x 2 = 8KB
...	
0xFF	4KB x 255 = 1020KB

#### 7.4.23 OPTIMAL\_WRITE\_SIZE [265]

This field provides the minimum optimal (for the device) write unit size for the different partitions.  
“Optimal” relates to the minimum wearout done by the device.

**Table 96 — Optimal write size value**

Value	Optimal Write Size
0x00	Not defined
0x01	4KB x 1 = 4KB
0x02	4KB x 2 = 8KB
...	
0xFF	4KB x 255 = 1020KB

#### 7.4.24 OPTIMAL\_TRIM\_UNIT\_SIZE [264]

This field provides the minimum optimal (for the device) trim unit size for the different partitions.  
“Optimal” relates to the minimum wearout done by the device.

**Table 97 — Optimal trim unit size value**

Value	Optimal Trim unit Size
0x00	Not defined
0x01	4KB x 1 = 4KB
0x02	4KB x 2 = 8KB
0x03	4KB x 4 = 16KB
...	
0x15	4KB x 2^20 = 4GB
Reserved	

#### 7.4.25 DEVICE\_VERSION [263-262]

This field provides the device version.

#### **7.4.26 FIRMWARE\_VERSION [261-254]**

This field provides the device firmware version.

#### **7.4.27 CACHE\_SIZE [252:249]**

This field indicates the existence and size of the volatile cache in the *e*•MMC device. Value 0x00 indicates that there is no cache existing. Any value higher than 0x00 indicates that there is a cache existing and the size of it. The size is indicated as multiple of kilobits. The value of the CACHE\_SIZE register informs the multiplier. The MSB of the multiplier is in the [252] byte and LSB in [249] byte.

Size of the Cache = CACHE\_SIZE x 1kb

#### **7.4.28 GENERIC\_CMD6\_TIME [248]**

This field indicates the default maximum timeout for a SWITCH command (CMD6) unless a specific timeout is defined when accessing a specific field. Additionally, this field doesn't define the timeout when starting a background operation (writing to field BKOPS\_START[164]) or starting a sanitize operation (writing to field SANITIZE\_START[165]) or flushing the cache (writing to field FLUSH\_CACHE[32]). Time is expressed in units of 10-milliseconds.

**Table 98 — Generic Switch Timeout Definition**

Value	Timeout value Definition
0x00	Not defined
0x01	10ms x 1 = 10 ms
0x02	10ms x 2 = 20 ms
...	...
0xFF	10 ms x 255 = 2550 ms

#### **7.4.29 POWER\_OFF\_LONG\_TIME [247]**

This field indicates the maximum timeout for the SWITCH command (CMD6) when notifying the device that power is about to be turned off by writing POWER\_OFF\_LONG to POWER\_OFF\_NOTIFICATION[34] byte. In case other modes are set in POWER\_OFF\_NOTIFICATION, the timeout is the generic CMD6 timeout. Time is expressed in units of 10-milliseconds.

**Table 99 — Power off long switch timeout definition**

Value	Timeout value Definition
0x00	Not defined
0x01	10ms x 1 = 10 ms
0x02	10ms x 2 = 20 ms
...	...
0xFF	10 ms x 255 = 2550 ms

#### 7.4.30 BKOPS\_STATUS [246]

This field indicates the level of background operations urgency.

**Table 100 — Background operations status**

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Reserved						OUTSTANDING	

Bit[7:2]: Reserved

Bit[1:0]: OUTSTANDING

0x0 : No operations required

0x1 : Operations outstanding (non critical)

0x2 : Operations outstanding (performance being impacted)

0x3 : Operations outstanding (critical)

#### 7.4.31 CORRECTLY\_PRG\_SECTORS\_NUM [245:242]

This field indicates how many sectors were successfully programmed by the last WRITE\_MULTIPLE\_BLOCK command (CMD25). The value is in terms of 512 Bytes or in multiple of eight 512Bytes sectors (4KBytes) depending on the value of the DATA\_SECTOR\_SIZE field

**Table 101 — Correctly programmed sectors number**

CORRECTLY_PRG_SECTORS_NUM	
EXT_CSD[245]	CORRECTLY_PRG_SECTORS_NUM_3
EXT_CSD[244]	CORRECTLY_PRG_SECTORS_NUM_2
EXT_CSD[243]	CORRECTLY_PRG_SECTORS_NUM_1
EXT_CSD[242]	CORRECTLY_PRG_SECTORS_NUM_0

Number of correctly programmed sectors =

$$[\text{CORRECTLY\_PRG\_SECTORS\_NUM\_3} * 2^{24} + \text{CORRECTLY\_PRG\_SECTORS\_NUM\_2} * 2^{16} + \text{CORRECTLY\_PRG\_SECTORS\_NUM\_1} * 2^8 + \text{CORRECTLY\_PRG\_SECTORS\_NUM\_0} * 2^0]$$

NOTE It is recommended for hosts to refer to this field for avoiding re-writing again the successfully programmed sectors when repeating an interrupted write command.

#### 7.4.32 INI\_TIMEOUT\_AP [241]

This register indicates the maximum initialization timeout during the first power up after successful partitioning of an e•MMC device. Note that all of the initialization timeouts during consecutive power ups will have timeout max 1s (like in case of non partitioned e•MMC device).

**Table 102 — Initialization Time out value**

Value	Timeout Value
0x00	Not defined
0x01	100ms × 1 = 100 ms
...	...
0xFF	100ms × 255 = 25500 ms

### 7.4.33 TRIM\_MULT [232]

This register is used to calculate the TRIM and DISCARD function timeout. The following formula defines the timeout value for the TRIM and DISCARD operation of inside a logical erase group.

$$\text{TRIM Timeout} = 300\text{ms} \times \text{TRIM\_MULT}$$

If the host executes TRIM or DISCARD operation including write sectors belonging to multiple erase groups, the total timeout value should be the multiple of the number of the erase groups involved.

**Table 103 — TRIM/DISCARD Time out value**

Value	Timeout Value
0x00	Not defined
0x01	$300\text{ms} \times 1 = 300\text{ ms}$
...	...
0xFF	$300\text{ms} \times 255 = 76500\text{ ms}$

### 7.4.34 SEC\_FEATURE\_SUPPORT [231]

This byte allows the host to determine which secure data management features are supported on the Device. The bits in this register determine whether the ERASE (CMD38) command arguments are supported and whether the host can manage the way defected portions of the memory array are retired by using SEC\_BAD\_BLK\_MGMT (EXT\_CSD[134])

**Table 104 — SEC Feature Support**

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Reserved	SEC_SANITIZE	Reserved	SEC_GB_CL_EN	Reserved	SEC_BD_BLK_EN	Reserved	Reserved (obsolete)

Bit 7: Reserved

Bit 6: SEC\_SANITIZE

0x1: Device supports the sanitize operation.

0x0: Device does not support the sanitize operation.

Bit 5: Reserved

Bit 4: SEC\_GB\_CL\_EN (R)

0x0: Device does not support the secure and insecure trim operations

0x1: Device supports the secure and insecure trim operations. This bit being set means that argument bits 15 and 0 are supported with CMD38

Bit 3: Reserved

Bit 2: SEC\_BD\_BLK\_EN (R)

0x0 : Device does not support the automatic erase operation on retired defective portions of the array.

0x1 : Device supports the automatic erase operation on retired defective portions of the array. This bit being set enables the host to set SEC\_BAD\_BLK\_MGMT (EXT\_CSD[134]).

Bit 1: Reserved

Bit 0: SECURE\_ER\_EN (R)

0x0: Secure purge operations are not supported on the device

0x1: Secure purge operations are supported. This bit being set allows the host to set bit 31 of the argument for the ERASE (CMD38) Command

#### 7.4.35 SEC\_ERASE\_MULT [230]

This register is used to calculate Secure\_Erase function timeout. The following formula defines the time out value for the Secure Erase operation of one logical erase group.

Secure Erase Timeout = 300ms x ERASE\_TIMEOUT\_MULT x SEC\_ERASE\_MULT.

If the host executes Secure Erase operation including erase groups the total timeout value should be the multiple of the number of the erase groups involved.

**Table 105 — Secure Erase time-out value**

Value	Timeout Value
0x00	Not defined
0x01	300ms × ERASE_TIMEOUT_MULT x 1
...	...
0xFF	300ms × ERASE_TIMEOUT_MULT x 255

#### 7.4.36 SEC\_TRIM\_MULT [229]

This register is used to calculate Secure\_TRIM function timeout. The following formula defines the time-out value for the Secure\_TRIM operation of one logical erase group.

Secure TRIM Timeout = 300ms x ERASE\_TIMEOUT\_MULT x SEC\_TRIM\_MULT

If the host executes Secure Trim operation including write sectors belonging to multiple erase groups, the total timeout value should be the multiple of the number of the erase groups involved.

**Table 106 — Secure Erase time-out value**

Value	Timeout Value
0x00	Not defined
0x01	300ms × ERASE_TIMEOUT_MULT x 1
...	...
0xFF	300ms × ERASE_TIMEOUT_MULT x 255

#### 7.4.37 BOOT\_INFO [228]

**Table 107 — Boot information**

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Reserved			HS_BOOT_MODE		DDR_BOOT_MODE	ALT_BOOT_MODE	

Bit[7:3]: Reserved

Bit[2]: HS\_BOOT\_MODE

0: Device does not support high speed timing during boot.

1: Device supports high speed timing during boot.

Bit[1]: DDR\_BOOT\_MODE

0: Device does not support dual data rate during boot.

1: Device supports dual data rate during boot.

Bit[0]: ALT\_BOOT\_MODE

0x0 : Device does not support alternative boot method (obsolete)

0x1 : Device supports alternative boot method. Device must show “1” since this is mandatory in v4.4 standard

The only currently valid values for this register are 0x0, 0x1, 0x05, and 0x07. A device supporting dual data rate mode during boot shall also have bit 2 set.

#### 7.4.38 BOOT\_SIZE\_MULT [226]

The boot partition size is calculated from the register by using the following equation: Boot Partition size = 128Kbytes × BOOT\_SIZE\_MULT

**Table 108 — Boot partition size**

Value	Boot Size Mult
0x00	No boot partition available / Boot mode not supported
0x01	$1 \times 128\text{Kbytes} = 128\text{Kbytes}$
0x02	$2 \times 128\text{Kbytes} = 256\text{Kbytes}$
:	:
0xFE	$254 \times 128\text{Kbytes} = 32512\text{Kbytes}$
0xFF	$255 \times 128\text{Kbytes} = 32640\text{Kbytes}$

#### 7.4.39 ACC\_SIZE [225]

**Table 109 — Access size**

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1
Reserved				SUPER_PAGE_SIZE		

Bit[7:4]: Reserved

Bit[3:0]: SUPER\_PAGE\_SIZE

This register defines one or multiple of programmable boundary unit which is programmed at the same time. This value can be used by the master for the following cases:

As a guide for format clusters

To prevent format-page misalignment

As a guide for minimum data-transfer size

Super-page size =  $512 \times 2^{(\text{SUPER\_PAGE\_SIZE} - 1)}$  :  $0 < X < 9$

**Table 110 — Superpage size**

Value	Superpage Size
0x0	Not defined
0x1	$512 \times 1 = 512$ bytes
0x2	$512 \times 2 = 1\text{K}$ bytes
:	:
0x8	$512 \times 128 = 64\text{K}$ bytes
0x9–0xF	Reserved

#### 7.4.40 HC\_ERASE\_GRP\_SIZE [224]

This register defines the erase-unit size for high-capacity memory. If the master enables bit “0” in the extended CSD register byte [175], the slave uses these value for the erase operation. Erase Unit Size = 512Kbyte × HC\_ERASE\_GRP\_SIZE

**Table 111 — Erase-unit size**

Value	Value definition
0x00	No support for high-capacity erase-unit size
0x01	$512\text{Kbyte} \times 1 = 524,288$ bytes
0x02	$512\text{Kbyte} \times 2 = 1,048,576$ bytes
:	:
0xFF	$512\text{Kbyte} \times 255 = 133,693,440$ bytes

If the ENABLE bit in ERASE\_GROUP\_DEF is cleared to LOW or HC\_WP\_GRP\_SIZE is set to 0x00, the write protect group size definition would be the original case.

#### 7.4.41 ERASE\_TIMEOUT\_MULT [223]

This register is used to calculate erase timeout for high-capacity erase operations and defines the timeout value for the erase operation of one erase group.

Erase Timeout =  $300\text{ms} \times \text{ERASE\_TIMEOUT\_MULT}$

If the host executes erase operations for multiple erase groups, the total timeout value should be the multiple of the number of erase groups issued.

If the master enables bit 0 in the extended CSD register byte [175], the slave uses ERASE\_TIMEOUT\_MULT values for the timeout value.

If ERASE\_TIMEOUT\_MULT is set to 0x00, the slave must support the previous timeout definition.

**Table 112 — Erase timeout values**

Value	Timeout Values
0x00	No support for high-capacity erase timeout
0x01	$300\text{ms} \times 1 = 300\text{ms}$
0x02	$300\text{ms} \times 2 = 600\text{ms}$
:	:
0xFF	$300\text{ms} \times 255 = 76,500\text{ms}$

#### 7.4.42 REL\_WR\_SEC\_C [222]

The REL\_WR\_SEC\_C [222] register shall be set to 1 and has no impact on the reliable write operation.

**Table 113 — Reliable write sector count**

Name	Field	Size	Cell Type
Reliable Write Sector Count	REL_WR_SEC_C	1	R

#### 7.4.43 HC\_WP\_GRP\_SIZE [221]

This register defines the write protect group size for high-capacity memory. If the ENABLE bit in ERASE\_GROUP\_DEF is set to HIGH, the write protect group size would be defined as follows: Write protect group size =  $512\text{KB} * \text{HC_ERASE_GRP_SIZE} * \text{HC_WP_GRP_SIZE}$ .

**Table 114 — Write protect group size**

Value	Value definition
0x00	No support for high-capacity write protect group size
0x01	1 high-capacity erase unit size
0x02	2 high-capacity erase unit size
0x03	3 high-capacity erase unit size
:	:
0xFF	255 high-capacity erase unit size

If the ENABLE bit in ERASE\_GROUP\_DEF is cleared to LOW or HC\_WP\_GRP\_SIZE is set to 0x00, the write protect group size definition would be the original case.

#### 7.4.44 S\_C\_VCC[220] and S\_C\_VCCQ[219]

The S\_C\_VCC and S\_C\_VCCQ registers define the max VCC current consumption during the Sleep state (slp). The formula to calculate the max current value is:

$$\text{Sleep current} = 1\mu\text{A} * 2^X : \text{register value} = X > 0$$

$$\text{Sleep current} = \text{no value (legacy)}: \text{register value} = 0$$

Max register value defined is 0x0D which equals 8.192mA. Values between 0x0E and 0xFF are reserved.

**Table 115 — S\_C\_VCC, S\_C\_VCCQ Sleep Current**

Value	Value definition
0x00	Not defined
0x01	$1\mu\text{A} \times 2^1 = 2\mu\text{A}$
0x02	$1\mu\text{A} \times 2^2 = 4\mu\text{A}$
:	:
0x0D	$1\mu\text{A} \times 2^{13} = 8.192\text{mA}$
0x0E–0xFF	Reserved

#### 7.4.45 PRODUCTION\_STATE\_AWARENESS\_TIMEOUT [218]

This field indicates the maximum timeout for the SWITCH command (CMD6) when setting a value to the PRODUCTION\_STATE\_AWARENESS [133] field.

The formula to calculate the max timeout value is:

$$\text{Production State Timeout} = 100\text{us} * 2^{\text{PRODUCTION\_STATE\_AWARENESS\_TIMEOUT}}$$

Max register value defined is 0x17 which equals 838.86s timeout. Values between 0x18 and 0xFF are reserved.

**Table 116 — Production State Awareness timeout definition**

Value	Timeout Values
0x00	Not defined
0x01	$100\text{us} \times 2^1 = 200\text{us}$
0x02	$100\text{us} \times 2^2 = 400\text{us}$
..	..
0x17	$100\text{us} \times 2^{23} = 838.86\text{s}$
0x18 – 0xFF	Reserved

#### 7.4.46 S\_A\_TIMEOUT [217]

This register defines the max timeout value for state transitions from Standby state (stby) to Sleep state (slp) and from Sleep state (slp) to Standby state (stby). The formula to calculate the max timeout value is:

$$\text{Sleep/Awake Timeout} = 100\text{ns} * 2^{\text{S_A_timeout}}$$

Max register value defined is 0x17 which equals 838.86ms timeout. Values between 0x18 and 0xFF are reserved.

**Table 117 — Sleep/awake timeout values**

Value	Timeout Values
0x00	Not defined
0x01	$100\text{ns} \times 2^1 = 200\text{ns}$
0x02	$100\text{ns} \times 2^2 = 400\text{ns}$
:	:
0x17	$100\text{ns} \times 2^{23} = 838.86\text{ms}$
0x18 – 0xFF	Reserved

#### 7.4.47 SLEEP\_NOTIFICATION\_TIME [216]

This field indicates the maximum timeout for the SWITCH command (CMD6) when notifying the device that it is about to be move to sleep state (slp) by writing SLEEP\_NOTIFICATION to POWER\_OFF\_NOTIFICATION [34] byte. Time is expressed in units of 10-millimicroseconds. The formula to calculate the max timeout value is:

- Sleep Notification Time out value =  $10\text{us} * 2^{\text{SLEEP\_NOTIFICATION\_TIME}}$
- Max register value defined is 0x17 which equals 83.88s timeout. Values between 0x18 and 0xFF are reserved.

**Table 118 — Sleep Notification timeout values**

Value	Timeout Values
0x00	Not defined
0x01	$10\text{us} \times 2^1 = 20\text{us}$
0x02	$10\text{us} \times 2^2 = 40\text{us}$
:	:
0x17	$10\text{us} \times 2^{23} = 83.88\text{s}$
0x18–0xFF	Reserved

#### 7.4.48 SEC\_COUNT [215:212]

The device density is calculated from the register by multiplying the value of the register (sector count) by 512B/sector as shown in following equation.

$$\text{Device density} = \text{SEC\_COUNT} \times 512\text{B}$$

The maximum density possible to be indicated is thus  $4\ 294\ 967\ 295 \times 512\text{B}$ .

The addressable sector range for the device will be from Sector 0 to Sector (SEC\_COUNT-1).

The least significant byte (LSB) of the sector count value is the byte [212].

When the partition configuration is executed by host, device will re-calculate the SEC\_COUNT value which can indicate the size of user data area after the partition.

#### 7.4.49 MIN\_PERF\_a\_b\_ff [210:205] and MIN\_PERF\_DDR\_a\_b\_ff [235:234]

These fields define the overall minimum performance value for the read and write access with different bus width and max clock frequency modes. The value in the register is coded as in Table 119 — . Values, other than those defined, are considered illegal.

**Table 119 — R/W access performance values**

Value	Performance
Single Data Rate mode	
0x00	For Devices not reaching the 2.4MB/s value
0x08	Class A: 2.4MB/s and is the next allowed value (16x150kB/s)
0x0A	Class B: 3.0MB/s and is the next allowed value (20x150kB/s)
0x0F	Class C: 4.5MB/s and is the next allowed value (30x150kB/s)
0x14	Class D: 6.0MB/s and is the next allowed value (40x150kB/s)
0x1E	Class E: 9.0MB/s and is the next allowed value (60x150kB/s)
0x28	Class F: Equals 12.0MB/s and is the next allowed value (80x150kB/s)
0x32	Class G: Equals 15.0MB/s and is the next allowed value (100x150kB/s)
0x3C	Class H: Equals 18.0MB/s and is the next allowed value (120x150kB/s)
0x46	Class J: Equals 21.0MB/s and is the next allowed value (140x150kB/s) This is also the highest class which any mobile e•MMC Device is needed to support in mid bus category operation mode (26MHz with 8bit data bus or 52MHz with 4bit data bus). A Device supporting any higher class than this have to support this Class (in mid category bus operation mode) and Class E also (in low category bus operation mode)
0x50	Class K: Equals 24.0MB/s and is the next allowed value (160x150kB/s)
0x64	Class M: Equals 30.0MB/s and is the next allowed value (200x150kB/s)
0x78	Class O: Equals 36.0MB/s and is the next allowed value (240x150kB/s)
0x8C	Class R: Equals 42.0MB/s and is the next allowed value (280x150kB/s)
0xA0	Class T: Equals 48.0MB/s and is the last defined value (320x150kB/s)
Dual Data Rate mode	
0x00	For Devices not reaching the 4.8MB/s value
0x08	Class A: Equals 4.8MB/s and is the next allowed value (16x300kB/s)
0x0A	Class B: Equals 6.0MB/s and is the next allowed value (20x300kB/s)
0x0F	Class C: Equals 9.0MB/s and is the next allowed value (30x300kB/s)
0x14	Class D: Equals 12.0MB/s and is the next allowed value (40x300kB/s)
0x1E	Class E: Equals 18.0MB/s and is the last defined value (60x300kB/s)
0x28	Class F: Equals 24.0MB/s and is the next allowed value (80x300kB/s)
0x32	Class G: Equals 30.0MB/s and is the next allowed value (100x300kB/s)
0x3C	Class H: Equals 36.0MB/s and is the next allowed value (120x300kB/s)
0x46	Class J: Equals 42.0MB/s and is the last defined value (140x300kB/s)
0x50	Class K: Equals 48.0MB/s and is the next allowed value (160x300kB/s)
0x64	Class M: Equals 60.0MB/s and is the next allowed value (200x300kB/s)
0x78	Class O: Equals 72.0MB/s and is the next allowed value (24 0x300kB/s)
0x8C	Class R: Equals 84.0MB/s and is the next allowed value (280x300kB/s)
0xA0	Class T: Equals 96.0MB/s and is the last defined value (320x300kB/s)

#### 7.4.50 PWR\_CL\_ff\_vvv [203:200] , PWR\_CL\_ff\_vvv[237:236] , PWR\_CL\_DDR\_ff\_vvv [239:238] and PWR\_CL\_DDR\_ff\_vvv[253]

These fields define the supported power classes by the Device. By default, the Device has to operate at maximum frequency using 1 bit bus configuration, within the default max current consumption, as stated in the table below. If 4 bit/8 bits bus configurations require increased current consumption, it has to be stated in these registers.

#### 7.4.50 PWR\_CL\_ff\_vvv [203:200] , PWR\_CL\_ff\_vvv[237:236] , PWR\_CL\_DDR\_ff\_vvv [239:238] and PWR\_CL\_DDR\_ff\_vvv[253] (cont'd)

By reading these registers the host can determine the power consumption of the Device in different bus modes. Bits [7:4] code the current consumption for the 8 bit bus configuration. Bits [3:0] code the current consumption for the 4 bit bus configuration.

The PWR\_52\_vvv registers are not defined for 26MHz e•MMCs.

PWR\_CL\_DDR\_200\_vvv[253] registers are for HS400 mode,

**Table 120 — Power classes**

Voltage	Value	Max RMS Current	Max Peak Current	Remarks
3.6V	0	100 mA	200 mA	Default current consumption for high voltage Devices
	1	120 mA	220 mA	
	2	150 mA	250 mA	
	3	180 mA	280 mA	
	4	200 mA	300 mA	
	5	220 mA	320 mA	
	6	250 mA	350 mA	
	7	300 mA	400 mA	
	8	350 mA	450 mA	
	9	400 mA	500 mA	
	10	450 mA	550 mA	
	11	500mA	600mA	
	12	600mA	700mA	
	13	700mA	800mA	
	14	800mA	900mA	
	15	>800mA	>900mA	
1.95V	0	65 mA	130 mA	Default current consumption for Dual voltage Devices
	1	70 mA	140 mA	
	2	80 mA	160 mA	
	3	90 mA	180 mA	
	4	100 mA	200 mA	
	5	120 mA	220 mA	
	6	140 mA	240 mA	
	7	160 mA	260 mA	
	8	180 mA	280 mA	
	9	200 mA	300 mA	
	10	250 mA	350 mA	
	11	300mA	400mA	
	12	350mA	450mA	
	13	400mA	500mA	
	14	500mA	600mA	
	15	>500mA	>600mA	

#### 7.4.50 PWR\_CL\_ff\_vvv [203:200] , PWR\_CL\_ff\_vvv[237:236] , PWR\_CL\_DDR\_ff\_vvv [239:238] and PWR\_CL\_DDR\_ff\_vvv[253] (cont'd)

The measurement for max RMS current is done as average RMS current consumption over a period of 100ms. Max peak current is defined as absolute max value not to be exceeded at all. The conditions under which the power classes are defined are:

- Maximum bus frequency
- Maximum operating voltage
- Worst case functional operation
- Worst case environmental parameters (temperature,...)

These registers define the maximum power consumption for any protocol operation in data transfer mode, Ready state and Identification state.

Device may specify in their datasheet the performance per Power Class and whether the package case (Tc) temperature conditions shall be met as given in Annex A.10

#### 7.4.51 PARTITION\_SWITCH\_TIME [199]

This field indicates the maximum timeout for the SWITCH command (CMD6) when switching partitions by changing PARTITION\_ACCESS bits in PARTITION\_CONFIG field (EXT\_CSD byte [179]). Time is expressed in units of 10-milliseconds.

**Table 121 — Partition switch timeout definition**

Value	Timeout value definition
0x00	Not defined
0x01	10ms x 1 = 10ms
0x02	10ms x 2 = 20ms
...	...
0xFF	10ms x 255 = 2550ms

#### 7.4.52 OUT\_OF\_INTERRUPT\_TIME [198]

This field indicates the maximum timeout to close a command interrupted by HPI – time between the end bit of CMD12/13 to the DAT0 release by the device. Time is expressed in units of 10-milliseconds.

**Table 122 — Out-of-interrupt timeout definition**

Value	Timeout value definition
0x00	Not defined
0x01	10ms x 1 = 10ms
0x02	10ms x 2 = 20ms
:	:
0xFF	10ms x 255 = 2550ms

#### 7.4.53 DRIVER\_STRENGTH [197]

Indicates the I/O driver strength types that are supported by a device.

**Table 123 — Supported Driver Strengths**

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Reserved	Reserved	Reserved	Type 4	Type 3	Type 2	Type 1	Type 0

Refer to Table 184 — for possible driver strength types supported by a device.

**7.4.54 DEVICE\_TYPE [196]**

This field defines the type of the Device.

**Table 124 — Device types**

<b>Bit</b>	<b>Device Type</b>
7	HS400 Dual Data Rate e•MMC @ 200MHz – 1.2V I/O
6	HS400 Dual Data Rate e•MMC @ 200MHz – 1.8V I/O
5	HS200 Single Data Rate e•MMC @ 200 MHz - 1.2V I/O
4	HS200 Single Data Rate e•MMC @ 200 MHz - 1.8V I/O
3	High-Speed Dual Data Rate e•MMC @ 52MHz - 1.2V I/O
2	High-Speed Dual Data Rate e•MMC @ 52MHz - 1.8V or 3V I/O
1	High-Speed e•MMC @ 52MHz - at rated device voltage(s)
0	High-Speed e•MMC @ 26MHz - at rated device voltage(s)

The - currently valid values for this field are including followings; 0x01, 0x03, 0x07, 0x0B, 0x0F, 0x13, 0x17, 0x1B, 0x1F, 0x23, 0x27, 0x2B, 0x2F, 0x33, 0x37, 0x3B, 0x3F, 0x41, 0x43, 0x47, 0x4B, 0x4F, 0x51, 0x53, 0x57, 0x5B, 0x5F, 0x61, 0x63, 0x67, 0x6B, 0x6F, 0x71, 0x73, 0x77, 0x7B, 0x7F, 0x81, 0x83, 0x87, 0x8B, 0x8F, 0x91, 0x93, 0x97, 0x9B, 0x9F, 0xA1, 0xA3, 0xA7, 0xAB, 0xAF, 0xB1, 0xB3, 0xB7, 0xBB, 0xBF, 0xC1, 0xC3, 0xC7, 0xCB, 0xCF, 0xD1, 0xD3, 0xD7, 0xDB, 0xDF, 0xE1, 0xE3, 0xE7, 0xEB, 0xEF, 0xF1, 0xF3, 0xF7, 0xFB, 0xFF . Ex) A dual voltage 1.2V/1.8V device which supports 52MHz DDR mode at 1.8V and not at 1.2V will be coded 0x7.

A dual voltage 1.2V/1.8V device which supports 52MHz Double-Data-Rate mode at 1.8V and 26Mhz/52MHz Single-Data-Rate mode at 1.2V will be also coded 0x7. For all the device types that cover several voltage ranges, the data sheet of the device shall specify the specific supported voltage range for VCC and VCCQ.

Dual Data Rate mode support is optional

**7.4.55 CSD\_STRUCTURE [194]**

This field is a continuation of the CSD\_STRUCTURE field in the CSD register

**Table 125 — CSD register structure**

<b>CSD_STRUCTURE</b>	<b>CSD structure version</b>	<b>Valid for System Specification Version</b>
0	CSD version No. 1.0	Allocated by MMCA
1	CSD version No. 1.1	Allocated by MMCA
2	CSD version No. 1.2	Version 4.1–4.2–4.3–4.41–4.5–4.51–5.0
3–255	Reserved for future use	

#### 7.4.56 EXT\_CSD\_REV [192]

Defines the fixed parameters related to the EXT\_CSD, according to its revision

**Table 126 — Extended CSD revisions**

EXT_CSD_REV	Extended CSD Revision
255–8	Reserved
7	Revision 1.7 (for MMC v5.0)
6	Revision 1.6 (for MMC v4.5, v4.51)
5	Revision 1.5 (for MMC v4.41)
4	Revision 1.4 (Obsolete)
3	Revision 1.3 (for MMC v4.3)
2	Revision 1.2 (for MMC v4.2)
1	Revision 1.1 (for MMC v4.1)
0	Revision 1.0 (for MMC v4.0)

#### 7.4.57 CMD\_SET [191]

CMD\_SET contains the binary code of the command set that is currently active in the Device. The command set can be changed using the Command Set-access type of the SWITCH command (CMD6). Note that while changing the command set with the SWITCH command, bit index values according to the S\_CMD\_SET register should be used. For backward compatibility, the CMD\_SET is set to 0x00 (standard MMC) following power-up. After switching back to the standard MMC command set with the SWITCH command, the value of the CMD\_SET is 0x01.

#### 7.4.58 CMD\_SET\_REV [189]

Contains a binary number reflecting the revision of the currently active command set. For Standard MMC. command set it is:

**Table 127 — Standard MMC command set revisions**

Code	MMC Revision
255–1	Reserved
0	v4.0

This field, though in the Modes segment of the EXT\_CSD, is read only.

#### 7.4.59 POWER\_CLASS [187]

This field contains the 4-bit value of the selected power class for the Device. The power classes are defined in Table 128 — . The host should be responsible of properly writing this field with the maximum power class it allows the Device to use. The Device uses this information to, internally, manage the power budget and deliver an optimized performance.

**Table 128 — Power class codes**

Bits	Description
[7:4]	Reserved
[3:0]	Device power class code (See Table 120 — )

This field is 0 after power-on or software reset.

#### 7.4.60 HS\_TIMING [185]

**Table 129 — HS\_TIMING (timing and driver strength)**

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Selected Driver Strength				Timing Interface			

- This field is used by the host to select both Timing Interface and Driver Strength. This byte is composed from two fields, each represented by a nibble.
- Timing Interface [0:3]: This field is 0 after power-on, H/W reset or software reset, thus selecting the backwards compatibility interface timing for the device. If the host sets 1 to this field, the device changes its timing to high speed interface timing (see 10.6.1). If the host sets value 2 the device changes its timing to HS200 interface timing (see 10.8.1). If the host sets HS\_TIMING[3:0] to 0x3, the device changes its timing to HS400 interface timing (see 10.7.1)

**Table 130 — HS\_TIMING Interface values**

Value	Timing Interface	Remarks
0x0	Selecting backwards compatibility interface timing	
0x1	High Speed	
0x2	HS200	
0x3	HS400	

- Selected Driver Strength [4:7]: Using this field the host sets the required Driver Strength from device. The default and mandatory value is (0x0). See 10.5.4 for specifications of Driver Strength values.

#### 7.4.61 BUS\_WIDTH [183]

It is set to ‘0’ (1 bit data bus) after power up and can be changed by a SWITCH command.

**Table 131 — Bus mode values**

Value	Bus Mode
255–7	Reserved
6	8 bit data bus (dual data rate)
5	4 bit data bus (dual data rate)
4–3	Reserved
2	8 bit data bus
1	4 bit data bus
0	1 bit data bus

HS\_TIMING must be set to “0x1” before setting BUS\_WIDTH for dual data rate operation (values 5 or 6)

#### 7.4.62 ERASED\_MEM\_CONT [181]

This field defines the content of an explicitly erased memory range.

**Table 132 — Erased memory content values**

Value	Erased Memory Content
255–2	Reserved
1	Erased memory range shall be ‘1’
0	Erased memory range shall be ‘0’

#### 7.4.63 PARTITION\_CONFIG (before BOOT\_CONFIG) [179]

This register defines the configuration for partitions.

**Table 133 — Boot configuration bytes**

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Reserved	BOOT_ACK	BOOT_PARTITION_ENABLE			PARTITION_ACCESS		
	R/W/E		R/W/E			R/W/E_P	

Bit 7: Reserved

Bit 6: BOOT\_ACK (R/W/E)

0x0 : No boot acknowledge sent (default)

0x1 : Boot acknowledge sent during boot operation Bit

[5:3] : BOOT\_PARTITION\_ENABLE (R/W/E)

User selects boot data that will be sent to master

0x0 : Device not boot enabled (default)

0x1 : Boot partition 1 enabled for boot

0x2 : Boot partition 2 enabled for boot

0x3–0x6 : Reserved

0x7 : User area enabled for boot

Bit[2:0] : PARTITION\_ACCESS (before BOOT\_PARTITION\_ACCESS, R/W/E\_P)

User selects partitions to access

0x0 : No access to boot partition (default)

0x1 : R/W boot partition 1

0x2 : R/W boot partition 2

0x3 : R/W Replay Protected Memory Block (RPMB)

0x4 : Access to General Purpose partition 1

0x5 : Access to General Purpose partition 2

0x6 : Access to General Purpose partition 3

0x7 : Access to General Purpose partition 4

#### 7.4.64 BOOT\_CONFIG\_PROT[178]

This register defines boot configuration protection

**Table 134 — Boot config protection**

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Reserved			PERM_BOOT_CONFIG_PROT	Reserved			PWR_BOOT_CONFIG_PROT
			R/W				R/W/C_P

Bit [7:5]: Reserved

Bit [4]: PERM\_BOOT\_CONFIG\_PROT (R/W)

0x0 : PERM\_BOOT\_CONFIG\_PROT is not enabled (default)

0x1 : Permanently disable the change of boot configuration register bits relating boot mode operation (BOOT\_PARTITION\_ENABLE, BOOT\_ACK, RESET\_BOOT\_BUS\_CONDITIONS, BOOT\_MODE and BOOT\_BUS\_WIDTH).

Bit[3:1] : Reserved

Bit[0] : PWR\_BOOT\_CONFIG\_PROT (R/W/C\_P)

0x0 : PWR\_BOOT\_CONFIG\_PROT is not enabled (default)

0x1 : Disable the change of boot configuration register bits relating to boot mode operation (BOOT\_PARTITION\_ENABLE, BOOT\_ACK, RESET\_BOOT\_BUS\_CONDITIONS, BOOT\_MODE and BOOT\_BUS\_WIDTH) from at this point until next power cycle or next H/W reset operation (but not CMD0 Reset operation).

If PERM\_BOOT\_CONFIG\_PROT is enabled, whether PWR\_BOOT\_CONFIG\_PROT is enable or not, BOOT mode is permanently locked and cannot reversed.

#### 7.4.65 BOOT\_BUS\_CONDITIONS [177]

This register defines the bus width for boot operation.

**Table 135 — Boot bus configuration**

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Reserved			BOOT_MODE	RESET_BOOT_BUS_CONDITIONS		BOOT_BUS_WIDTH	

Bit[7:5] : Reserved

Bit [4:3] : BOOT\_MODE (non-volatile)

0x0 : Use single data rate + backward compatible timings in boot operation (default)

0x1 : Use single data rate + High Speed timings in boot operation mode

0x2 : Use dual data rate in boot operation

0x3 : Reserved

NOTE HS200 & HS400 is not supported during BOOT operation.

#### 74.65 BOOT\_BUS\_CONDITIONS [177] (cont'd)

Bit [2]: RESET\_BOOT\_BUS\_CONDITIONS (non-volatile)

- 0x0 : Reset bus width to x1, single data rate and backward compatible timings after boot operation (default)
- 0x1 : Retain BOOT\_BUS\_WIDTH and BOOT\_MODE values after boot operation. This is relevant to Push-pull mode operation only.

Bit[1:0] : BOOT\_BUS\_WIDTH (non-volatile)

- 0x0 : x1 (sdr) or x4 (ddr) bus width in boot operation mode (default)
- 0x1 : x4 (sdr/ddr) bus width in boot operation mode
- 0x2 : x8 (sdr/ddr) bus width in boot operation mode
- 0x3 : Reserved

The settings in the BOOT\_BUS\_CONDITIONS register control any data transfer in boot mode, while the HS\_TIMING and the BUS\_WIDTH register control the behavior in other modes. The BOOT\_BUS\_CONDITIONS register is nonvolatile, while the HS\_TIMING and BUS\_WIDTH registers will be reset after a power cycle, hardware reset, or a CMD0 (unless sent to exit boot mode). This requires software to set the BUS\_WIDTH and HS\_TIMING registers after completing the boot procedure.

To avoid having to write these registers after completing the boot operation, the host may set the RESET\_BOOT\_BUS\_CONDITIONS register to '1' which will automatically set the values of BUS\_WIDTH and HS\_TIMING registers to the values set in the BOOT\_BUS\_CONDITIONS register, when exiting boot mode. In this case, CMD0 to exit boot mode does not reset BUS\_WIDTH and HS\_TIMING. However, if CMD0 is sent in other cases (with any argument), it shall reset the BUS\_WIDTH and HS\_TIMING to their reset values (1-bit bus width and single data rate, backward-compatible interface timing respectively).

Any power cycle or hardware reset shall reset the BUS\_WIDTH and HS\_TIMING to their reset values (1-bit bus width and single data rate, backward-compatible interface timing respectively).

If the RESET\_BOOT\_BUS\_CONDITIONS bit is set after boot operation, this will not affect bus width and interface timing until the device goes through the Boot state. Bus width and timing mode transitions are shown in Table 136.

**Table 136 — Bus Width and Timing Mode Transition**

RESET_BOOT_BUS_CONDITIONS bit	Event	BUS_WIDTH, HS_TIMING
1	Power cycle or hardware reset, entering boot mode	BOOT_BUS_WIDTH, BOOT_MODE
1	Power cycle or hardware reset, skipping boot mode	x1, SDR (backward compatibility)
1	CMD0, exiting boot mode	BOOT_BUS_WIDTH, BOOT_MODE
1	CMD0, anywhere but when exiting boot mode	x1, SDR (backward compatibility)
0	Any power cycle, hardware reset or CMD0	x1, SDR (backward compatibility)

#### 7.4.66 ERASE\_GROUP\_DEF [175]

This register allows master to select high capacity erase unit size, timeout value, and write protect group size. Bit defaults to “0” on power on.

**Table 137 — ERASE\_GROUP\_DEF**

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Reserved							ENABLE

Bit[7:1]: Reserved

Bit0: ENABLE

0x0 : Use old erase group size and write protect group size definition (default)

0x1 : Use high-capacity erase unit size, high capacity erase timeout, and high-capacity write protect group size definition.

#### 7.4.67 BOOT\_WP\_STATUS [174]

This byte allows the host to read the current protection status of the boot partitions.

Bit [7:4]	Bit [3:2]	Bit [1:0]
Reserved	B_AREA_2_WP	B_AREA_1_WP

Bit[7:3]: Reserved

Bit[3:2]: B\_AREA\_2\_WP (R)

0x00: Boot Area 2 is not protected

0x01: Boot Area 2 is Power on protected

0x10: Boot Area 2 is Permanently Protected

0x11: Reserved

Bit[1:0]: B\_AREA\_1\_WP (R)

0x00: Boot Area 1 is not protected

0x01: Boot Area 1 is Power on protected

0x10: Boot Area 1 is Permanently Protected

0x11: Reserved

#### 7.4.68 BOOT\_WP [173]

This byte allows the host to apply permanent or power-on write protection to the boot area. Also, the register allows the master to disable either power-on or permanent write protection or both. The default state of the bits is zero. This register can only be written once per power cycle. The process for setting boot area write protection is outlined in 6.3.7.

**Table 138 — BOOT area Partitions write protection**

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
B_SEC_WP_SEL	B_PWR_WP_DIS	Reserved	B_PERM_WP_DIS	B_PERM_WP_EN M_WP_SEC_SEL	B_PERM_WP_E_N	B_PWR_WP_SEC_SEL	B_PWR_WP_EN
R/W/C_P	R/W/C_P		R/W	R/W/C_P	R/W	R/W/C_P	R/W/C_P

Bit[7]: B\_SEC\_WP\_SEL (R/W/C\_P)

- 0x0: B\_PERM\_WP\_EN(bit2) and B\_PWR\_WP\_EN (bit 0) apply to both boot partitions and B\_PERM\_WP\_SEC\_SEL (bit 3) and B\_PWR\_WP\_SEC\_SEL (bit 1) have no impact
- 0x1: B\_PERM\_WP\_EN(bit2) and B\_PWR\_WP\_EN (bit 0) apply to only boot partition selected by B\_PERM\_WP\_SEC\_SEL (bit 3) and B\_PWR\_WP\_SEC\_SEL (bit 1) respectively.

NOTE Once a device has been set to enable protection on the boot partitions separately this cannot be reverted for a power cycle. This bit enables a mix of Permanent protect, power on protected boot partitions.

Bit[6]: B\_PWR\_WP\_DIS (R/W/C\_P)

- 0x0:Master is permitted to set B\_PWR\_WP\_EN(bit 0)
- 0x1: Disable the use of B\_PWR\_WP\_EN(bit 0). This bit must be zero if PWR\_WP\_EN is set.

Bit[5]: Reserved

Bit[4]: B\_PERM\_WP\_DIS (R/W)

- 0x0: Master is permitted to set B\_PERM\_WP\_EN(bit 2)
- 0x1: Permanently disable the use of B\_PERM\_WP\_EN(bit 2). This bit must be zero if B\_PERM\_WP\_EN is set. This bit has no impact on the setting of CSD[13].

Bit[3]: B\_PERM\_WP\_SEC\_SEL(R/W/C\_P)

- 0x0: B\_PERM\_WP\_EN(Bit 2) applies to boot Area1 only, if B\_SEC\_WP\_SEL (bit 7 is set)
- 0x1: B\_PERM\_WP\_EN(Bit 2) applies to boot Area2 only, if B\_SEC\_WP\_SEL (bit 7 is set)

Bit[2]: B\_PERM\_WP\_EN (R/W)

- 0x0: Boot region is not permanently write protected.
- 0x1: Boot region is permanently write protected. This bit must be zero if B\_PERM\_WP\_DIS is set. When read, this bit only indicates if permanent protection has been set specifically for a boot region. How permanent protection has been applied depends on the setting of bits 7 and 3. To verify boot region protection read BOOT\_WP\_STATUS[174]. This bit may be zero if the whole device is permanently protected using CSD[13].

#### 7.4.68 BOOT\_WP [173] (cont'd)

Bit[1]: B\_PWR\_WP\_SEC\_SEL(R/W/C\_P)

0x0: B\_PWR\_WP\_EN(Bit 0) applies to boot Area1 only, if B\_SEC\_WP\_SEL (bit 7 is set)

0x1: B\_PWR\_WP\_EN(Bit 0) applies to boot Area2 only, if B\_SEC\_WP\_SEL (bit 7 is set)

Bit[0]: B\_PWR\_WP\_EN (R/W/C\_P)

0x0: Boot region is not power-on write protected.

0x1: Enable Power-On Period write protection to the boot area. This bit must be zero if B\_PWR\_WP\_DIS (bit 6) is set. When read, this bit only indicates if power on protection has been set specifically for a boot region. How power on protection has been applied depends on the setting of bits 7 and 1. To verify boot region protection read BOOT\_WP\_STATUS[174].

An attempt to set both the disable and enable bit for a given protection mode (permanent or power-on) in a single switch command will have no impact. If both permanent and power on protection are applied to the same partition(s), permanent protection will take precedence and the partition(s) will be permanently protected.

If the host enables Power-On write protection to a boot partition after enabling Permanent write protection to the other boot area, the host shall set Bit 3as same value as set for Permanent write protection to the other boot partition (see A.11 for details).

#### 7.4.69 USER\_WP [171]

This byte allows the host to apply permanent or power-on write protection to all the partitions in the user area. Also, the register allows the host to disable the different protection modes that apply to the user area.

**Table 139 — User area write protection**

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
PERM_PSWD_DIS	CD_PERM_WP_DIS	Reserved	US_PERM_WP_DIS	US_PWR_WP_DIS	US_PERM_WP_EN	Reserved	US_PWR_WP_EN
R/W	R/W		R/W	R/W/C_P	R/W/E_P		R/W/E_P

Bit[7]: PERM\_PSWD\_DIS (R/W)

- 0x0: Password protection features are enabled.
- 0x1: Password protection features (ERASE (Forcing erase), LOCK, UNLOCK, CLR\_PWD, SET\_PWD) are disabled permanently.

Bit[6]: CD\_PERM\_WP\_DIS (R/W)

- 0x0: Host is permitted to set PERM\_WP\_PROTECT (CSD[13])
- 0x1: Disable the use of PERM\_WP\_PROTECT (CSD[13]).

Bit[5]: Reserved

Bit[4]: US\_PERM\_WP\_DIS (R/W)

- 0x0: Permanent write protection can be applied to write protection groups.
- 0x1: Permanently disable the use of permanent write protection for write protection groups within all the partitions in the user area from the point this bit is set forward. Setting this bit does not impact areas that are already protected.

Bit[3]: US\_PWR\_WP\_DIS (R/W/C\_P)

- 0x0: Power-on write protection can be applied to write protection groups.
- 0x1: Disable the use of power-on period write protection for write protection groups within all the partitions in the user area from the point this bit is set until power is removed or a hardware reset occurs. Setting this bit does not impact areas that are already protected.

Bit[2]: US\_PERM\_WP\_EN (R/W/E\_P)

- 0x0: Permanent write protection is not applied when CMD28 is issued.
- 0x1: Apply permanent write protection to the protection group indicated by CMD28. This bit cannot be set if US\_PERM\_WP\_DIS is set.

Bit[1]: Reserved

Bit[0]: US\_PWR\_WP\_EN (R/W/E\_P)

- 0x0: Power-on write protection is not applied when CMD28 is issued.
- 0x1: Apply Power-On Period protection to the protection group indicated by CMD28. This bit cannot be set if US\_PWR\_WP\_DIS is set. This bit has no impact if US\_PERM\_WP\_EN is set.

This field is set to zero after power on or hardware reset.

Issuing CMD28 when both US\_PERM\_WP\_EN and US\_PWR\_WP\_EN, will result in the write protection group being permanently protected.

#### 7.4.70 FW\_CONFIG [169]

The Update\_Disable bit disables the possibility to update the firmware of the e•MMC.

**Table 140 — FW Update Disable**

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Reserved						Update_Disable	

Bit[7:1]: Reserved

Bit[0]: Update\_Disable

0x0: FW updates enabled.

0x1: FW update disabled permanently

#### 7.4.71 RPMB\_SIZE\_MULT [168]

The RPMB partition size is calculated from the register by using the following equation: RPMB partition size = 128kB x RPMB\_SIZE\_MULT

**Table 141 — RPMB Partition Size**

Value	Value definition
0x00	No RPMB partition available.
0x01	1 x 128Kbyte = 128Kbytes
0x02	2 x 128Kbyte = 256Kbytes
:	:
0x80	128x128Kbyte = 16384Kbytes
0x81-0xFF	Reserved <sup>1</sup>

NOTE 1 RPMB data frame format definition supports a maximum of 16 MB. This limits the size of the RPMB area.

#### 7.4.72 WR\_REL\_SET [167]

The write reliability settings register indicates the reliability setting for each of the user and general area partitions in the device.

**Table 142 — Write reliability setting**

Name	Field	Bit	Type
Write Data Reliability (user Area)	WR_DATA_REL_USR	0	R (if HS_CTRL_REL =0) R/W (if HS_CTRL_REL =1)
Write Data Reliability Partition 1	WR_DATA_REL_1	1	R (if HS_CTRL_REL =0) R/W (if HS_CTRL_REL =1)
Write Data Reliability Partition 2	WR_DATA_REL_2	2	R (if HS_CTRL_REL =0) R/W (if HS_CTRL_REL =1)
Write Data Reliability Partition 3	WR_DATA_REL_3	3	R (if HS_CTRL_REL =0) R/W (if HS_CTRL_REL =1)
Write Data Reliability Partition 4	WR_DATA_REL_4	4	R (if HS_CTRL_REL =0) R/W (if HS_CTRL_REL =1)
Reserved		7:5	

Bit[7:5]: Reserved Bit

[4]: WR\_DATA\_REL\_4

- 0x0: In general purpose partition 4, the write operation has been optimized for performance and existing data in the partition could be at risk if a power failure occurs.
- 0x1: In general purpose partition 4, the device protects previously written data if power failure occurs.

Bit[3]: WR\_DATA\_REL\_3

- 0x0: In general purpose partition 3, the write operation has been optimized for performance and existing data in the partition could be at risk if a power failure occurs.
- 0x1: In general purpose partition 3, the device protects previously written data if power failure occurs.

Bit[2]: WR\_DATA\_REL\_2

- 0x0: In general purpose partition 2, the write operation has been optimized for performance and existing data in the partition could be at risk if a power failure occurs.
- 0x1: In general purpose partition 2, the device protects previously written data if power failure occurs.

Bit[1]: WR\_DATA\_REL\_1

- 0x0: In general purpose partition 1, the write operation has been optimized for performance and existing data in the partition could be at risk if a power failure occurs.
- 0x1: In general purpose partition 1, the device protects previously written data if power failure occurs.

Bit[0]: WR\_DATA\_REL\_USR

- 0x0: In the main user area, write operations have been optimized for performance and existing data could be at risk if a power failure occurs.
- 0x1: In the main user area, the device protects previously written data if power failure occurs.

#### 7.4.73 WR\_REL\_PARAM [166]

All eMMC 5.0 devices shall support write reliability. Both bits in this register should be set to 1.

**Table 143 — Write reliability parameter register**

Name	Field	Bit	Type
Host controlled data reliability	HS_CTRL_REL	0	R
Reserved		1	
Enhanced Reliable Write	EN_REL_WR	2	R
Reserved		7:3	

Bit[7:3]: Reserved

Bit[2]: EN\_REL\_WR (R)

0x0: obsolete

0x1: The device supports the enhanced definition of reliable write

Bit[1]: Reserved

Bit[0]: HS\_CTRL\_REL (R)

0x0: obsolete

0x1: All the WR\_DATA\_REL parameters in the WR\_REL\_SET registers are R/W.

#### 7.4.74 SANITIZE\_START[165]

Writing any value to this field shall manually start a sanitize operation. Device shall stay busy until sanitize is complete.

#### 7.4.75 BKOPS\_START [164]

Writing any value to this field shall manually start background operations. Device shall stay busy till no more background operations are needed.

#### 7.4.76 BKOPS\_EN [163]

This field allows the host to indicate to the device if it is expected to periodically manually start background operations by writing to the BKOPS\_START field.

**Table 144 — Background operations enable**

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Reserved							ENABLE

Bit[7:1]: Reserved

Bit[0]: ENABLE

0x0: Host does not support background operations handling and is not expected to write to BKOPS\_START field.

0x1: Host is indicating that it shall periodically write to BKOPS\_START field to manually start background operations.

#### 7.4.77 RST\_n\_FUNCTION [162]

For backward compatibility reason, RST\_n signal is temporary disabled in device by default. Host may need to set the signal as either permanently enable or permanently disable before it uses the Device.

**Table 145 — H/W reset function**

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Reserved						RST_n_ENABLE	

Bit[7:2]: Reserved

Bit[1:0]: RST\_n\_ENABLE (Readable and Writable once)

0x0: RST\_n signal is temporarily disabled (default)

0x1: RST\_n signal is permanently enabled

0x2: RST\_n signal is permanently disabled

0x3: Reserved

By default, RST\_n\_ENABLE is set to 0x0, which is RST\_n is temporarily disabled. Host can change the value to either 0x1 (permanently enabled) or 0x2 (permanently disabled). Once host sets the value to either one, the value cannot be changed again.

Once host sets RST\_n\_ENABLE bits to 0x2 (permanently disabled), the Device will not accept the input of RST\_n signal permanently. During the disable period, the Device has to take care that any state of RST\_n (high, low and floating) will not cause any issue (i.e. mal function and high leakage current in the input buffer) in the device.

When RST\_n\_ENABLE is set to 0x1 (permanently enabled), the Device accepts the input of RST\_n permanently. Host cannot change the bits back to the disabled values. Also, when host set RST\_n\_ENABLE to 0x1, the Device must not start resetting internal circuits by triggering the register bit change. Internal reset sequence must be triggered by RST\_n rising edge but not by the register change.

Since Device does not have any internal pull up or pull down resistor on RST\_n terminal, host has to pull up or down RST\_n to prevent the input circuits from flowing unnecessary leakage current when RST\_n is enabled.

#### 7.4.78 HPI\_MGMT [161]

This field allows the host to activate the HPI mechanism.

**Table 146 — HPI management**

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Reserved						HPI_EN	

Bit[7:1]: Reserved

Bit[0]: HPI\_EN

0x0 : HPI mechanism not activated by the host (default)

0x1 : HPI mechanism activated by the host

#### 7.4.79 PARTITIONING\_SUPPORT [160]

This register defines supported partition features. eMMC 5.0 requires that all values in this register are set.

**Table 147 — Partitioning Support**

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Reserved					EXT_ATTRIBUTE_EN	ENH_ATTRIBUTE_EN	PARTITIONING_EN

Bit[7:3]: Reserved

Bit[2]: EXT\_ATTRIBUTE\_EN

0x0: n/a.

0x1: Device can have extended partitions attribute

Bit[1]: ENH\_ATTRIBUTE\_EN

0x0: obsolete

0x1: Device can have enhanced technological features in partitions and user data area

Bit[0]: PARTITIONING\_EN

0x0: obsolete.

0x1: Device supports partitioning features

#### 7.4.80 MAX\_ENH\_SIZE\_MULT [159:157]

This register defines max. amount of memory area which can have the enhanced attribute. The Write Protect Group size refers to the high capacity definition.

**Table 148 — Max. Enhanced Area Size**

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
MAX_ENH_SIZE_MULT_2							
MAX_ENH_SIZE_MULT_1							
MAX_ENH_SIZE_MULT_0							

Max Enhanced Area = MAX\_ENH\_SIZE\_MULT x HC\_WP\_GRP\_SIZE x HC\_ERASE\_GRP\_SIZE x 512kBytes

$\sum$  Enhanced general partition Size(i) + Enhanced user data area  $\leq$  Max Enhanced Area

#### 7.4.81 PARTITIONS\_ATTRIBUTE [156]

This register bits sets enhanced attribute in general purpose partitions.

**Table 149 — Partitions Attribute**

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
	Reserved		ENH_4	ENH_3	ENH_2	ENH_1	ENH_USR

Bit[7:5]: Reserved

Bit[4]: ENH\_4

0x0: Default

0x1: Set Enhanced attribute in General Purpose partition 4

Bit[3]: ENH\_3

0x0: Default

0x1: Set Enhanced attribute in General Purpose partition 3

Bit[2]: ENH\_2

0x0: Default

0x1: Set Enhanced attribute in General Purpose partition 2

Bit[1]: ENH\_1

0x0: Default

0x1: Set Enhanced attribute in General Purpose partition 1

Bit[0]: ENH\_USR

0x0: Default

0x1: Set Enhanced attribute in User Data Area

#### 7.4.82 PARTITION\_SETTING\_COMPLETED [155]

Default value states that any partitions configuration procedure has been issued by the host. The bit is set to notify the device that the definition of parameters has been completed and the device can start its internal configuration activity. If a sudden power loss occurs and this bit has not been set yet, the configuration of partitions shall be invalidated and must be repeated.

**Table 150 — Partition Setting**

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Reserved						PARTITION_SETTING_COMPLETED	

#### 7.4.83 GP\_SIZE\_MULT\_GP0 - GP\_SIZE\_MULT\_GP3 [154:143]

This register defines general purpose partition size. General Purpose Partitions size shall be expressed in terms of high capacity write protect groups.

**Table 151 — General Purpose Partition Size**

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
GP_SIZE_MULT_X_2							
GP_SIZE_MULT_X_1							
GP_SIZE_MULT_X_0							

#### GP\_SIZE\_MULT\_X\_Y

Where X refers to the General Purpose Partition (from 1 to 4) and Y refers to the factors in the formula (from 0 to 2), so;

General\_Purpose\_Partition\_X Size =

$$(GP\_SIZE\_MULT\_X\_2 \times 2^{16} + GP\_SIZE\_MULT\_X\_1 \times 2^8 + GP\_SIZE\_MULT\_X\_0 \times 2^0) \times HC\_WP\_GRP\_SIZE \times HC\_ERASE\_GRP\_SIZE \times 512kBytes$$

GPP1:

- GP\_SIZE\_MULT\_1\_0 = EXT\_CSD[143]
- GP\_SIZE\_MULT\_1\_1 = EXT\_CSD[144]
- GP\_SIZE\_MULT\_1\_2 = EXT\_CSD[145]

GPP2:

- GP\_SIZE\_MULT\_2\_0 = EXT\_CSD[146]
- GP\_SIZE\_MULT\_2\_1 = EXT\_CSD[147]
- GP\_SIZE\_MULT\_2\_2 = EXT\_CSD[148]

GPP3:

- GP\_SIZE\_MULT\_3\_0 = EXT\_CSD[149]
- GP\_SIZE\_MULT\_3\_1 = EXT\_CSD[150]
- GP\_SIZE\_MULT\_3\_2 = EXT\_CSD[151]

GPP4:

- GP\_SIZE\_MULT\_4\_0 = EXT\_CSD[152]
- GP\_SIZE\_MULT\_4\_1 = EXT\_CSD[153]
- GP\_SIZE\_MULT\_4\_2 = EXT\_CSD[154]

#### 7.4.84 ENH\_SIZE\_MULT [142:140]

This register defines enhanced user data area size. Enhanced User Data Area size is defined in terms of High Capacity Write Protect Groups.

**Table 152 — Enhanced User Data Area Size**

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
ENH_SIZE_MULT_2							
ENH_SIZE_MULT_1							
ENH_SIZE_MULT_0							

Enhanced User Data Area x Size =

$$(ENH\_SIZE\_MULT\_2 \times 2^{16} + ENH\_SIZE\_MULT\_1 \times 2^8 + ENH\_SIZE\_MULT\_0 \times 2^0) \times HC\_WP\_GRP\_SIZE \times HC\_ERASE\_GRP\_SIZE \times 512\text{kBytes}$$

#### 7.4.85 ENH\_START\_ADDR [139:136]

This register defines starting address of the enhanced user data area.

Start address of the Enhanced User Data Area segment in the User Data Area (expressed in bytes or in sectors in case of high capacity devices).

**Table 153 — Enhanced User Data Start Address**

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
ENH_START_ADDR_3							
ENH_START_ADDR_2							
ENH_START_ADDR_1							
ENH_START_ADDR_0							

#### 7.4.86 SEC\_BAD\_BLK\_MGMNT [134]

In some memory array technologies that are used for e•MMC portions of the memory array can become defective with use. In these technologies the Device will recover the information from the defective portion of the memory array before it retires the block. This register bit, when set, requires the device to perform an erase on the contents of the defective region before it is retired. This feature requires only those bits that are not defective in the region to be erased.

**Table 154 — Secure Bad Block management**

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Reserved						SEC_BAD_BLK	

Bit[7:1]: Reserved

Bit[0]: SEC\_BAD\_BLK (R/W)

0x0: (Default) Feature disabled

0x1: All data must be erased from defective memory array regions before they are retired from use. SEC\_BD\_BLK\_EN (EXT\_CSD[231] bit 2) must be set in order to use this bit.

#### 7.4.87 PRODUCTION\_STATE\_AWARENESS [133]

Through this field the host reports to the device its production state.

This field has the following values:

- NORMAL (Field) – This value represents a state in which the device is the field and the device uses “regular” operations.
- PRE\_SOLDERING\_WRITES – This value represents a state in which the device is in production prior soldering and before the host loaded content to the device. The host sets the device to this state for loading the content to the device.
- PRE\_SOLDERING\_POST\_WRITES - This value represents a state in which the device is in production and the host completed to load the content to the device. The host sets the device to this state after content was loaded and just before soldering. Once transferred to this state the host should not write content to the device.
- AUTO\_PRE\_SOLDERING –This value should be set by the host if auto pre-soldering data is desired. If the data is transferred as much as PRE\_LOADING\_DATA\_SIZE, then the device state is changed back to normal state by changing the value of PRODUCTION\_STAT\_AWARENESS to 0x0(Normal) automatically. i.e., no separate command to change to normal state is needed.

**Table 155 — PRODUCTION\_STATE\_AWARENESS states**

Value	Value definition
0x00	NORMAL(Field)
0x01	PRE_SOLDERING_WRITES
0x02	PRE_SOLDERING_POST_WRITES
0x03	AUTO_PRE_SOLDERING
0x04 – 0x0F	Reserved
0x10 – 0x1F	Reserved for Vendor Proprietary Usage
0x20 – 0xFF	Reserved

#### 7.4.88 TCASE\_SUPPORT [132]

*e*MMC device may condition their maximum performance to cases in which host conforms to the Tcase control temperature tables as given in Annex A.10. In that case host that wish to utilize the maximum performance and conforms to the given Case temperature (Tc) tables shall set the TCASE\_SUPPORT bits accordingly:

- TCASE\_SUPPORT = 0x01: Table 204 — in Annex A.10 is supported. Heat relief through Case only is assumed.
- TCASE\_SUPPORT = 0x10: Table 204 — in Annex A.10 is supported. Heat relief through Case & PCB/Balls is assumed.

If TCASE\_SUPPORT bit is =“0x00” the above mentioned device may limit the maximum available performance. Host should set the TCASE\_SUPPORT value as 0x01 or 0x10 as soon as possible for the device to run its maximum available performance.

#### 7.4.89 PERIODIC\_WAKEUP [131]

How often the host shall wake up the device.

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	
WAKEUP_UNIT			WAKEUP_PERIOD					
0x0 = infinity (no wakeups) 0x1 = months 0x2 = weeks 0x3 = days 0x4 = hours 0x5 = minutes 0x6, 0x7 reserved								

Where the period between wakeups is WAKEUP\_PERIOD in units of WAKEUP\_UNIT. For example, a value of 01000110b means: WAKEUP\_UNIT=010b=weeks, WAKEUP\_PERIOD=00110b=6 => 6 weeks.

If WAKEUP\_UNIT is 0, WAKEUP\_PERIOD is ignored and the period between wake ups is infinity (no wake ups).

#### 7.4.90 PROGRAM\_CID\_CSD\_DDR\_SUPPORT [130]

This field indicates if the CMD26 and CMD27 are supported in dual data rate mode by the device.

**Table 156 — CMD26 and CMD27 in DDR mode Support**

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Reserved						PROGRAM_CID_CSD_DDR_S UPPORT	

Bit[7:1]: Reserved

Bit[0]: PROGRAM\_CID\_CSD\_DDR\_SUPPORT (R)

0x0: (Default) CMD26 and CMD27 must be used in single data rate mode.

0x1: CMD26 and CMD27 are considered legal in both single data rate and dual data rate mode.

#### 7.4.91 NATIVE\_SECTOR\_SIZE [63]

This field indicates the native size of sectors supported by the device:

0x00:Native sector size is 512B

0x01:Native sector size is 4KB

0x02-0xFF: Reserved

#### 7.4.92 USE\_NATIVE\_SECTOR [62]

This field controls if sector size of 512B is emulated on a native sector size other than 512B:

0x00:Device is emulating a 512B sector size or uses a native 512B sector size

0x01:Device is using the larger than 512B native sector size

0x02-0xFF: Reserved

When shipped, a large sector device is always configured with USE\_NATIVE\_SECTOR=0. If device supports larger than 512B native sector size, host may disable the emulation mode by writing 0x01 followed by a power cycle. Emulation mode cannot be re-enabled.

If NATIVE\_SECTOR\_SIZE is 512B, writing this field shall fail with SWITCH\_ERROR.

#### **7.4.93 DATA\_SECTOR\_SIZE [61]**

This field indicates the current sector size that can be accessed or addressed:

0x00: Data sector size is 512B

0x01: Data sector size is 4KB

0x02-0xFF: Reserved

#### **7.4.94INI\_TIMEOUT\_EMU [60]**

This register indicates the maximum initialization timeout during the first power up after successful disabling of the 512B emulation mode.

**Table 157 — Initialization Time out value**

<b>Value</b>	<b>Timeout Value</b>
0x00	Not defined
0x01	$100\text{ms} \times 1 = 100\text{ ms}$
...	...
0xFF	$100\text{ms} \times 255 = 25500\text{ ms}$

#### **7.4.95 CLASS\_6\_CTRL[59]**

This field controls the usage of class 6 command set (CMD28, CMD29, CMD30 and CMD31). By setting this field to 0x00, class 6 command set is used for WP. By setting this field to 0x1, class 6 command set is used to manipulate the dynamic capacity functionality.

Setting any other value (0x02-0xFF) is forbidden.

**Table 158 — Class 6 usage**

<b>Value</b>	<b>Value definition</b>
0x00	Write Protect (Default)
0x01	Dynamic Capacity
0x02-0xFF	Reserved

#### **7.4.96 DYNCAP\_NEEDED [58]**

This field is a read only field through which the device indicates to the host the amount of WP-Groups that the device requests to be released from the user area address space.

#### **7.4.97 EXCEPTION\_EVENTS\_CTRL [57:56]**

Each bit enables the use of the relevant exception event bit, allowing it to raise the EXCEPTION\_EVENT bit in Device Status.

**Table 159 — EXCEPTION\_EVENTS\_CTRL[56]**

<b>Bit 7</b>	<b>Bit 6</b>	<b>Bit 5</b>	<b>Bit 4</b>	<b>Bit 3</b>	<b>Bit 2</b>	<b>Bit 1</b>	<b>Bit 0</b>
Reserved	Reserved	Reserved	EXTENDED_SECURITY_EN	PACKED_EVENT_EN	SYSPOOL_EVENT_EN	DYNCAP_EVENT_EN	Reserved

**Table 160 — EXCEPTION\_EVENTS\_CTRL[57]**

<b>Bit 15</b>	<b>Bit 14</b>	<b>Bit 13</b>	<b>Bit 12</b>	<b>Bit 11</b>	<b>Bit 10</b>	<b>Bit 9</b>	<b>Bit 8</b>
Reserved							

NOTE For backward compatibility reasons, if BKOPS\_SUPPORT bit [0] is set, then the urgent background operations event (URGENT\_BKOPS) is always enabled and cannot be disabled. All other enable bits start disabled after power up until set by host.

#### 7.4.98 EXCEPTION\_EVENTS\_STATUS [55:54]

Each bit reports the status of a specific exception event.

**Table 161 — EXCEPTION\_EVENTS\_STATUS[54]**

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Reserved	Reserved	Reserved	EXTENDED_SECURITY_FAILURE	PACKED_FAILURE	SYSPOOL_EXHAUSTED	DYNCAP_NEEDED	URGENT_BKOPS

**Table 162 — EXCEPTION\_EVENT\_STATUS[55]**

Bit 15	Bit 14	Bit 13	Bit 12	Bit 11	Bit 10	Bit 9	Bit 8
Reserved							

- URGENT\_BKOPS – Urgent background operations needed: if set, the device needs to perform background operations urgently. Host can check EXT\_CSD field BKOPS\_STATUS for the detailed level.
- DYNCAP\_NEEDED – Dynamic capacity needed: If set, device needs some capacity to be released.
- SYSPOOL\_EXHAUSTED – System resources pool exhausted: If set, system resources pool has no more available resources and some data needs to be untagged before other data can be tagged
- PACKED\_FAILURE – Packed command failure: If set, the last packed command has failed. Host may check EXT\_CSD field PACKED\_COMMAND\_STATUS for the detailed cause.
- EXTENDED\_SECURITY\_FAILURE – An error caused while using the PROTOCOL\_WR (CMD54) or PROTOCOL\_RD (CMD53) commands or in relation to the Extended Protocols usage. If set the host may check the EXT\_CSD field EXT\_SECURITY\_ERR [505] for the detailed cause.

#### 7.4.99 EXT\_PARTITIONS\_ATTRIBUTE [53:52]

This register bits sets extended attribute in general purpose partitions.

**Table 163 — First Byte EXT\_PARTITIONS\_ATTRIBUTE[52]**

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
EXT_2				EXT_1			

**Table 164 — Second Byte EXT\_PARTITIONS\_ATTRIBUTE[53]**

Bit 15	Bit 14	Bit 13	Bit 12	Bit 11	Bit 10	Bit 9	Bit 8
EXT_4				EXT_3			

Each four-bits nibble describes the extended attribute of a specific general purpose partition. The specific meaning of each type follows:

0x0: Default (no extended attribute)

0x1: System code

0x2: Non-persistent

0x3-0xF: Reserved

Bit[15:12]: Extended partition attribute for general purpose partition 4

Bit[11:8]: Extended partition attribute for general purpose partition 3

Bit[7:4]: Extended partition attribute for general purpose partition 2

Bit[3:0]: Extended partition attribute for general purpose partition 1

#### 7.4.100 CONTEXT\_CONF [51:37]

CONTEXT\_CONF is an array of 15 bytes, each controlling the configuration of the relevant ID, starting with ID #1 associated to CONTEXT\_CONF[37].up to ID #15 associated to CONTEXT\_CONF[51]. Context ID #0 is reserved for context-less operation and has no configuration register.

Each configuration register holds the following format:

**Table 165 — CONTEXT\_CONF configuration format**

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Reliability Mode		Large Unit Multiplier		Large Unit Context		Config direction and activate	

Bit[7:6]: Reliability mode

0x0: MODE0 (normal)

0x1: MODE1 (non-Large Unit, reliable mode or Large Unit unit-by-unit mode)

0x2: MODE2 (Large Unit, one-unit-tail mode)

0x3: Reserved

Bit[5:3]: Large Unit multiplier

If Large Unit context is set, then the unit is multiplied by (Bit[5:3] + 1), else it is ignored

Bit[2]: Large Unit context

0x0: Context is not following Large Unit rules

0x1: Context follows Large Unit rules

Bit [1:0]: Activation and direction selection

00b: Context is closed and is no longer active

01b: Context is configured and activated as a write-only context and according to the rest of the bits in this configuration register

10b: Context is configured and activated as a read-only context and according to the rest of the bits in this configuration register

11b: Context is configured and activated as a read/write context and according to the rest of the bits in this configuration register

#### 7.4.101 PACKED\_COMMAND\_STATUS [36]

This register reports the status of the last packed command.

**Table 166 — Packed Command Status Register**

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Reserved	Reserved	Reserved	Reserved	Reserved	reserved	Indexed Error	Error

In case any error occurs during a packed command, the ‘Error’ bit (bit 0) shall be set.

If the error is a result of one of the individual commands inside the packed command, its index is reported in PACKED\_FAILURE\_INDEX [35] and ‘Indexed Error’ bit (bit 1) is set as well.

#### 7.4.102 PACKED\_FAILURE\_INDEX [35]

If the ‘Indexed Error’ bit (bit 1) in PACKED\_COMMAND\_STATUS is set, this field specifies the index in the header of the failed command.

#### 7.4.103 POWER\_OFF\_NOTIFICATION [34]

This field allows host to notify the device before the device is powered off. Values not in the below table are invalid and setting them will result in SWITCH\_ERROR.

**NOTE** e•MMC device should be able to guard against sudden power loss even when POWER\_OFF\_NOTIFICATION is set to 0x01 (POWER\_ON) since unintentional power loss event may still occur.

**Table 167 — Valid POWER\_OFF\_NOTIFICATION values**

Value	Name	Description
0x00	NO_POWER_NOTIFICATION	Power off notification is not supported by host, device shall not assume any notification
0x01	POWERED_ON	Host shall notify before powering off the device, and keep power supplies alive and active until then
0x02	POWER_OFF_SHORT	Host is going to power off the device, The device shall respond within GENERIC_CMD6_TIME.
0x03	POWER_OFF_LONG	Host is going to power off the device The device shall respond within POWER_OFF_LONG_TIME.
0x04	SLEEP_NOTIFICATION	Host is going to put the device in Sleep Mode. The device shall respond within SLEEP_NOTIFICATION_TIME

#### 7.4.104 CACHE\_CTRL [33]

The cache shall be turned ON and OFF by writing the CACHE\_EN bit. The status of CACHE\_CTRL can be read from this byte.

Bit [7:1]: Reserved

Bit [0]: CACHE\_EN

0x0: Cache is OFF

0x1: Cache is ON

**Table 168 — CACHE\_ENABLE**

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Reserved						CACHE_EN	

#### 7.4.105 FLUSH\_CACHE [32]

Data in the cache shall be flushed to the non-volatile storage by setting the FLUSH bit.

Bit [7:1]: Reserved

Bit [0]: FLUSH

0x0: Reset value

0x1: Triggers the flush

**Table 169 — FLUSH CACHE**

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Reserved							FLUSH

#### 7.4.106 MODE\_CONFIG [30]

Using this field the host can change the mode of the device

**Table 170 — Valid MODE\_CONFIG values**

Value	Name	Description
0x00	Normal Mode	To keep the compatibility
0x01	FFU Mode	
0x10	Vendor Specific Mode	
Others	Reserved	

#### 7.4.107 MODE\_OPERATION\_CODES [29]

Using this field the host sets the operation to be performed at the selected mode.

In case MODE\_CONFIG is set to FFU Mode, MODE\_OPERATION\_CODES could have the following values:

**Table 171 — Valid MODE\_OPERATION\_CODES values**

Value	Name	Description
0x00	Reserved	
0x01	FFU_INSTALL	
0x02	FFU_ABORT	
Others	Reserved	

#### **7.4.108 FFU\_STATUS [26]**

Using this field the device reports the status of the FFU process

**Table 172 — FFU Status codes**

Value	Description
0x00	Success
0x01 – 0xF	Reserved
0x10	General error
0x11	Firmware install error
0x12	Error in downloading firmware
Others	Reserved

#### **7.4.109 PRE\_LOADING\_DATA\_SIZE [25-22]**

This filed is used to set the size of the contents to be loaded on to the device during pre-loading.

PRE\_LOADING\_DATA\_SIZE represents the number of sectors which the host is expected to write to all partitions in the pre-soldering state.

$$\text{Pre\_Loading\_Data\_Size} = \text{PRE\_LOADING\_DATA\_SIZE} * \text{Sector Size}$$

If PRE\_LOADING\_DATA\_SIZE is 0xFFFFFFFF, the ranges that can be covered by the parameter are::

- If Sector size is 512 bytes - Pre>Loading>Data\_Size=  $(2^{32}-1) * 512B = 2TB$
- If Sector size is 4K bytes - Pre>Loading>Data\_Size=  $(2^{32}-1) * 4KB = 16TB$

NOTE Host should set the value of PRE\_LOADING\_DATA\_SIZE not to exceed the value of MAX\_PRE\_LOADING\_DATA\_SIZE. In case the value of the PRE\_LOADING\_DATA\_SIZE exceeds the value of the MAX PRE\_LOADING\_DATA\_SIZE, device shall generate switch error and the value will not be set.

#### **7.4.110 MAX\_PRE\_LOADING\_DATA\_SIZE [21-18]**

This field indicates the maximum data size that can be loaded to the device. This value shall be set by the device vendor.

$$\text{Max\_Pre\_Loading\_Data\_Size} = \text{MAX PRE\_LOADING\_DATA\_SIZE} * \text{Sector Size}$$

If MAX\_PRE\_LOADING\_DATA\_SIZE is 0xFFFFFFFF, the ranges that can be covered by the parameter are:

- If Sector size is 512 bytes – Max Pre>Loading>Data\_Size=  $(2^{32}-1) * 512B = 2TB$
- If Sector size is 4K bytes – Max Pre>Loading>Data\_Size=  $(2^{32}-1) * 4KB = 16TB$

NOTE For RPMB partition each data frame which contains 256 bytes of data is counted in PRE\_LOADING\_DATA\_SIZE as one sector.

#### **7.4.111 PRODUCT\_STATE\_AWARENESS\_ENABLEMENT [17]**

This field is composed of 2 sub-fields:

- Capabilities [0:3] used to indicate the capabilities of product state awareness. Host should refer this value to decide which mode can be used by the host vendor. This sub-field is read only. In case the host enables a mode which is not supported by the device a switch error shall be returned by the device.
    - Bit 0 – ‘1’ indicates that Manual mode is supported by the device
    - Bit 1 - ‘1’ indicates that Auto mode is supported by the device
  - Enablement [4:7] Host will enable the product state awareness feature by setting this register
    - Bit 4
      - ‘0’ - Production State Awareness is disabled.
      - ‘1’ - Production State Awareness is enabled.
    - Bit 5
      - ‘0’ – Manual mode is enabled.
      - ‘1’ – Auto mode is enabled.

**NOTE** Bit 5 is ignored by the device when bit 4 is set to '0'.

#### **7.4.112 SECURE\_REMOVAL\_TYPE [16]**

This field indicates that how information is removed from the physical memory during a Purge operation. The first 4 bits(Bit0~Bit3) indicate the capability of the e•MMC device. The next two bit indicates configurable option. It can be set once during system integration by host.

**Table 173 — Secure Removal Type**

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Reserved	Configure Secure Removal Type			Supported Secure Removal Type			
	R/W			R			

Supported Secure Removal Type

Bit [7:6]: Reserved

Bit [5:4]: Configure Secure Removal Type

0x0: information removed by an erase of the physical memory

0x1: information removed by an overwriting the addressed locations with a character followed by an erase

0x2: information removed by an overwriting the addressed locations with a character, its complement, then a random character

0x3: information removed using a vendor defined

Bit [3:0]: Supported Secure Removal Type

Bit 0: information removed by an erase of the physical memory

Bit 1: information removed by an overwriting the addressed locations with a character followed by an erase

Bit 2: information removed by an overwriting the addressed locations with a character, its complement, then a random character

Bit 3: information removed using a vendor defined.

#### **7.4.113 VENDOR\_SPECIFIC\_FIELD [127:64]**

The purpose and type of these fields are reserved for definition by the device manufacturer.

### **7.5     RCA register**

The writable 16-bit relative Device address (RCA) register carries the Device address assigned by the host during the Device identification. This address is used for the addressed host-Device communication after the Device identification procedure. The default value of the RCA register is 0x0001. The value 0x0000 is reserved to set all Devices into the *Stand-by State* with CMD7.

### **7.6     DSR register**

The 16-bit driver stage register (DSR) is described in detail in 0. It can be optionally used to improve the bus performance for extended operating conditions (depending on parameters like bus length, transfer rate or number of Devices). The CSD register carries the information about the DSR register usage. The default value of the DSR register is 0x404.

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## 8 Error protection

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The CRC is intended for protecting *e*•MMC commands, responses and data transfer against transmission errors on *e*•MMC bus. One CRC is generated for every command and checked for every response on the CMD line. For data blocks one CRC per transferred block is generated.

### 8.1 Error correction codes (ECC)

In order to detect data defects on the Devices the host may include error correction codes in the payload data. For error free devices this feature is not required. With the error correction implemented off Device, an optimal hardware sharing can be achieved. On the other hand the variety of codes in a system must be restricted or one will need a programmable ECC controller, which is beyond the intention of a *e*•MMC adapter.

If an *e*•MMC requires external error correction (external means outside of the Device), then an ECC algorithm has to be implemented in the *e*•MMC host. The DEFAULT\_ECC field in the CSD register defines the recommended ECC algorithm for the Device.

The shortened BCH (542,512) code was chosen for matching the requirement of having high efficiency at lowest costs. Table 174 gives a brief overview of this code.

**Table 174 — Error correction codes**

Parameter	Value
Code type	Shortened BCH (542,512) code
Payload block length	512 bit
Redundancy	5.5%
Number of correctable errors in a block	3
Codec complexity (error correction in HW)	Encoding + decoding: 5k gates
Decoding latency (HW @ 20MHz)	< 30 microSec
Codec gate count (error detection in HW, error correction in SW-only if block erroneous)	Encoding + error detection: ~ 1k gates Error correction: ~ 20 SW instructions/each bit of the erroneous block
Codec complexity (SW only)	Encoding: ~ 6 instructions/bit Error detection: ~ 8 instructions/bit Error correction: ~ 20 instructions/each bit of erroneous block

As the ECC blocks are not necessarily byte-aligned, bit stuffing is used to align the ECC blocks to byte boundaries. For the BCH (542,512) code, there are two stuff bits added at the end of the 542-bits block, leading to a redundancy of 5.9%.

### 8.2 Cyclic redundancy codes (CRC)

The CRC is intended for protecting *e*•MMC commands, responses and data transfer against transmission errors on the *e*•MMC bus. One CRC is generated for every command and checked for every response on the CMD line. For data blocks one CRC per transferred block, per data line, is generated. The CRC is generated and checked as described in the following.

### 8.2.1 CRC7

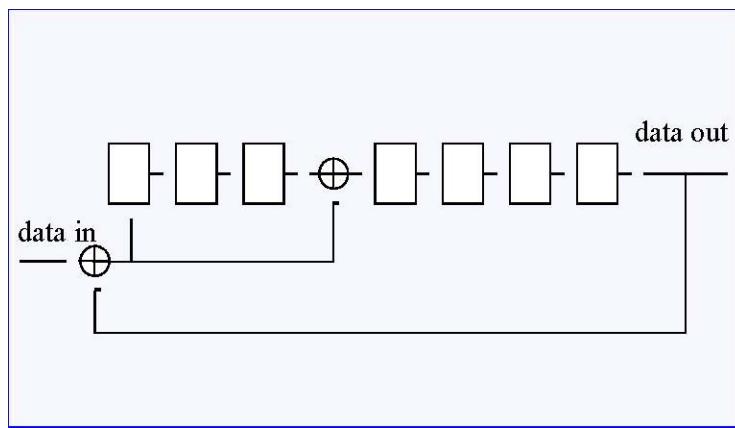
The CRC7 check is used for all commands, for all responses except type R3, and for the CSD and CID registers. The CRC7 is a 7-bit value and is computed as follows:

$$\text{Generator polynomial } G(x) = x^7 + x^3 + 1$$

$$M(x) = (\text{first bit}) \times x^n + (\text{second bit}) \times x^{n-1} + \dots + (\text{last bit}) \times x^0$$

$$\text{CRC [6:0]} = \text{Remainder}[(M(x) \times x^7) / G(x)]$$

All CRC registers are initialized to zero. The first bit is the most left bit of the corresponding bit string (of the command, response, CID or CSD). The degree  $n$  of the polynomial is the number of CRC protected bits decreased by one. The number of bits to be protected is 40 for commands and responses ( $n = 39$ ), and 120 for the CSD and CID ( $n = 119$ ).



**Figure 64 — CRC7 generator/checker**

### 8.2.2 CRC16

The CRC16 is used for payload protection in block transfer mode. The CRC check sum is a 16-bit value and is computed as follows:

$$\text{Generator polynomial } G(x) = x^{16} + x^{12} + x^5 + 1$$

$$M(x) = (\text{first bit}) \times x^n + (\text{second bit}) \times x^{n-1} + \dots + (\text{last bit}) \times x^0$$

$$\text{CRC [15:0]} = \text{Remainder}[(M(x) \times x^{16}) / G(x)]$$

CRC registers are initialized to zero. The first bit is the first data bit of the corresponding block. The degree  $n$  of the polynomial denotes the number of bits of the data block decreased by one (e.g.,  $n = 4095$  for a block length of 512 bytes). The generator polynomial  $G(x)$  is a standard CCITT polynomial. The code has a minimal distance  $d=4$  and is used for a payload length of up to 2048 Bytes ( $n \leq 16383$ ).

The same CRC16 calculation is used for all bus configurations. In 4 bit and 8 bit bus configurations, the CRC16 is calculated for each line separately. Sending the CRC is synchronized so the CRC code is transferred at the same time in all lines.

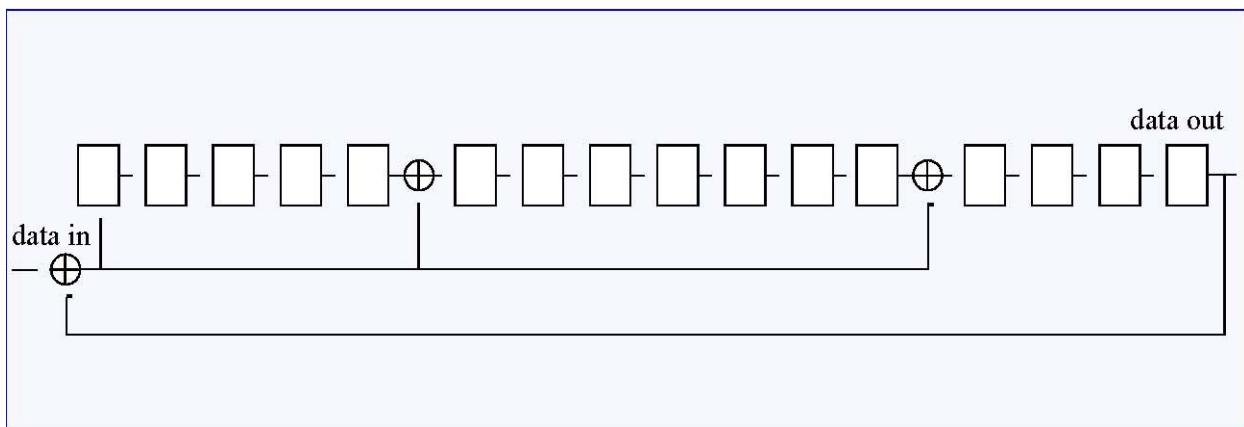


Figure 65 — CRC16 generator/checker

**9      *e*•MMC mechanical standard**

*e*•MMC Mechanical Standard JESD84-C44

There are two types of *e*•MMC ball outs defined for *e*•MMC. One ballout supports *e*•MMC devices while the second ballout only supports *e*<sup>2</sup>•MMC Devices.

## 10 The e•MMC bus

The e•MMC bus has eleven communication lines:

- CMD: Command is a bidirectional signal. The host and Device drivers are operating in two modes, open drain and push/pull.
- DAT0-7: Data lines are bidirectional signals. Host and Device drivers are operating in push-pull mode
- CLK: Clock is a host to Device signal. CLK operates in push-pull mode
- Data Strobe: Data Strobe is a Device to host signal. Data Strobe operates in push-pull mode.

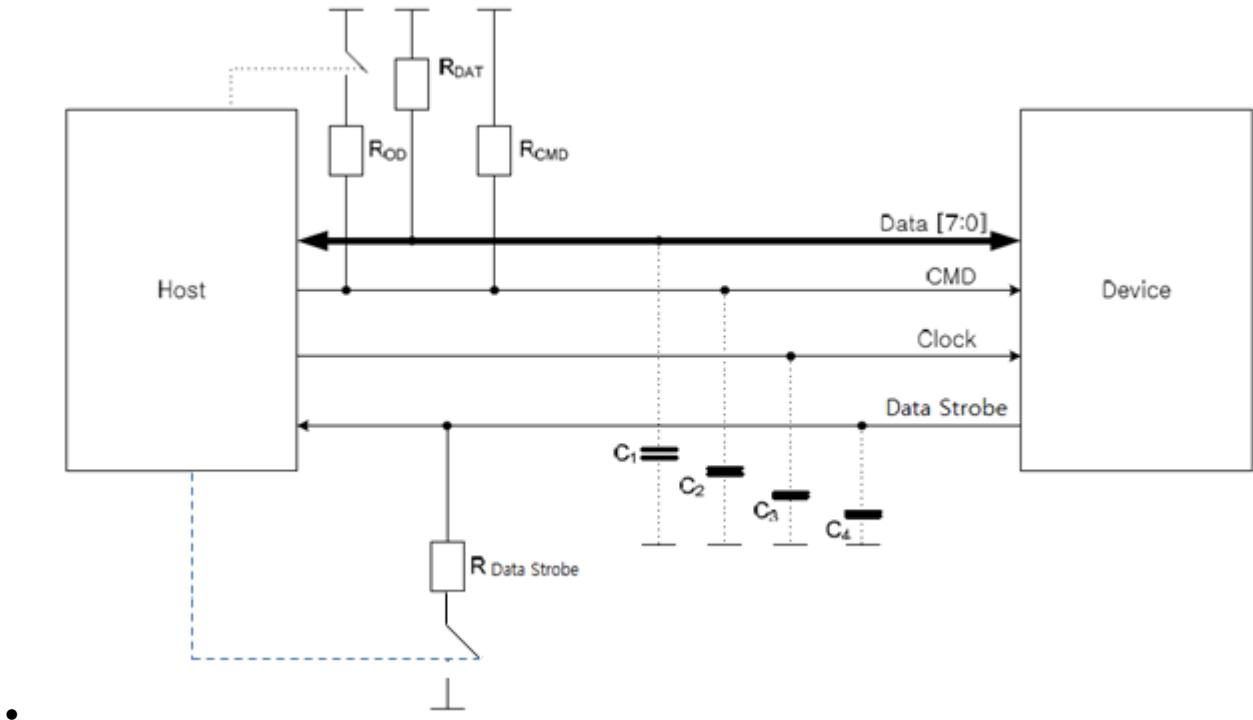


Figure 66 — Bus circuitry diagram

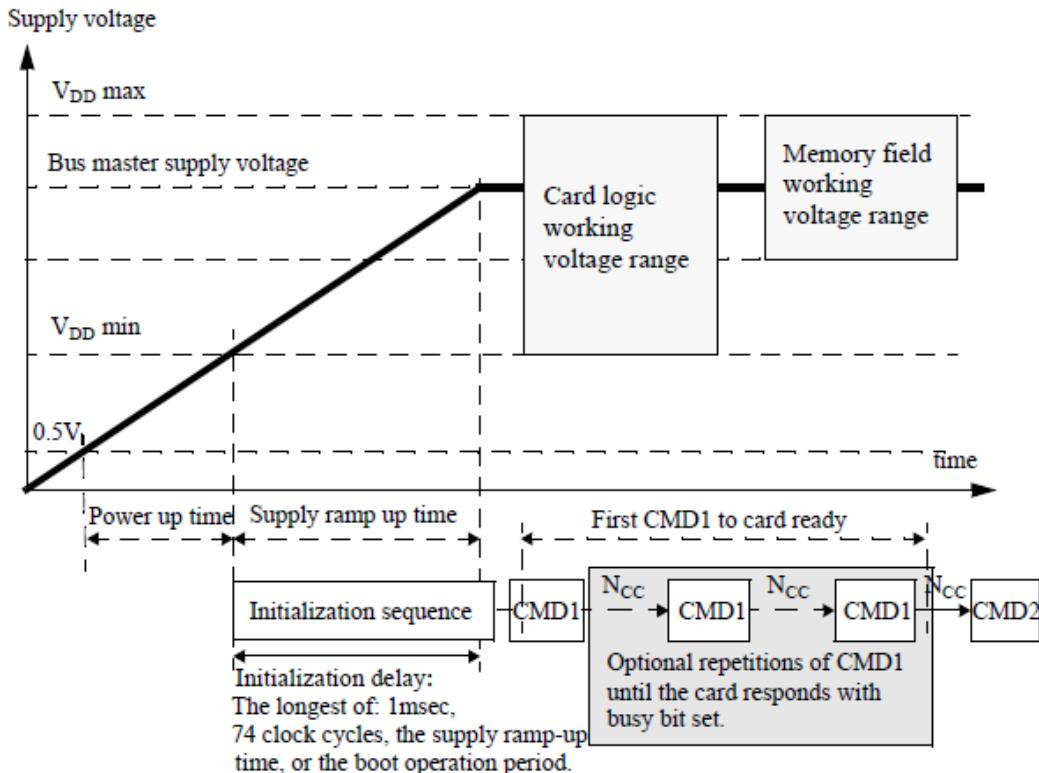
The  $R_{OD}$  is switched on and off by the host synchronously to the open-drain and push-pull mode transitions. The host does not have to have open drain drivers, but must recognize this mode to switch on the  $R_{OD}$ .  $R_{DAT}$  and  $R_{CMD}$  are pull-up resistors protecting the CMD and the DAT lines against bus floating device when all device drivers are in a high-impedance mode.

A constant current source can replace the  $R_{OD}$  by achieving a better performance (constant slopes for the signal rising and falling edges). If the host does not allow the switchable  $R_{OD}$  implementation, a fixed  $R_{CMD}$  can be used). Consequently the maximum operating frequency in the open drain mode has to be reduced if the used  $R_{CMD}$  value is higher than the minimal one given in.

$R_{Data\ Strobe}$  is pull-down resistor used in HS400 device.

## 10.1 Power-up

The power up of the e•MMC bus is handled locally in the Device and in the bus master.



**Figure 67 — Power-up diagram**

- After power up (including hot insertion, i.e., inserting a Device when the bus is operating), the Device enters the *pre-idle* state. The power up time of the supply voltage should be less than the specified tPRU for the Bus master supply voltage.
- If the Device does not support boot mode, or its BOOT\_PARTITION\_ENABLE bit is cleared, the Device moves immediately to the *idle* state. While in the *idle* state, the Device ignores all bus transactions until CMD1 is received. If the Device supports only standard v4.2 or earlier versions, it enters the *idle* state immediately following power-up.
- If the Device BOOT\_PARTITION\_ENABLE bit is set, the Device moves to the *pre-boot* state. The Device then waits for boot initiation sequence. Following the boot operation period, the Device enters the *idle* state. During the *pre-boot* state, if the Device receives any CMD line transaction other than CMD1 or the boot initiation sequence (keeping the CMD line low for at least 74 clock cycles, or issuing CMD0 with the argument of 0xFFFFFFFFFA), the Device moves to the *idle* state. If the Device receives the boot initiation sequence (keeping the CMD line low for at least 74 clock cycles, or issuing CMD0 with the argument of 0xFFFFFFFFFA), the Device begins boot operation. If boot acknowledge is enabled, the Device shall send acknowledge pattern “010” to the host within the specified time. After boot operation is terminated, the Device enters the *idle* state and shall be ready for CMD1 operation. If the Device receives CMD1 in the *pre-boot* state, it begins responding to the command and moves to Device identification mode.
- While in the *idle* state, the Device ignores all bus transactions until CMD1 is received.

### 10.1 Power-up (cont'd)

- The maximum initial load (after power up or hot insertion) that the *e*MMC can present on the VDD line shall be a maximum of 10 uF in parallel with a minimum of 330 ohms. At no time during operation shall the Device capacitance on the VDD line exceed 10 uF.
- CMD1 is a special synchronization command used to negotiate the operation voltage range and to poll the Device until it is out of its power-up sequence. Besides the operation voltage profile of the Device, the response to CMD1 contains a busy flag, indicating that the Device is still working on its power-up procedure and is not ready for identification. This bit informs the host that the Device is not ready. The host has to wait until this bit is cleared.
  - The Device shall complete its initialization within 1 second from the first CMD1 with a valid OCR range if boot operation is not executed.
  - Getting the Device out of *idle* state is up to the responsibility of the bus master. Since the power up time and the supply ramp up time depend on application parameters as the bus length and the power supply unit, the host must ensure that the power is built up to the operating level (the same level which will be specified in CMD1) before CMD1 is transmitted.
  - After power up the host starts the clock and sends the initializing sequence on the CMD line. The sequence length is the longest of: 1msec, 74 clocks, the supply-ramp-up-time, or the boot operation period. The additional 10 clocks (over the 64 clocks after what the Device should be ready for communication) is provided to eliminate power-up synchronization problems.
  - Every bus master has to implement CMD1. The CMD1 implementation is mandatory for all *e*MMCs.

### 10.1.1 e•MMC power-up

An e•MMC bus power-up is handled locally in each device and in the bus master. Figure 68 shows the power-up sequence and is followed by specific instructions regarding the power-up sequence

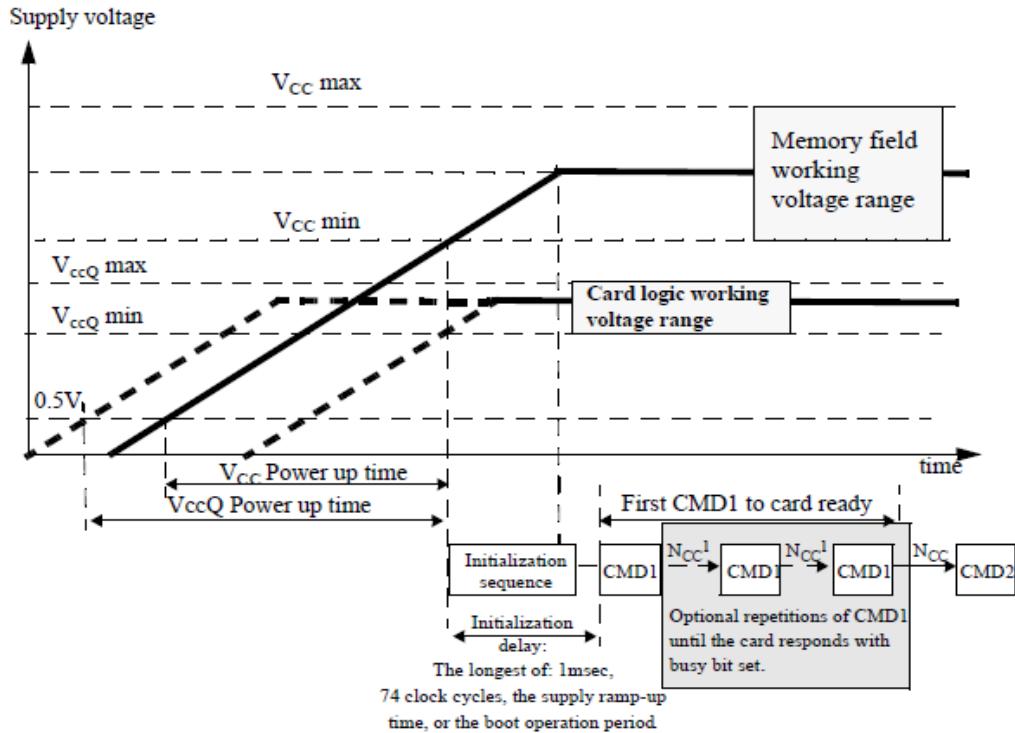


Figure 68 — e•MMC power-up diagram

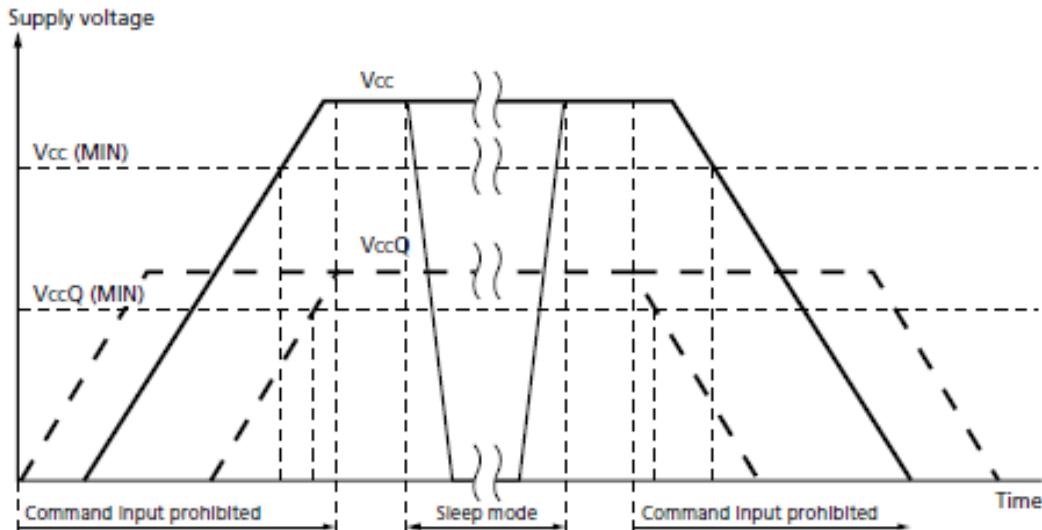
### 10.1.2 e•MMC power-up guidelines

An e•MMC power-up must adhere to the following guidelines:

- When power-up is initiated, either  $V_{cc}$  or  $V_{cc}Q$  can be ramped up first, or both can be ramped up simultaneously.
- After power up, the e•MMC enters the *pre-idle* state. The power up time of each supply voltage should be less than the specified tPRU (tPRUH, tPRUL or tPRUV) for the appropriate voltage range.
- If the e•MMC does not support boot mode or its BOOT\_PARTITION\_ENABLE bit is cleared, the e•MMC moves immediately to the *idle* state. While in the *idle* state, the e•MMC ignores all bus transactions until CMD1 is received. If the e•MMC supports only standard v4.2 or earlier versions, the device enters the *idle* state immediately following power-up.
- If the BOOT\_PARTITION\_ENABLE bit is set, the e•MMC moves to the *pre-boot* state, and the e•MMC waits for the boot-initiation sequence. Following the boot operation period, the e•MMC enters the *idle* state. During the *pre-boot* state, if the e•MMC receives any CMD-line transaction other than the boot initiation sequence (keeping CMD line low for at least 74 clock cycles, or issuing CMD0 with the argument of 0xFFFFFFF0) and CMD1, the e•MMC moves to the *Idle* state. If e•MMC receives the boot initiation sequence (keeping the CMD line low for at least 74 clock cycles, or issuing CMD0 with the argument of 0xFFFFFFF0), the e•MMC begins boot operation. If boot acknowledge is enabled, the e•MMC shall send acknowledge pattern “010” to the host within the specified time. After boot operation is terminated, the e•MMC enters the *idle* state and shall be ready for CMD1 operation. If the e•MMC receives CMD1 in the *pre-boot* state, it begins responding to the command and moves to the Device identification mode.
- While in the *idle* state, the e•MMC ignores all bus transactions until CMD1 is received.
- CMD1 is a special synchronization command used to negotiate the operation voltage range and to poll the device until it is out of its power-up sequence. In addition to the operation voltage profile of the device, the response to CMD1 contains a busy flag indicating that the device is still working on its power-up procedure and is not ready for identification. This bit informs the host that the device is not ready, and the host must wait until this bit is cleared. The device must complete its initialization within 1 second of the first CMD1 issued with a valid OCR range.
  - If the e•MMC device was successfully partitioned during the previous power up session (bit 0 of EXT\_CSD byte [155] PARTITION\_SETTING\_COMPLETED successfully set) then the initialization delay is (instead of 1s) calculated from INI\_TIMEOUT\_PA (EXT\_CSD byte [241]). This timeout applies only for the very first initialization after successful partitioning. For all the consecutive initialization 1sec timeout will apply.
- The bus master moves the device out of the *idle* state. Because the power-up time and the supply ramp-up time depend on application parameters such as the bus length and the power supply unit, the host must ensure that power is built up to the operating level (the same level that will be specified in CMD1) before CMD1 is transmitted.
- After power-up, the host starts the clock and sends the initializing sequence on the CMD line. The sequence length is the longest of: 1ms, 74 clocks, the supply ramp-up time, or the boot operation period. An additional 10 clocks (beyond the 64 clocks of the power-up sequence) are provided to eliminate power-up synchronization problems.
- Every bus master must implement CMD1.
- All above rules apply also for e<sup>2</sup>•MMC ( $V_{CC}$  and  $V_{CCQ}$ ). In addition the e<sup>2</sup>•MMC D-V<sub>DD</sub> must ramp up before D-V<sub>DDQ</sub>. There is no restriction for order of ramping up  $V_{CC}/V_{CCQ}$  versus D-V<sub>DD</sub>/D-V<sub>DDQ</sub>.

### 10.1.3 e•MMC power cycling

The master can execute any sequence of  $V_{cc}$  and  $V_{ccQ}$  power-up/power-down. However, the master must not issue any commands until  $V_{cc}$  and  $V_{ccQ}$  are stable within each operating voltage range. After the slave enters sleep mode, the master can power-down  $V_{cc}$  to reduce power consumption. It is necessary for the slave to be ramped up to  $V_{cc}$  before the host issues CMD5 (SLEEP\_AWAKE) to wake the slave unit.



**Figure 69 — e•MMC power cycle**

If  $V_{CC}$  or  $V_{CCQ}$  are below 0.5 V for longer than 1 ms, the slave shall always return to the *pre-idle* state, and perform the appropriate boot behavior, as appropriate. The slave will behave as in a standard power-up condition once the voltages have returned to their functional ranges.

An exception to this behavior is if the device is in sleep state, in which the voltage on  $V_{CC}$  is not monitored.

In addition to the above rules, in case of  $e^2\text{-MMC}$ , the  $D-V_{DDQ}$  shall be ramped down before  $D-V_{DD}$  and also  $D-V_{DDQ}$  /  $D-V_{DD}$  shall both be in stable state within the operation voltage range before any commands may be issued. Both  $D-V_{DDQ}$  and  $D-V_{DD}$  may be powered-down while the device is in Sleep state. Still again both  $D-V_{DDQ}$  and  $D-V_{DD}$  shall be powered-up before host issues CMD5 to wake-up the slave device.

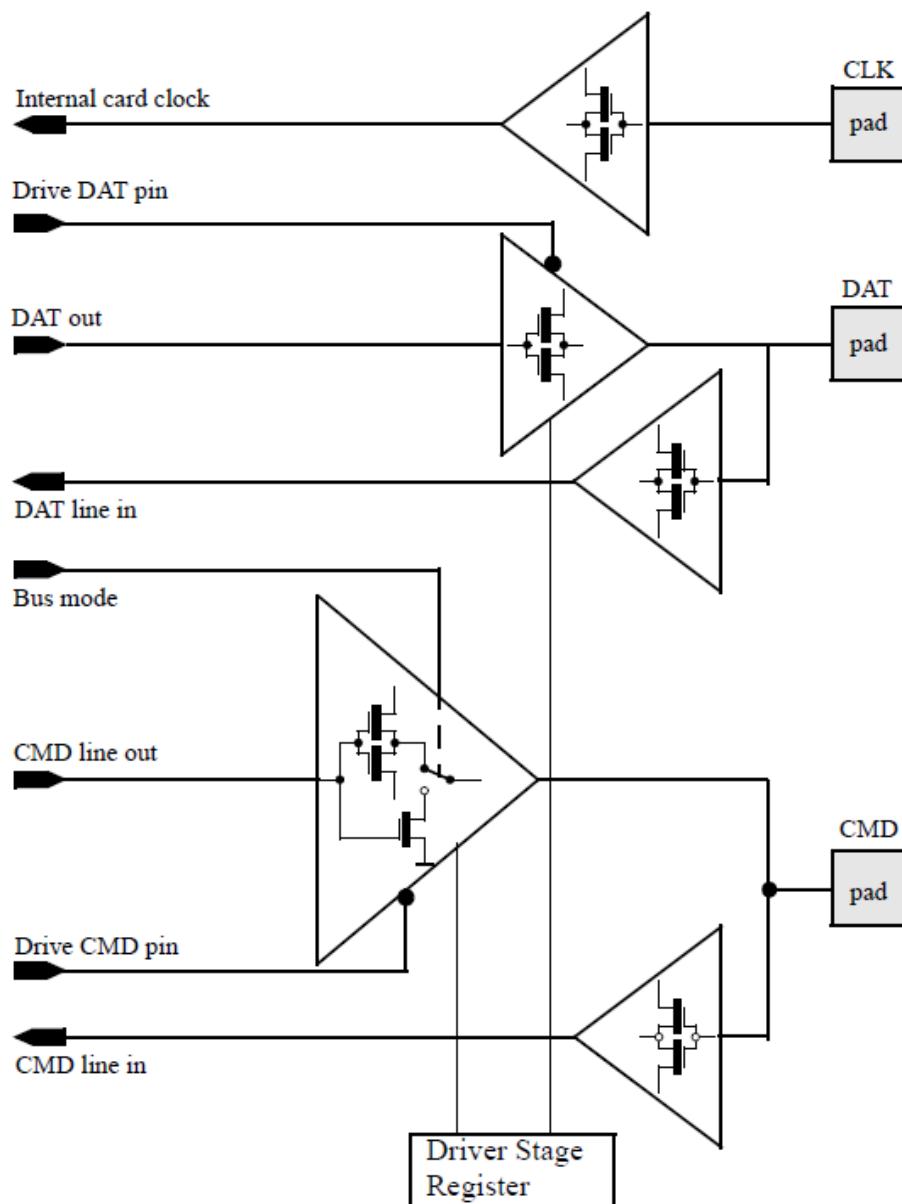
## 10.2 Programmable Device output driver

The bus capacitance of each line of the *e*•MMC bus is the sum of the bus master capacitance, the bus capacitance itself and the capacitance of each inserted Device. The sum of host and bus capacitance are fixed for one application, but may vary between different applications. The Device load may vary in one application with each of the inserted Devices.

The CMD and DAT bus drivers consist of a pre-driver stage and a complementary driver transistor (Figure 70). The DSR register is used to configure the pre-driver stage output rise and fall time, and the complementary driver transistor size. The proper combination of both allows optimum bus performance. Table 175 — defines the DSR register contents:

**Table 175 — DSR register content**

## 10.2 Programmable Device output driver (cont'd)



**Figure 70 — eMMC bus driver**

All data is valid for the specified operating range (voltage, temperature). The DSR register has two byte codes (e.g., bits 0-7 = 0x02, bits 8-15 = 0x01) that define specific min and max values for the switching speed and current drive of the register, respectively (actual values are TBD). Any combination of switching speed and driving force may be programmed. The selected speed settings must be in accordance with the system frequency. The following relationship must be kept:

$$t_{\text{switch-on-max}}^{\pm 0.4 * (\text{FOD})-1}$$

### 10.3 Bus operating conditions

Table 176 — General operating conditions

Parameter	Symbol	Min	Max.	Unit	Remark
Peak voltage on all lines		-0.5	VCCQ + 0.5	V	
<b>All Inputs</b>					
Input Leakage Current (before initialization sequence and/or the internal pull up resistors connected)		-100	100	µA	
Input Leakage Current (after initialization sequence and the internal pull up resistors disconnected)		-2	2	µA	
<b>All Outputs</b>					
Output Leakage Current (before initialization sequence)		-100	100	µA	
Output Leakage Current (after initialization sequence)		-2	2	µA	
NOTE 1 Initialization sequence is defined in 10.1					

#### 10.3.1 Power supply: e•MMC

In the e•MMC, VCC is used for the memory device; VCCQ is for the controller and the MMC interface voltage. Either VCC or VCCQ is for memory interface voltage shown in Figure 71. The core regulator is optional and only required when internal core logic voltage is regulated from VCCQ. A Creg capacitor must be connected to the VDDi terminal to stabilize regulator output on the system.

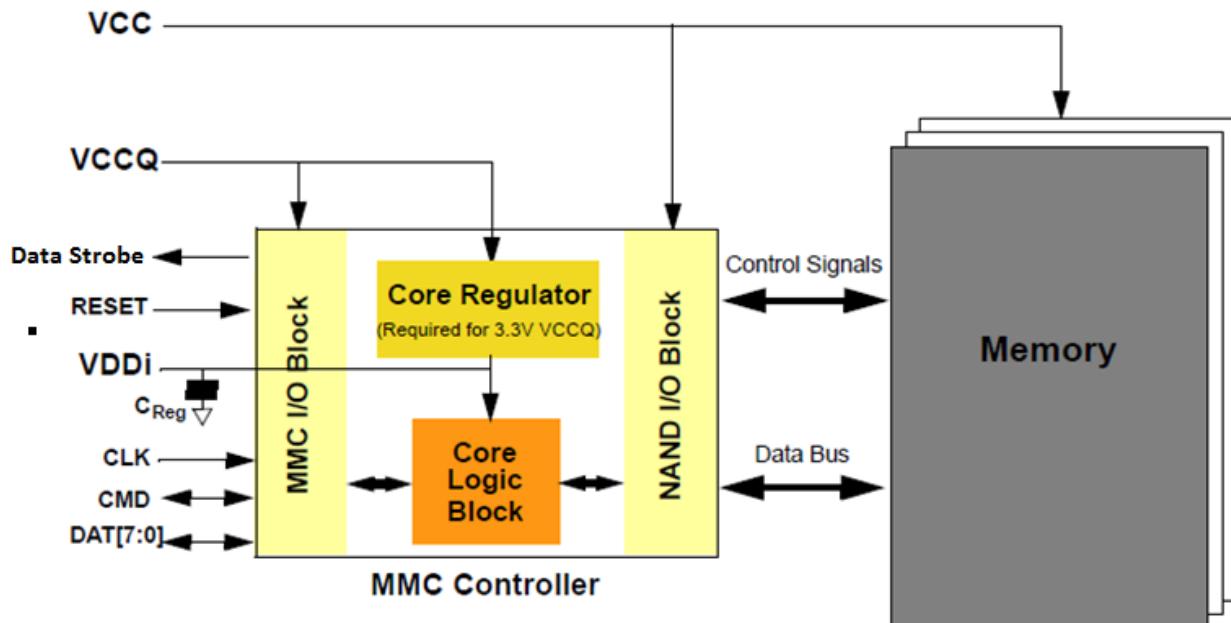


Figure 71 — e•MMC internal power diagram (as an example)

### 10.3.2 Power supply: e<sup>2</sup>•MMC

In the e<sup>2</sup>•MMC, VCC is used for the memory device; VCCQ is for the controller and the MMC. Either VCC or VCCQ is used for memory interface voltage shown in Figure 72. The core regulator is optional and only required when internal core logic voltage is regulated from VCCQ. A Creg capacitor must be connected to the VDDi terminal to stabilize regulator output on the system.

D-V<sub>DDQ</sub> and D-V<sub>DD</sub> are for the cache memory. D-V<sub>DD</sub> is for the core of the cache memory and D-V<sub>DDQ</sub> for the IO between memory controller and cache memory.

VDDi2 and VDDi3 are other internal voltage terminals. Each of those is generated from one of the external power supplies through a regulator to reduce power consumption or to avoid noise interference internally. Creg2 and Creg3 capacitors must be connected to VDDi2 and VDDi3 respectively. These are device optional for e<sup>2</sup>•MMC devices.

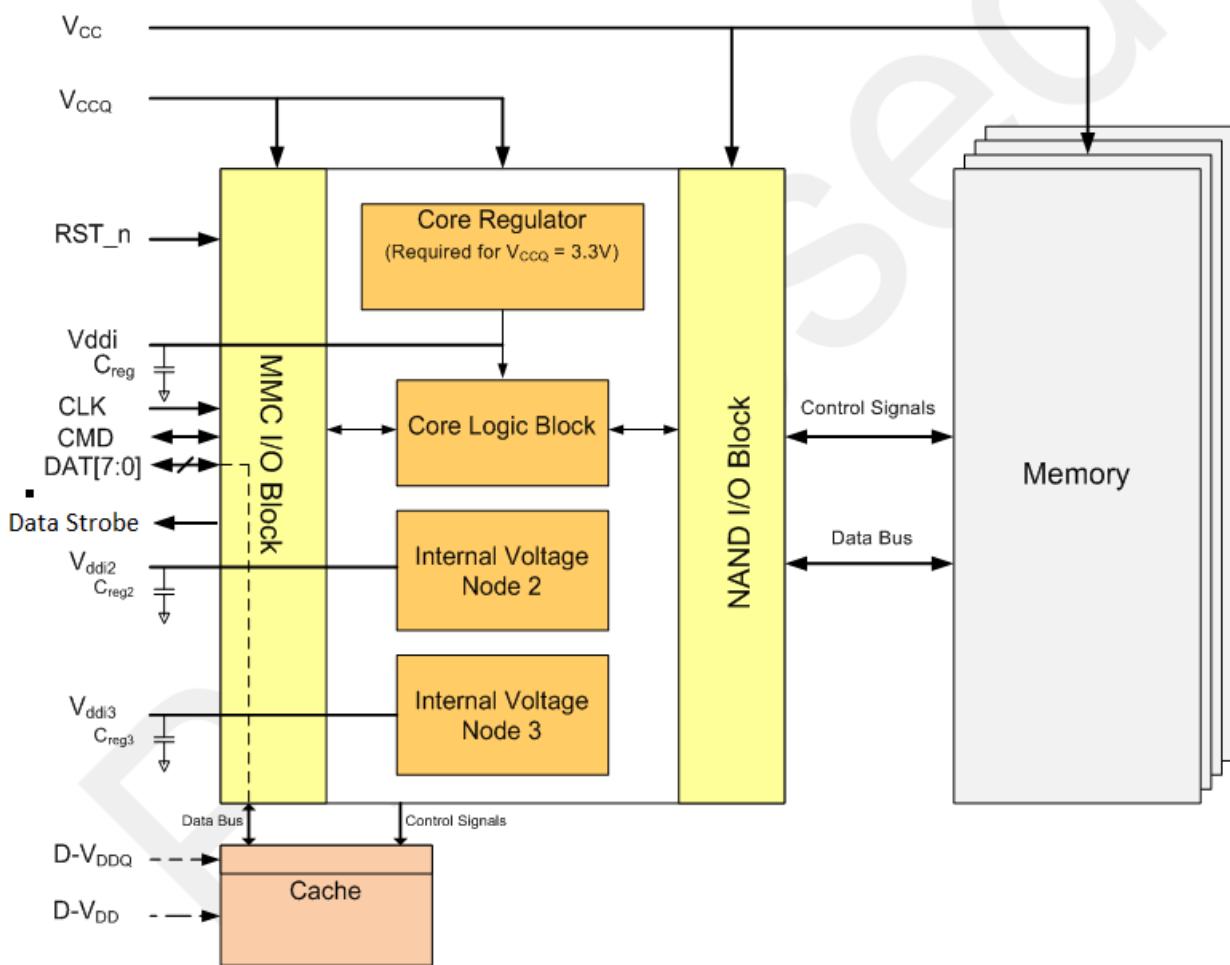


Figure 72 — e<sup>2</sup>•MMC internal power diagram (as an example)

### 10.3.3 Power supply Voltages

The *e*•MMC supports one or more combinations of  $V_{cc}$  and  $V_{cc}Q$  and either combinations of D- $V_{DDQ}$  and D- $V_{DD}$  as shown in Table 177 — . The  $V_{cc}Q$  must be defined at equal to or less than  $V_{cc}$ . The available voltage configuration is shown in Table 178 — .

**Table 177 — *e*•MMC power supply voltage**

Parameter	Symbol	Min	Max	Unit	Remarks
Supply voltage (NAND)	$V_{CC}$	2.7	3.6	V	
		1.7	1.95	V	
Supply voltage (I/O)	$V_{CCQ}$	2.7	3.6	V	
		1.70	1.95	V	
		1.1	1.3	V	
Supply voltage (cache) ( <i>e</i> <sup>2</sup> •MMC)	$D-V_{DD}$	1.7	1.9	V	
Supply voltage (cache IO) ( <i>e</i> <sup>2</sup> •MMC)	$D-V_{DDQ}$	1.7	1.9	V	
		1.14	1.3	V	
Supply power-up for 3.3V	tPRUH		35	ms	
Supply power-up for 1.8V	tPRUL		25	ms	
Supply power-up for 1.2V	tPRUV		20	ms	

The *e*•MMC must support at least one of the valid voltage configurations, and can optionally support all valid voltage configurations (see Table 178 — ).

**Table 178 — *e*•MMC voltage combinations**

		VccQ		
		1.1V–1.3V	1.70V–1.95V	2.7V–3.6V
$V_{cc}$	2.7V–3.6V	Valid	Valid	Valid (1)
	1.7V–1.95V	Valid	Valid	NOT VALID
(1) VccQ (I/O) 3.3 volt range is not supported in either HS200 or HS400 devices				

### 10.3.4 Bus signal line load

The total capacitance  $C_L$  of each line of the *e*•MMC bus is the sum of the bus master capacitance  $C_{HOST}$ , the bus capacitance  $C_{BUS}$  itself, and the capacitance  $C_{DEVICE}$  of the Device connected to this line,

$$C_L = C_{HOST} + C_{BUS} + C_{DEVICE}$$

and requiring the sum of the host and bus capacitances not to exceed 20 pF (see Table 179).

**Table 179 — Capacitance**

### 10.3.5 HS 400 reference load

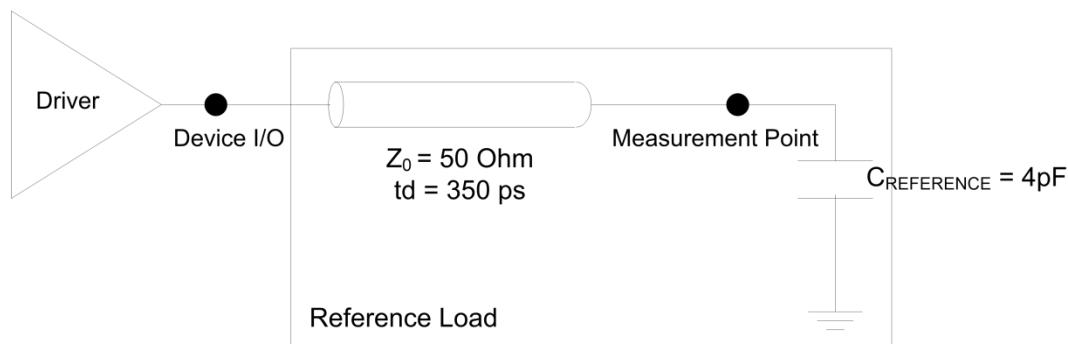
The circuit in Figure 73 shows the reference load used to define the HS400 Device Output Timings and overshoot / undershoot parameters.

The reference load is made up by the transmission line and the  $C_{\text{REFERENCE}}$  capacitance.

The reference load is not intended to be a precise representation of the typical system environment nor a depiction of the actual load presented by a production tester.

System designers should use IBIS or other simulation tools to correlate the reference load to system environment. Manufacturers should correlate to their production test conditions.

Delay time ( $td$ ) of the transmission line has been introduced to make the reference load independent from the PCB technology and trace length.



**Figure 73 — HS400 reference load**

#### 10.4 Overshoot/Undershoot Specification

		$V_{CCQ}$	Unit
		1.70V – 1.95V	
Maximum peak amplitude allowed for overshoot area. (See Figure 74)	Max	0.9	V
Maximum peak amplitude allowed for undershoot area. (See Figure 74)	Max	0.9	V
Maximum area above $V_{CCQ}$ (See Figure 74)	Max	1.5	V-ns
Maximum area below $V_{SSQ}$ (See Figure 74)	Max	1.5	V-ns

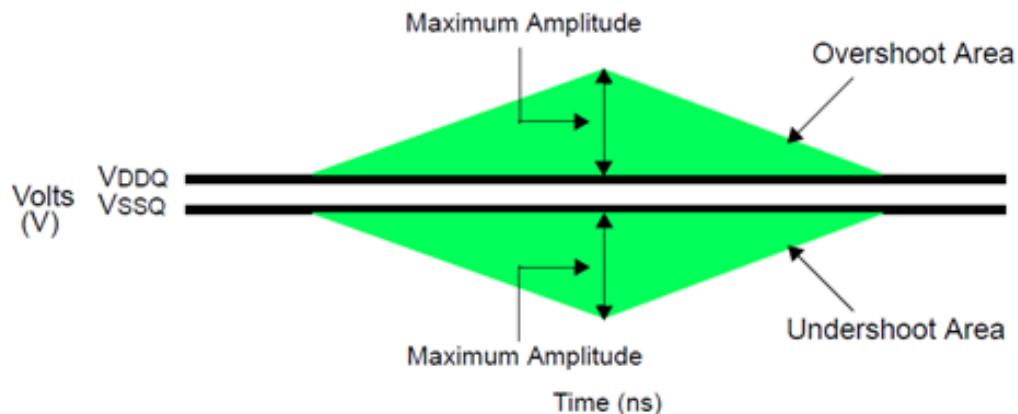


Figure 74 — Overshoot/Undershoot definition

#### 10.5 Bus signal levels

As the bus can be supplied with a variable supply voltage, all signal levels are related to the supply voltage.

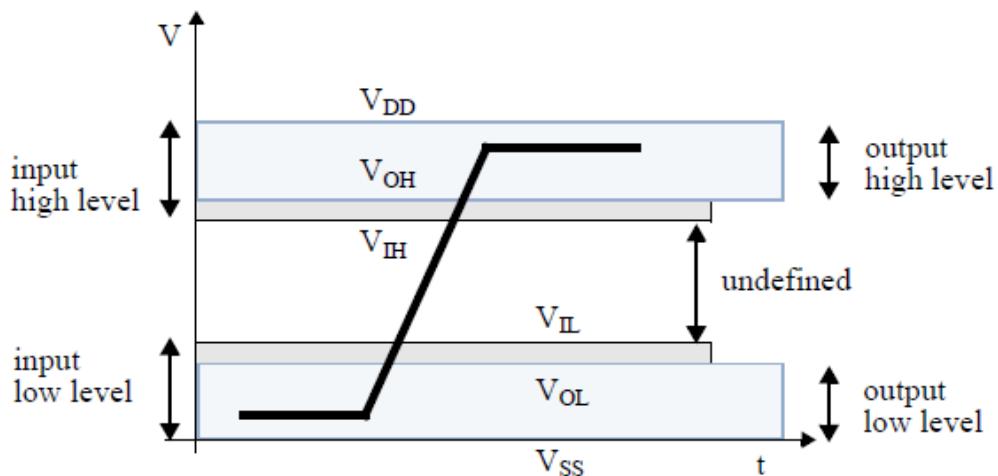


Figure 75 — Bus signal levels

### 10.5.1 Open-drain mode bus signal level

**Table 180 — Open-drain bus signal level**

Parameter	Symbol	Min	Max.	Unit	Conditions
Output HIGH voltage	V <sub>OH</sub>	V <sub>DD</sub> - 0.2		V	NOTE 1
Output LOW voltage	V <sub>OL</sub>		0.3	V	I <sub>OL</sub> = 2 mA

NOTE 1 Because V<sub>oh</sub> depends on external resistance value (including outside the package), this value does not apply as device specification. Host is responsible to choose the external pull-up and open drain resistance value to meet V<sub>oh</sub> Min value.

The input levels are identical with the push-pull mode bus signal levels.

### 10.5.2 Push-pull mode bus signal level—e•MMC

The device input and output voltages shall be within the following specified ranges for any V<sub>DD</sub> of the allowed voltage range

For 2.7V-3.6V V<sub>CCQ</sub> range (compatible with JESD8C.01)

**Table 181 — Push-pull signal level—high-voltage e•MMC**

Parameter	Symbol	Min	Max.	Unit	Conditions
Output HIGH voltage	V <sub>OH</sub>	0.75 * V <sub>CCQ</sub>		V	I <sub>OH</sub> = -100 μA @ V <sub>CCQ</sub> min
Output LOW voltage	V <sub>OL</sub>		0.125 * V <sub>CCQ</sub>	V	I <sub>OL</sub> = 100 μA @ V <sub>CCQ</sub> min
Input HIGH voltage	V <sub>IH</sub>	0.625 * V <sub>CCQ</sub>	V <sub>CCQ</sub> + 0.3	V	
Input LOW voltage	V <sub>IL</sub>	V <sub>SS</sub> - 0.3	0.25 * V <sub>CCQ</sub>	V	

For 1.70 V - 1.95V V<sub>CCQ</sub> range as defined in Table 182.

**Table 182 — Push-pull signal level—1.70 -1.95 VCCQ voltage Range**

Parameter	Symbol	Min	Max.	Unit	Conditions
Output HIGH voltage	V <sub>OH</sub>	V <sub>CCQ</sub> - 0.45V		V	I <sub>OH</sub> = -2mA
Output LOW voltage	V <sub>OL</sub>		0.45V	V	I <sub>OL</sub> = 2mA
Input HIGH voltage	V <sub>IH</sub>	0.65 * V <sub>CCQ</sub> (1)	V <sub>CCQ</sub> + 0.3	V	
Input LOW voltage	V <sub>IL</sub>	V <sub>SS</sub> - 0.3	0.35 * V <sub>DD</sub> (2)	V	

(1) 0.7 \* V<sub>DD</sub> for MMC4.3 and older revisions.  
(2) 0.3 \* V<sub>DD</sub> for MMC4.3 and older revisions.

For 1.1V-1.3V V<sub>CCQ</sub> range as defined in Table 183.

**Table 183 — Push-pull signal level—1.1V-1.3V VCCQ range e•MMC**

Parameter	Symbol	Min	Max.	Unit	Conditions
Output HIGH voltage	V <sub>OH</sub>	0.75*V <sub>CCQ</sub>		V	I <sub>OH</sub> = -2mA
Output LOW voltage	V <sub>OL</sub>		0.25*V <sub>CCQ</sub>	V	I <sub>OL</sub> = 2mA
Input HIGH voltage	V <sub>IH</sub>	0.65 * V <sub>CCQ</sub>	V <sub>CCQ</sub> + 0.3	V	
Input LOW voltage	V <sub>IL</sub>	V <sub>SS</sub> - 0.3	0.35 * V <sub>CCQ</sub>	V	

NOTE Both the 1.95 to 2.7 V range and the 1.3 V – 1.70 V are undefined. The e•MMC device does not operate at this voltage range.

### 10.5.3 Bus Operating Conditions for HS200 & HS400

The bus operating conditions for HS200 & HS400 devices is the same as specified in 10.5.1 through 10.5.2. The only exception is that V<sub>CCQ</sub>=3.3v is not supported.

### 10.5.4 Device Output Driver Requirements for HS200 & HS400

#### 10.5.4.1 Driver Types Definition

Driver Type-0 is defined as mandatory for e•MMC HS200 & HS400 Device While four additional Driver Types (1, 2, 3 and 4) are defined as optional, to allow the support of wider Host loads. The Host may select the most appropriate Driver Type of the Device (if supported) to achieve optimal signal integrity performance.

NOTE Drive strength definitions are same for 1.8V signaling level and for 1.2V signaling level.

Driver Type-0 is targeted for transmission line, based distributed system with  $50\Omega$  nominal line impedance. Therefore, it is defined as  $50\Omega$  nominal driver.

For HS200, when tested with  $C_L = 15\text{pF}$  Driver Type-0 shall meet all AC characteristics (see 10.5.4.2) and HS200 Device output timing requirements (see 10.8.3). The test circuit defined in 10.5.4.3 is used for testing of Driver Type-0.

For HS400, when tested with the reference load defined in 10.3.5, Driver Type-0 or Drive Type-1 or Drive Type-4 shall meet all AC characteristics (see 10.5.4.2) and HS400 Device output timing requirements (see 10.10.2).

The Optional Driver Types are defined with reference to Driver Type-0.

Table 184 — summarizes the nominal impedance characteristics for the five Driver Types.

**Table 184 — I/O driver strength types**

Driver Type Values	Support	Nominal Impedance	Approximated driving capability compared to Type-0	Remark
0x0	Mandatory	$50\Omega$	x1	Default Driver Type. Supports up to 200MHz operation.
0x1	Optional	$33\Omega$	x1.5	Supports up to 200MHz operation.
0x2	Optional	$66\Omega$	x0.75	The weakest driver that supports up to 200MHz operation.
0x3	Optional	$100\Omega$	x0.5	For low noise and low EMI systems. Maximal operating frequency is decided by Host design.
0x4	Optional	$40\Omega$	x1.2	

NOTE 1 Support of Driver Type-0 is mandatory for HS200 & HS400 device.

NOTE 2 Nominal impedance is defined by I-V characteristics of output driver at 0.9V when  $V_{CCQ} = 1.8V$ .

NOTE 3 Nominal impedance is defined by I-V characteristics of output driver at 0.6V when  $V_{CCQ} = 1.2V$ .

If Device supports the optional Driver Types, the Host may use them to optimize the signal integrity in its system. To do so, the Host designer may simulate its specific system, using a Device driver models. Host can select the optimal Driver Type that may drive the Host system load at the desired operating frequency with minimal noise generated.

#### 10.5.4.2 Driver Type-0 AC Characteristics

Table 185 — is the mandatory requirement from Driver Type-0, for HS200 & HS400 Device.

AC requirements for HS400 device are defined in 10.10.

The I-V curves (current-voltage characteristics) of Driver Types 1, 2, 3 and 4 are approximately x1.5, x0.75 and x0.5 from the default Driver Type-0.

**Table 185 — Driver Type-0 AC Characteristics**

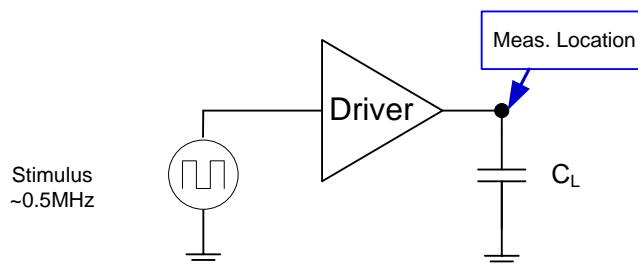
Parameter	Symbol	Min.	Typ.	Max.	Units	Remark
Rise/Fall Time	$T_{R0}, T_{F0}$	0.40	0.88	1.32	ns	$C_L = 15\text{pF}$ , Note1
Ratio of fall time to rise time	$R_{FR}$	0.7	1.0	1.4	-	$R_{FR} = T_{F0} / T_{R0}$ , Note2, 3

NOTE 1  $T_{R0}$  is measured between  $V_{OL}$  to  $V_{OH}$ ,  $T_{F0}$  is measured between  $V_{OH}$  to  $V_{OL}$ .

NOTE 2 Worst case  $R_{FR}$  is expected when the P and N CMOS processes are unbalanced.  $R_{FR}$  is defined for all possible specific operating condition points. ( $R_{FR}$  shall be verified individually for each valid operating point with fixed temperature, voltage and process condition)

#### 10.5.4.3 Driver Type-0 Test Circuit

The test circuit as describes in Figure 76 is used to verify driver characteristics defined in 10.5.4.2. Measured characteristics should meet specification under all corner conditions (process and environmental).



NOTE 1  $C_L$  is total equivalent lumped capacitance for each Driver.

NOTE 2  $C_L$  incorporates device die load, device package load and equivalent lumped load external to the device.

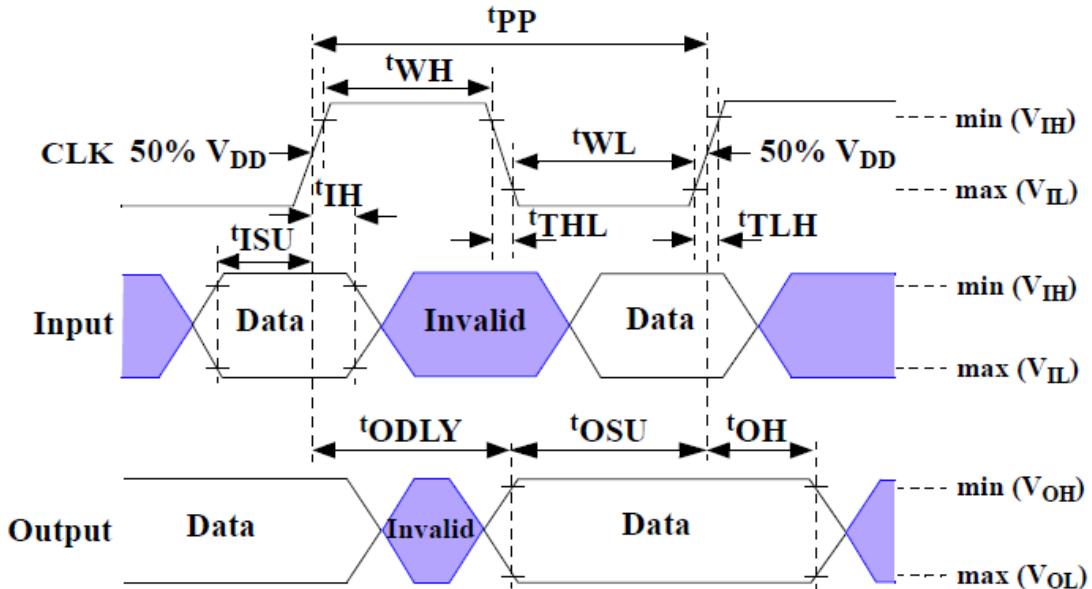
NOTE 3 In distributed transmission lines only part of the line capacitance considered as load for the Driver.

**Figure 76 — Outputs test circuit for rise/fall time measurement**

#### 10.5.4.4 Driver Type Selection

The levels of Driver Types supported by the device are indicated in the DRIVER\_STRENGTH [197] field of the Extended CSD register. The host sets the desired level by writing (through CMD6) to the "Selected Driver Strength" field in HS\_TIMING[185] byte of the Extended CSD register.

## 10.6 Bus timing



Data must always be sampled on the rising edge of the clock.

Figure 77 — Timing diagram: data input/output

### 10.6.1 Device interface timings

Table 186 — High-speed Device interface timing

Parameter	Symbol	Min	Max.	Unit	Remark
<b>Clock CLK<sup>(1)</sup></b>					
Clock frequency Data Transfer Mode (PP) <sup>(2)</sup>	f <sub>PP</sub>	0	52 <sup>(3)</sup>	MHz	CL ≤ 30 pF Tolerance: +100KHz
Clock frequency Identification Mode (OD)	f <sub>OD</sub>	0	400	kHz	Tolerance: +20KHz
Clock high time	t <sub>WH</sub>	6.5		ns	CL ≤ 30 pF
Clock low time	t <sub>WL</sub>	6.5		ns	CL ≤ 30 pF
Clock rise time <sup>(4)</sup>	t <sub>TLH</sub>		3	ns	CL ≤ 30 pF
Clock fall time	t <sub>THL</sub>		3	ns	CL ≤ 30 pF
<b>Inputs CMD, DAT (referenced to CLK)</b>					
Input set-up time	t <sub>ISU</sub>	3		ns	CL ≤ 30 pF
Input hold time	t <sub>IH</sub>	3		ns	CL ≤ 30 pF
<b>Outputs CMD, DAT (referenced to CLK)</b>					
Output delay time during data transfer	t <sub>TDL</sub>		13.7	ns	CL ≤ 30 pF
Output hold time	t <sub>OH</sub>	2.5		ns	CL ≤ 30 pF
Signal rise time <sup>(5)</sup>	t <sub>RISE</sub>		3	ns	CL ≤ 30 pF
Signal fall time	t <sub>FALL</sub>		3	ns	CL ≤ 30 pF
NOTE 1 CLK timing is measured at 50% of VDD.					
NOTE 2 A eMMC shall support the full frequency range from 0-26Mhz, or 0-52MHz					
NOTE 3 Device can operate as high-speed Device interface timing at 26 MHz clock frequency.					
NOTE 4 CLK rise and fall times are measured by min (VIH) and max (VIL).					
NOTE 5 Inputs CMD, DAT rise and fall times are measured by min (VIH) and max (VIL), and outputs CMD, DAT rise and fall times are measured by min (VOH) and max (VOL).					

### 10.6.1 Device interface timings (cont'd)

**Table 187 — Backward-compatible Device interface timing**

Parameter	Symbol	Min	Max.	Unit	Remark <sup>(1)</sup>
<b>Clock CLK<sup>(2)</sup></b>					
Clock frequency Data Transfer Mode (PP) <sup>(3)</sup>	fPP	0	26	MHz	CL ≤ 30 pF
Clock frequency Identification Mode (OD)	fOD	0	400	kHz	
Clock high time	tWH	10			CL ≤ 30 pF
Clock low time	tWL	10		ns	CL ≤ 30 pF
Clock rise time <sup>(4)</sup>	tTLH		10	ns	CL ≤ 30 pF
Clock fall time	tTHL		10	ns	CL ≤ 30 pF
<b>Inputs CMD, DAT (referenced to CLK)</b>					
Input set-up time	tISU	3		ns	CL ≤ 30 pF
Input hold time	tIH	3		ns	CL ≤ 30 pF
<b>Outputs CMD, DAT (referenced to CLK)</b>					
Output set-up time <sup>(5)</sup>	tOSU	11.7		ns	CL ≤ 30 pF
Output hold time <sup>(5)</sup>	tOH	8.3		ns	CL ≤ 30 pF
NOTE 1	The Device must always start with the backward-compatible interface timing. The timing mode can be switched to high-speed interface timing by the host sending the SWITCH command (CMD6) with the argument for high-speed interface select.				
NOTE 2	CLK timing is measured at 50% of VDD.				
NOTE 3	For compatibility with Devices that support the v4.2 standard or earlier, host should not use > 26 MHz before switching to high-speed interface timing.				
NOTE 4	CLK rise and fall times are measured by min (VIIH) and max (VIL).				
NOTE 5	tOSU and tOH are defined as values from clock rising edge. However, there may be Devices or devices which utilize clock falling edge to output data in backward compatibility mode. Therefore, it is recommended for hosts either to set tWL value as long as possible within the range which will not go over tCK-tOH(min) in the system or to use slow clock frequency, so that host could have data set up margin for those devices. In this case, each device which utilizes clock falling edge might show the correlation either between tWL and tOSU or between tCK and tOSU for the device in its own datasheet as a note or its' application notes.				

### 10.7 Bus timing for DAT signals during 2x data rate operation

These timings applies to the DAT[7:0] signals only when the device is configured for dual data mode operation. In this dual data mode, the DAT signals operates synchronously of both the rising and the falling edges of CLK. the CMD signal still operates synchronously of the rising edge of CLK and therefore complies with the bus timing specified in 10.6, therefore there is no timing change for the CMD signal.

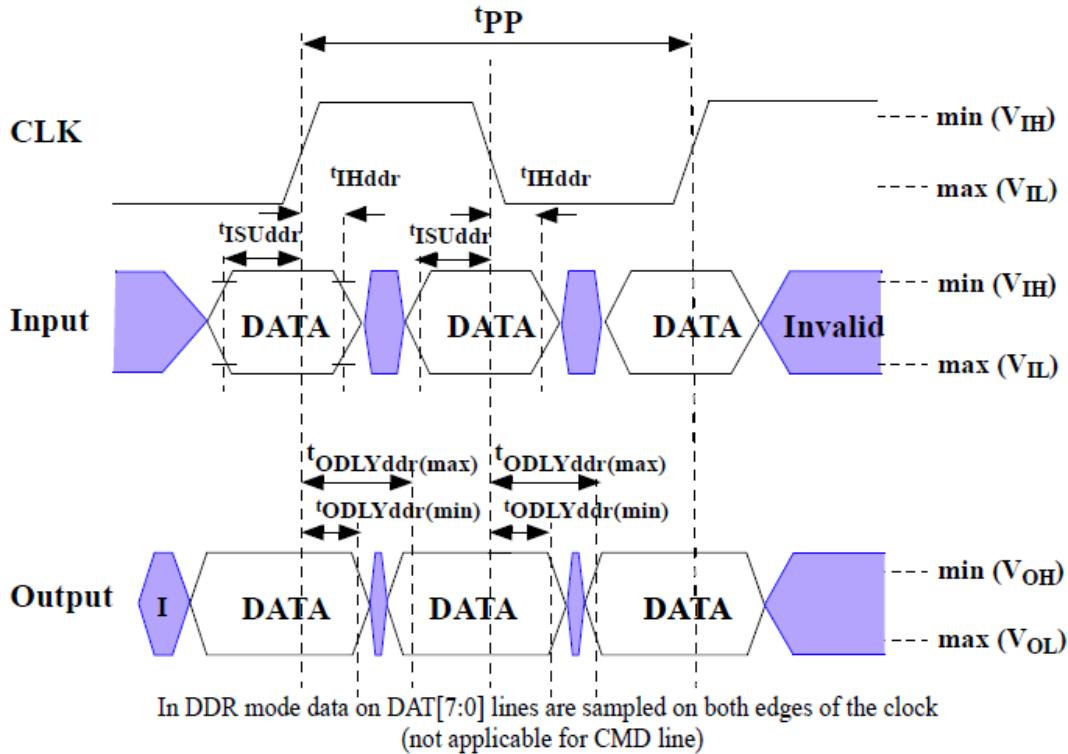


Figure 78 — Timing diagram: data input/output in dual data rate mode

### 10.7.1 Dual data rate interface timings

**Table 188 — High-speed dual rate interface timing**

Parameter	Symbol	Min	Max.	Unit	Remark
<b>Input CLK<sup>(1)</sup></b>					
Clock duty cycle		45	55	%	Includes jitter, phase noise
Clock rise time	t <sub>TLH</sub>		3	ns	CL≤ 30pF
Clock fall time	t <sub>THL</sub>		3	ns	CL≤ 30pF
<b>Input CMD (referenced to CLK-SDR mode)</b>					
Input set-up time	t <sub>ISUddr</sub>	3		ns	CL≤ 20 pF
Input hold time	t <sub>IHddr</sub>	3		ns	CL≤ 20 pF
<b>Output CMD (referenced to CLK-SDR mode)</b>					
Output delay time during data transfer	t <sub>ODLY</sub>		13.7	ns	CL≤ 20 pF
Output hold time	t <sub>OH</sub>	2.5		ns	CL≤ 20 pF
Signal rise time	t <sub>RISE</sub>		3	ns	CL≤ 20 pF
Signal fall time	t <sub>FALL</sub>		3	ns	CL≤ 20 pF
<b>Input DAT (referenced to CLK-DDR mode)</b>					
Input set-up time	t <sub>ISUddr</sub>	2.5		ns	CL≤ 20 pF
Input hold time	t <sub>IHddr</sub>	2.5		ns	CL≤ 20 pF
<b>Output DAT (referenced to CLK-DDR mode)</b>					
Output delay time during data transfer	t <sub>ODLYddr</sub>	1.5	7	ns	CL≤ 20 pF
Signal rise time (DAT0-7) <sup>(2)</sup>	t <sub>RISE</sub>		2	ns	CL≤ 20 pF
Signal fall time (DAT0-7)	t <sub>FALL</sub>		2	ns	CL≤ 20 pF

NOTE 1 CLK timing is measured at 50% of VDD.

NOTE 2 Inputs DAT rise and fall times are measured by min (VIH) and max (VIL), and outputs DAT rise and fall times are measured by min (VOH) and max (VOL)

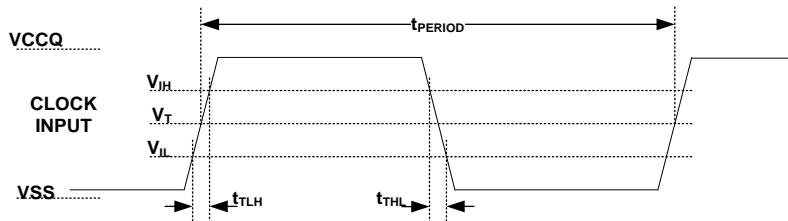
## 10.8 Bus Timing Specification in HS200 mode

### 10.8.1 HS200 Clock Timing

Host CLK Timing in HS200 mode shall conform to the timing specified in Figure 79 and Table 189 — .

CLK input shall satisfy the clock timing over all possible operation and environment conditions. CLK input parameters should be measured while CMD and DAT lines are stable high or low, as close as possible to the Device.

The maximum frequency of HS200 is 200MHz. Hosts can use any frequency up to the maximum that HS200 mode allows.



NOTE 1  $V_{IH}$  denote  $V_{IH}(\min.)$  and  $V_{IL}$  denotes  $V_{IL}(\max.)$ .

NOTE 2  $V_T=0.975V$  - Clock Threshold ( $V_{CCQ}=1.8V$ ) and  $V_T=0.65V$  - Clock Threshold ( $V_{CCQ}=1.2V$ ) , indicates clock reference point for timing measurements.

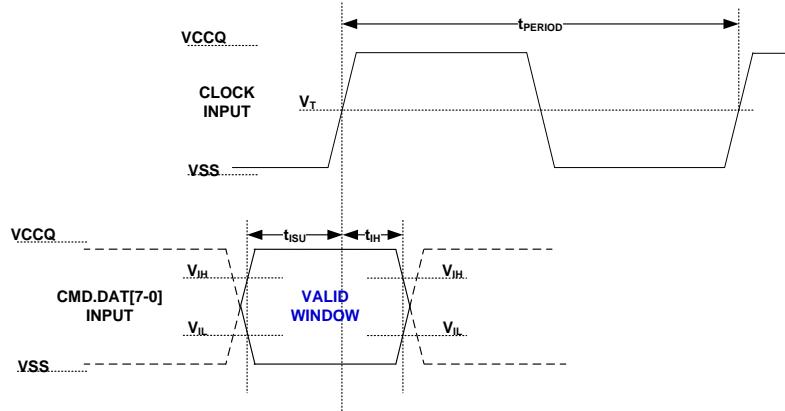
**Figure 79 — HS200 Clock signal timing**

**Table 189 — HS200 Clock signal timing**

Symbol	Min.	Max.	Unit	Remark
$t_{PERIOD}$	5	-	ns	200MHz (Max.), between rising edges
$t_{TLH}, t_{THL}$	-	$0.2 \cdot t_{PERIOD}$	ns	$t_{TLH}, t_{THL} < 1\text{ns}$ (max.) at 200MHz, $C_{DEVICE}=6\text{pF}$ , The absolute maximum value of $t_{TLH}, t_{THL}$ is 10ns regardless of clock frequency.
Duty Cycle	30	70	%	

### 10.8.2 HS200 Device Input Timing

Figure 80 and Table 190 — define Device input timing.



NOTE 1  $t_{ISU}$  and  $t_{IH}$  are measured at  $V_{IL}(\text{max.})$  and  $V_{IH}(\text{min.})$ .

NOTE 2  $V_{IH}$  denote  $V_{IH}(\text{min.})$  and  $V_{IL}$  denotes  $V_{IL}(\text{max.})$ .

Figure 80 — HS200 Device input timing

Symbol	Min.	Max.	Unit	Remark
$t_{ISU}$	1.40	-	ns	$C_{\text{DEVICE}} \leq 6\text{pF}$
$t_{IH}$	0.8		ns	$C_{\text{DEVICE}} \leq 6\text{pF}$

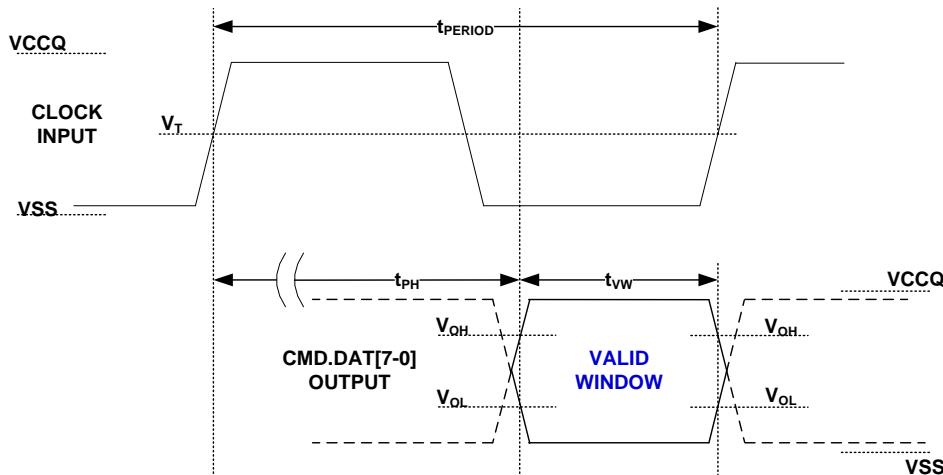
Table 190 — HS200 Device input timing

### 10.8.3 HS200 Device Output Timing

$t_{PH}$  parameter is defined to allow device output delay to be longer than  $t_{PERIOD}$ . After initialization, the  $t_{PH}$  may have random phase relation to the clock. The Host is responsible to find the optimal sampling point for the Device outputs, while switching to the HS200 mode.

Figure 81 and Table 191 — define Device output timing.

While setting the sampling point of data, a long term drift, which mainly depends on temperature drift, should be considered. The temperature drift is expressed by  $\Delta_{TPH}$ . Output valid data window ( $t_{VW}$ ) is available regardless of the drift ( $\Delta_{TPH}$ ) but position of data window varies by the drift, as described in Figure 82.



NOTE  $V_{OH}$  denotes  $V_{OH}(\min.)$  and  $V_{OL}$  denotes  $V_{OL}(\max.)$ .

Figure 81 — HS200 Device output timing

Table 191 — Output timing

Symbol	Min.	Max.	Unit	Remark
$t_{PH}$	0	2	UI	Device output momentary phase from CLK input to CMD or DAT lines output. Does not include a long term temperature drift.
$\Delta_{TPH}$	-350 ( $\Delta T = -20^\circ C$ )	+1550 ( $\Delta T = 90^\circ C$ )	ps	Delay variation due to temperature change after tuning. Total allowable shift of output valid window ( $T_{VW}$ ) from last system Tuning procedure $\Delta_{TPH}$ is 2600ps for $\Delta T$ from $-25^\circ C$ to $125^\circ C$ during operation.
$t_{VW}$	0.575	-	UI	$t_{VW}=2.88\text{ns}$ at 200MHz Using test circuit in Figure 76 including skew among CMD and DAT lines created by the Device. Host path may add Signal Integrity induced noise, skews, etc. Expected $T_{VW}$ at Host input is larger than 0.475UI.

NOTE Unit Interval (UI) is one bit nominal time. For example, UI=5ns at 200MHz.

### 10.8.3 HS200 Device Output Timing (cont'd)

Figure 82 —  $\Delta_{TPH}$  consideration

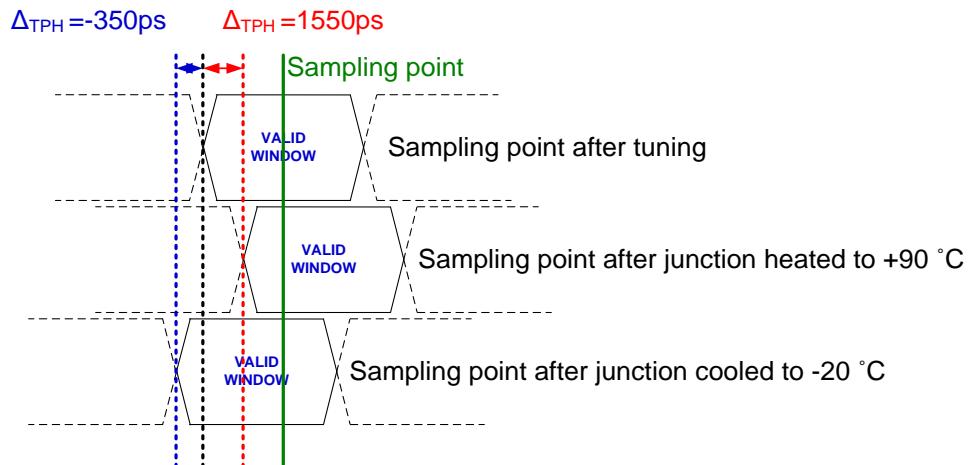


Figure 82 —  $\Delta_{TPH}$  consideration

Implementation Guide:

Host should design to avoid sampling errors that may be caused by the  $\Delta_{TPH}$  drift.  
It is recommended to perform tuning procedure while Device wakes up, after sleep.  
One simple way to overcome the  $\Delta_{TPH}$  drift is by reduction of operating frequency.

## 10.9 Temperature Conditions

Table 192 — Temperature Conditions

Condition	Ambient Temperature <sup>(1)</sup> – $T_a$
Operating	$-25^\circ\text{C}$ to $+85^\circ\text{C}$
Storage	$-40^\circ\text{C}$ to $+85^\circ\text{C}$

NOTE 1 To achieve optimized power/performance, refer to Annex A.10 for package case ( $T_{case}$ ) temperature control nominal time. For example,  $UI=5\text{ns}$  at 200MHz.

## 10.10 Bus Timing Specification in HS400 mode

### 10.10.1 HS400 Device Input Timing

The CMD input timing for HS400 mode is the same as CMD input timing for HS200 mode.

Figure 83 and Table 193 — show Device input timing.

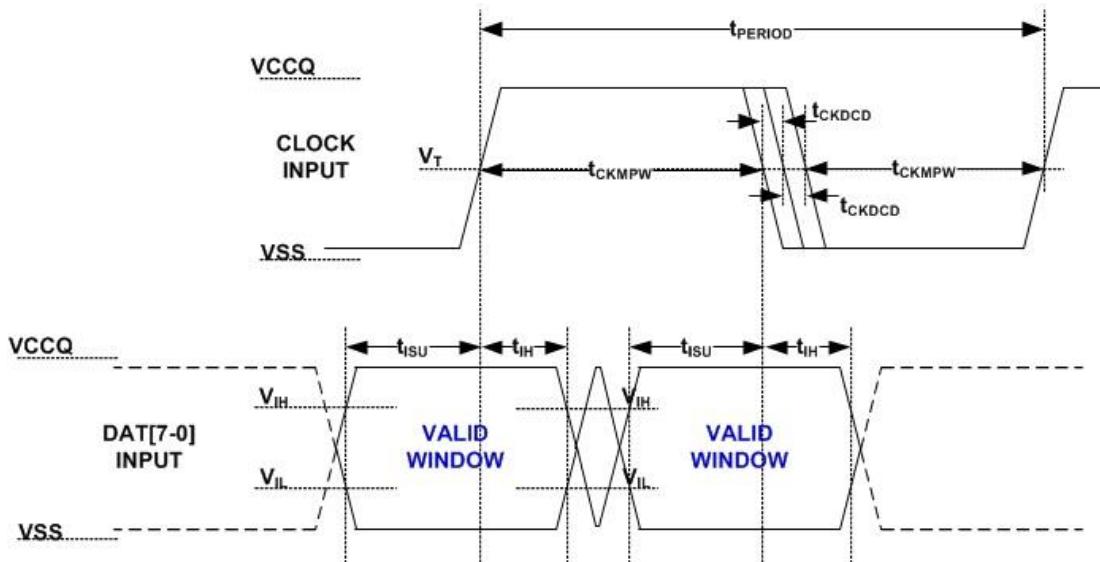


Figure 83 — HS400 Device Data input timing

Table 193 — HS400 Device input timing

Parameter	Symbol	Min	Max	Unit	Remark
<b>Input CLK</b>					
Cycle time data transfer mode	t <sub>PERIOD</sub>	5			200MHz(Max), between rising edges With respect to V <sub>T</sub> .
Slew rate	SR	1.125		V/ns	With respect to V <sub>IH</sub> /V <sub>IL</sub> .
Duty cycle distortion	t <sub>CKDCD</sub>	0.0	0.3	ns	Allowable deviation from an ideal 50% duty cycle. With respect to V <sub>T</sub> . Includes jitter, phase noise
Minimum pulse width	t <sub>CKMPW</sub>	2.2		ns	With respect to V <sub>T</sub> .
<b>Input DAT (referenced to CLK)</b>					
Input set-up time	t <sub>ISU</sub> addr	0.4		ns	C <sub>Device</sub> ≤ 6pF With respect to V <sub>IH</sub> /V <sub>IL</sub> .
Input hold time	t <sub>IH</sub> addr	0.4		ns	C <sub>Device</sub> ≤ 6pF With respect to V <sub>IH</sub> /V <sub>IL</sub> .
Slew rate	SR	1.125		V/ns	With respect to V <sub>IH</sub> /V <sub>IL</sub> .

### 10.10.2 HS400 Device Output Timing

The Data Strobe is used to read data in HS400 mode. The Data Strobe is toggled only during data read or CRC status response.

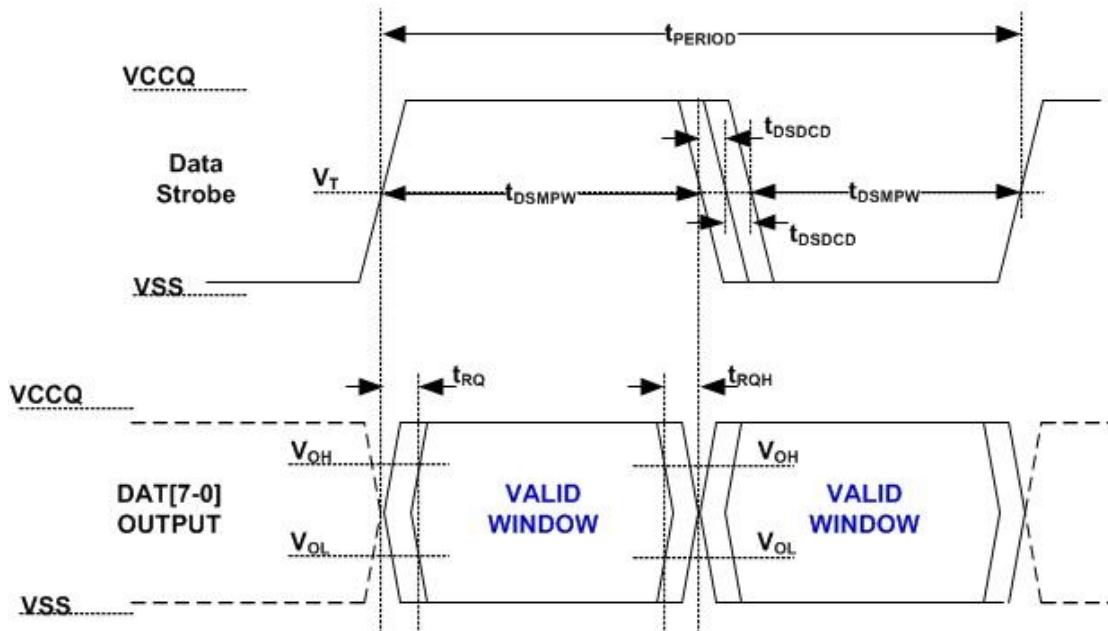


Figure 84 — HS400 Device output timing

Table 194 — HS400 Device Output timing

Parameter	Symbol	Min	Max	Unit	Remark
Data Strobe					
Cycle time data transfer mode	t <sub>PERIOD</sub>	5			200MHz(Max), between rising edges With respect to V <sub>T</sub>
Slew rate	SR	1.125	—	V/ns	With respect to V <sub>OH</sub> /V <sub>OL</sub> and HS400 reference load
Duty cycle distortion	t <sub>DSDCD</sub>	0.0	0.2	ns	Allowable deviation from the input CLK duty cycle distortion (t <sub>CKDCD</sub> ) With respect to V <sub>T</sub> Includes jitter, phase noise
Minimum pulse width	t <sub>DSMPW</sub>	2.0		ns	With respect to V <sub>T</sub>
Read pre-amble	t <sub>RPRE</sub>	0.4	-	t <sub>PERIOD</sub>	Max value is specified by manufacturer. Value up to infinite is valid
Read post-amble	t <sub>RPST</sub>	0.4	-	t <sub>PERIOD</sub>	Max value is specified by manufacturer. Value up to infinite is valid
Output DAT (referenced to Data Strobe)					
Output skew	t <sub>RQ</sub>		0.4	ns	With respect to V <sub>OH</sub> /V <sub>OL</sub> and HS400 reference load
Output hold skew	t <sub>RQH</sub>		0.4	ns	With respect to V <sub>OH</sub> /V <sub>OL</sub> and HS400 reference load.
Slew rate	SR	1.125		V/ns	With respect to V <sub>OH</sub> /V <sub>OL</sub> and HS400 reference load

### 10.10.2 HS400 Device Output Timing (cont'd)

**Table 195 — HS400 Capacitance**

Parameter	Symbol	Min	Type	Max	Unit	Remark
Pull-up resistance for CMD	R <sub>CMD</sub>	4.7		100 <sup>(1)</sup>	Kohm	
Pull-up resistance for DAT0-7	R <sub>DAT</sub>	10		100 <sup>(1)</sup>	Kohm	
Pull-down resistance for Data Strobe	R <sub>DS</sub>	10		100 <sup>(1)</sup>	Kohm	
Internal pull up resistance DAT1-DAT7	R <sub>int</sub>	10		150	Kohm	
Bus signal line capacitance	CL			13	pF	
Single Device capacitance	C <sub>Device</sub>			6	pF	

## 11 e•MMC standard compliance

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The *e*•MMC standard provides all the necessary information required for media exchangeability and compatibility.

- Generic Device access and communication protocol (Section 6, Section 7)
- Data integrity and error handling (Section 8)
- Mechanical interface parameters, Device form factor (Section 9)
- Electrical interface parameters, such as: power supply, peak and average current consumption and data transfer frequency (Section 10)

However, due to the wide spectrum of targeted *e*•MMC applications—from a full blown PC based application down to the very-low-cost market segments—it is not always cost effective, nor useful to implement every *e*•MMC standard feature, in a specific *e*•MMC system. Therefore, many of the parameters are configurable and can be tailored per implementation.

A device is compliant with the standard as long as all of its configuration parameters are within the valid range. An *e*•MMC host is compliant as long as it supports at least one *e*•MMC class as defined below. Every provider of *e*•MMC system components is required to clearly specify (in its product manual) all the *e*•MMC specific restrictions of the device.

*e*•MMCs (slaves) provide their configuration data in the Device Specific Data (CSD) register (refer to 7.3). The *e*•MMC protocol includes all the necessary commands for querying this information and verifying the system concept configuration. *e*•MMC hosts (masters) are required (as part of the system boot-up process) to verify host-to-Device compatibility with each of the Devices connected to the bus.

Table 196 summarizes the requirements from a *e*•MMC host for each Device class (CCC = Device command class, see 6.10). The meaning of the entries is as follows:

- *Mandatory*: any *e*•MMC host supporting the specified Device class must implement this function.
- *Optional*: this function is an added option. The host is compliant to the specified Device class without having implemented this function.
- *Not required*: this function has no use for the specified Device class.

## 11 e•MMC standard compliance (cont'd)

**Table 196 — e•MMC host requirements for Device classes**

Function	e•MMC	e <sup>2</sup> •MMC
52 – 200 MHz transfer rate	Optional	Optional
26–52 MHz transfer rate	Mandatory	Mandatory
20–26 MHz transfer rate	Mandatory	Mandatory
0–26 MHz transfer rate	Mandatory	Mandatory
2.7–3.6V power supply	Optional	Optional
1.70–1.95V power supply	Optional	Optional
CCC 0 Basic	Mandatory	Mandatory
CCC 1 Sequential Read	Obsolete	Obsolete
CCC 2 Block Read	Mandatory	Mandatory
CCC 3 Sequential Write	Obsolete	Obsolete
CCC 4 Block Write	Mandatory	Mandatory
CCC 5 Erase	Mandatory	Mandatory
CCC 6 Write Protection Functions	Mandatory	Mandatory
CCC 7 Lock Device Commands	Mandatory	Mandatory
CCC 8 Application Specific Commands	Optional	Optional
CCC 9 Interrupt and Fast Read/Write	Optional	Optional
CCC10 Security Protocols	Optional	Optional
DSR	Optional	Optional
SPI Mode	Obsolete	n/a

Comments on the optional functions:

- The interrupt command is intended for reducing the overhead on the host side required during polling for some events.
- The setting of the DSR allows the host to configure the e•MMC bus in a very flexible, application dependent manner
- The external ECC in the host allows the usage of extremely low-cost Devices.
- The Device Status bits relevance, according to the supported classes, is defined in Table 58 — .
- Sanitize and bad block management are features that enable the device to be used in secure applications.
- The Trim and discard command allows the host to assist with the optimization of the internal Device garbage collection operations

## 11 e•MMC standard compliance (cont'd)

**Table 197 — New Features List for device type**

Function	e•MMC	e <sup>2</sup> •MMC
Boot	Mandatory	Mandatory
RPMB	Mandatory	Mandatory
Reset Pin	Mandatory	Mandatory
Write Protection (including Perm & Temp)	Mandatory	Mandatory
1.2 V I/O	Optional	Optional
Dual Data Rate timing	Optional	Optional
HS200	Optional	Optional
Multi Partitioning	Mandatory	Mandatory
Secure Erase/Secure Trim	Optional	Optional
Trim	Mandatory	Mandatory
High Priority Interrupt	Mandatory	Mandatory
Background Operation	Mandatory	Mandatory
Enhance Reliable Write	Mandatory	Mandatory
Discard Command	Mandatory	Mandatory
Security Features	Mandatory	Mandatory
Partition types	Mandatory	Mandatory
Context ID	Mandatory	Mandatory
Data Tag	Mandatory	Mandatory
Packed commands	Mandatory	Mandatory
Real Time Clock	Mandatory	Mandatory
Dynamic Device Capacity	Mandatory	Mandatory
Power Off Notification	Mandatory	Mandatory
Thermal Spec	Mandatory	Mandatory
Minimum Sector Size = 4 KB ( $\leq$ 256GB)	Optional	Optional
Minimum Sector Size = 4KB ( $>$ 256GB)	Mandatory	Mandatory
Cache	Optional	Mandatory
Extended Security Protocols	Optional	Optional
HS400	Optional	Optional
Field Firmware Update	Optional	Optional
Product State Awareness	Optional	Optional
Secure Removal Type	Optional	Optional
Device Health Report	Optional	Optional

## A. Annex A Application Notes

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### A.1 Device Payload block length and ECC types handling

There are two entries in the CSD register concerning the payload block length:

- block length type and
- external ECC.

The block length entry depends on the Device memory field architecture. There are fixed values in 2-exponent steps defined for the block length size in the range 1 Byte - 2 kByte. Alternatively, the device allows application of any block length in the range between 1 Byte and the maximum block size.

The other CSD entry having an influence on the block length is the selected external ECC type. If there is an external ECC code option selected, this entry generally does not have to match with the block length entry in the CSD. If these entries do not match, however, there is an additional caching at the host side required. To avoid that, using Devices allowing the usage of any block length within the allowed range for applications with an external ECC is strongly recommended.

## A.2 Description of method for storing passwords on the Device

In order to improve compatibility and inter-operability of the Device between different applications, it is required that different host applications use identical algorithms and data formats. Following is a recommended way of storing passwords in the 128-bit password block on the Device. It is provided as application note only.

This method is applicable only if the password consists of text, possibly entered by the user. The application may opt to use another method if inter-operability between devices is not important, or if the application chooses to use, for example, a random bit pattern as the password.

Get the password (from the user, from a local storage on the device, or something else). The password can be of any length, and in any character set.

- Normalize the password into UTF-8 encoded Unicode character set. This guarantees inter-operability with all locales, character sets and country-specific versions. In UTF-8, the first 128 characters are mapped directly to US-ASCII, and therefore a device using only US-ASCII for the password can easily conform to this standard.
- Run the normalized password through SHA-1 secure hash algorithm. This uses the whole key space available for password storage, and makes it possible to use also longer passwords than 128 bits. As an additional bonus, it is not possible to reverse-engineer the password from the Device, since it is not possible to derive the password from its hash.
- Use the first 128 bits of this hash as the Device password. (SHA-1 produces a 160-bit hash. The last 32 bits are not used.)

Following is an example (note that the exact values need to be double-checked before using this as implementation reference):

The password is “foobar”. First, it is converted to UTF-8. As all of the characters are US-ASCII, the resulting bit string (in hex) is:

66 6F 6F 62 61 72

After running this string through SHA-1, it becomes:

88 43 d7 f9 24 16 21 1d e9 eb b9 63 ff 4c e2 81 25 93 28 78

Of which the first 128 bits are:

88 43 d7 f9 24 16 21 1d e9 eb b9 63 ff 4c

Which is then used as the password for the device.

UTF-8 is specified in *UTF-8, a transformation format of Unicode and ISO 10646*, RFC 2044, October 1996. <ftp://ftp.nordu.net/rfc/rfc2044.txt>

SHA-1 is specified in *Secure Hash Standard*, Federal Information Processing Standards Publication (FIPS PUB) 180-1, April 1995. <http://www.itl.nist.gov/fipspubs/fip180-1.htm>

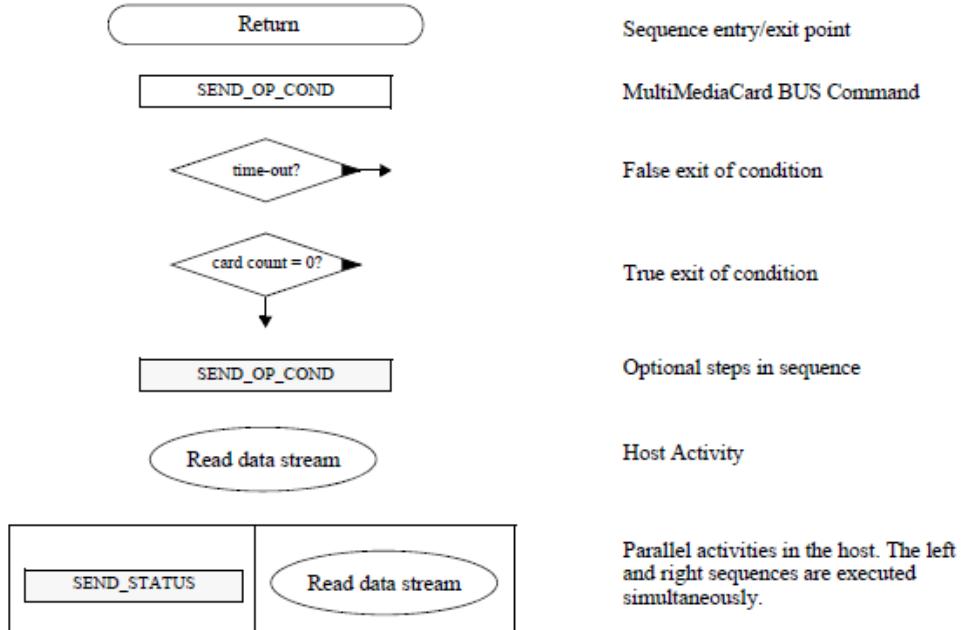
### A.3 e•MMC macro commands

This section defines the way complex *e*•MMC bus operations (e.g., erase, read, etc.) may be executed using predefined command sequences. Executing these sequences is the responsibility of the Multi-MediaDevice bus master. Nevertheless, it may be used for host compatibility test purposes.

**Table 198 — Macro commands**

Mnemonic	Description
CIM_SINGLE_DEVICE_AC_Q	Starts an identification cycle of a single Device.
CIM_SETUP_DEVICE	Select a Device by writing the RCA and reads its CSD.
CIM_READ_BLOCK	Sets the block length and the starting address and reads a data block from the Device.
CIM_READ_MBLOCK	Sets the block length and the starting address and reads (continuously) data blocks from the Device. Data transfer is terminated by a stop command.
CIM_WRITE_BLOCK	Sets the block length and the starting address and writes a data block from the Device.
CIM_WRITE_MBLOCK	Sets the block length and the starting address and writes (continuously) data blocks to the Device. Data transfer is terminated by a stop command.
CIM_ERASE_GROUP	Erases a range of erase groups on the Device.
Mnemonic	Description
CIM_TRIM	Erases a number of ranges of write blocks on the Device.
CIM_US_PWR_WP	Applies power-on write protection to a write protection group on the Device.
CIM_US_PERM_WP	Applies permanent write protection to a write protection group on the Device.

The *e*•MMC command sequences are described in the following paragraphs. Figure 85 provides a legend for the symbols used in the sequence flow charts. The status polling by CMD13 can explicitly be done any time after a response to the previous command has been received.



**Figure 85 — Legend for command-sequence flow charts**

### A.3 e•MMC macro commands (cont'd)

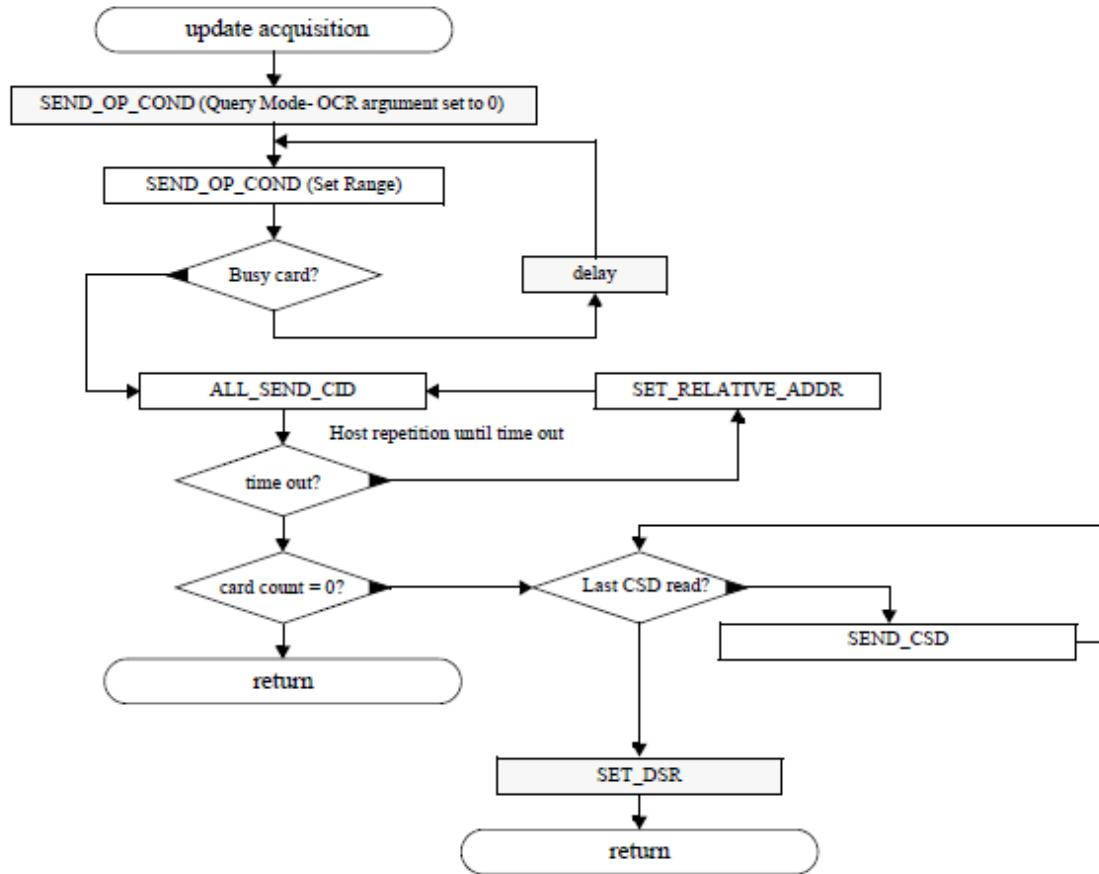


Figure 86 — SEND\_OP\_COND command flow chart

### A.3 eMMC macro commands (cont'd)

- CIM\_SINGLE\_DEVICE\_ACQ

The host knows that there is a single Device in the system and, therefore, does not have to implement the identification loop. In this case only one ALL\_SEND\_CID is required. Similarly, a single SEND\_CSD is sufficient.

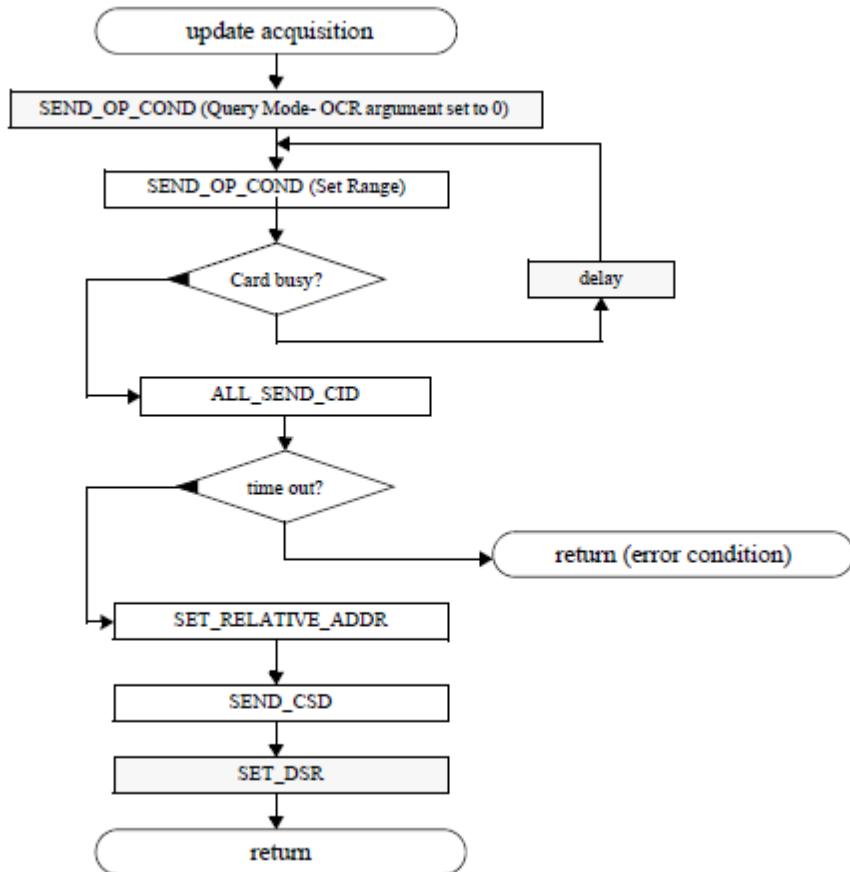
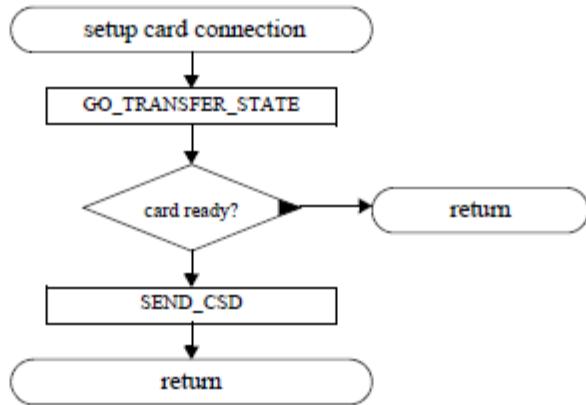


Figure 87 — CIM\_SINGLE\_DEVICE\_ACQ

### A.3 eMMC macro commands (cont'd)

- CIM\_SETUP\_DEVICE

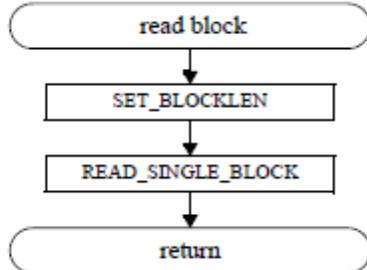


**Figure 88 — CIM\_SETUP\_DEVICE**

The setup Device connection procedure (CIM\_SETUP\_DEVICE) links the bus master with a single Device. The argument required for this command is the RCA of the chosen Device. A single Device is selected with GO\_TRANSFER\_STATE (CMD7) command by its RCA. The response indicates whether the Device is ready or not. If the Device confirms the connection, the adapter will read the Device specific data with SEND\_CSD (CMD9). The information within the response is used to configure the data path and controller options.

### A.3 eMMC macro commands (cont'd)

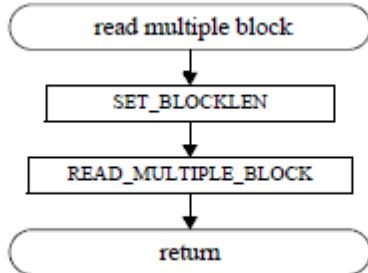
- CIM\_READ\_BLOCK



**Figure 89 — CIM\_READ\_BLOCK**

The read block procedure (CIM\_READ\_BLOCK) reads a data block from a Device. The arguments required for this command are the block length (4 bytes) and the starting address of the block (4 bytes). This operation also includes a data portion (in this case, the read block). The procedure starts by setting the required block length with the SET\_BLOCKLEN (CMD16) command. If the Device accepts this setting, the data block is transferred via command READ\_SINGLE\_BLOCK (CMD17), starting at the given address.

- CIM\_READ\_MBLOCK



**Figure 90 — CIM\_READ\_MBLOCK**

The read multiple block procedure (CIM\_READ\_MBLOCK) sequentially reads blocks of data from a Device. The arguments required for this command are the block length (4 bytes) and the starting address of the first block (4 bytes). This operation also includes a data portion (in this case, the read blocks). The procedure starts by setting the required block length with the SET\_BLOCKLEN (CMD16) command. If the Device accepts this setting, the data blocks are transferred via command READ\_MULTIPLE\_BLOCK (CMD18), starting at the given address.

- CIM\_WRITE\_BLOCK

This command sequence is similar to multiple block write except that there is no repeat loop for write data block.

### A.3 e•MMC macro commands (cont'd)

- CIM\_WRITE\_MBLOCK

The sequence of write multiple block starts with an optional SET\_BLOCK\_LEN command. If there is no change in block length this command can be omitted. If the Device accepts the two starting commands the host will begin sending data blocks on the data line. After each data block the host will check the Device response on the DAT line. If the CRC is OK, the Device is not busy and the host will send the next block if there are more data blocks.

While sending data blocks, the host may query the Device status register (using the SEND\_STATUS command) to poll any new status information the Device may have (e.g., WP\_VIOLATION, MISALIGNMENT, etc.) The sequence must be terminated with a STOP command.

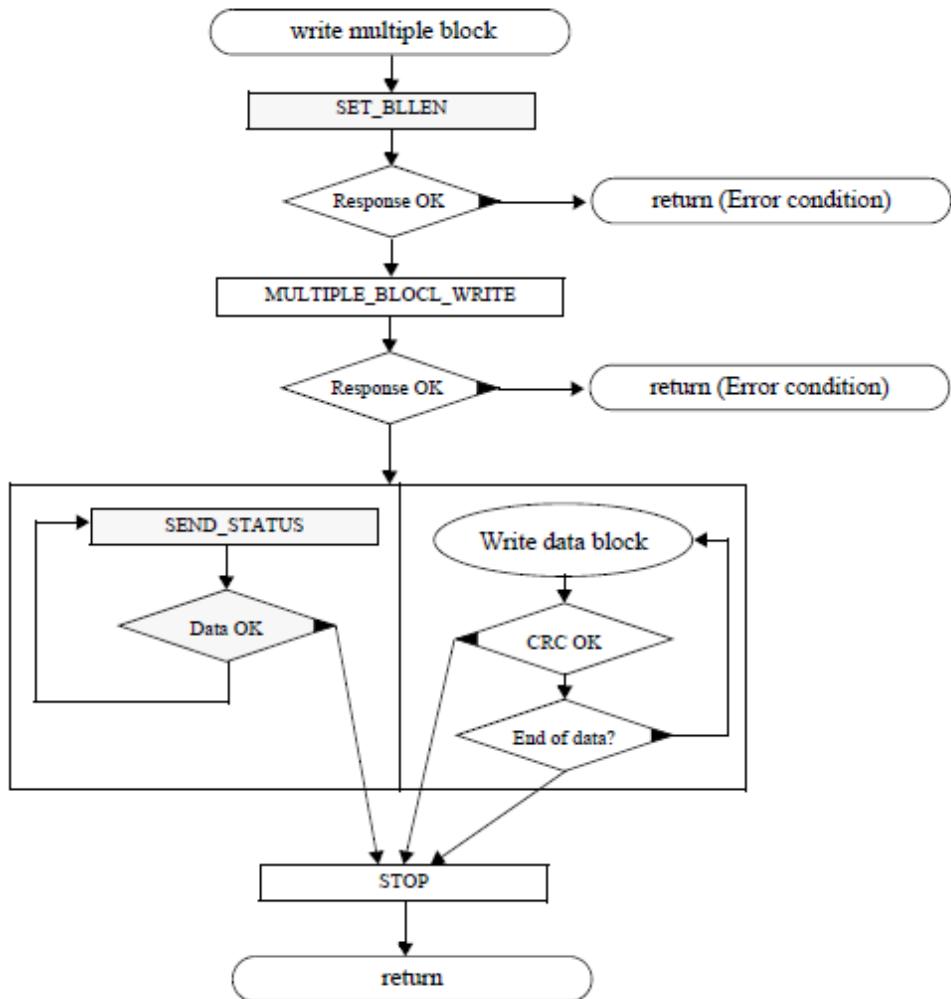


Figure 91 — CIM\_WRITE\_MBLOCK

### A.3 eMMC macro commands (cont'd)

- CIM\_ERASE\_GROUP

The erase group procedure starts with ERASE\_START (CMD35) and ERASE\_END (CMD336 commands. Once the erase groups are selected the host will send an ERASE (CMD38) command. It is recommended that the host terminates the sequence with a SEND\_STATUS (CMD13) to poll any additional status information the Device may have (e.g., WP\_ERASE\_SKIP, etc.).

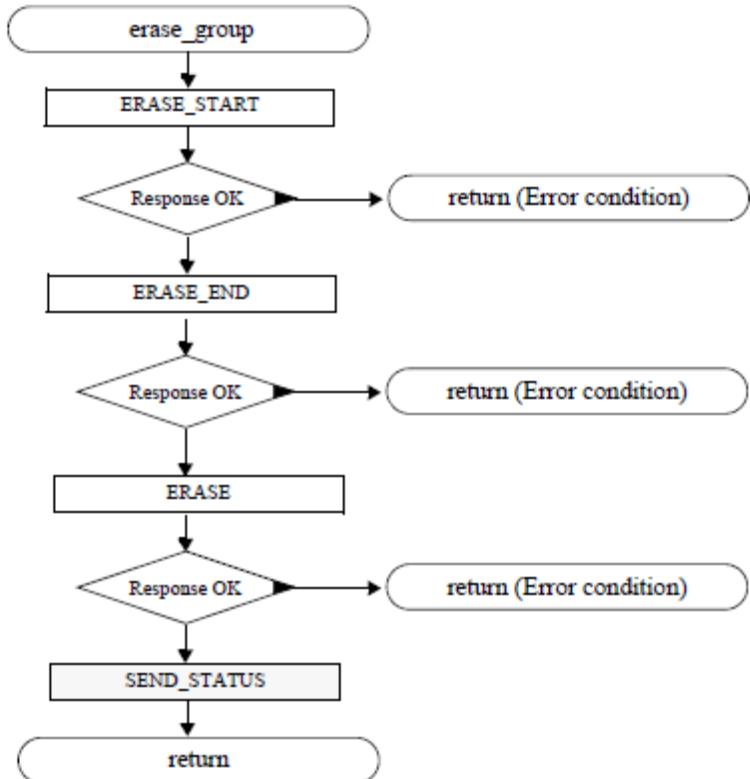


Figure 92 — CIM\_ERASE\_GROUP

### A.3 eMMC macro commands (cont'd)

- CIM\_TRIM

The trim procedure starts with ERASE\_START (CMD35) and ERASE\_END (CMD36) commands, these commands are used to select write block. Once the write blocks are selected the host will send an ERASE (CMD38) command with argument bit 0 set to one and the remainder of the bits set to zero. It is recommended that the host terminates the sequence with a SEND\_STATUS (CMD13) to poll any additional status information the Device may have (e.g., WP\_ERASE\_SKIP, etc.).

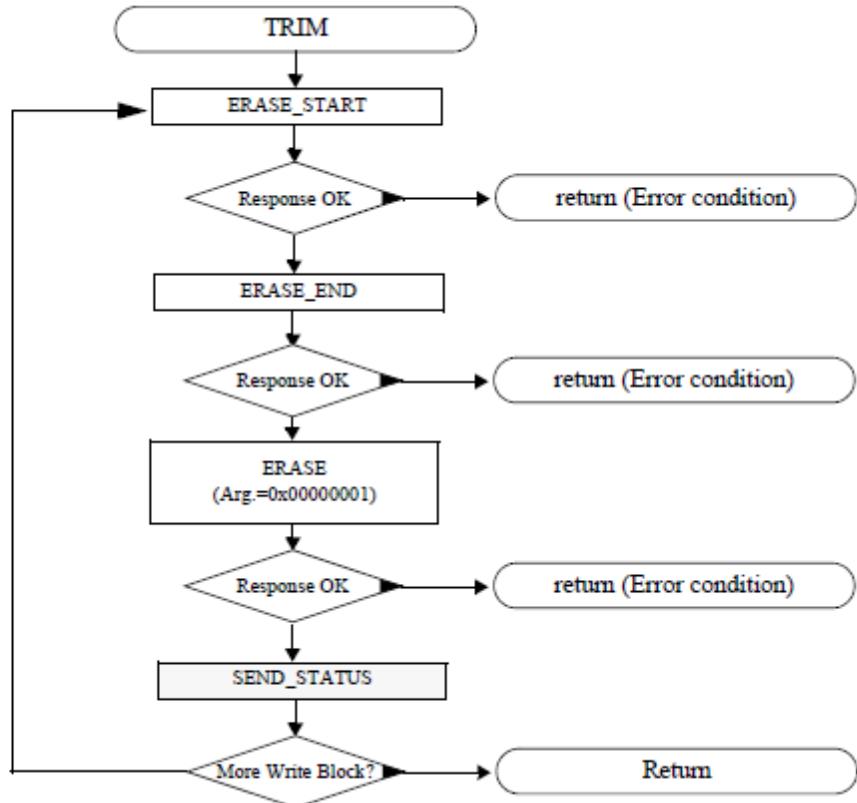


Figure 93 — CIM\_TRIM

### A.3 eMMC macro commands (cont'd)

- CIM\_US\_PWR\_WP

The minimum required sequence to apply Power-On write protection to a write protection group is to set US\_PWR\_WP\_EN (EXT\_CSD[171] bit 0) and then use the SET\_WR\_PROT(CMD28) command.

It is recommended to disable permanent write protection, if it is not needed, before issuing the first power-on write protection sequence since if an area is permanently protected then power-on write protection cannot be applied.

The host can check if power-on protection has been disabled before following the minimum required sequence to apply power-on protection by reading US\_DIS\_PWR\_WP (EXT\_CSD[171] bit 3). Also, the host can verify the protection status of the write group after the required sequence has been executed by using the SEND\_WR\_PROTECT\_TYPE (CMD31) command.

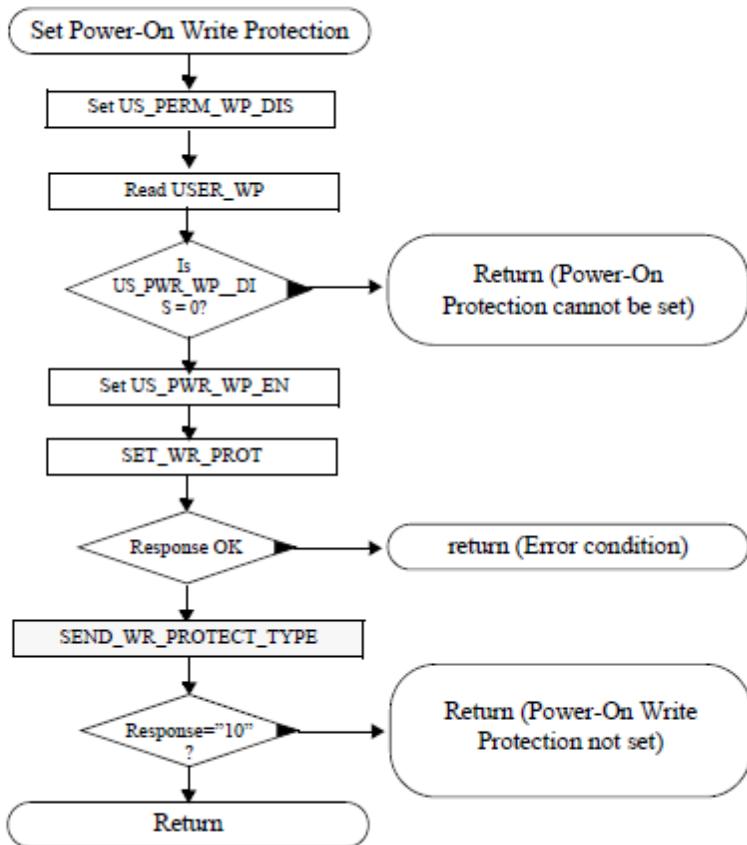


Figure 94 — CIM\_US\_PWR\_WP

### A.3 eMMC macro commands (cont'd)

- CIM\_US\_PERM\_WP

The minimum required sequence to apply permanent write protection to a write protection group is to set US\_PERM\_WP\_EN (EXT\_CSD[171] bit 2) and then use the SET\_WR\_PROT(CMD28) command.

The host has the option to check that permanent protection is not disabled before setting permanent write protection by reading US\_DIS\_PERM\_WP (EXT\_CSD[171] bit 4). Also, the host can verify the protection status of the write group after the required sequence has been executed by using the SEND\_WR\_PROTECT\_TYPE (CMD31) command.

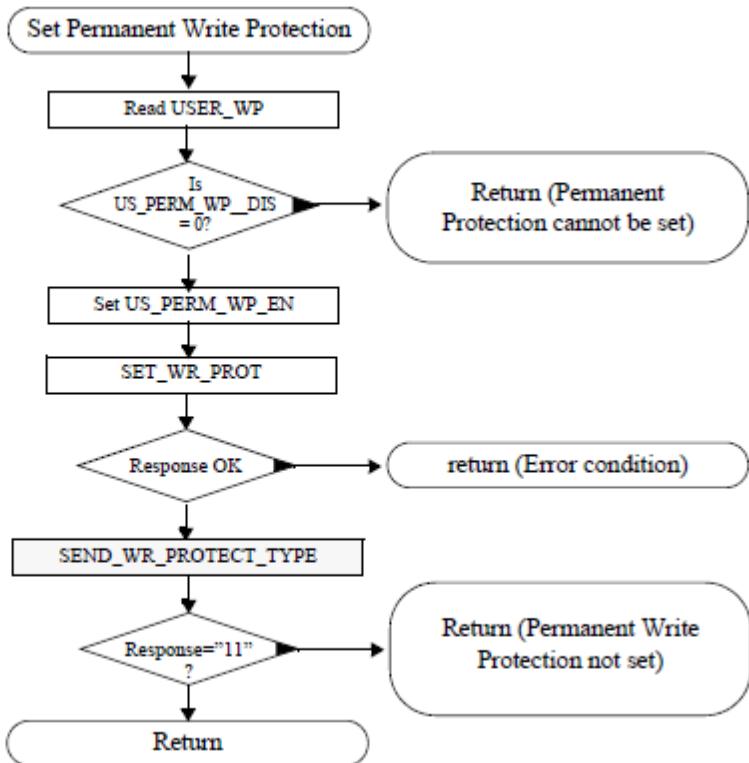


Figure 95 — CIM\_US\_PERM\_WP

#### A.4 Host interface timing

With the introduction of *e*•MMC standard version 4.0, higher clock speeds are used in both hosts and Devices. In order to maintain backward and forward compatibilities, the Device, and the host, are required to implement two different sets of timings. One set of timings is the interface timing aimed at high speed systems, working at clock frequencies higher than 20MHz, up to 52MHz. The other set of timing is different for the Device and for the host. The Device has to maintain backwards compatibility, allowing it to be inserted into an older *e*•MMC system. The host has to maintain forward compatibility, allowing old *e*•MMC to be inserted into new high speed *e*•MMC systems.

Table 199 defines the forward compatibility interface timing. The high speed interface timing is already defined in Table 186 — .

**Table 199 — Forward-compatible host interface timing**

Parameter	Symbol	Min	Max.	Unit	Remark
<b>Clock CLK1</b>					
Clock frequency Data Transfer Mode (PP)	fPP	0	20	MHz	CL <= 30 pF
Clock frequency Identification Mode (OD)	fOD	0	400	kHz	
Clock low time	tWL	10		ns	CL <= 30 pF
Clock rise time <sup>2</sup>	tTLH		10	ns	CL <= 30 pF
Clock fall time	tTHL		10	ns	CL <= 30 pF
<b>Inputs CMD, DAT (referenced to CLK)</b>					
Input set-up time	tISU	4.8		ns	CL <= 30 pF
Input hold time	tIH	4.4		ns	CL <= 30 pF
<b>Outputs CMD, DAT (referenced to CLK)</b>					
Output set-up time	tOSU	5		ns	CL <= 30 pF
Output hold time	tOH	5		ns	CL <= 30 pF
NOTE 1. All timing values are measured relative to 50% of voltage level					
NOTE 2. Rise and fall times are measured from 10%-90% of voltage level.					

#### A.5 Handling of passwords

There is only one length indicator for the password instead of having separate length bytes reserved for both new and old passwords. Due to this there is a possibility for conflict during the password change operation after which the new password does not match to the one which the user set. There has also proven to be various interpretations related to the removal of the lock function in Device implementations.

Thus the procedures in the following sections are recommended to be used to enable best possible compatibility over host-Device systems.

##### A.5.1 Changing the password

This applies for the host systems. Instead of using the password replacement function implement the password change as follows:

- First, remove the old password
- Second, set the new password

##### A.5.2 Removal of the password

This applies to the host systems. Before resetting the password (CLR\_PWD) unlock the Device.

## A.6 High-speed *e*•MMC bus functions

### A.6.1 Bus initialization

There is more than one way to use the new features, introduced in v4.0 of this document. This application note describes a way to switch a high speed *e*•MMC from the initial lower frequency to the high frequency and different bus configuration.

High Speed *e*•MMCs are backwards compatible, therefore after power up, they behave identically to old Devices, with no visible difference.<sup>4</sup> The steps a host can do to identify a High Speed *e*•MMC, and to put it to high speed mode are described next, from power-up until the Device is ready to work at high data rates.

#### a. Power-up

1. Apply power to the bus, communication voltage range (1.70V – 1.95V or 2.7-3.6V/ 1.1V – 1.3V opt)
2. Set clock to 400KHz, or less
3. Wait for 1ms, then wait for 74 more clock cycles , voltage supply ramp-up time, boot operation duration (see Figure 68)
4. Send CMD1 with the address mode required by the host (0x80FF8080 - capacity less than or equal to 2GB – or 0xC0FF8080 - capacity greater than 2GB)
5. Receive R3
6. If the OCR busy bit is “0”(0x00FF8080 or 0x40FF8080 in R3 response and the host shall ignore the access bits), repeat steps 5 and 6
7. When the device returns 0x80FF8080 or 0xC0FF8080, it moves to Ready State if compatible to the host CMD1 argument
8. If R3 returned some other value, the Device is not compliant (since it should have put itself into *inactive* state, due to voltage incompatibility, and not respond); in such a case the host must power down the bus and start its error recovery procedure (the definition of error recovery procedures is host dependent and out of the scope of this application note)

#### Low-voltage power-up

Do the following steps if low voltage operations are supported by the host; otherwise skip to step 16.

9. If the host is a low voltage host, and recognized a dual voltage Device, power down the MMC bus
  10. Apply power to the MMC bus, in the low voltage range (1.70 -1.95V)
  11. Wait for 1ms, then for 74 more clock cycles
  12. Send CMD1 with argument 0x00000080
  13. Receive R3, it should read 0x00FF8080
  14. If the OCR busy bit is ‘0’, repeat steps 13 and 14
- 
- b. CID retrieval and RCA assignment
  15. Send CMD2
  16. Receive R2, and get the Device’s CID
  17. Send CMD3 with a chosen RCA, with value greater than 1

---

<sup>4</sup> Some legacy Devices correctly set the ILLEGAL\_CMD bit, when the bus testing procedure is executed upon them, and some other legacy Devices in the market do not show any error.

- c. CSD retrieval and host adjustment
- 18. Send CMD9
- 19. Receive R2, and get the Device's CSD from it.
- 20. If necessary, adjust the host parameters according to the information in the CSD. If the SPEC\_VERS indicates a version 4.0 or higher, the Device is a high speed Device and supports SWITCH and SEND\_EXT\_CSD commands. Otherwise the Device is an old MMC Device. Regardless of the type of Device, the maximum clock frequency that can be set at this point is defined in the TRAN\_SPEED field.

#### A.6.2 Switching to high-speed mode

The following steps are supported by Devices implementing version 4.0 or higher. For switching to HS200 mode introduced in v 4.5 refer to 6.6.4. Do these steps after the bus is initialized according to A.6.1, Bus initialization.

- 21. Send CMD7 with the Device's RCA to place the Device in tran state
- 22. Send CMD8, SEND\_EXT\_CSD. From the EXT\_CSD the host can learn the power class of the Device, and choose to work with a wider data bus (See steps 26-37)
- 23. Send CMD6, writing 0x1 to the HS\_TIMING byte of the EXT\_CSD. The argument 0x03B9\_0100 will do it.
  - 23.1-The Device might enter BUSY right after R1, if so, wait until the BUSY signal is de-asserted
  - 23.2-After the Device comes out of BUSY it is configured for high speed timing
- 24. Change the clock frequency to the chosen frequency (any frequency between 0 and 26/52MHz).

#### A.6.3 Changing the data bus width

The following steps are optionally done if the Device's power class allows the host to work on a wider bus, within the host power budget. Do these steps after the bus is initialized according to A.6.1 Bus initialization.

- a. Bus testing procedure
- 25. Send CMD19
- 26. Send a block of data, over all the bus data lines, with the data pattern as follows (CRC16 is optional):
  - 26.1-For 8 data lines the data block would be (MSB to LSB): 0x0000\_0000\_0000\_AA55
  - 26.2-For 4 data lines the data block would be (MSB to LSB): 0x0000\_005A
  - 26.3-For only 1 data line the data block would be: 0x80

### A.6.3 Changing the data bus width (cont'd)

**Table 200 — Bus testing for eight data lines**

	Start	Test Pattern								Optional	End
DAT7	0	0	1	0	0	0	0	0	0	CRC16	1
DAT6	0	1	0	0	0	0	0	0	0	CRC16	1
DAT5	0	0	1	0	0	0	0	0	0	CRC16	1
DAT4	0	1	0	0	0	0	0	0	0	CRC16	1
DAT3	0	0	1	0	0	0	0	0	0	CRC16	1
DAT2	0	1	0	0	0	0	0	0	0	CRC16	1
DAT1	0	0	1	0	0	0	0	0	0	CRC16	1
DAT0	0	1	0	0	0	0	0	0	0	CRC16	1
		LSB 0x55	0xAA	0x00	0x00	0x00	0x00	0x00	MSB 0x00		

**Table 201 — Bus testing for four data lines**

	Start	Test Pattern								Optional	End
DAT3	0	0	1	0	0	0	0	0	0	CRC16	1
DAT2	0	1	0	0	0	0	0	0	0	CRC16	1
DAT1	0	0	1	0	0	0	0	0	0	CRC16	1
DAT0	0	1	0	0	0	0	0	0	0	CRC16	1
		LSB 0x5A		0x00		0x00		0x00	MSB 0x00		

**Table 202 — Bus testing for one data line**

	Start	Test Pattern								Optional	End
DAT0	0	1	0	0	0	0	0	0	0	CRC16	1
		0x80									

27. Wait for at least NCR clock cycles before proceeding
28. Send CMD14 and receive a block of data from all the available data lines<sup>5</sup>
  - 28.1-For 8 data lines receive 8 bytes
  - 28.2-For 4 data lines receive 4 bytes
  - 28.3-For 1 data line receive 1 byte
29. XNOR the masked data with the data sent in step 27

---

<sup>5</sup> This represents the host expected values. The Device always responds to CMD19 over all eight DAT lines.

### A.6.3 Changing the data bus width (cont'd)

**Table 203 — XNOR values**

A	B	A XNOR B
0	0	1
0	1	0
1	0	0
1	1	1

30. Mask the result according to the following:
  - 30.1-For 8 data lines the mask is (MSB to LSB): 0x0000\_0000\_0000\_FFFF
  - 30.2-For 4 data lines the mask is (MSB to LSB): 0x0000\_00FF
  - 30.3-For 1 data line the mask is 0xC0
31. The result should be 0 for all. Any other result indicates a problem in the Device connection to the system; in such a case the host must power down the bus and start its error recovery procedure (the definition of error recovery procedures is host dependent and out of the scope of this application note)
  - b. Power and bus-width selection
  32. Choose the width of bus you want to work with
  33. If the power class, for the chosen width, is different from the default power class, send CMD6, and write the POWER\_CLASS byte of the EXT\_CSD with the required power class.
  34. The Device might signal BUSY after CMD6; wait for the Device to be out of BUSY
  35. Send CMD6, writing the BUS\_WIDTH byte of the EXT\_CSD with the chosen bus width. An argument of 0x03B7\_0100 will set a 4-bits bus, an argument 0x03B7\_0200 will set an 8-bit bus.
  36. The bus is ready to exchange data using the new width configuration.

### A.7 Erase-unit size selection flow

The flow chart in Figure 96 shows how the master selects the erase unit size if the master supports the JEDEC MMC Electrical Interface standard v4.3.

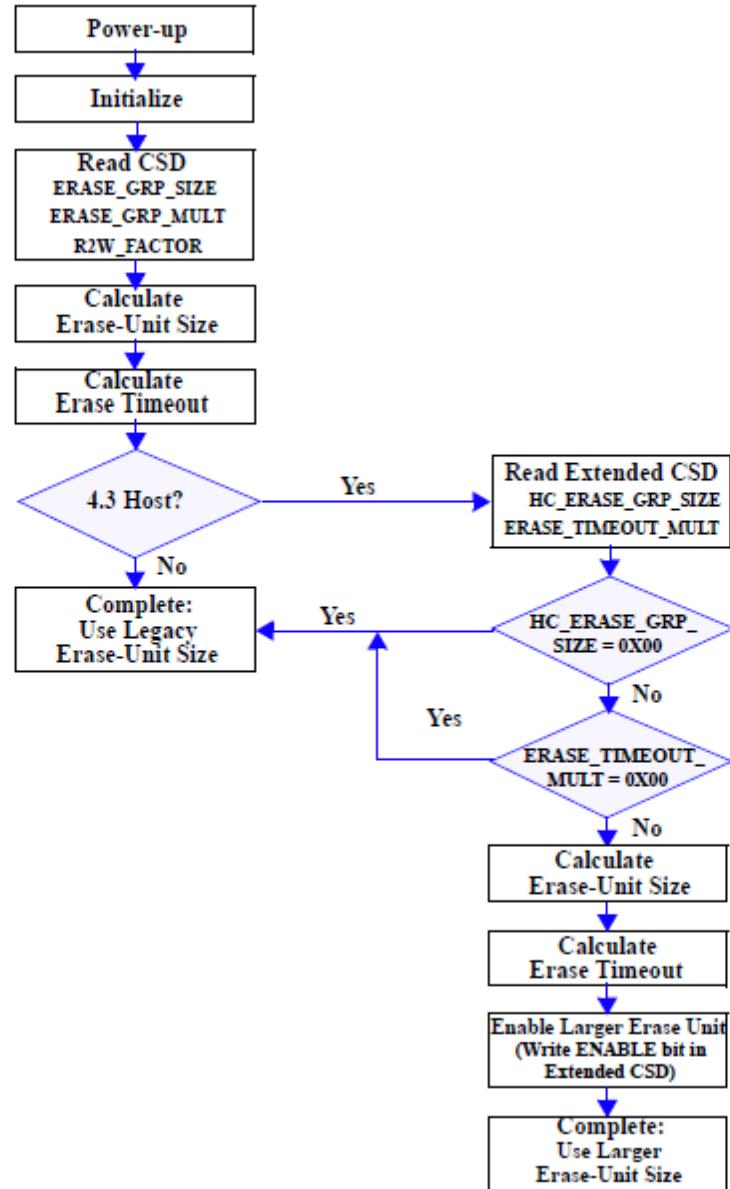


Figure 96 — Erase-unit size selection flow

## A.8 HPI background and one of possible solutions

### 11.1.1 Background - issues with HPI

There are concerns with the High Priority Interrupt (HPI).

One case is when the interruptible operation (e.g., write) is being repeatedly interrupted in order to allow execution of the High Priority Read operations. There is concern that the delaying the write operation for too long time can stall the host system. If it really would be a problem or not is hard to predict because of different system characteristics; different types of applications that will be launched by High Priority Read, different types of applications that might have their write operations interrupted, different timing of the systems, etc.

Another case is when a process with high priority has requested a write operation and a process with lower priority has requested a new code page, and in the case that the write operation is being interrupted by the HPI, we are facing a priority violation against the intention of the scheduling defined in the system.

### 11.1.2 One of possible solutions

There might be different solutions to resolve the observed issues with the HPI.

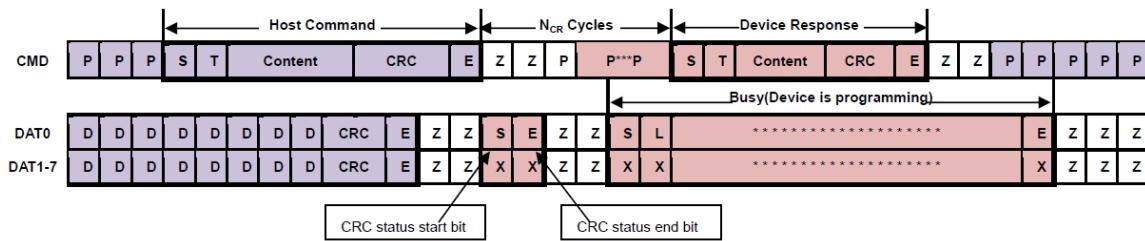
One of possible solutions to the observed issues is to resolve a conflict at the host by letting the write operation come through when a dedicated timer has been expired. With an adjustable timeout value depending on the context, flexibility is gained making it possible to adopt the method for different needs.

Using the following examples, a possible method is explained for the two most interesting use cases. Assume that we want to protect the write commands not being delayed by more than 1s after the write command has been originally sent to the memory device. In such case we need to set the timeout value 1s for each write command. A timer will be started when the write command has been sent to the memory device. If HPI is requested while the write command is still ongoing, the driver in the host will check the timer value. If the timer value has expired compared to the timeout (1s), the HPI will not be able to interrupt the write command. On the other hand, if the timer value is lower than the timeout (1s), then the HPI will interrupt the write operation and the requested read operation will be provided. When the write operation has finally been concluded, the timer will be reset.

Assume another case, protecting high priority write operations in Linux. When a write operation has been requested, the check will be made of the priority of the process that has requested this operation. If it is a real time process or a kernel process, the timeout value will be set to zero and a timer will be started in the same way as in the example above. If HPI is requested while the write command is still ongoing, the driver in the host will check the timer value. The timer value will be checked towards the timeout (0s), indicating the expiration of the timer that means that the write command will never be interrupted. When the write operation has been concluded, the timer will be reset.

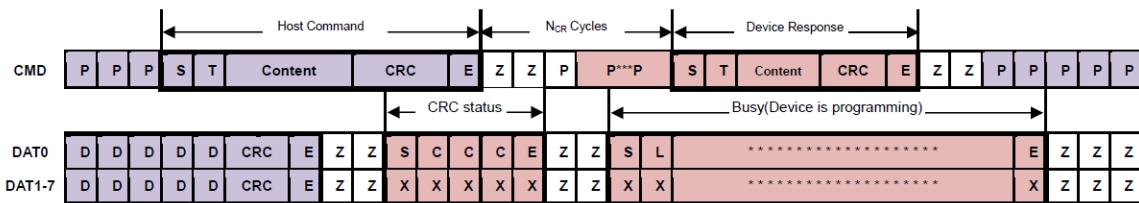
### A.9 Stop transmission timing

Previous versions of the e•MMC spec did not describe the timing of the stop command in all different device states. Also, they did not fully specify whether the received block is valid, after the stop command is received, for all cases. The following section is intended to clarify this behavior for future designs. However, since these clarifications did not exist for previous versions of the spec not all devices may adhere to this clarification. It is for this reason that a host should take the necessary precautions to ensure that the STOP command functions as expected in its design and should not rely on the following behavior. Figure 97 describes busy signal timing of the stop command just before CRC status transfer from the device. Considering backward compatibility, the end bit of CRC status is followed by two Z clock cycles even the device doesn't need two Z bits between CRC status and busy signal. This behavior is based on Figure 42-Stop transmission during CRC status transfer from the device. However, some devices may not to adhere to Figure 97. It is for this reason that a host should ensure behavior of the device and is recommended to indicate busy signal 4 clock cycles after STOP command.



**Figure 97 — Stop transmission just before CRC status transfer from the device**

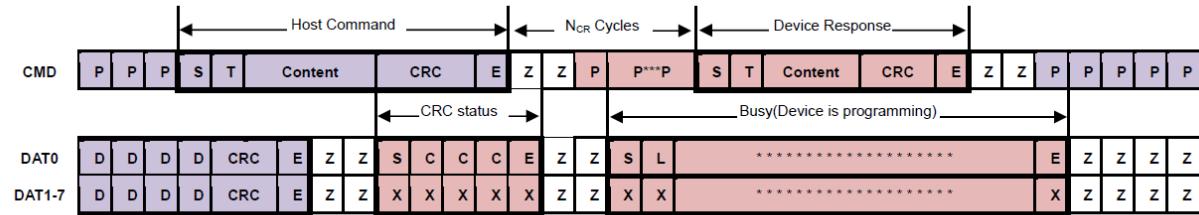
Figure 98 and Figure 99 describe data block validity. End bit which is followed 2 clock cycles after STOP command on Figure 98 follows CRC status, however, device considers CRC status is interrupted. For this reason, the received data block on Figure 98 is considered incomplete and will not be programmed.



**Figure 98 — Stop transmission during CRC status transfer from the device**

### A.9 Stop transmission timing (cont'd)

The received data block on Figure 99 is considered complete and the device will program it.



**Figure 99 — Stop transmission during CRC status transfer from the device**

NOTE For Stop transmission in HS200 Mode, the time from the End bit of Stop transmission until the Busy starts (named Nsb-a) may vary. Please refer to 6.15.8, "Timing Changes in HS200 Mode", for further info on HS200 case."

### A.10 Temperature Conditions per Power Classes (Tcase controlled)

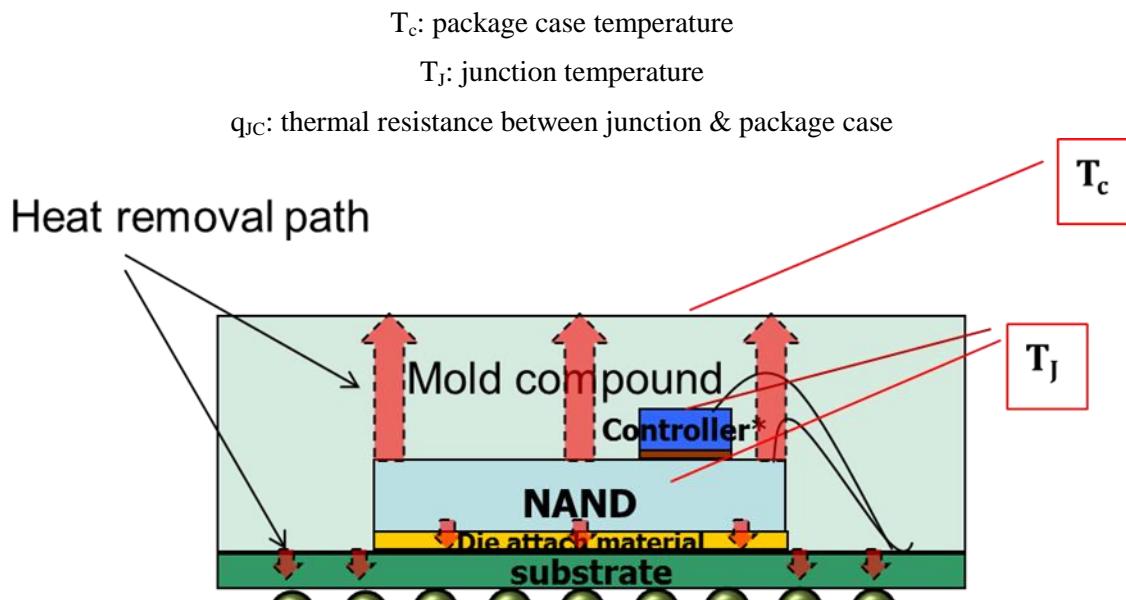
Increasing e•MMC performance increases the heat generated by the device.

Simulation data of future e•MMC devices operating in higher performance shows:

- a. Memory and controller junction temperature may exceed its maximum allowed limit for silicon device operation if natural air convection is relied upon as the only means of heat removal and Ambient Temperature limit is the only given standard spec parameter
- b. In addition, system level solution designed by host manufactures, such as removing heat from the top surface of the package, is required to improve the thermal management challenge

In order to enable more efficient system solution utilizing high speed operations following set of package case temperature per different current consumptions is defined.

It is assumed that Device vendors may specify in data sheets the Max performance supported per certain Power Class and condition the maximum available performance upon system solution that conforms to the Tc temperatures given in Table 204 — . Hosts that conform to the given table shall set the TCASE\_SUPPORT bits in the EX\_CSD register. If TCASE\_SUPPORT bits are not set(= “00”) device may limit its maximum performance levels as a self protection mechanism.



**Figure 100 — Heat Removal - Nomenclatures**

Heat path through conduction from solder-balls into PCB will be dependent upon the host PCB designs.

Two cases were assumed:

- Heat removal through package case is the main path
- Heat removal is 50% through case and 50% through Balls/PCB.

#### A.10 Temperature Conditions per Power Classes (T<sub>case</sub> controlled) (cont'd)

Table 204 — provides set of T<sub>c</sub> temperatures for the various power class current levels.

Package surface to be held at or below the T<sub>c</sub> temperature shown for given current consumption.

Having T<sub>c</sub> defined provides a reference for Device manufacturers and Host vendors assuming that each will take its own responsibility on the following:

- Memory Device Vendors: Making thermally efficient packages: Assuring the storage device junction temp never to exceed its maximum T<sub>j</sub> as long as T<sub>c</sub> is kept per e•MMC spec Table 204 —
- Host Vendors: Efficient cooling system to assure that the package case temp never exceeds the T<sub>c</sub> as defined in Table 204 — .

**Table 204 — Package Case Temp (T<sub>c</sub>) per current consumption**

Max RMS Current (mA)	100	150	200	250	300	350	400	450
Pkg Case Temp T <sub>c</sub> (°C) for Standard Package Type "14x18" & "12x16"								
Heat relief through package case : 100%	85	85	85	85	75	75	75	75
Heat relief through Balls/PCB : 0%								
Heat relief through package case : 50%	85	85	85	85	85	85	85	85
Heat relief through Balls/PCB : 50%								

NOTE Packages types are as defined in JEDEC document MO-276D. "14x18" = Package type "AC" and "12x16" = Package type "AA"

### A.11 Handling write protection for each boot area individually

The following steps describe how to enable power-on write protection to a boot area when the other boot area is permanently write protected.

- When permanent write protection was applied to BOOT Area 2, BOOT\_WP register would be like below:

<b>Bit 7</b>	<b>Bit 6</b>	<b>Bit 5</b>	<b>Bit 4</b>	<b>Bit 3</b>	<b>Bit 2</b>	<b>Bit 1</b>	<b>Bit 0</b>
B_SEC_WP_SEL	B_PWR_WP_DIS	Reserved	B_PERM_WP_DIS	B_PERM_WP_SEC_SEL	B_PERM_WP_EN	B_PWR_WP_SEC_SEL	B_PWR_WP_EN
1	0	x	0	1	1	0	0

- According to 7.4.49, some bits of BOOT\_WP register can only be written once per power cycle, the device power shall be turned off and on again to apply write protection to the other Boot area. BOOT\_WP register value would be like below after power cycle:

<b>Bit 7</b>	<b>Bit 6</b>	<b>Bit 5</b>	<b>Bit 4</b>	<b>Bit 3</b>	<b>Bit 2</b>	<b>Bit 1</b>	<b>Bit 0</b>
B_SEC_WP_SEL	B_PWR_WP_DIS	Reserved	B_PERM_WP_DIS	B_PERM_WP_SEC_SEL	B_PERM_WP_EN	B_PWR_WP_SEC_SEL	B_PWR_WP_EN
0	0	x	0	0	1	0	0

The host should take notice that B\_SEC\_WP\_SEL(bit 7) and B\_PERM\_WP\_SEC\_SEL(bit3) turned to zero as they are type R/W/C\_P.

- In order to apply power-on write protection to BOOT Area 1, following values shall be set:

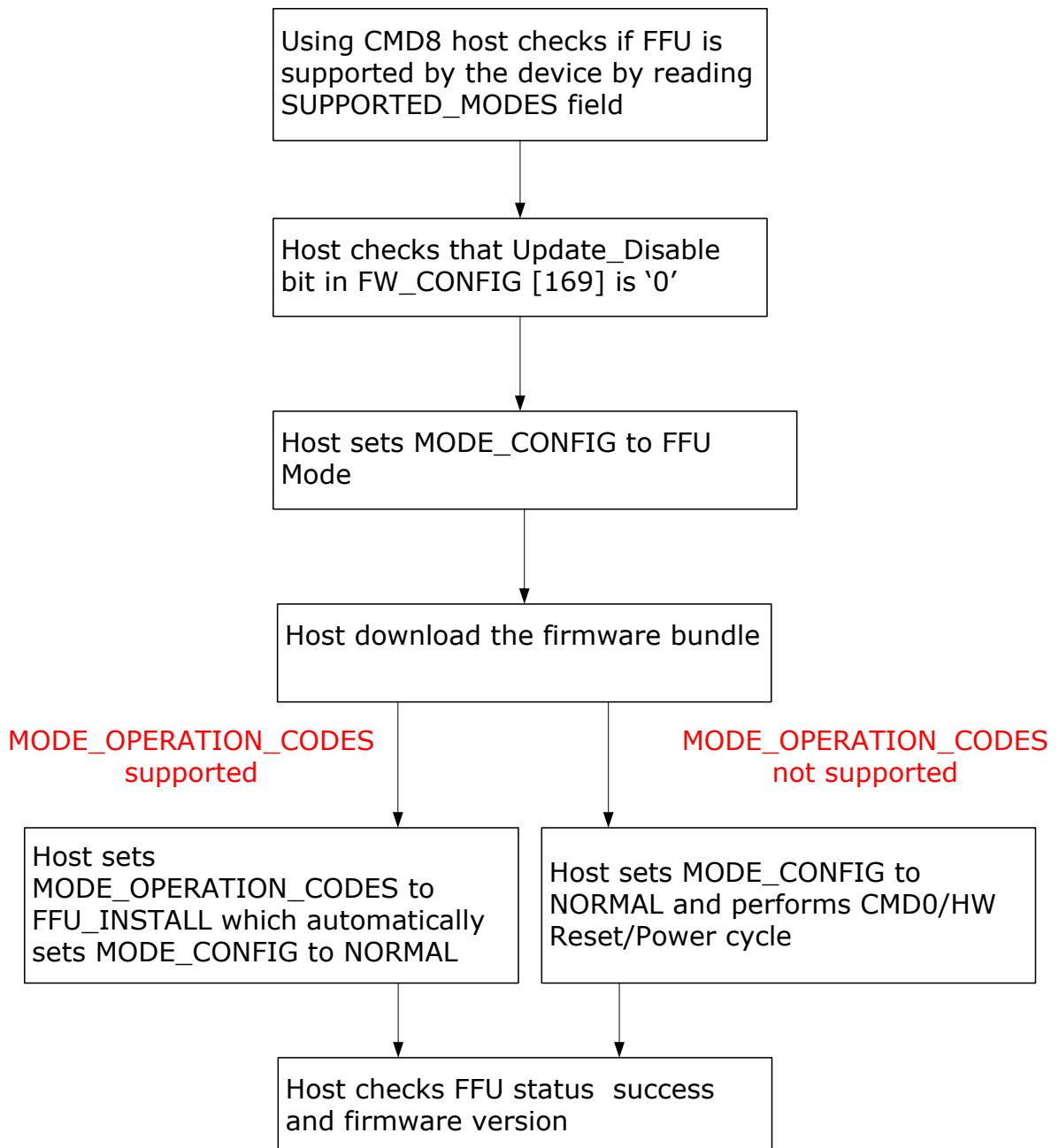
<b>Bit 7</b>	<b>Bit 6</b>	<b>Bit 5</b>	<b>Bit 4</b>	<b>Bit 3</b>	<b>Bit 2</b>	<b>Bit 1</b>	<b>Bit 0</b>
B_SEC_WP_SEL	B_PWR_WP_DIS	Reserved	B_PERM_WP_DIS	B_PERM_WP_SEC_SEL	B_PERM_WP_EN	B_PWR_WP_SEC_SEL	B_PWR_WP_EN
1	0	x	0	1	1	0	1

When trying to independently power-on write protect the other boot partition, the configuration of bit3 in EXT\_CSD173 is required to be in agreement with the value read back from BOOT\_WP\_STATUS[174].

Especially in this case, Boot Area 2 was previously permanently write protected, two bits B\_SEC\_WP\_SEL(bit7) and B\_PERM\_WP\_SEC\_SEL(bit3) must be set. Otherwise, both Boot areas will be permanent write protected unintentionally.

## A.12 Field Firmware Update

The following flow describes the positive oriented FFU flow.



## Annex B (informative) Changes between system specification versions

---

### B.1. Version 4.1, the first version of this standard

This Electrical Standard is derived from the MMCA System Specification version 4.1. There are no technical changes made. The editorial changes are listed below.

- The pin number references were removed.
- The form factor references were removed.
- The CSD\_STRUCTURE and SPEC\_VERS registers were modified to include only allocations applicable to this Electrical standard.
- The S\_CMD\_SET allocations were removed from this standard and are defined in detail in a separate Application Note.
- The mechanical standard was removed.
- The Appendix A was removed and introduced as a separate document.

### B.2. Changes from version 4.1 to 4.2

A major new item is handling densities greater than 2GB.

Additional changes include:

- A definition for implementation of media higher than 2GB was introduced.
- The definition for the Device pull-up resistors was clarified.
- Switching between the tran state and standby states by CMD7 was clarified.
- A new register for indication of the state of an erased block was introduced.
- Command CMD39 argument was clarified.
- The definition of busy indication during write operations was partly changed and partly clarified.
- The minimum voltage of the Low-Voltage range was changed from 1.65V to 1.70V.

### B.3. Changes from version 4.2 to 4.3

- Major new items added to this standard are the *e*MMC definition, boot operation, sleep mode, voltage configuration for *e*MMC, and reliable write. The chapter dedicated to SPI mode was removed. Additional changes include:
  - Added new *e*MMC features to the feature list.
  - Boot operation mode was introduced.
  - Sector address definition for Erase and Write Protection was defined.
  - CID register setting was changed to recognize either *e*MMC or a Device.
  - The chapter defining SPI mode and all SPI-mode references were removed.
  - Sleep mode was introduced.
  - Voltage configuration for *e*MMC was defined.
  - Reliable Write was defined.
  - Input capacitance for *e*MMC was defined.
  - New bus timings (setup & Hold) were redefined.

- Switch command definition was clarified.
- Peak voltage on all signal lines are redefined for Device and defined for *e*MMC.
- Redefined Access size register.
- Redefined input capacitance for MMC*micro*, MMC*mobile*, and MMC*plus*.
- Redefined erase-unit size and erase timeout for high-capacity memory.
- Removed “Absolute Minimum” section formerly 4.8.2.
- Defined OCR setting and response for *e*MMC.
- Defined high-capacity WP group size.
- Alternative boot operation (device-optional) introduced.
- Added “/JEDEC” to “MMCA” as the source of definitions for MID and OID.

#### B.4. Changes from version 4.3 to 4.4

- Major new items added to this standard are the Dual Data Rate mode, Multiple Partition Supports and Security Enhancement. Additional changes include:
- Introduce of Partition Management features with enhanced storage option.
- Add *Pre-idle* reset arguments at CMD0.
- Clarify CMD1 for Voltage Operation Range and Access mode validation.
- Introduce of New Secure Features, Replay Protected Memory Block.
- Introduce of dual data rate interface with maximum 104MB/s.
- Introduce of Secure Erase, Secure TRIM.
- Introduce of TRIM
- Introduce of New Time value for Secure Erase, Trim.
- Enhancement of write protection with H/W reset and non-reversible register setting.
- Introduce of Replay Protected Memory Block and access control.
- Alternative boot operation was changed as mandatory for device instead of device-optional.
- Introduce of H/W reset signal.
- Introduce New Extended CSD registers.
- Clarify maximum density calculation from SEC\_COUNT.
- Clarify of tOSU timing for compatibility.

#### B.5. Changes from version 4.4 to 4.41

- Major new items assed to this standard are the Background Operations and High Priority Interrupt. Additional changes include:
- Added clarification for command operation in RPMB partition.
- Added clarification of address sequence for user area including enhanced area and error condition for partition configuration.
- Added clarification for error behavior when partition is configured without setting ERASE\_GROUP\_DEF and clarification for the device behavior in case the device received a write/erase command when the condition of ERASE\_GROUP\_DEF bit has been changed from the previous power cycle.
- Add a clarification for C\_SIZE and SEC\_COUNT after configuring partitions.
- Added Clarification for the configuration of boot and alternative boot operation.
- Introduce of Enhanced Reliable Write.

- Added clarification for LOCK\_UNLOCK feature of the *e*MMC.
- Introduce of Background Operations.
- Introduce of High Priority Interrupt mechanism, HPI background and one of possible solutions.
- Introduce New Extended CSD registers.
- Corrected equation of General purpose partition size and Enhanced user data area size.
- Removed “File formats for the e.MMC” section formerly section 14.

#### B.6. Changes from version 4.41 to 4.5

- Removed references to cards in the spec and made an embedded only spec
- Removed stream write and read
- Removed secure erase and Secure trim
- Added HS200 mode
- Added *e*<sup>2</sup>MMC which supports 2 additional internal voltage nodes and the optional cache command.
- Added the Discard command
- Added the Sanitize command
- Added enhance host and device communication techniques to improve Performance:
  - Extended partition types
  - Packed commands
  - Context IDs
  - Data Tag
- Added Enhance host and device communication techniques to improve Reliability: real time clock and dynamic device capacity
- Added Thermal Specification and Package Case Temperature
- Allocated a region for vendor specific registers
- Provided a path to move from a minimum 512 B access to a minimum 4 KB access
- Updated boot protection to allow boot area protection to be set independently
- Clarified operation for:
  - DDR timing for CRC status, boot acknowledge, start bit and end bit timing
  - Boot diagram
  - CID and CSD in DDR mode
  - Lock/unlock command password replacement
  - Stop transmission
  - RPMB
  - Resistor value in 1.2 V mode
  - SDR voltage range
- Removed “Errata” Annex B

#### B.7. Changes from version 4.5 to 4.51

- Added Extended Security Commands
- Re-introduced Secure Erase and Secure Trim
- Clarification on *e*<sup>2</sup>MMC
- Clarified boot bus width retain behavior
- Editorial Clarifications on Context ID, Packet commands, Correctly Programmed Sector Count, Cache, Driver Strength, Illegal commands

### B.8. Changes from version 4.51 to 5.0

- Introduced of HS400
  - Data Strobe Line
- Introduced Production State Awareness
- Introduced Field Firmware Update
- Added Sleep Notification in Power Off Notification
- Introduced Device Health Report
- Added Secure Removal Type
- Added overshoot and undershoot
- Added reference load for HS400
- Added pre-amble and post-amble
- Clarified RPMB address failure on Read operation.
- Clarified I/O timing values
- Edit to support Ver.5.0 in EXT\_CSD\_REV[192]
  - Note: A host system should work properly considering future eMMC version. For example, a host system is expected not to exit only due to the EXT\_CSD\_REV[192] value greater than 7 which will be used for next *e*MMC revision.”





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**Standard Improvement Form****JEDEC**

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The purpose of this form is to provide the Technical Committees of JEDEC with input from the industry regarding usage of the subject standard. Individuals or companies are invited to submit comments to JEDEC. All comments will be collected and dispersed to the appropriate committee(s).

If you can provide input, please complete this form and return to:

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**1. I recommend changes to the following:**

Requirement, clause number \_\_\_\_\_

Test method number \_\_\_\_\_ Clause number \_\_\_\_\_

The referenced clause number has proven to be:

Unclear  Too Rigid  In Error

Other \_\_\_\_\_

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**2. Recommendations for correction:**  
\_\_\_\_\_  
\_\_\_\_\_  
\_\_\_\_\_

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**3. Other suggestions for document improvement:**  
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\_\_\_\_\_  
\_\_\_\_\_

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**Submitted by**

Name: \_\_\_\_\_

Phone: \_\_\_\_\_

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City/State/Zip: \_\_\_\_\_

Date: \_\_\_\_\_

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